



IO-Link

Test Specification

D1.1.4

**Related to
IO-Link Interface and System
Specification V1.1.4**

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Version D1.1.4 based on Intermediate I1.1.3A as well as Change Requests 17 to 123 from AK-Test WG. The causing change request is referenced via yellow text marks -CRxxx-. By default, a change request in "Implementation" can only cover bug fixes in technical or editorial aspects, or clarifications in case of ambiguity of definitions.

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Publisher:

IO-Link Community

Ohiostrasse 8

76149 Karlsruhe

Germany

Phone: +49 721 / 98 61 97 0

Fax: +49 721 / 98 61 97 11

E-mail: info@io-link.com

Web site: www.io-link.com

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0 Introduction

0.1 General

This document together with its parent IEC 61131-9 is part of a series of standards on programmable controllers and the associated peripherals and should be read in conjunction with the other parts of the series.

IEC 61131-9 specifies the Single-Drop digital Communication Interface (IO-Link™¹) technology as a generic interface for connecting digital/analog sensors and actuators to a Master unit, which may be combined with gateway capabilities to become a fieldbus remote I/O node.

The SDCI physical interface is backward compatible with the usual 24 V I/O signalling specified in IEC 61131-2 and allows in addition digital point-to-point communication at transmission rates of 4,8 kbit/s, 38,4 kbit/s and 230,4 kbit/s.

The SDCI technology specifies parameterization, cyclic exchange of process data, and diagnosis as well as parameter Data Storage capabilities.

This subpart specifies the test cases and associated test environments for SDCI Master and Devices designed and developed according to IEC 61131-9. It provides the necessary preconditions for conformity testing to ensure interoperability and enables manufacturers of Master and Devices to sign a corresponding conformity declaration.

The structure of this document is described in clause 4.2.

Where a conflict exists between this and other IEC standards (except basic safety standards), the provisions of this standard should be considered to govern in the area of programmable controllers and their associated peripherals.

Conformity with IEC 61131-9 cannot be claimed unless the requirements of this document are fulfilled.

Terms of general use are defined in IEC 61131-1 or in the IEC 60050 series. More specific terms are defined in each part.

0.2 Patent declaration

There are no known patents related to the content of this document.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. The IO-Link Community shall not be held responsible for identifying any or all such patent rights.

¹ IO-Link™ is a trade name of the "IO-Link Community". Compliance to this standard does not require use of the registered logos for IO-Link™. Use of the registered logos for IO-Link™ requires permission of the "IO-Link Community".

1 PROGRAMMABLE CONTROLLERS —

2 **Test specification for Master and Devices according to IEC 61131-9** 3 **(Single-drop Digital Communication Interface - SDCI)**

6 **1 Scope and objectives**

7 The single-drop digital communication interface (SDCI) technology described in part 9 of the
8 IEC 61131 series focuses on simple sensors and actuators in factory automation, which are
9 nowadays using small and cost-effective microcontrollers. With the help of the SDCI technology,
10 the existing limitations of traditional signal connection technologies such as switching 0/24 V,
11 analog 0 to 10 V, etc. can be turned into a smooth migration. Classic sensors and actuators are
12 usually connected to a fieldbus system via input/output modules in so-called remote I/O peripherals.
13 The (SDCI) Master function enables these peripherals to map SDCI Devices onto a
14 fieldbus system or build up direct gateways. Thus, parameter data can be transferred from the
15 PLC level down to the sensor/actuator level and diagnosis data transferred back in turn by
16 means of the SDCI communication. This is a contribution to consistent parameter storage and
17 maintenance support within a distributed automation system. SDCI is compatible to classic sig-
18 nal switching technology according to part 2 of the IEC 61131 series.

19 This subpart specifies the test cases and associated test environments for Master and Devices
20 designed and developed according to [7]. The objectives for the specification have been to

- 21 • provide a test coverage guaranteeing interoperability of Master and Device,
- 22 • protect Master and Devices from destruction or disturbance through operation with partner
23 devices,
- 24 • enable manufacturers of Master and Devices to sign a corresponding "manufacturer decla-
25 ration".

26 It was not an objective, to care for

- 27 • Interoperability of Master-Tools and Master,
- 28 • Test of the specific technology of a Device (for example profile tests),
- 29 • Stress test of multiple Master Port operations,
- 30 • Compliance with standards except for EMC.

31 **2 Normative references**

32 The following referenced documents are indispensable for the application of this document. For
33 dated references, only the edition cited applies. For undated references, the latest edition of
34 the referenced document (including any amendments) applies.

35 IEC 60947-5-2, *Low-voltage switchgear and controlgear – Part 5-2: Control circuit Devices and*
36 *switching elements – Proximity switches*

37 IEC 61131-2, *Programmable controllers – Part 2: Equipment requirements and tests*

38 IEC 61131-9, *Programmable controllers – Part 9: Single-drop digital communication interface*
39 *for small sensors and actuators (SDCI)*

40 **3 Terms, definitions, symbols, abbreviated terms and conventions**

41 **3.1 Terms and definitions**

42 For the purposes of this document, the following terms and definitions in addition to those given
43 in IEC 61131-1, IEC 61131-2, and IEC 61131-9 apply.

44 3.1.1**45 address**

46 part of the M-sequence control to reference data within data categories of a communication
47 channel

48 3.1.2**49 application layer (AL)**

50 <SDCI> part of the protocol responsible for the transmission of Process Data objects and On-
51 Request Data objects

52 3.1.3**53 block parameter**

54 consistent parameter access via multiple Indices or Subindices

55 3.1.4**56 checksum**

57 <SDCI> complementary part of the overall data integrity measures in the data link layer in ad-
58 dition to the UART parity bit

59 3.1.5**60 CHKPDU**

61 integrity protection data within an ISDU communication channel generated through XOR pro-
62 cessing the octets of a request or response

63 3.1.6**64 coded switching**

65 SDCI communication, based on the standard binary signal levels of IEC 61131-2

66 3.1.7**67 COM1**

68 SDCI communication mode with transmission rate of 4,800 kbit/s

69 3.1.8**70 COM2**

71 SDCI communication mode with transmission rate of 38,400 kbit/s

72 3.1.9**73 COM3**

74 SDCI communication mode with transmission rate of 230,400 kbit/s

75 3.1.10**76 COMx**

77 one out of three possible SDCI communication modes COM1, COM2, or COM3

78 3.1.11**79 communication error**

80 unexpected disturbance of the SDCI transmission protocol

81 3.1.12**82 cycle time**

83 time to transmit a frame between a Master and its Device including the following idle time

84 3.1.13**85 communication channel**

86 logical connection between Master and Device

87 NOTE Four communication channels are defined: process channel, page and ISDU channel (for parameters) and
88 diagnostic channel.

89 3.1.14**90 Device**

91 single passive peer to a Master such as a sensor or actuator

92 NOTE Uppercase "Device" is used for SDCI equipment, while lowercase "Device" is used in a generic manner.

- 93 **3.1.15**
94 **direct parameters**
95 directly (page) addressed parameters transferred acyclically via the page communication chan-
96 nel without acknowledgement
- 97 **3.1.16**
98 **dynamic parameter**
99 part of a Device's parameter set defined by on-board user interfaces such as teach-in buttons
100 or control panels in addition to the static parameters
- 101 **3.1.17**
102 **event**
103 an instance of a change of conditions
- 104 NOTE An event is indicated via the event flag within the Device's status cyclic information, then acyclic transfer of
105 event data (typically diagnostics information) is conveyed through the diagnostic communication channel.
106 [IEC 61158-5-x, modified]
- 107 **3.1.18**
108 **fallback**
109 transition of a port from coded switching to switching signal mode
- 110 **3.1.19**
111 **framing error**
112 perturbed UART frames (physical layer)
- 113 **3.1.20**
114 **interleave**
115 segmented cyclic data exchange for process data with more than 2 octets through subsequent
116 cycles
- 117 **3.1.21**
118 **ISDU**
119 indexed service data unit used for acyclic acknowledged transmission of parameters that can
120 be segmented in a number of M-sequences
- 121 **3.1.22**
122 **Legacy-Device**
123 Device developed according to version V1.0 [5], the predecessor of [1]
- 124 **3.1.23**
125 **Legacy-Master**
126 Master developed according to version V1.0 [5], the predecessor of [1]
- 127 **3.1.24**
128 **Master**
129 active peer connected through ports to one up to n Devices and which provides an interface to
130 the gateway to the upper-level communication systems or PLCs
- 131 NOTE Uppercase "Master" is used for SDCI equipment, while lowercase "Master" is used in a generic manner.
- 132 **3.1.25**
133 **message**
134 <SDCI> coherent set of data octets transferred either from a Master to its Device or vice versa
135 following the rules of the SDCI protocol
- 136 **3.1.26**
137 **M-sequence**
138 sequence of two messages comprising a Master message and its subsequent Device message
- 139 **3.1.27**
140 **M-sequence control**
141 first octet in a Master message indicating the read/write operation, the type of the communica-
142 tion channel, and the address, for example offset or flow control

3.1.28**M-sequence error**

unexpected or wrong message content, or no response

3.1.29**M-sequence type**

one particular M-sequence format out of a set of specified M-sequence formats

3.1.30**on-request data**

acyclically transmitted data upon request of the Master application consisting of parameters or event data

3.1.31**PHY-3W (IEC 61131-9 → 3-wire system)**

three wire connection to Devices for power, ground, communication and/or switching signals defined in IEC 60947-5-2

3.1.32**physical layer**

part of the communication protocol concerned with transmitting raw bits over a communication channel

NOTE Physical layer provides means for wake-up and fallback procedures.

3.1.33**port**

communication medium interface of the Master to one Device

3.1.34**port operating mode**

state of a Master's port that can be either INACTIVE, DO, DI, SDCI, or ScanMode

3.1.35**process data**

input or output values from or to a discrete or continuous automation process cyclically transferred with high priority and in a configured schedule automatically after start-up of a Master

3.1.36**process data cycle**

complete transfer of all process data from or to an individual Device that may comprise several cycles in case of segmentation (interleave)

3.1.37**single parameter**

independent parameter access via one single Index or Subindex

3.1.38**SIO**

port operation mode in accordance with digital input and output defined in IEC 61131-2 that is established after power-up or fallback or unsuccessful communication attempts

3.1.39**static parameter**

part of a Device's parameter set to be saved in a Master for the case of replacement without engineering tools

3.1.40**switching signal**

binary signal from or to a Device when in SIO mode (as opposed to the "coded switching" SDCI communication)

191 **3.1.41**
192 **system management (SM)**
193 <SDCI> means to control and coordinate the internal communication layers and the exceptions
194 within the Master and its ports, and within each Device

195 **3.1.42**
196 **UART frame**
197 <SDCI> bit sequence starting with a start bit, followed by eight bits to carry a data octet, fol-
198 lowed by an even parity bit and ending with one stop bit

199 **3.1.43**
200 **wake-up**
201 procedure for causing a Device to change its mode from SIO to SDI

202 **3.1.44**
203 **wake-up request (WURQ)**
204 physical layer service used by the Master to initiate wake-up of a Device, and put it in a receive
205 ready state

206 **3.2 Symbols and abbreviated terms**

| | |
|-------------------|---|
| ΔfDTR | Permissible deviation from data transfer rate, measured in % |
| ΔPS | Power supply ripple, measured in V |
| AL | Application Layer |
| BEP | Bit error probability |
| C/Q | Connection for communication (C) or switching (Q) signal (SIO) |
| CL _{eff} | Effective total cable capacity, measured in nF |
| CQ | Input capacity at C/Q connection, measured in nF |
| DI | Digital input |
| DL | Data Link Layer |
| DO | Digital output |
| PPP1 | Direct Parameter Page 1 |
| PPP2 | Direct Parameter Page 2 |
| DTU | Device tester unit |
| fDTR | Data transfer rate, measured in bit/s |
| H/L | High/low signal at receiver output |
| ICS | Current sink for testing |
| I/O | Input / output |
| ILL | Input load current at input C/Q to V ₀ , measured in A |
| IQ | Driver current in saturated operating status ON, measured in A |
| IQH | Driver current on high-side driver in saturated operating status ON, measured in A |
| IQL | Driver current on low-side driver in saturated operating status ON, measured in A |
| IQPK | Maximum driver current in unsaturated operating status ON, measured in A |
| IQPKH | Maximum driver current on high-side driver in unsaturated operating status ON, measured in A |
| IQPKL | Maximum driver current on low-side driver in unsaturated operating status ON, measured in A |
| IQQ | Quiescent current at input C/Q to V ₀ with inactive output drivers, measured in A |
| IQWU | Amplitude of Master's wake-up request current, measured in A |
| IS | Supply current at V+, measured in A |
| ISIR | Current pulse supply capability at V+, measured in A |

| | |
|-------------------------|---|
| LED | Light emitting diode |
| L- | Ground connection |
| L+ | Power supply connection |
| MTU | Master tester unit |
| NRZ | Non return to zero |
| nwu | Wake-up retry count |
| On/Off | Driver's ON/OFF switching signal |
| ON-REQ | On-request data |
| OVD | Signal Overload Detect |
| PDCT | Port and Device configuration tool |
| PL | Physical layer |
| PLC | Programmable logic controller |
| PLT | Physical layer test equipment |
| PS | Power supply, measured in V |
| PSM | Power supply of the Master ("24 V" mains or other) |
| r | Time to reach a stable level with reference to the beginning of the start bit, measured in TBIT |
| RL _{eff} | Loop resistance of cable, measured in Ω |
| s | Time to exit a stable level with reference to the beginning of the start bit, measured in TBIT |
| SDCI | Single-drop digital communication interface |
| SIO | Standard Input Output (digital switching mode) |
| SM | System Management |
| t ₁ | Character transfer delay on Master, measured in TBIT |
| t ₂ | Character transfer delay on Device, measured in TBIT |
| t _A | Response delay on Device, measured in TBIT |
| TBIT | Bit time, measured in s |
| t _{CYC} | Cycle time on M-sequence level, measured in s |
| t _{DF} | Fall time, measured in s |
| T _{DMT} | Delay time while establishing Master port communication, measured in TBIT |
| t _{DR} | Rise time, measured in s |
| T _{DSIO} | Delay time on Device for transition to SIO mode following wake-up request, measured in s |
| T _{DWU} | Wake-up retry delay, measured in s |
| t _{M-sequence} | M-sequence duration, measured in TBIT |
| t _{idle} | Idle time between two M-sequences, measured in s |
| t _H | Detection time for high level, measured in s |
| t _L | Detection time for low level, measured in s |
| t _{ND} | Noise suppression time, measured in s |
| T _{OFS} | Temporal offset for process data processing on the Device with reference to start of cycle, measured in s |
| T _{PON} | Ramp-up time following power ON, measured in s |
| T _{RDL} | Wake-up readiness following power ON, measured in s |
| T _{REN} | Receive enable, measured in s |
| T _{SD} | Device detect time, measured in s |

| | |
|------|--|
| Twu | Pulse duration of wake-up request, measured in s |
| UART | Universal asynchronous receiver transmitter |
| UML | Unified modelling language |
| V+ | Voltage at L+ |
| V0 | Voltage at L- |
| VD- | Voltage drop on the line between the L- connections on Master and Device, measured in V |
| VD+ | Voltage drop on the line between the L+ connections on Master and Device, measured in V |
| VDQ | Voltage drop on the line between the C/Q connections on Master and Device, measured in V |
| VHYS | Hysteresis of receiver threshold voltage, measured in V |
| VI | Input voltage at connection C/Q with reference to V0, measured in V |
| VIH | Input voltage range at connection C/Q for high signal, measured in V |
| VIL | Input voltage range at connection C/Q for low signal, measured in V |
| VRQ | Residual voltage on driver in saturated operating status ON, measured in V |
| VRQH | Residual voltage on high-side driver in operating status ON, measured in V |
| VRQL | Residual voltage on low-side driver in saturated operating status ON, measured in V |
| VTH | Threshold voltage of receiver with reference to V0, measured in V |
| VTHH | Threshold voltage of receiver for safe detection of a high signal, measured in V |
| VTHL | Threshold voltage of receiver for safe detection of a low signal, measured in V |
| WURQ | Wake-up request pulse |

207

208 **3.3 Conventions**209 **3.3.1 Test case template**210 This document uses a dedicated template as shown in Table 1 for the particular test cases. It
211 contains explanations on how to use items in left column.

212

Table 1 – Test case template

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_nnnn (nnnn = 4-digit consecutive number starting with 0001) |
| Name | Characteristic name of the test case (see 3.3.1.1) |
| Purpose (short) | Short description of the purpose of the test case (one line maximum) |
| Equipment under test (EUT) | Master/Master + Port or Device |
| Test case version | Starts with 1.0. Incremented first number indicates significant changes due to new functionality, the second one indicates changes within the test case |
| Category / type | See 3.3.1.2 |
| Specification (clause) | [Bibliography, nn], clause or subclause, figure, table, chart, etc. |
| Configuration / setup | For example, Master-Tester-System (see Figure A.20) shall detect all transmission rates and measure the corresponding delays. It shall not react to the requests. |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Comprehensive description of the purpose of the test case (can be several lines). Shall not contain preconditions or instructions. |
| Precondition | Initial mode of the test set (both EUT and test environment) to be set prior to testing or ID of previous test. Examples: |

213

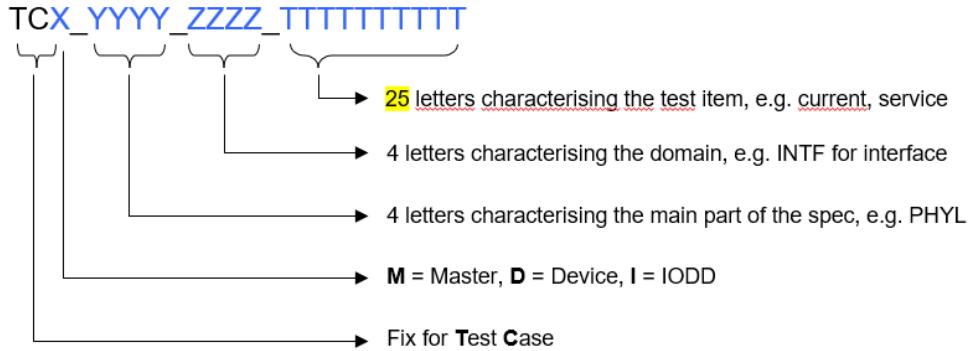
| TEST CASE | CONDITIONS / PERFORMANCE |
|----------------------------|--|
| | <p><i>Tester precondition/Measurement instrument pre-set</i> ... <i>EUT precondition</i> ...</p> |
| Procedure | <ul style="list-style-type: none"> - Step by step description of the test, each step marked by characters a), b), c), etc. - Loops are possible. - "Test step macros" are possible, shall be named "TS_<domain>_xxxx", and defined within the general clause. Examples: <ul style="list-style-type: none"> a) Test step macro α b) Evaluation 1) c) Single instruction d) Evaluation 2) ... |
| Test parameter | <ul style="list-style-type: none"> - Shall be specified using definitions within [7] - Can be identified using A), B), C), etc. - Shall be linked to procedure steps, for example a), b), c), etc. - Test loops can be used as specified in 3.3.1.3 |
| Post condition | Final mode of the EUT and its test environment. It is possible to keep evaluation results as input for subsequent test cases if a certain test case gets too complex. |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | <ul style="list-style-type: none"> - A sequence of steps, where the status of the EUT is checked at each step - Each evaluation step is linked to a procedure step - Each evaluation step to be marked by a numeric character 1), 2), 3), etc. Example: <ul style="list-style-type: none"> 1) Parameter β, Parameter γ, ... 2) Value λ ... |
| Test passed | <ul style="list-style-type: none"> - Approve reaction at each evaluation step whether it is correct ("AND"). - In case of alternate paths are defined, they shall be approved as defined ("OR"). - Approve if deviations can be tolerated as exceptions (see [8]). |
| Test not passed (examples) | Describe incorrect reaction and describe the reasons for failing |
| Report | Create brief data of test results such as measurement values, states, Events, implementation exceptions, test exceptions (see [8]), etc., and if test passed or not passed. Data shall be sufficient for a test certificate (option). |

214

215

216 **3.3.1.1 Name of a test case**

217 Figure 1 shows the structure of the name of a test case.



218

219 **Figure 1 – Structure of the test case name**220 **3.3.1.2 Categories and types of test cases**221 **-CR037-**

222 Table 2 shows the used test case categories within this document.

223

Table 2 – Test case categories

| Category | Definition |
|----------------------------------|--|
| Master PL test | Measure port voltages, currents, and timings |
| Device PL test | Measure Device voltages, currents, and timings |
| Master/Device signal test | Transmission signal testing (eye diagram, UART frame, etc.) |
| Device protocol test | Device protocol test (STARTUP, PREOPERATE, OPERATE) |
| Device ISDU test | Device ISDU protocol test |
| Device Event test | Device Event handling test |
| Device DS test | Device Data Storage test |
| Device/legacy Master test | Device operation on legacy Master |
| Device DPP test | Test of Device's Direct Parameter page handling |
| Device application test | Test of Device's behavior with single parameters |
| Device Block parameter test | Test of Device's behavior with Block parameters |
| IODD parameter verification test | Test of IODD/Device matching in parameter |
| IODD functional system test | Test of IODD/Device matching in function |
| Master protocol test | Master protocol test (timings, STARTUP, PREOPERATE, OPERATE) |
| Master M-sequence test | Test of used Master M-sequence TYPEs (PD and OD) |
| Master robustness test | Test of Master's fallback and retry behavior |
| Master ISDU test | Test of Master's ISDU behavior (error types, limits) |
| Master Event test | Test of Master's Event behavior (error, notification) |
| Master DS test | Test of Master Data Storage mechanisms |
| Master legacy Device test | Test of Master behavior with legacy Device |

224

225 Table 3 shows the used test case types within this document

226

Table 3 – Test case types

| Types | Definition |
|--------------|--|
| Test to pass | Positive test. A function shall perform as specified. Usually, the tests of a domain are beginning with these tests, where no stress is applied. |
| Test to fail | Negative or stress test. A function shall react with a defined behavior, for example an error indication when boundary conditions are exceeded. |

227

228 **3.3.1.3 Use of test loops (TL)**229 One means to reduce the complexity of test case descriptions or the number of test cases is
230 using test loops (procedure iterations).231 Test loops shall be limited to variations of procedure variables listed in field "Test parameter".
232 Branches in test case procedures shall not depend on these variables, e.g. "if variable = xyz
233 then...". Evaluations should be independent from procedure variables.

234 Variations of procedure variables are specified in field "Test parameter" as follows:

| | |
|----------------|-----------------------|
| Test parameter | config = {c1, c2, c3} |
|----------------|-----------------------|

235 That means, the values c1, c2, c3 are sequentially assigned to the procedure variable "Config".
236 Within the procedure steps, the assignment of an actual list value shall be specified as shown
237 in the example below:

| | |
|-----------|---|
| Procedure | e) ... f) Initialize "config" with first value in list g) ... |
|-----------|---|

238 If more than one procedure variable is assigned in the same step, these variables shall be
 239 separated by a comma. A test loop can be specified as shown in the example below:

| | |
|-----------|---|
| Procedure | i) ... j) Repeat from g) with next value in list k) ... |
|-----------|---|

240 A complete example with assignments, evaluations, and test passed is shown below:

| | |
|----------------|--|
| Procedure | a) Assign first value to "mode" b) Assign first values to "config", "voltage" c) Procedure step using "config", "voltage", "mode" if needed d) Acquire results e) Evaluation 1) f) Repeat from c) with next "config", "voltage" g) Repeat from b) with next "mode" |
| Test parameter | config = {c1, c2, c3}, voltage = {18V, 24V, 30V} mode = {mode1, mode2} |
| Evaluation | 1) Check results (should be independent from procedure variables) |
| Test passed | Result1 (mode1, config=c1, voltage=18 V) = conditions for test to pass Result2 (mode1, config=c2, voltage=24 V) = conditions for test to pass Result3 (mode1, config=c3, voltage=30 V) = conditions for test to pass Result4 (mode2, config=c1, voltage=18 V) = conditions for test to pass Result5 (mode2, config=c2, voltage=24 V) = conditions for test to pass Result6 (mode2, config=c3, voltage=30 V) = conditions for test to pass Hint: As shown above, different "test passed" conditions can be necessary if the conditions to pass a test are depending on certain procedure variables. |

241

3.3.1.4 Handling of reports

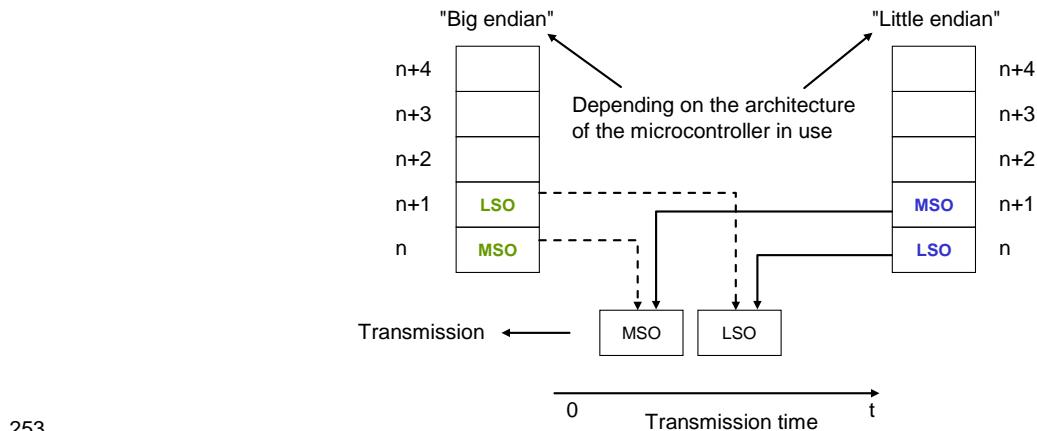
243 Some test case reports require the presentation of measurement values others a flat summary.
 244 Generally, for the designer of tester equipment it is possible to always indicate a flat summary
 245 if all evaluations are positive (passed) and to show details if evaluations are negative.

3.3.2 Names of variables

247 Due to the possible implementation of the test cases in software, all used symbols and abbreviations
 248 in this document (see 3.2) are written in upper case letters without superscript or
 249 subscript.

3.3.3 Memory and transmission octet order

250 Figure 2 demonstrates the order that shall be used when transferring WORD based data types
 251 from memory to transmission and vice versa.



253

254 **Figure 2 – Memory and transmission octet order**

255 **3.3.4 Behavioral descriptions**

256 For the behavioral descriptions the notations of UML 2 [2] are used, mainly timing diagrams.

257 **4 Test strategy for SDCI (IO-Link^{TM2}) Master and Devices**

258 **4.1 Purpose of this specification**

259 This specification describes the test cases and specifies the necessary test equipment in conjunction with its parent document IEC 61131-9 and updates from its support organization. The functionality of Masters supporting legacy Devices according to [5] is covered also. Necessary supplements or clarifications regarding [5] are covered in Annex B.

263 This document provides the necessary information for the development of testers for a test suite
264 in test laboratories.

265 **4.2 Structure of this document**

266 Clause 5 describes the test cases for the physical layer test of Master and Devices. They mainly
267 require individual manual tests with variable power supplies, individual capacitive and resistive
268 loads, voltage, and current meters as well as oscilloscopes and logic analyzers.

269 Clause 6 describes the test cases for the Device protocol tests, which can be performed nearly
270 automatically via a Device-Tester-System (see Annex A.2).

271 Clause 7 describes the concepts of the XML schema and business rules tests for IODDs that
272 have been shifted to [3]. Dedicated test cases verify the consistency of IODD parameters and
273 the real parameters within the associated Device.

274 Clause 8 describes the test cases for the Master protocol tests, which can be performed auto-
275 matically via a Master-Tester-System (see Annex A.3).

276 Clause 9 defines the standards for the environmental tests of Master and Devices. Annex A
277 describes the test tools, their requirements, and the test configurations. Annex B contains a few
278 supplementary specifications filling the gaps of [5]. Annex C provides cross reference listings
279 for test case IDs and test case names. Annex D provides information about an SDCI support
280 organization.

² IO-LinkTM is a trade name of the "IO-Link Community". Compliance to this standard does not require use of the registered logos for IO-LinkTM. Use of the registered logos for IO-LinkTM requires permission of the "IO-Link Community".

4.3 Conformity classes**4.3.1 Legacy Devices (V1.0)**

Test cases for Devices designed and implemented according to [5] are no more supported by this document.

4.3.2 Devices without ISDU

Devices designed and implemented according to [7] that are not supporting the ISDU feature shall either require no parameters or provide a system conform mechanism for the Device replacement without tools. These Devices shall pass all test cases marked correspondingly in this document.

4.3.3 Devices with ISDU

Devices designed and implemented according to [7] shall pass all test cases marked correspondingly in this document. If they omit to implement the Data Storage mechanism according to [7] they still shall provide access to Index 3 and shall provide system conform means for the Device replacement without tools. These Devices shall pass all test cases marked correspondingly in this document.

4.3.4 Legacy Master

Master solely designed and implemented according to [5] are no more supported by this document. However, since Master designed and implemented according to [7] shall support "Legacy Devices", all the corresponding test cases apply.

4.3.5 Master

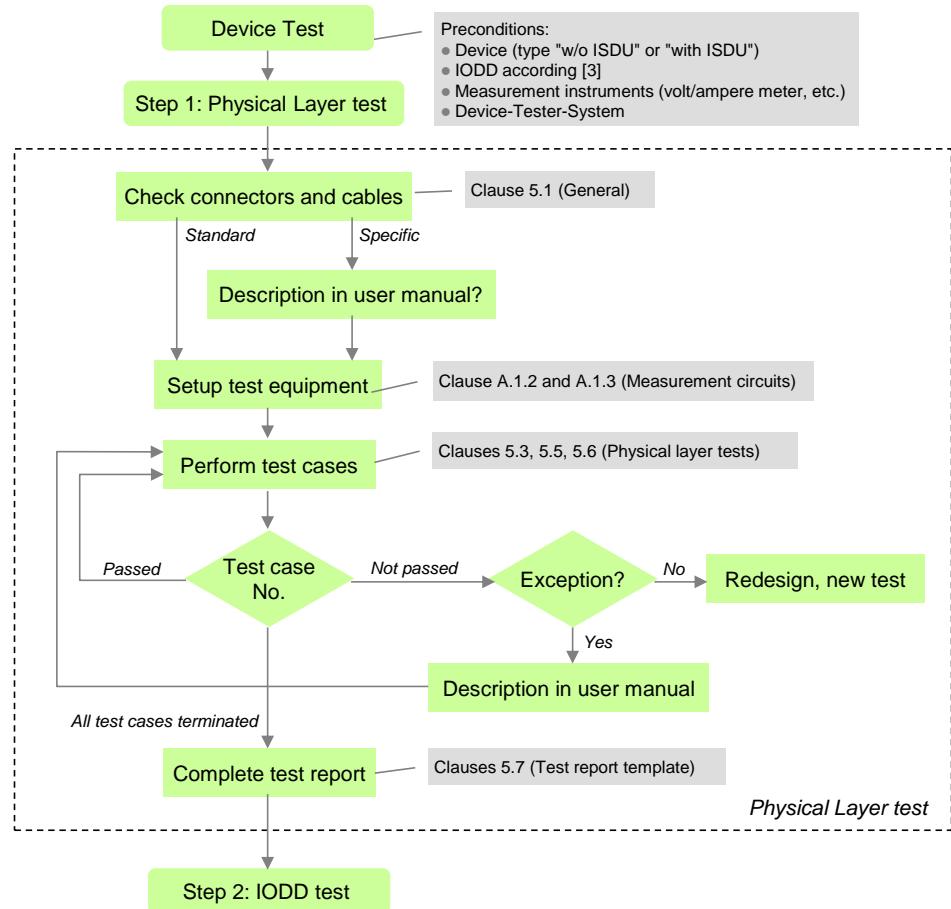
Master designed and implemented according to [7] shall provide all the specified features. All test cases within this document for Master apply.

4.4 Test of Devices

The test of Devices consists of four steps: Physical layer test, IODD test, protocol test, and environmental test. The protocol tests of SDCI Devices can be performed by a Device-Tester-System that shall be approved by the organization noted in Annex D. The requirements for Device-Tester-Systems are specified in Annex A.2.2.

Figure 3 shows step 1 of the Device test. It contains references to the relevant clauses in this specification and consists of a visual check and manually performed measurements.

If the Device shows specific connectors, cables, or color codings, these deviations shall be documented within the user manual with respect to the original definitions in the standard [7].



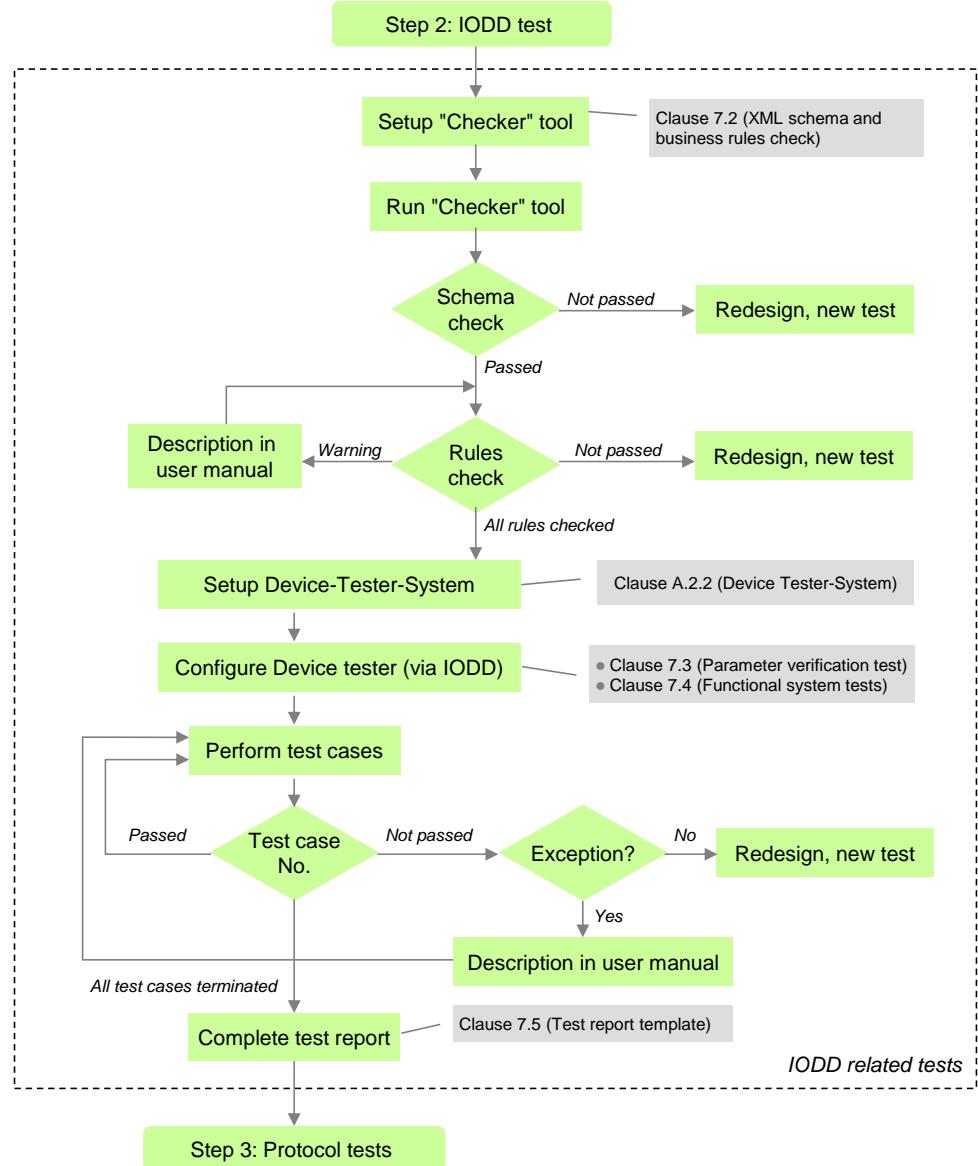
312

Figure 3 – Step 1 of the Device test sequence (PL)

If a Device did not pass a certain test case due to measurement values close to the tolerance limits or similar situations it is possible to send an informal request to the organization listed in Annex D. This request shall be comprehensive enough for the experts to allow for an exception under certain conditions or clarification of the specifications. If an exception applies, it shall be documented in the user manual mentioning the possible implications (see [8] for details).

319 Instead of pursuing such a time-consuming and uncertain way, it is highly recommended for the
320 applicant to rather strive for a robust implementation and conformity of the Device.

321 Figure 4 shows step 2 of the Device test. It contains references to the relevant clauses in this
322 specification and consists of an IODD-Test with a so-called IODD-Checker-Tool (7.2) and a
323 parameter verification test with the help of the protocol test (Device-Tester-System).



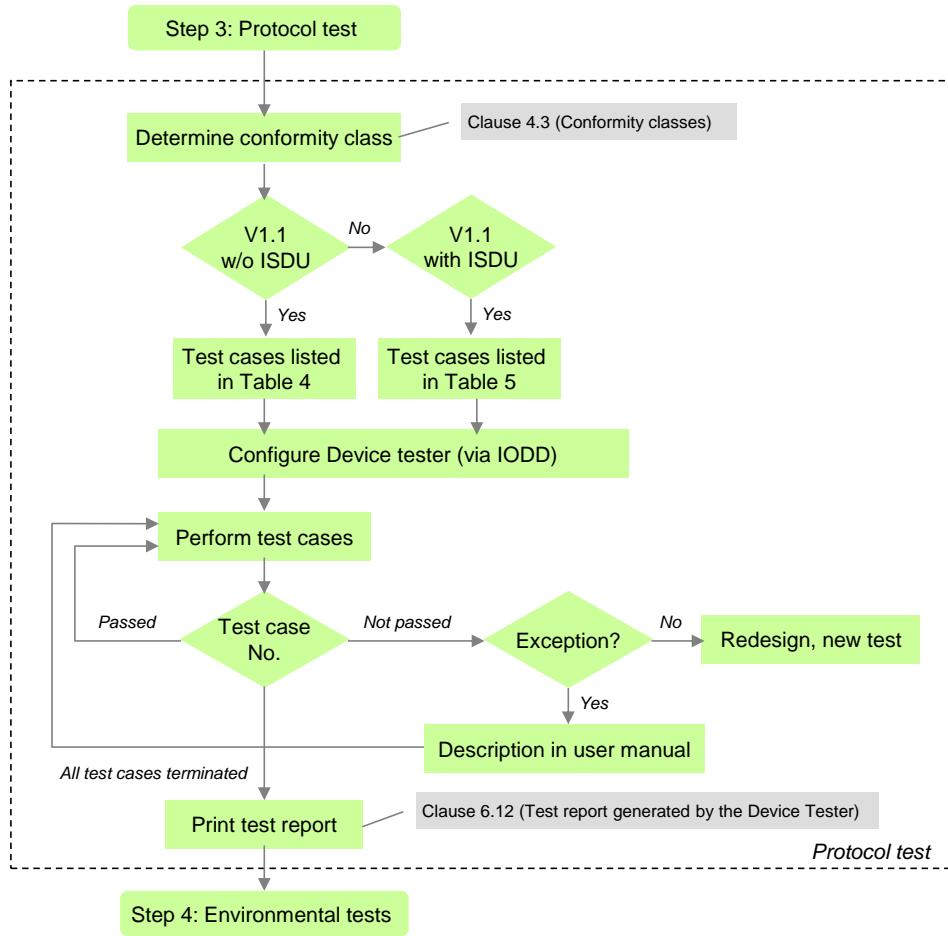
324

325

Figure 4 – Step 2 of the Device test sequence (IODD)

326 Figure 5 shows step 3 of the Device test. It contains references to the relevant clauses in this
 327 specification and consists of an automated protocol test with the help of the Device-Tester-
 328 System defined in A.2.2.

329 Two different sets of test cases are necessary to adjust the tests for the two Device conformity
 330 classes: Devices without the ISDU feature developed according to [7], and Devices with ISDU
 331 support developed according to [7].



332

Figure 5 – Step 3 of the Device test sequence (protocol)

-CR043- -CR070- -CR022- -CR066- -CR094- -CR036-

335 The set of test cases for Devices without ISDU support is defined in Table 4.

Table 4 – Set of test cases for Devices without ISDU support

| Major feature | Test cases | Remarks |
|-------------------------|--|--|
| STARTUP | TC_0034 to TC_0038, TC_0306 | New TC_0306 for test of revision management |
| PREOPERATE | TC_0039 to TC_0044 TC_0374, TC_0378 | TC_0042 removed from list |
| OPERATE | TC_0045 to TC_0049 TC_0312 and TC_0313 TC_0373 , TC_0375 , TC_0376 | TC_0048 and TC_0051 removed from list |
| Events | TC_0069 to TC_0076 | Exceptions exist (see 6.6.1) |
| Legacy Master (V1.0) | TC_0085 to TC_0087 | If restricted to 134 ms; exceptions for PDIinvalid exist (see Table 107) |
| Direct Parameter page 1 | TC_0089 to TC_0097 TC_0101 | TC_100 removed |

337

338 The set of test cases for Devices with ISDU support is defined in Table 5.

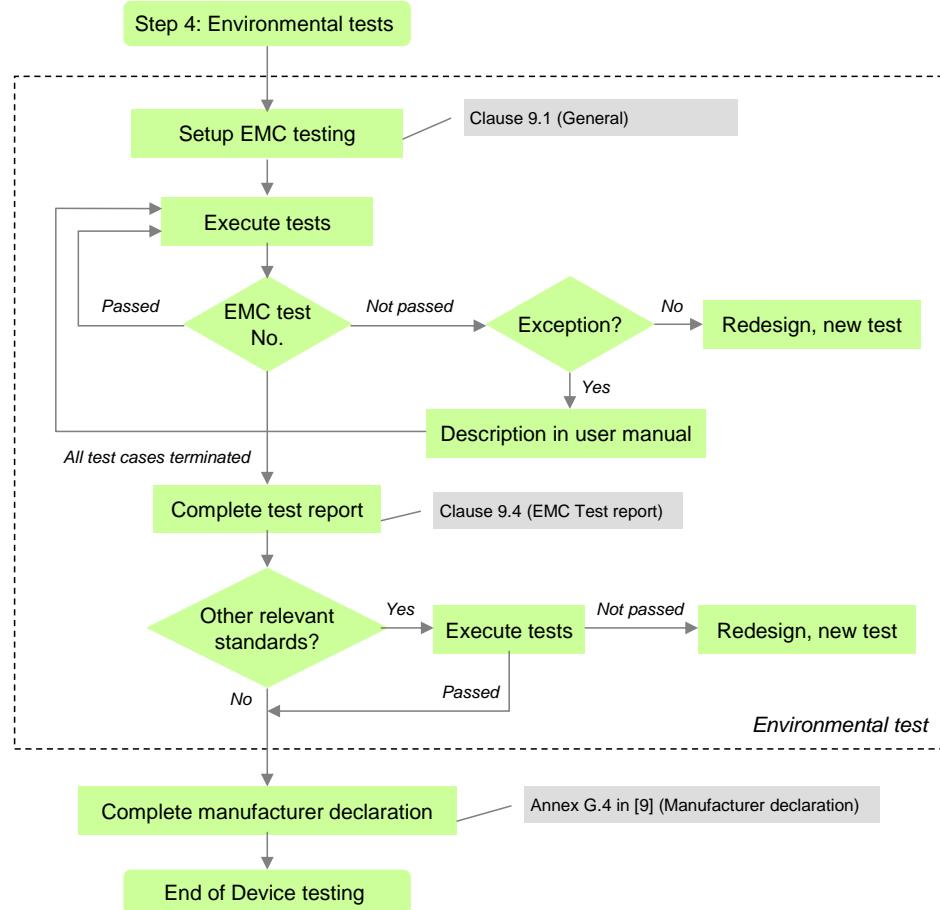
Table 5 – Set of test cases for Devices with ISDU support

-CR102- -CR043- -CR070- -CR022- -CR066- -CR094- -CR036-

| Major feature | Test cases | Remarks |
|-------------------------|--|---|
| STARTUP | TC_0034 to TC_0038 TC_0306 | New TC_0306 for test of revision management |
| PREOPERATE | TC_0039 to TC_0044 TC_0377 TC_0374, TC_0378 | TC_0042 removed from list |
| OPERATE | TC_0045 to TC_0049 TC_0312 and TC_0313 TC_0373 , TC_0375 , TC_0376 | TC_0048 and TC_0051 removed from list. |
| ISDU | TC_0052 to TC_0068 TC_0309 | New TC_0309 for repeated ISDU segments |
| Events | TC_0069 to TC_0076 | Exceptions exist (see 6.6.1) |
| Data Storage | TC_0077 to TC_0084 TC_0321 to TC_0322 | New TC_0321/322 for Parameter manager, upload flag |
| Legacy Master (V1.0) | TC_0085 to TC_0087 | If compatible; exceptions for PDInvalid exist (see Table 107) |
| Direct Parameter page 1 | TC_0089 to TC_0097 TC_0101 | TC_0100 removed |
| Predefined parameters | TC_0104 TC_0323 TC_0107 to TC_0124 TC_0128 to TC_0134 TC_0136 to TC_0137 TC_0140 to TC_0142 | TC_0105 removed TC_0323 for DS termination marker TC_0135 removed TC_0136/0137 for profile parameter |
| Block parameter | TC_0143 to TC_0148 TC_0324 to TC_0330 | TC_0146 reactivated New TC_0324 to TC_0330 for Parameter manager |
| IODD based tests | TC_0149 to TC_0152 TC_0157 TC_0155 to TC_0156 TC_0314 to TC_0318 | IODD parameter verification New for functional system tests (reset, locking, etc.) |

341

342 Figure 6 shows step 4 of the Device test. It contains references to the relevant clauses in this
 343 specification and consists of an EMC test defined in [7] and possible tests according to relevant
 344 product standards such as for example the IEC 60947 series. A successfully terminated Device
 345 test can be completed by a manufacturer declaration (see Annex D).



346

347

Figure 6 – Step 4 of the Device test sequence (environment)

348 **4.5 Test of Masters**

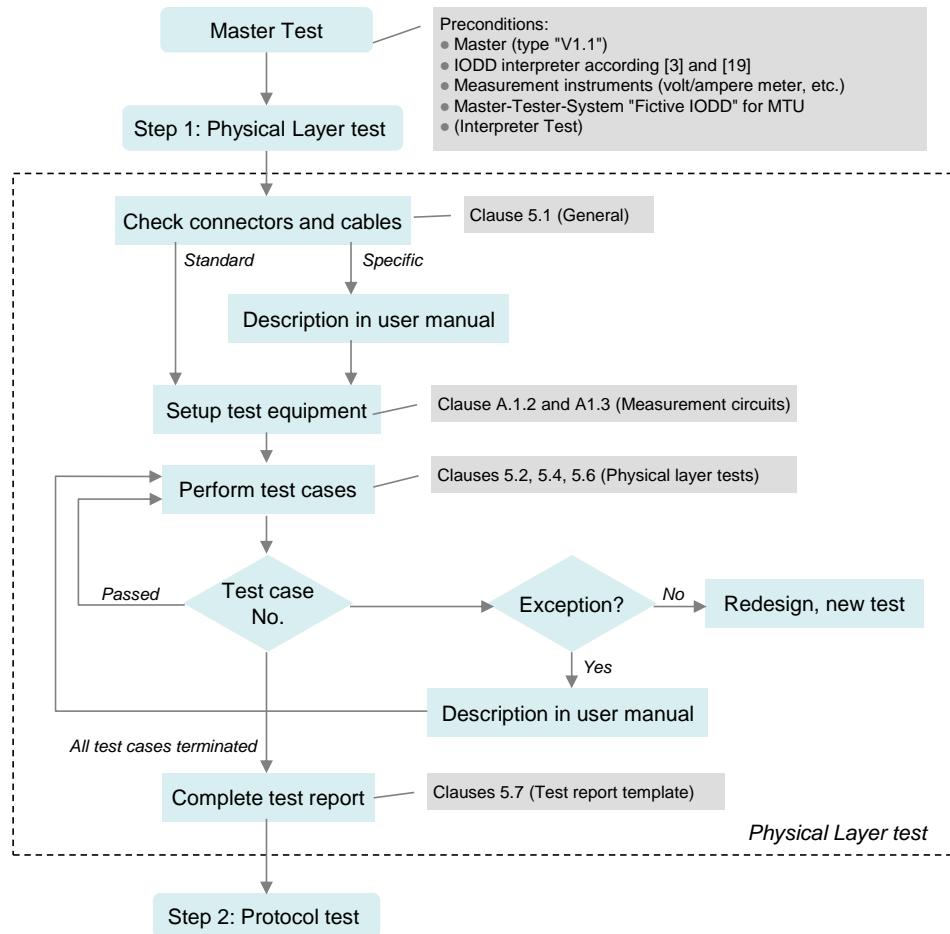
349 The test of Masters consists of four steps: Physical layer test, protocol test, IODD interpreter
 350 test, and environmental test. The protocol tests of Master can be performed by a Master-Tester-
 351 System approved by the organization noted in Annex D. The requirements for Master-Tester-
 352 Systems are specified in Annex A.3.

353 Figure 7 shows step 1 of the Master test sequence. It contains references to the relevant
 354 clauses in this specification and consists of a visual check and manually performed measure-
 355 ments.

356 If the Master shows specific connectors, cables, or color codings, these deviations shall be
 357 documented within the user manual in respect to the original definitions in the standard [7].

358 If a Master did not pass a certain test case due to measurement values close to the tolerance
 359 limits or similar situations it is possible to send an informal request to the organization listed in
 360 Annex D. This request shall be comprehensive enough for the experts to allow for an exception
 361 under certain conditions or clarification of the specifications. If an exception applies, it shall be
 362 documented in the user manual mentioning the possible implications (see [8] for details).

363 Instead of pursuing such a time-consuming and uncertain way, it is highly recommended for an
 364 applicant to rather strive for a robust implementation and conformity of the Master.

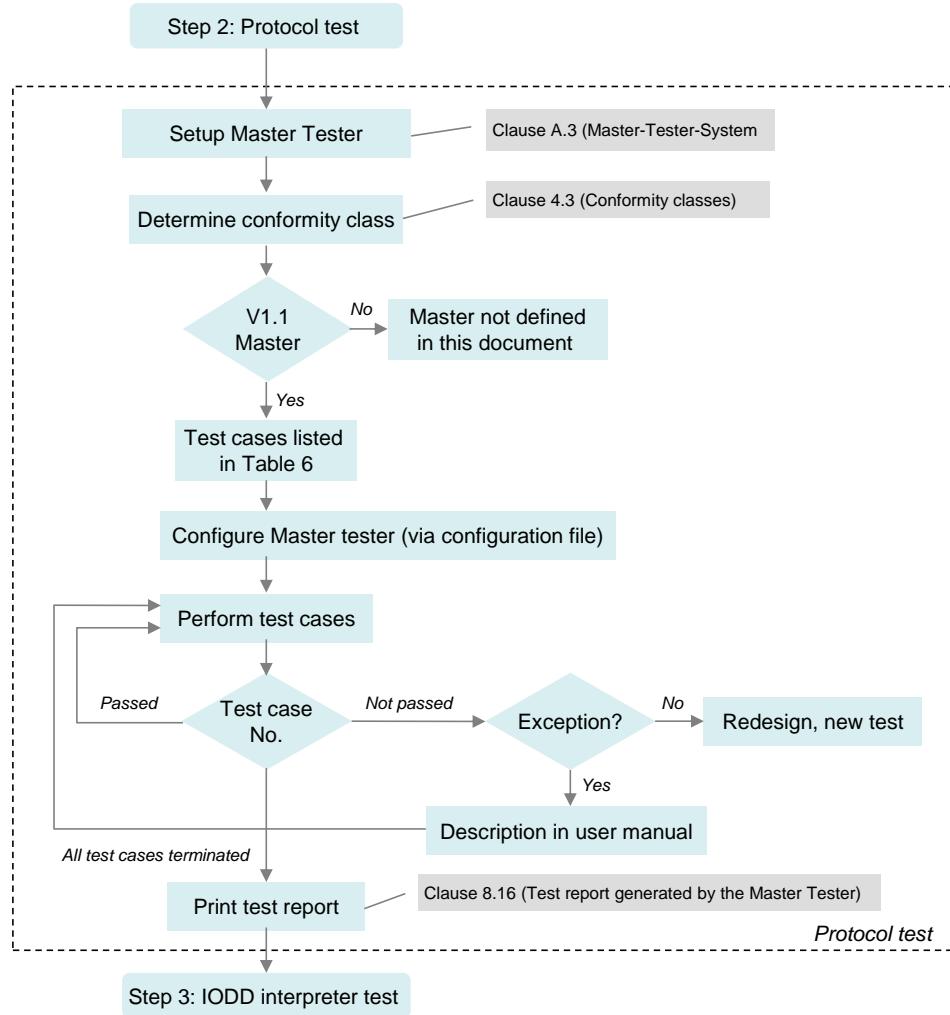


365

366

Figure 7 – Step 1 of the Master test sequence (PL)

367 Figure 8 shows step 2 of the Master test sequence. It contains references to the relevant
 368 clauses in this specification and consists of an automated protocol test with the help of a Mas-
 369 ter-Tester-System defined in Annex A.3.



370

371

Figure 8 – Step 2 of the Master test sequence (PL)

372 The set of test cases for Masters (V1.1) is defined in Table 6.

373

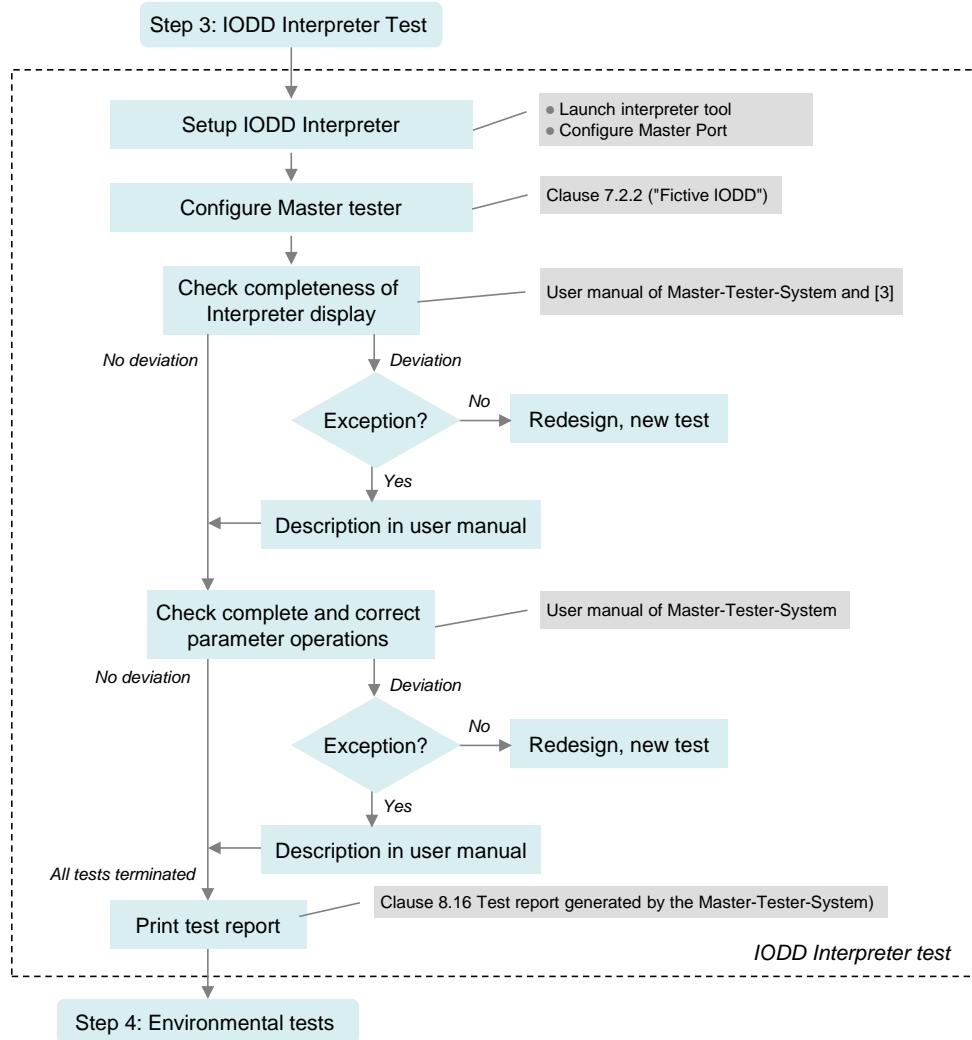
Table 6 – Set of test cases for Masters (V1.1)

| Major feature | Test cases | Remarks |
|---------------------------|---|---|
| Timings | TC_0158 to TC_0167 TC_0331 to TC_0333 | New TC_0331ff: delay time of Master messages |
| Process Data (PD) | TC_0168 to TC_0173 TC_0298 TC_0334 to TC_0335 | TC_0174/0175 removed New TC_0334ff: TYPE_2_V |
| On-request Data (OD) | TC_0179 to TC_0182 TC_0288 | New TC_0288 for Idle after ISDU service |
| STARTUP | TC_0183 to TC_0194 TC_0307 | TC_0195 to TC_0201 removed New TC_0307 for test of revision management |
| PREOPERATE | TC_0202 to TC_0209 | |
| OPERATE | TC_0336 to TC_0337 TC_0210 to TC_0212 | New TC_0336ff: TYPE_1_V |
| Fallback | TC_0213 to TC_0216 | TC_0213 and TC_0214 are optional |
| Retry | TC_0338 to TC_0349 TC_0221 to TC_0222 | New approach: TC_0217 to TC_0220 removed |
| ISDU (application errors) | TC_0223 to TC_0238 | TC_0236 removed |
| ISDU (derived errors) | TC_0239 to TC_0242 TC_0244 | |

| Major feature | Test cases | Remarks |
|----------------------|--|--|
| ISDU (Limit checks) | TC_0243 TC_0245 to TC_0246 TC_0248 to TC_0255 | |
| Events | TC_0256 TC_0261 to TC_0262 TC_0308 TC_0263 to TC_0267 TC_0350 to TC_0353 | New TC_0261ff for Events with details New TC_0308 for Notifications TC_0268/0269 removed New TC_0350ff for Events outside OPERATE |
| Data Storage | TC_0354 to TC_0372 | New approach: TC_0270 to TC_0284 removed |
| Legacy Device (V1.0) | TC_0285 to TC_0290 | TC_0291 removed |

374

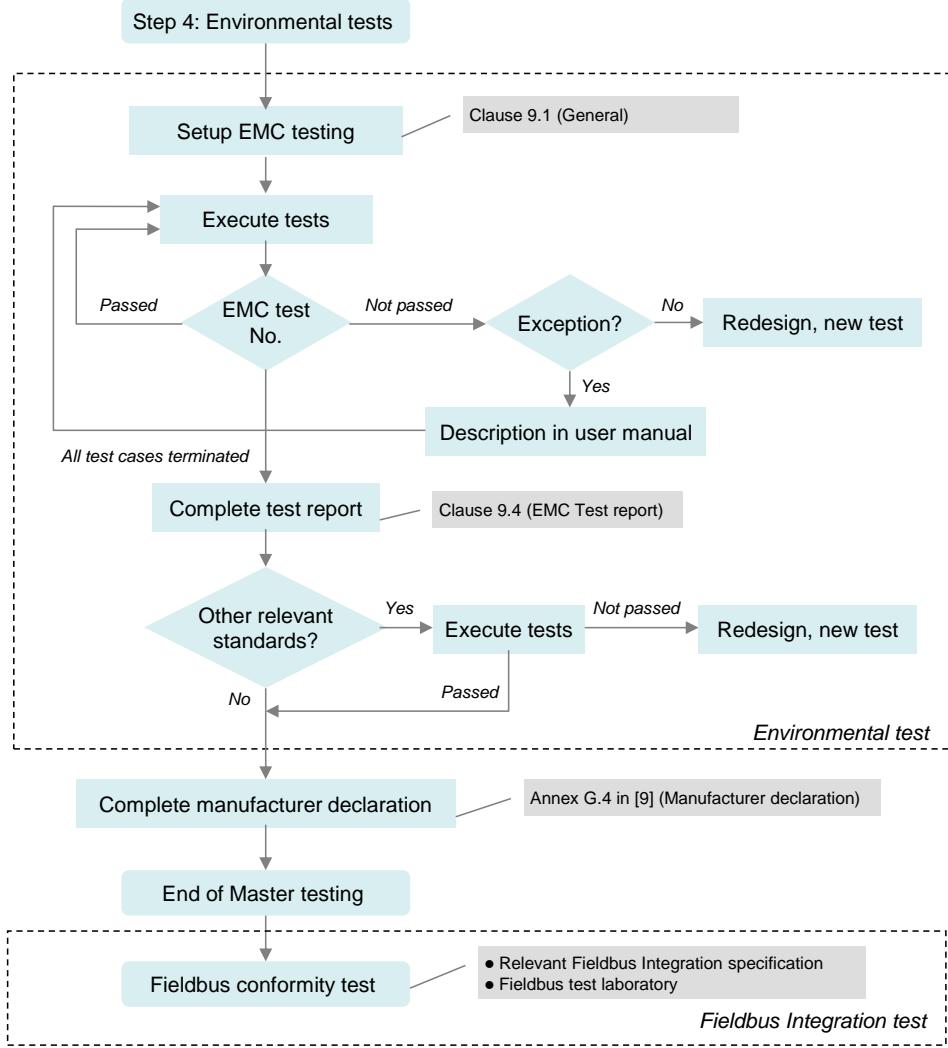
375 Figure 9 shows step 3 of the Master test sequence. It contains references to the relevant
 376 clauses in this specification. The Master-Tester-System defined in Annex A.3 provides a "Fictive
 377 IODD" (see 7.2.2) in accordance with [3]. The user manual of the tool demonstrates how this
 378 IODD shall be presented to the user with respect to completeness and correctness.



379

380 **Figure 9 – Step 3 of the Master test sequence (Interpreter)**

381 Figure 10 shows step 4 of the Master test. It contains references to the relevant clauses in this
 382 specification and consists of an EMC test defined in [7] and possible tests according to relevant
 383 product standards such as for example the IEC 61131-2. A successfully terminated Master test
 384 can be completed by a manufacturer declaration (see Annex D).



385

386 **Figure 10 – Step 4 of the Master test sequence (environment)**

387

388 **5 Physical Layer (PL) tests**389 **5.1 General**

390 The physical layer tests comprise a visual inspection of the type of connector, cable, maximum
 391 cable length and color coding of the wires. If customer specific or region specific connectors,
 392 cable, and the color coding of the wires deviate from the specifications in [7], the user manual
 393 of the Device shall document clearly the differences in comparison with the definitions in the
 394 standard.

395 The physical layer tests comprise also measurements of voltage levels and currents as well as
 396 timing limits, slopes and line and message signals. The necessary measurement instruments
 397 are defined in Annex A.1.1 and the necessary measurement circuits are defined in Annex A.1.2.

398 Physical layer tests are carried out at room temperature (15 °C to 35 °C). However, the tests
 399 shall pass within the whole operating temperature range for a Device specified by the man-
 400 ufacturer.

401

402 **5.2 Static parameters of the Master interface**

403 **5.2.1 DC supply current capability of Master Port L+**

404 Table 7 defines the test conditions for this test case.

405 **Table 7 – DC supply current capability of Master Port L+**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|
| Identification (ID) | SDCI_TC_0001 | |
| Name | TCM_PHYL_INTF_VSMISMBEHAV | |
| Purpose (short) | DC supply voltage and current capability of Master Port | |
| Equipment under test (EUT) | Master | |
| Test case version | 1.1 | |
| Category / type | Master PL test: test to pass | |
| Specification (clause) | [7], see 5.3.2.3, Table 6 | |
| Configuration / setup | Variable Master input voltage PSM and variable current sink according to Figure A.3 | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | DC supply voltage and current capability of Master Port L+ shall be within specified boundaries. Behavior of both quantities shall be monitored for a certain time. | |
| Precondition | PLT: Current sink between L+ and L- EUT: PORT_DI (see A.4.2) | |
| Procedure | a) Apply first PSM value to Master b) Adjust current sink to ISM value c) Monitor VSM and ISM at L+ for 30 s d) Evaluation 1) e) Repeat test with next PSM value and ISM value from c) | <i>; Test parameter</i> <i>; Test parameter</i> |
| Test parameter | PSM = {PSMmin, PSMmax} (according to user manual) ISM = {ISMmax, 0 mA} (ISMmax according to user manual) | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check VSM and ISM flow | |
| Test passed | 20 V ≤ VSM ≤ 30 V, AND ISM is constantly flowing | |
| Test not passed (examples) | VSM < 20 V, OR VSM > 30 V, OR ISM is interrupted | |
| Report | VSM (PSMmin): <value> VSM (PSMmax): <value> Steady current flow: <yes/no> | <ok nok> <ok nok> <ok nok> |

406

407

408

409

410 **5.2.2 Power-On supply current capability of Master Port L+**

411 Table 8 defines the test conditions for this test case.

412 **Table 8 – Power-On supply current capability of Master Port L+**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0002 |
| Name | TCM_PHYL_INTF_ISIRM |
| Purpose (short) | Power-on/Port turn-on supply current capability at Master Port |
| Equipment under test (EUT) | Master (see Annex B.2). |
| Test case version | 1.3 |
| Category / type | Master PL test: test to pass |
| Specification (clause) | [7], see 5.3.2.3, Table 6 |
| Configuration / setup | Supply current at Master Port is monitored according to Figure A.3 |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Driver capability of the Master Port L+ supply at power-on or switch-on of Port L+. Monitor supply current drawn from the Master Port. |
| Precondition | PLT: Current sink between L+ and L-; current sink shall be configured to consume ≥ 1000 mA (ISIRM) EUT: PORT_INACTIVE (see A.4.2) |
| Procedure | a) Set supply voltage of Master to first value of PSM b) Exemplary: SMI_PortPowerOffOn(ABPS_PORTPOWERON) (see A.4.6) c) Identify time tmin, where ISM reaches ISIRMmin = 400mA d) Monitor current ISIRM at L+ after tmin for 50 ms e) Evaluation 1) f) Repeat test from step b) with next PSM value |
| Test parameter | PSM = {PSMmin, PSMmax} (according to user manual) |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Evaluate charge QMI using the formula $QMI = \int_{tmin}^{tmin+50ms} ISM(t)dt$ |
| Test passed | Charge QMI ≥ 20 mAs |
| Test not passed (examples) | Charge QMI < 20 mAs (see Annex B.2) |
| Report | QMI (PSMmin): <value> QMI (PSMmax): <value> |
| | <ok nok> |

415

416

417 **5.2.3 Load current at Master Port C/Q**

418 Table 9 defines the test conditions for this test case.

419 **Table 9 – Load current at Master Port C/Q**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|
| Identification (ID) | SDCI_TC_0003 | |
| Name | TCM_PHYL_INTF_ILLM | |
| Purpose (short) | Load current at C/Q of Master Port | |
| Equipment under test (EUT) | Master | |
| Test case version | 1.2 | |
| Category / type | Master PL test: test to pass | |
| Specification (clause) | [7], see 5.3.2.3, Table 6 | |
| Configuration / setup | The input current at C/Q of the Master Port is monitored. | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Quiescent current at Master Port C/Q in input mode. Monitor current flowing into C/Q. | |
| Precondition | PLT: Voltage source with value VIM between L- and C/Q EUT: PORT_DI | |
| Procedure | a) Set supply voltage of Master to first PSM value b) Measure VSM c) Set voltage VIM = 5V d) Measure current ILLM into C/Q e) Evaluation 1) f) Set voltage VIM = 5,1 V g) Measure current ILLM into C/Q h) Evaluation 2) i) Set voltage VIM = 15V j) Measure current ILLM into C/Q k) Evaluation 3) l) Set voltage VIM = measured value of VSM in b) m) Measure current ILLM into C/Q n) Evaluation 4) o) Repeat from b) with next PSM value | ;Test parameter |
| Test parameter | PSM = {PSMmin, PSMmax} (according to user manual) | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check ILLM < 15 mA 2) Check 2 mA < ILLM < 15 mA 3) Check 2 mA < ILLM < 15 mA 4) Check 2 mA < ILLM < 15 mA | |
| Test passed | All checks OK | |
| Test not passed (examples) | One of the checks above failed | |
| Report | ILLM (VIM = 5 V, PSMmin): <value> ILLM (VIM = 5,1 V, PSMmin): <value> ILLM (VIM = 15 V, PSMmin): <value> ILLM (VIM = measured value of VSM, PSMmin): <value> ILLM (VIM = 5 V, PSMmax): <value> ILLM (VIM = 5,1 V, PSMmax): <value> ILLM (VIM = 15 V, PSMmax): <value> ILLM (VIM = measured value of VSM, PSMmax): <value> | <ok nok> <ok nok> <ok nok> <ok nok> <ok nok> <ok nok> <ok nok> <ok nok> |

422

423

424 **5.2.4 High-side residual voltage at Master Port C/Q**

425 Table 10 defines the test conditions for this test case.

426 **Table 10 – High-side residual voltage at Master Port C/Q**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0004 |
| Name | | TCM_PHYL_INTF_VRESHIGH |
| Purpose (short) | | Static high-side driver capability |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.2 |
| Category / type | | Master PL test: test to pass |
| Specification (clause) | | [7], see 5.3.2.3, Table 6 |
| Configuration / setup | | The output level at Master C/Q output is measured |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Driver capability of the Master Port high-side driver. Measurement of the voltage drop between supply L+ and C/Q output. |
| Precondition | | PLT: Current sink IQHMmin between C/Q and L-; Voltage measurement for VRQHM between L+ and C/Q EUT: PORT_DO (see A.4.2) |
| Procedure | | a) Set supply voltage of Master to first PSM value b) SMI_PDOOut(ABPS_DO_HIGH) (see A.4.6) c) Measure VRQHM d) Evaluation 1) e) Repeat from b) with next PSM value |
| | | <i>;Test parameter</i> |
| Test parameter | | PSM = {PSMmin, PSMmax} (according to user manual) |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check VRQHM ≤ 3V |
| Test passed | | All checks OK |
| Test not passed (examples) | | Any of the checks above failed |
| Report | | VRQHM (PSMmin): <value> VRQHM (PSMmax): <value> |
| | | <ok nok> <ok nok> |

429

430

431 **5.2.5 Low-side residual voltage at Master Port C/Q**

432 Table 11 defines the test conditions for this test case.

433 **Table 11 – Low-side residual voltage at Master Port C/Q**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0005 |
| Name | | TCM_PHYL_INTF_VRESLOW |
| Purpose (short) | | Static low-side driver capability |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.1 |
| Category / type | | Master PL test: test to pass |
| Specification (clause) | | [7], see 5.3.2.3, Table 6 |
| Configuration / setup | | The output level at Master Port C/Q output is measured |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Driver capability of the Master Port low-side driver. Measurement of the voltage drop between C/Q output and supply L-. |
| Precondition | | PLT: Current source IQHMIN between L+ and C/Q; Voltage measurement for VRQLM between C/Q and L- EUT: PORT_DO (see A.4.2) |
| Procedure | | a) Set supply voltage of Master to first PSM value b) SMI_PDO(ABPS_DO_LOW) (see A.4.6) c) Measure VRQLM d) Evaluation 1) e) Repeat from b) with next PSM value |
| | | <i>;Test parameter</i> |
| Test parameter | | PSM = {PSMmin, PSMmax} (according to user manual) |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check VRQLM ≤ 3V |
| Test passed | | All checks OK |
| Test not passed (examples) | | Any of the checks above failed |
| Report | | VRQLM (PSMmin): <value> VRQLM (PSMmax): <value> |
| | | <ok nok> <ok nok> |

436

437

438 5.2.6 High-level input threshold voltage at Master Port C/Q

439 Table 12 defines the test conditions for this test case.

Table 12 – High-level input threshold voltage at Master Port C/Q

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|------------|
| Identification (ID) | SDCI_TC_0006 | | |
| Name | TCM_PHYL_INTF_VTHHM | | |
| Purpose (short) | Test of static input high-level threshold at C/Q | | |
| Equipment under test (EUT) | Master | | |
| Test case version | 1.2 | | |
| Category / type | Master PL test: test to pass | | |
| Specification (clause) | [7], see 5.3.2.2, Table 5 | | |
| Configuration / setup | The digital input signal for C/Q input is monitored (see Figure A.6) | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | Measurement of the threshold voltage for high-level at the C/Q | | |
| Precondition | PLT: Voltage source with value VIM between C/Q and L- EUT: PORT_DI (see A.4.2) | | |
| Procedure | a) Set supply voltage of Master to first PSM value b) Sweep voltage VIM at C/Q from 5 V to 15 V in steps of maximum 0,1 V c) Exemplary: Repeat SMI_PDI until DI_C/Q = 1; (see Reference for SMI: [7], 11.2.17, Figure 113) d) Measure VIM Transition e) Evaluation 1) f) Repeat from b) with next PSM value | | |
| Test parameter | PSM = {PSMmin, PSMmax} (according to user manual) | | |
| Post condition | Memorize VIM at DI transition 0→1 (all PSM) | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | 1) Check voltage VIM at DI transition "low" to "high" | | |
| Test passed | All checks: 10,5 V < VIM < 13 V (range of VTHHM) | | |
| Test not passed (examples) | One of the checks failed | | |
| Report | VIM @ Transition 0→1 (PSMmin): <value> | | <ok nok> |
| | VIM @ Transition 0→1 (PSMmax): <value> | | <ok nok> |

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445 **5.2.7 Low-level input threshold voltage at Master Port C/Q**

446 Table 13 defines the test conditions for this test case.

447 **Table 13 – Low-level input threshold voltage at Master Port C/Q**

448 -CR118-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0007 |
| Name | TCM_PHYL_INTF_VTHLM |
| Purpose (short) | Static input low-level threshold at C/Q |
| Equipment under test (EUT) | Master |
| Test case version | 1.2 |
| Category / type | Master PL test: test to pass |
| Specification (clause) | [7], see 5.3.2.2, Table 5 |
| Configuration / setup | The digital input signal for C/Q input is monitored (see Figure A.6) |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Measurement of the threshold voltage for low-level at C/Q. |
| Precondition | PLT: Voltage source with value VIM between and C/Q and L-EUT: PORT_DI (see A.4.2) |
| Procedure | a) Set supply voltage of Master to first PSM value ; <i>Test parameter</i> b) Sweep voltage VIM at C/Q from 15 V to 5 V in steps of maximum 0,1 V c) Exemplary: Repeat SMI_PDIn until DI_C/Q = 0; (see Reference for SMI: [7], 11.2.17, Figure 113) d) Measure VIM Transition e) Evaluation 1 f) Repeat from b) with next PSM value ; <i>Test parameter</i> |
| Test parameter | PSM = {PSMmin, PSMmax} (according to user manual) |
| Post condition | Memorize VIM at DI transition 1→0 (all PSM) |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check voltage VIM at DI transition "high" to "low" |
| Test passed | For all checks: 8.0 V < VIM < 11,5 V (range of VTHLM) |
| Test not passed (examples) | One of the checks failed |
| Report | VIM @ Transition 1→0 (PSMmin): <value> <ok nok> VIM @ Transition 1→0 (PSMmax): <value> <ok nok> |

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453 **5.2.8 Input hysteresis voltage at Master Port C/Q**

454 Table 14 defines the test conditions for this test case.

455 **Table 14 – Input hysteresis voltage at Master Port C/Q**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--------------------------|
| Identification (ID) | SDCI_TC_0008 | |
| Name | TCM_PHYL_INTF_VHYSM | |
| Purpose (short) | Calculation of input hysteresis at C/Q | |
| Equipment under test (EUT) | Master | |
| Test case version | 1.2 | |
| Category / type | Master PL test: test to pass | |
| Specification (clause) | [7], see 5.3.2.2, Table 5 | |
| Configuration / setup | See TC_0006 and TC_0007 | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Calculation of the hysteresis voltage at C/Q. | |
| Precondition | Value VIM(TC_0006) from TC_0006 is available for all PSM values Value VIM(TC_0007) from TC_0007 is available for all PSM values | |
| Procedure | – | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | For all PSM values: VHYSM = Value VIM(TC_0006) – Value VIM(TC_0007) | |
| Test passed | For all PSM values: Voltage VHYSM is ≥ 0 V | |
| Test not passed (examples) | For any PSM value: Voltage VHYSM is < 0 V | |
| Report | VHYSM (PSMmin): <value> VHYSM (PSMmax): <value> | <ok nok> <ok nok> |

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461 **5.2.9 Permissible voltage range at Master Port C/Q**

462 Table 15 defines the test conditions for this test case.

463 **Table 15 – Permissible voltage range at Master Port C/Q**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0299 |
| Name | TCM_PHYL_INTF_VOLTRANGECQ |
| Purpose (short) | Permissible voltage range at Master C/Q |
| Equipment under test (EUT) | Master |
| Test case version | 1.1 |
| Category / type | Master PL test: test to pass |
| Specification (clause) | [7], see 5.3.2.2, Table 5, VIL and VIH |
| Configuration / setup | See Precondition |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | The receiver behavior at signal voltages equal to both the negative and positive supply voltage is tested. |
| Precondition | PLT: Resistor between L+ and C/Q or C/Q and L- respectively EUT: PORT_DI (see A.4.2) |
| Procedure | a) Set supply voltage of Master to first PSM value <i>;Test parameter</i> b) Apply resistor value between L+ and C/Q temporarily for at least 1 min c) Apply resistor value between C/Q and L- temporarily for at least 1 min d) Attach a Device e) Set Master to communication, for example: SMI_PortConfiguration(ABPS_NO_TYPE_CHECK) (see A.4.6) f) Get Master state, for example: SMI_PortStatus <i>;returns ArgBlock "PortStatusList"</i> g) Evaluation 1) h) Repeat from b) with next PSM value |
| Test parameter | PSM = {PSMmin, PSMmax} (according to user manual) Resistor = {1 Ohm} |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check Argblock |
| Test passed | For all PSM values: PortStatusList.PortstatusInfo = OPERATE |
| Test not passed (examples) | For any PSM value: State OPERATE not reached |
| Report | Communication established: <yes/no> <i><ok nok></i> |

468 **5.2.10 Electrical isolation of Master Port class B**

469 Table 16 defines the test conditions for this test case.

470 **Table 16 – Electrical isolation of Master Port class B**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0310 |
| Name | | TCM_PHYL_INTF_MRGI |
| Purpose (short) | | Electrical isolation of Master Port class B power lines |
| Equipment under test (EUT) | | Master with Port class B |
| Test case version | | 1.0 |
| Category / type | | Master PL test: test to pass |
| Specification (clause) | | [7], see 5.4.2 |
| Configuration / setup | | See Figure A.1 |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test of electrical isolation between Power 1 and Power 2 for a Class B Master Port measured with isolation test voltages. |
| Precondition | | PLT: See Figure A.1 EUT: PORT_DI (see A.4.2) |
| Procedure | | a) Set PSM to first value ; <i>Test parameter</i> b) Set Vaux to first value ; <i>Test parameter</i> c) Measure Igim0 and voltage VL+ at L+ d) Evaluation 1) e) Set PSM to second value ; <i>Test parameter</i> f) Set Vaux to second value ; <i>Test parameter</i> g) Measure Igim1 h) Evaluation 2) |
| Test parameter | | PSM = {PSMmax, 0 V} according to user manual Vaux = {0 V, 30 V} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check RIsoM0 = VL+/Igim0 2) Check RIsoM1 = 30 V/Igim1 |
| Test passed | | RIsoM0 > 2 MΩ, and RIsoM1 > 2 MΩ |
| Test not passed (examples) | | Any evaluation failed |
| Report | | RIsoM0: <value> RIsoM1: <value> |
| | | <ok nok> <ok nok> |

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5.3 Static parameters of the Device interface

5.3.1 Power supply current consumption of the Device I

Table 17 defines the test conditions for this test case.

Table 17 – Power supply current consumption of the Device I

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|----------------------------|--|
| Identification (ID) | SDCI_TC_0011 | | |
| Name | TCD_PHYL_INTF_ISD | | |
| Purpose (short) | Static power supply current consumption | | |
| Equipment under test (EUT) | Device | | |
| Test case version | 1.3 | | |
| Category / type | Device PL test: test to pass | | |
| Specification (clause) | [7], see 5.3.2.3, Table 6 | | |
| Configuration / setup | The supply current at Device L+ is measured | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | Measurement of the static power supply current at the L+ of the Device | | |
| Precondition | PLT: Voltage source with value VSD between L+ and L- EUT: Device set to operation mode with maximum power consumption. Maximum current consumption ISDman according to Device manual is provided. | | |
| Procedure | a) Apply first value of supply voltage VSD to the Device b) Measure current at L+ c) Evaluation 1) d) Set Device to OPERATE with MinCycleTime e) Measure current at L+ in OPERATE f) Evaluation 2) g) Repeat from b) with next VSD value | | |
| Test parameter | VSD = {18V, 30V} | | |
| Post condition | Memorize measured currents | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | For all VSD values: 1) Check value of ISDSIOMax 2) Check value of ISDIOLmax | | |
| Test passed | ISDSIOMax ≤ 200 mA (Warning if > 200 mA, but ≤ ISDman), and ISDSIOMax ≤ ISDman, and ISDIOLmax ≤ 200 mA (Warning if > 200 mA, but ≤ ISDman), and ISDIOLmax ≤ ISDman | | |
| Test not passed (examples) | ISDSIOMax > ISDman, or ISDIOLmax > ISDman | | |
| Report | ISDSIOMax (VSD = 18 V): <value/ n/a> ISDSIOMax (VSD = 30 V): <value/ n/a> ISDIOLmax (VSD = 18 V): <value> ISDIOLmax (VSD = 30 V): <value> | | <ok nok warning> <ok nok warning> <ok nok warning> <ok nok warning> |

482 5.3.2 Power supply current consumption of the Device II

483 Table 18 defines the test conditions for this test case.

Table 18 – Power supply current consumption of the Device II

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|--|
| Identification (ID) | SDCI_TC_0320 | | |
| Name | TCD_PHYL_INTF_DOCISD | | |
| Purpose (short) | Power supply current consumption above recommendation | | |
| Equipment under test (EUT) | Device, supply current ISD > 200mA (see TC_0011 report: Table 17) | | |
| Test case version | 1.0 | | |
| Category / type | Device PL test: test to pass | | |
| Specification (clause) | [7], see 5.3.2.3, 5.4.1, Table 6 | | |
| Configuration / setup | – | | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Verification in Device datasheet or user manual for increased power supply current requirement (> 200 mA) of the Device. | | |
| Precondition | PLT: not required EUT: Device datasheet or user manual (maximum current consumption ISDman) | | |
| Procedure | a) Check Device documentation for hint on constraints or user responsibility due to increased power supply current requirement b) Input: Documentation available / not available c) Evaluation 1) | | |
| Test parameter | – | | |
| Post condition | – | | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | 1) Retrieve information on maximum current consumption | | |
| Test passed | Information available | | |
| Test not passed (examples) | Information insufficient or not available in documentation for user | | |
| Report | Type of information: <value> | <ok nok warning> | |

490 **5.3.3 Power-on behavior of the Device**

491 Table 19 defines the test conditions for this test case.

492 **Table 19 – Power-on behavior of the Device**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0012 |
| Name | TCD_PHYL_INTF_ISIRD |
| Purpose (short) | Power-on current consumption (charge) and Device behavior |
| Equipment under test (EUT) | Device with maximum supply current ISD ≤ 200 mA |
| Test case version | 1.2 |
| Category / type | Device PL test: test to pass |
| Specification (clause) | [7], see 5.3.2.3, Table 6 and 5.4.1, Table 10 |
| Configuration / setup | The Device is powered by a Master with current supply capabilities according to ISIRM and ISM. See Figure A.4. |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | The current and communication of the Device is monitored upon power-on: The Device charge requirements and behavior at power-on are verified at minimum and maximum power supply conditions. |
| Precondition | PLT: Voltage source with value VSD and current monitor for ISD between L+ and L- EUT: Device is powered off |
| Procedure | a) Switch on Device with first value of supply voltage VSD ; <i>Test parameter</i> b) Trigger ISD measurement, if VSDmin (18V) is reached (tSTART) c) Stop ISD measurement at time tSTART + TRDL d) Evaluation 1) e) Set Device to OPERATE f) Count attempts in STARTUP g) Evaluation 2) h) Switch off Device (de-energize) i) Switch on Device with next value of supply voltage VSD ; <i>Test parameter</i> j) Repeat from b) with next VSD value |
| Test parameter | VSD = {18 V, 30 V} |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | For all VSD values: 1) Evaluate charge QISD using the formula $QISD = \int_{tSTART}^{tSTART+TRDL} ISD(t)dt$ 2) Check if communication is established and check STARTUP count |
| Test passed | QISD ≤ 70mAs, and OPERATE established and STARTUP count = 1 |
| Test not passed (examples) | Charge QISD > 70 mAs, or OPERATE not established, or STARTUP count > 1 |
| Report | QISD (VSD = 18 V): <value> STARTUP count (VSD = 18 V): <value> QISD (VSD = 30 V): <value> STARTUP count (VSD = 30 V): <value> |

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497 **5.3.4 High-side residual voltage at Device C/Q**

498 Table 20 defines the test conditions for this test case. This test case is only applicable for
 499 Devices with SIO mode or Devices where the output driver can be stimulated as if in SIO mode
 500 (e.g. via ASICs).

501 **Table 20 – High-side residual voltage at Device C/Q**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0013 |
| Name | | TCD_PHYL_INTF_VRESHIGH |
| Purpose (short) | | Static high-side driver capability |
| Equipment under test (EUT) | | Device where C/Q can be configured as output with static high level |
| Test case version | | 1.3 |
| Category / type | | Device PL test: test to pass |
| Specification (clause) | | [7], see 5.3.2.4, Table 7 |
| Configuration / setup | | The high-side output level of the Device C/Q output is measured according to Figure A.3 |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Driver capability of the Device high-side driver. Measurement of the voltage drop between supply L+ and C/Q output under load condition of 50 mA. |
| Precondition | | PLT: Voltage source with value VSD between L+ and L- EUT: Device is powered off |
| Procedure | | a) Apply first supply voltage VSD to the Device b) Apply current sink/source with 50 mA to C/Q c) Measure voltage VCQ between L+ and C/Q d) Evaluation 1) e) Repeat from b) with next VSD value |
| Test parameter | | <i>;Test parameter</i> VSD = {18 V, 30 V} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check VCQ |
| Test passed | | For all VSD values: VCQ ≤ 3,0 V |
| Test not passed (examples) | | For any VSD value: VCQ > 3,0 V |
| Report | | VCQ (VSD = 18 V): <value> VCQ (VSD = 30 V): <value> |
| | | <ok nok> <ok nok> |

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5.3.5 Low-side residual voltage at Device C/Q

Table 21 defines the test conditions for this test case. This test case is only applicable for Devices with SIO mode or Devices where the output driver can be stimulated as if in SIO mode (e.g. via ASICs).

Table 21 – Low-side residual voltage at Device C/Q

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|--------------------------|
| Identification (ID) | SDCI_TC_0014 | | |
| Name | TCD_PHYL_INTF_VRESLOW | | |
| Purpose (short) | Static low-side driver capability | | |
| Equipment under test (EUT) | Device where C/Q can be configured as output with static low level | | |
| Test case version | 1.3 | | |
| Category / type | Device PL test: test to pass | | |
| Specification (clause) | [7], see 5.3.2.4, Table 7 | | |
| Configuration / setup | The output level of the Device C/Q output is measured according to Figure A.3 | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | Driver capability of the Device low-side driver. Measurement of the voltage drop between negative supply L- and C/Q output at sink current of 50 mA | | |
| Precondition | PLT: Voltage source with value VSD between L+ and L- EUT: Device is powered off | | |
| Procedure | a) Apply first supply voltage VSD to the Device b) Apply current sink/source with 50 mA to C/Q c) Measure voltage VCQ between C/Q and L- d) Evaluation 1) e) Repeat from b) with next VSD value | | <i>; Test parameter</i> |
| Test parameter | VSD = {18 V, 30 V} | | |
| Post condition | – | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | 1) Check VCQ | | |
| Test passed | For all VSD values: $VCQ \leq 3,0\text{ V}$ | | |
| Test not passed (examples) | For any VSD value: $VCQ > 3,0\text{ V}$ | | |
| Report | VCQ (VSD = 18 V): <value> VCQ (VSD = 30 V): <value> | | <ok nok> <ok nok> |

515 **5.3.6 Pull-down or quiescent current at Device C/Q**

516 Table 22 defines the test conditions for this test case.

517 **Table 22 – Pull-down or quiescent current at Device C/Q**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0015 |
| Name | | TCD_PHYL_INTF_IQQD |
| Purpose (short) | | Static quiescent current |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.1 |
| Category / type | | Device PL test: test to pass |
| Specification (clause) | | [7], see 5.3.2.4, Table 7 |
| Configuration / setup | | Measurement of current at C/Q in receive mode |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Measurement of the quiescent current into C/Q in receive mode |
| Precondition | | PLT: Voltage source with value VSD between L+ and L- and stimulus voltage source VID between C/Q and L-. EUT: Device C/Q is set to a receive mode |
| Procedure | | a) Apply first value of supply voltage VSD to the Device ; <i>Test parameter</i> b) Apply voltage VID with value of input threshold high voltage (VTHHD = 13 V) c) Measure current ICQ at C/Q d) Evaluation 1) e) Apply voltage VID with value of positive supply voltage VSD f) Measure current ICQ at C/Q g) Evaluation 2) h) Repeat from b) with next VSD value |
| Test parameter | | VSD = {18 V, 30 V} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | For all VSD values: 1) Check value 1 of ICQ 2) Check value 2 of ICQ |
| Test passed | | For all VSD values: Value 1 and value 2 ≤ 15 mA |
| Test not passed (examples) | | For all VSD values: Value 1 or value 2 > 15 mA |
| Report | | ICQ (VSD = 18 V, VID = 13V): <value> <ok nok> ICQ (VSD = 18 V, VID = VSD): <value> <ok nok> ICQ (VSD = 30 V, VID = 13V): <value> <ok nok> ICQ (VSD = 30 V, VID = VSD): <value> <ok nok> |

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522 **5.3.7 High-level input threshold voltage at Device C/Q**

523 Table 23 defines the test conditions for this test case.

524 **Table 23 – High-level input threshold voltage at Device C/Q**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0016 |
| Name | | TCD_PHYL_INTF_VTHHD |
| Purpose (short) | | Statically input high-level threshold at C/Q |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.1 |
| Category / type | | Device PL test: test to pass |
| Specification (clause) | | [7], see 5.3.2.2, Table 5 |
| Configuration / setup | | See Figure A.10 |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Measurement of the threshold voltage for high-level at the C/Q |
| Precondition | | PLT: Voltage source with value VSD between L+ and L- and a stimulus voltage VID between C/Q and L- EUT: Device set to a <i>PL test set-up</i> , where a monitor signal of internal UART is available. This test set-up assumes C/Q port is in receive mode and change of the state at the monitor signal is observed. Otherwise, appropriate information. |
| Procedure | | a) If <i>PL test set-up</i> is available perform steps b) to f) b) Apply first value of supply voltage VSD to the Device ; <i>Test parameter</i> c) Sweep stimulus voltage VID from 5 V to 15 V in steps of maximum 0,1 V d) Capture the value of VID on the state change of monitor signal e) Evaluation 1) f) Repeat from c) with next VSD value g) If <i>PL test set-up</i> is not available perform steps h) to i) h) Provide VID manually as input from ASIC data sheet or earlier measurements i) Evaluation 1) |
| Test parameter | | VSD = {18 V, 30 V} |
| Post condition | | Memorize value VID (for all VSD) |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | For all measured values: 1) Check VID |
| Test passed | | VID ≥ 10.5V, and VID ≤ 13.0 V |
| Test not passed (examples) | | VID < 10.5V, or VID > 13.0 V |
| Report | | VID @ Transition 0→1 (VSD = 18 V): <value> VID @ Transition 0→1 (VSD = 30 V): <value> |
| | | <ok nok> |

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529 **5.3.8 Low-level input threshold voltage at Device C/Q**

530 Table 24 defines the test conditions for this test case.

531 **Table 24 – Low-level input threshold voltage at Device C/Q**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0017 |
| Name | TCD_PHYL_INTF_VTHLD |
| Purpose (short) | Static input low-level threshold at C/Q |
| Equipment under test (EUT) | Device |
| Test case version | 1.1 |
| Category / type | Device PL test: test to pass |
| Specification (clause) | [7], see 5.3.2.2, Table 5 |
| Configuration / setup | See Figure A.10 |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Measurement of the threshold voltage for low-level at the C/Q |
| Precondition | PLT: Voltage source with value VSD between L+ and L- and a stimulus voltage VID between C/Q and L- EUT: Device set to a <i>PL test set-up</i> , where a monitor signal of internal UART is available. This test set-up assumes C/Q port is in receive mode and change of the state at the monitor signal is observed. Otherwise, appropriate information. |
| Procedure | a) If <i>PL test set-up</i> is available perform steps b) to f) b) Apply first value of supply voltage VSD to the Device ; <i>Test parameter</i> c) Sweep stimulus voltage VID from 15 V to 5 V in steps of maximum 0,1 V d) Capture the value of VID on the state change of monitor signal e) Evaluation 1) f) Repeat from c) with next VSD value g) If <i>PL test set-up</i> is not available perform steps h) to i) h) Provide VID manually as input from ASIC data sheet or earlier measurements i) Evaluation 1) |
| Test parameter | VSD = {18 V, 30 V} |
| Post condition | Memorize value VID (for all VSD) |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | For all measured values: 1) Check VID |
| Test passed | VID \geq 8,0 V, AND VID \leq 11,5 V |
| Test not passed (examples) | VID < 8,0V, OR VID > 11,5 V |
| Report | VID @ Transition 1 \rightarrow 0 (VSD = 18 V): <value> VID @ Transition 1 \rightarrow 0 (VSD = 30 V): <value> |
| | <ok nok> <ok nok> |

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536 **5.3.9 Input hysteresis voltage at Device C/Q**

537 Table 25 defines the test conditions for this test case.

538 **Table 25 – Input hysteresis voltage at Device C/Q**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0018 |
| Name | | TCD_PHYL_INTF_VHYSD |
| Purpose (short) | | Calculation of input hysteresis at C/Q |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.1 |
| Category / type | | Device PL test: test to pass |
| Specification (clause) | | [7], see 5.3.2.2, Table 5 |
| Configuration / setup | | See TC_0016 and TC_0017 |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Calculation of the hysteresis voltage at C/Q based on VTHHD and VTHLD |
| Precondition | | Value VID(TC_0016) from TC_0016 is available for all VSD values Value VID(TC_0017) from TC_0017 is available for all VSD values |
| Procedure | | – |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | For all VSD values: VHYSD = Value VID(TC_0016) – Value VID(TC_0017) |
| Test passed | | For all VSD values: VHYSD \geq 0 V |
| Test not passed (examples) | | For any VSD value: VHYSD < 0 V |
| Report | | VHYSD (VSD = 18 V): <value> VHYSD (VSD = 30 V): <value> |
| | | <ok nok> <ok nok> |

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545 **5.3.10 Permissible voltage range at Device C/Q**

546 Table 26 defines the test conditions for this test case.

547 **Table 26 – Permissible voltage range at Device C/Q**

548 -CR115-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0300 |
| Name | TCD_PHYL_INTF_VOLTRANGECQ |
| Purpose (short) | Permissible voltage range at Device C/Q |
| Equipment under test (EUT) | Device |
| Test case version | 1.1 |
| Category / type | Device PL test: test to pass |
| Specification (clause) | [7], see 5.3.2.2, Table 5, VIL and VIH |
| Configuration / setup | See Figure A.10 with modifications (see Precondition) |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | The Device behavior is tested after exposures to signal voltages exceeding the supply voltage |
| Precondition | PLT: Voltage source with value VSD between L+ and L- and a stimulus voltage VID between C/Q and L- via a series resistance of 1 Ohm, and a Master compliant to [7] EUT: Device is attached to PLT |
| Procedure | <ul style="list-style-type: none"> a) Apply supply voltage (VSD = 29 V) to Device b) Start SDCI communication c) Stop SDCI communication (disconnect C/Q from Master port, EUT C/Q is still in receive mode) d) Apply first value of stimulus voltage VID for at least 1 min ;Test parameter e) Apply next value of stimulus voltage VID for at least 1 min ;Test parameter f) Remove stimulus voltage VID g) Reconnect C/Q to Master port h) Start SDCI communication i) Evaluation 1) |
| Test parameter | VID = {(VSD + 1 V), -1 V} |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check communication |
| Test passed | Communication established on first start-up Device established communication at least in 5 s and no errors. |
| Test not passed (examples) | Communication not established in 5 s , or Errors occurred |
| Report | Communication established: <yes/no> <ok nok> |

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553 **5.3.11 Electrical isolation of Device power supplies**

554 Table 27 defines the test conditions for this test case.

555 **Table 27 – Electrical isolation of Device power supplies**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0311 |
| Name | | TCD_PHYL_INTF_DRGI |
| Purpose (short) | | Electrical isolation of Device with Master Port class B requirements |
| Equipment under test (EUT) | | Device using Power 1 and Power 2 |
| Test case version | | 1.1 |
| Category / type | | Device PL test: test to pass |
| Specification (clause) | | [7], see 5.4.2 |
| Configuration / setup | | See Figure A.2 |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test of electrical isolation between Power 1 and Power 2 of a Device with Master Port Class B requirements |
| Precondition | | PLT: See Figure A.2 EUT: Device is operational |
| Procedure | | a) Apply supply VSD to Device with VSDmax (VSD = 30 V) b) Apply first value of Vaux at auxiliary power supply c) Measure current IgID0 d) Evaluation 1 e) Apply next value of Vaux at auxiliary power supply f) Measure current IgID1 g) Evaluation 2) |
| Test parameter | | Vaux = {0 V, 30 V} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check RIsoD0 = VSDmax/IgID0 2) Check RIsoD1 = VSDmax/IgID1 |
| Test passed | | RIsoD0 > 2 MOhm, and RIsoD1 > 2 MOhm |
| Test not passed (examples) | | Any evaluation failed |
| Report | | RIsoD0: <value> RIsoD1: <value> |
| | | <ok nok> <ok nok> |

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559

560 **5.4 Wake-Up generation of the Master interface**

561 **5.4.1 Wake-Up current pulse high**

562 Table 28 defines the test conditions for this test case.

563 **Table 28 – Wake-Up current pulse high**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0021 |
| Name | TCM_PHYL_INTF_IQWUH |
| Purpose (short) | Driver capability of the wake-up pulse – high-side driver |
| Equipment under test (EUT) | Master |
| Test case version | 1.1 |
| Category / type | Master PL test: test to pass |
| Specification (clause) | [7], see 5.3.3.3, Table 8 |
| Configuration / setup | See Figure A.5 |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | The minimum requirement for the Master output peak current IQPKHM is verified with a resistive load at Master C/Q. A voltage VIM above the threshold VTHHmax during a wakeup pulse indicates that the minimum requirement is met. |
| Precondition | PLT: See Figure A.5 EUT: PORT_AUTOSTART (see A.4.2) |
| Procedure | a) Apply first supply voltage PSM to Master b) Measure voltage VIM during Wake-up pulse c) Evaluation 1) d) Repeat from b) with next PSM value |
| Test parameter | PSM = {PSMmin, PSMmax} (according to user manual); Rload = {L+(PSMmin) / IQPKHMmin, L+(PSMmax) / IQPKHMmin} |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check voltage VIM |
| Test passed | For all PSM: VIM ≥ VTHHmax |
| Test not passed (examples) | For any PSM: VIM < VTHHmax |
| Report | VIM @ WURQ (PSMmin): <value> VIM @ WURQ (PSMmax): <value> |
| | <ok nok> <ok nok> |

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568 **5.4.2 Wake-Up pulse duration high**

569 Table 29 defines the test conditions for this test case.

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Table 29 – Wake-Up pulse duration high

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--------------------------|
| Identification (ID) | SDCI_TC_0022 | |
| Name | TCM_PHYL_INTF_TWUH | |
| Purpose (short) | Wake-Up pulse duration (high pulse) | |
| Equipment under test (EUT) | Master | |
| Test case version | 1.1 | |
| Category / type | Master PL test: test to pass | |
| Specification (clause) | [7], see 5.3.3.3 Table 8 | |
| Configuration / setup | See Figure A.7 | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Verify the requirements for the wake-up pulse duration (high pulse) at Master C/Q under maximum resistive load conditions. The minimum and maximum pulse duration is measured with evaluations at the extreme values of the thresholds VTHL and VTHH. | |
| Precondition | PLT: Resistive load (Rload) between C/Q and L-; voltage measurement between C/Q and L- EUT: PORT_AUTOSTART (see A.4.2) | |
| Procedure | a) Apply first supply voltage PSM to Master and Rload ; <i>Test parameter</i> b) Trigger time measurement t1 on voltage level at C/Q \geq VTHHmin c) Trigger time measurement t2 on voltage level at C/Q \leq VTHLmin d) Evaluation 1) e) Trigger time measurement t3 on voltage level at C/Q \geq VTHHmax f) Trigger time measurement t4 on voltage level at C/Q \leq VTHLmax g) Evaluation 2) h) Repeat from b) with next PSM value | |
| Test parameter | PSM = {PSMmin, PSMmax} (according to user manual); Rload = {L+(PSMmin) / IQPKHMmin, L+(PSMmax) / IQPKHMmin} | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | For all PSM values (see Figure A.17): 1) Determine tWUmax = t2 – t1 2) Determine tWUmin = t4 – t3 | |
| Test passed | 75 μ s \leq tWUmin, and tWUmax \leq 85 μ s | |
| Test not passed (examples) | tWUmax > 85 μ s, or tWUmin < 75 μ s | |
| Report | tWUmin @ WURQ: <value> tWUmax @ WURQ: <value> | <ok nok> <ok nok> |

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5.4.3 Wake-Up current pulse low

576 Table 30 defines the test conditions for this test case.

Table 30 – Wake-Up current pulse low

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|--------------------------|
| Identification (ID) | SDCI_TC_0023 | | |
| Name | TCM_PHYL_INTF_IQWUL | | |
| Purpose (short) | Drive capability of the wake-up pulse – low-side driver | | |
| Equipment under test (EUT) | Master | | |
| Test case version | 1.1 | | |
| Category / type | Master PL test: test to pass | | |
| Specification (clause) | [7], see 5.3.3.3 Table 8 | | |
| Configuration / setup | See Figure A.8 | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | The minimum requirement for the Master output peak current IQPKLM is verified with a resistive load at Master C/Q. A voltage at C/Q below the threshold low level of a receiver VTHLmin during a wake-up pulse indicates that the minimum requirement is met. | | |
| Precondition | PLT: Resistive load (Rload) between L+ and C/Q; voltage measurement between C/Q and L- EUT: PORT_AUTOSTART (see A.4.2) | | |
| Procedure | a) Apply first supply voltage PSM to the Master and first Rload ; <i>Test parameter</i> b) Measure voltage VIM during Wake-up pulse c) Evaluation 1) d) Repeat from b) with next PSM value and next Rload value | | |
| Test parameter | PSM = {PSMmin, PSMmax} (according to user manual); Rload = {(VL+min - 8 V)/0,5 A, (VL+max - 8 V)/0,5 A} | | |
| Post condition | – | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | For all PSM values: 1) Check voltage VIM | | |
| Test passed | For all PSM values: VIM ≤ VTHLmin | | |
| Test not passed (examples) | For any PSM value: VIM > VTHLmin | | |
| Report | VIM @ WURQ (PSMmin): <value> VIM @ WURQ (PSMmax): <value> | | <ok nok> <ok nok> |

582 **5.4.4 Wake-Up pulse duration low**

583 Table 31 defines the test conditions for this test case.

584 **Table 31 – Wake-Up pulse duration low**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0024 |
| Name | TCM_PHYL_INTF_TWUL |
| Purpose (short) | Wake-Up pulse duration (low pulse) |
| Equipment under test (EUT) | Master |
| Test case version | 1.1 |
| Category / type | Master PL test: test to pass |
| Specification (clause) | [7], see 5.3.3.3, Table 8 |
| Configuration / setup | See Figure A.8 |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Verify the requirements for the wake-up pulse duration (low pulse) at Master C/Q under maximum resistive load conditions. The minimum and maximum pulse duration is measured with evaluations at the extreme values of thresholds VTHL and VTHH |
| Precondition | PLT: Resistive load (Rload) between L+ and C/Q; voltage measurement between C/Q and L- EUT: PORT_AUTOSTART (see A.4.2) |
| Procedure | a) Apply first supply voltage PSM to Master and first Rload ; b) Trigger time measurement t1 on voltage level at C/Q ≤ VTHLmax c) Trigger time measurement t2 on voltage level at C/Q ≥ VTHHmax d) Evaluation 1) e) Trigger time measurement t3 on voltage level at C/Q ≤ VTHLmin f) Trigger time measurement t4 on voltage level at C/Q ≥ VTHHmin g) Evaluation 2) h) Repeat from b) with next PSM value and next Rload value |
| Test parameter | PSM = {PSMmin, PSMmax} (according to user manual); Rload = {(VL+min - 8 V)/0,5 A, (VL+max - 8 V)/0,5 A} |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | For all PSM values (see Figure A.18): 1) Determine tWUmax = t2 – t1 2) Determine tWUmin = t4 – t3 |
| Test passed | 75 µs ≤ tWUmin, and tWUmax ≤ 85 µs |
| Test not passed (examples) | tWUmax > 85 µs, or tWUmin < 75 µs |
| Report | tWUmin @ WURQ: <value> tWUmax @ WURQ: <value> |

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589 **5.5 Wake-Up detection of the Device interface**

590 **5.5.1 Wake-Up pulse detection high**

591 Table 32 defines the test conditions for this test case.

592 **Table 32 – Wake-Up pulse detection high**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|
| Identification (ID) | SDCI_TC_0025 | |
| Name | TCD_PHYL_INTF_TWUH | |
| Purpose (short) | Wake-Up pulse detection capability (high pulse) | |
| Equipment under test (EUT) | Device with SIO mode, C/Q with signal low | |
| Test case version | 1.2 | |
| Category / type | Device PL test: test to pass | |
| Specification (clause) | [7], see 5.3.3.3, Table 8 | |
| Configuration / setup | Signal generator connected to EUT according Figure A.11 | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | A wake-up pulse is applied to Device C/Q with timing at specified limits. The wake-up pulse is indicated via a test signal/indicator on the Device side. The Device reaction is evaluated. This test is only applicable for Devices that can drive C/Q in SIO mode to low and where means to monitor the reaction on the WURQ are provided (e.g. Interrupt line of IO-Link PHY). | |
| Precondition | PLT: Signal Generator with high impedance or low output EUT: SIO mode. Device set to a <i>PL test set-up</i> , where a monitor signal of the wake-up detection is available, e.g. interrupt line of PHY. Otherwise appropriate information is available. | |
| Procedure | a) If <i>PL test set-up</i> is available, perform b) to j) b) Set L+ Voltage VSD of the Device to first value ; <i>Test parameter</i> c) Configure EUT to drive output in SIO mode to signal low d) Apply current pulse with IQWU = IQPKHmin (current source) and of TWUmin (75 µs) to C/Q. e) Monitor test signal/WURQ indication at Device f) Evaluation 1) g) Apply current pulse with IQWU = IQPKHmin (current source) and of TWUmax (85 µs) to C/Q. h) Monitor test signal/WURQ indication at Device i) Evaluation 1) j) Repeat test from c) with next VSD voltage k) If <i>PL test set-up</i> is not available, proof of correct pulse detection is provided by manufacturer | |
| Test parameter | VSD = {18V, 30V} | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check monitored test signal for WURQ indication | |
| Test passed | WURQ indicated, or Proof of correct pulse detection is provided by manufacturer | |
| Test not passed (examples) | WURQ not indicated, or No proof | |
| Report | WURQ (VSD = 18 V): <yes/no> WURQ (VSD = 30 V): <yes/no> Proof of correct pulse detection: <yes/no> | <ok nok> <ok nok> <ok nok> |

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597 **5.5.2 Wake-Up pulse detection low**

598 Table 33 defines the test conditions for this test case.

599 **Table 33 – Wake-Up pulse detection low**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|---|--|
| Identification (ID) | SDCI_TC_0026 | |
| Name | TCD_PHYL_INTF_TWUL | |
| Purpose (short) | Wake-Up pulse detection capability (low pulse) | |
| Equipment under test (EUT) | Device with SIO mode, C/Q with signal high | |
| Test case version | 1.2 | |
| Category / type | Device PL test: test to pass | |
| Specification (clause) | [7], see 5.3.3.3, Table 8 | |
| Configuration / setup | Signal generator connected to EUT according Figure A.11 | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | A wake-up pulse is applied at the Device C/Q port with timing at specified limits. The wake-up request "WURQ" is indicated via a test signal / indicator. The Device reaction is evaluated. This test is only applicable for Devices that can drive C/Q in SIO mode to high and where means to monitor the reaction on the WURQ are provided (e.g. Interrupt line of IO-Link PHY). | |
| Precondition | PLT: Signal Generator with high impedance or high output EUT: SIO mode. Device set to a <i>PL test set-up</i> , where a monitor signal of the wake-up detection is available, e.g. interrupt line of PHY. Otherwise appropriate information is available. | |
| Procedure | a) If <i>PL test set-up</i> is available, perform b) to j) b) Set L+ Voltage VSD to Device to first value ; <i>Test parameter</i> c) Configure EUT to drive output in SIO mode to signal high d) Apply current pulse with IQWU = IQPKHmin (current source) and of TWUmin (75 µs) to C/Q. e) Monitor test signal / WURQ indication at Device f) Evaluation 1) g) Apply current pulse with IQWU = IQPKHmin (current source) and of TWUmax (85 µs) to C/Q. h) Monitor test signal / WURQ indication at Device i) Evaluation 1) j) Repeat test from c) with next VSD voltage k) If <i>PL test set-up</i> is not available, proof of correct pulse detection is provided by manufacturer | |
| Test parameter | VSD = {18V, 30V} | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check monitored test signal for WURQ indication | |
| Test passed | WURQ indicated, or Proof of correct pulse detection is provided by manufacturer | |
| Test not passed (examples) | WURQ not indicated, or No proof | |
| Report | WURQ (VSD = 18 V): <yes/no> WURQ (VSD = 30 V): <yes/no> Proof of correct pulse detection: <yes/no> | <ok nok> <ok nok> <ok nok> |

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604 5.5.3 Wake-Up receive enable delay (C/Q high)

605 Table 34 defines the test conditions for this test case.

Table 34 – Wake-Up receive enable delay (C/Q high)

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|------------|
| Identification (ID) | SDCI_TC_0027 | | |
| Name | TCD_PHYL_INTF_TRENHIGH | | |
| Purpose (short) | Determine Receive Enable Delay after Wake-up Request | | |
| Equipment under test (EUT) | Device with SIO mode, C/Q signal high | | |
| Test case version | 1.3 | | |
| Category / type | Device PL test: test to pass | | |
| Specification (clause) | [7], see 5.3.3.3, Table 10 | | |
| Configuration / setup | See Figure A.12 | | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | The Device shall release the high-side output driver after successful reception of a wake-up request. Measure wake-up receive enable delay of the Device with high signal at C/Q. The delay time is measured with a resistive voltage divider applied between L+ to C/Q and C/Q to L. | | |
| Precondition | PLT: Signal generator with high impedance or high output EUT: SIO Mode (output signal high) | | |
| Procedure | a) Stimulate Device for SIO mode output signal = high b) Apply wake-up request pulse (negative pulse) and return to high impedance c) Monitor C/Q signal starting from negative edge of wake-up request pulse for a duration of TRENmax d) Evaluation 1) | | |
| Test parameter | – | | |
| Post condition | – | | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | 1) Check tREN = time from start of wake-up request until level of C/Q reaches VTHLmin | | |
| Test passed | tREN ≤ 500 µs | | |
| Test not passed (examples) | VTHLmin not reached | | |
| Report | tREN @ C/Q = high: <value> | | <ok nok> |

611 **5.5.4 Wake-Up receive enable delay (C/Q low)**

612 Table 35 defines the test conditions for this test case.

613 **Table 35 – Wake-Up receive enable delay (C/Q low)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|---|------------|
| Identification (ID) | SDCI_TC_0028 | |
| Name | TCD_PHYL_INTF_TRENLOW | |
| Purpose (short) | Determine Receive Enable Delay after Wake-up Request | |
| Equipment under test (EUT) | Device with SIO mode, C/Q signal low | |
| Test case version | 1.3 | |
| Category / type | Device PL test: test to pass | |
| Specification (clause) | [7], see 5.3.3.3, Table 10 | |
| Configuration / setup | See Figure A.13 | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | The Device shall release the low-side output driver after successful reception of a wake-up request. Measure wake-up receive enable delay of the Device with C/Q low. The delay time is measured with a resistive voltage divider applied between L+ to C/Q and C/Q to L. | |
| Precondition | PLT: Signal Generator with high impedance or low output EUT: SIO mode (output signal low) | |
| Procedure | a) Stimulate Device for SIO mode output signal = low b) Apply wake-up request pulse (positive pulse) and return to high impedance c) Monitor C/Q signal starting from positive edge of wake-up request pulse for a duration of TRENmax d) Evaluation 1) | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check tREN = time from start of wake-up request until level of C/Q reaches VTHHmax | |
| Test passed | tREN ≤ 500 µs | |
| Test not passed (examples) | VTHHmax not reached | |
| Report | tREN @ C/Q = low: <value> | <ok nok> |

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618 5.5.5 SDCI readiness delay

619 Table 36 defines the test conditions for this test case.

Table 36 – SDCI readiness delay

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|------------|
| Identification (ID) | SDCI_TC_0029 | | |
| Name | TCD_PHYL_INTF_TRDL | | |
| Purpose (short) | SDCI Receive Enable Delay after Power-On | | |
| Equipment under test (EUT) | Device | | |
| Test case version | 1.1 | | |
| Category / type | Device PL test: test to pass | | |
| Specification (clause) | [7], see 5.3, 7.3.2, Table 7, Table 9, Table 42 | | |
| Configuration / setup | Reference-Master and EUT with VSD and C/Q monitoring (see Figure A.14) | | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | The Device shall be able to enter communication after the SDCI readiness delay. Measure SDCI readiness delay of the Device after a power-on situation. | | |
| Precondition | PLT: Reference-Master, Port power = OFF EUT: unpowered | | |
| Procedure | a) Port power = ON, e.g. via SMI_PortPowerOffOn(ABPS_PORTPOWERON) b) Monitor VSD voltage at L+ c) Identify time t0 when VSD reaches VSDmin = 18V d) Master starts communication with wake-up sequence at t0 + TRDLmax e) Monitor C/Q signal for more than t0 + TRDLmax + TDWU f) Evaluation 1) | | |
| Test parameter | VSM = 24 V | | |
| Post condition | – | | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | 1) Check Device responses to Wake-up request at Device transmission rate | | |
| Test passed | Device responds to first Wake-up request and communicates | | |
| Test not passed (examples) | Device does not respond to first Wake-up request | | |
| Report | Response to first Wake-up request @ TRDL: <yes/no> | | <ok nok> |

5.5.6 Time to return to SIO after failed wake-up

Table 37 defines the test conditions for this test case.

Table 37 – Time to return to SIO after failed wake-up

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0301 |
| Name | | TCD_PHYL_INTF_TDELAYTOSIO |
| Purpose (short) | | Time TDSIO within permitted range |
| Equipment under test (EUT) | | Device with SIO mode, C/Q signal high |
| Test case version | | 1.1 |
| Category / type | | Device PL test: test to pass |
| Specification (clause) | | [7], see 7.3.2.2, Table 42 |
| Configuration / setup | | Master and EUT with CQ monitoring according to Figure A.9 |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Delay time TDSIO from an unsuccessful Wake-Up to the return of the Device to SIO-mode is tested. |
| Precondition | | PLT: See Figure A.9 EUT: SIO mode. Device set to a <i>PL test set-up</i> , where the output of the Device can be set to high level |
| Procedure | | a) Apply negative wake-up request pulse to Device b) Monitor signal at C/Q c) Measure tDSIO from WURQ to transition to stable 'H'-level at C/Q d) Repeat another 5 times steps a) to c). Memorize all values of tDSIO e) Evaluation 1) |
| Test parameter | | VSD = 24 V |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) tDSIO of all 6 measurements shall be within specified limits. Identify minimum and maximum values from all measured values of TDSIO |
| Test passed | | For all values: $60 \text{ ms} \leq \text{tDSIO} \leq 300 \text{ ms}$ |
| Test not passed (examples) | | For any value: $\text{tDSIO} < 60 \text{ ms}$, or $\text{tDSIO} > 300 \text{ ms}$ |
| Report | | tDSIomin: <value> tDSIomax: <value> tDSIO within specified boundaries: <yes/no> |
| | | <ok nok> |

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632 **5.5.7 Time to Fallback after Master command**

633 Table 38 defines the test conditions for this test case.

634 **Table 38 – Time to Fallback after Master command**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0302 |
| Name | | TCD_PHYL_INTF_TTOFallback |
| Purpose (short) | | Time tFBD within permitted range |
| Equipment under test (EUT) | | Device with C/Q high in SIO mode (indicated in IODD) |
| Test case version | | 1.2 |
| Category / type | | Device PL test: test to pass |
| Specification (clause) | | [7], see 7.3.2.3, Table 42 |
| Configuration / setup | | Reference-Master and EUT (see A.1.5) |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | tFBD from a confirmed MasterCommand "Fallback" to the return of the Device to SIO-mode is tested. |
| Precondition | | Reference-Master: PORT_INACTIVE EUT: C/Q high in SIO mode |
| Procedure | | <ul style="list-style-type: none"> a) Set Device to OPERATE mode e.g. via SMI_PortConfiguration(ABPS_NO_TYPE_CHECK) b) Read VendorID e.g. via SMI_PortStatus c) Read MasterCycleTime from Master or EUT d) Set Device to SIO mode (apply "Fallback" MasterCommand), e.g. via SMI_PortConfiguration(ABPS_PORTINACTIVE) e) Monitor signal level at C/Q f) Measure tFBD from end of the first Device reply message to a Master Write message with MasterCommand "Fallback" and the transition to stable 'H'-level at C/Q g) Evaluation 1) h) Set Device to PREOPERATE mode e.g. via SMI_PortConfiguration (ABPS_TPYE_COMP <VendorID ≠ PortStatus.VendorID>) ;stimulate config error i) Set Device to SIO mode (apply "Fallback" MasterCommand), e.g. via SMI_PortConfiguration(ABPS_PORTINACTIVE) j) Monitor level at C/Q k) Measure tFBD from end of the first Device reply message to a Master Write message with MasterCommand "Fallback" and the transition to stable 'H'-level at C/Q l) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Fallback delay tFBD @ OPERATE 2) Check Fallback delay tFBD @ PREOPERATE |
| Test passed | | Three times MasterCycleTime ≤ tFBD @ OPERATE ≤ 500 ms, and Three times RecoveryTime ≤ tFBD @ PREOPERATE ≤ 500 ms |
| Test not passed (examples) | | tFBD @ OPERATE < three times MasterCycleTime, or tFBD @ OPERATE > 500 ms, or tFBD @ PREOPERATE < three times RecoveryTime, or tFBD @ PREOPERATE > 500 ms |
| Report | | tFBD @ OPERATE: <value> tFBD @ PREOPERATE: <value> |
| | | <ok nok> <ok nok> |

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639 **5.6 Dynamic parameters of the Master and Device interface**

640 **5.6.1 Bit eye-diagram with maximum load (Master)**

641 Table 39 defines the test conditions for this test case.

642 **Table 39 – Bit eye-diagram with maximum load (Master)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0030 |
| Name | TCM_PHYL_INTF_BITEYEMAXLOAD |
| Purpose (short) | Eye-diagram of ‘low’ and ‘high’ bits |
| Equipment under test (EUT) | Master |
| Test case version | 1.2 |
| Category / type | Master signal test: test to pass |
| Specification (clause) | [7], see 5.3.3.2, Figure 22, Table 5, Table 9 |
| Configuration / setup | EUT and Reference-Device (see Figure A.15 and clause A.1.5) |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | The waveform shall meet the requirements of the eye diagram under maximum load conditions. Test waveform for bits at the C/Q input on the receiver side with a maximum permissible load applied. UART frames shall provide rising and falling edges at every bit position. |
| Precondition | Reference-Device: disconnected EUT: PORT_INACTIVE |
| Procedure | a) Attach line simulation circuit b) Attach Reference-Device with first values from COM and CQD ; <i>Test parameter</i> c) Apply first value of PSM to Master ; <i>Test parameter</i> d) Set Master to SDCI mode, e.g. via SMI_PortConfiguration(ABPS_NO_TYPE_CHECK) e) Wait until OPERATE is reached to check for communication, e.g. via SMI services f) Record waveforms on Device side for a minimum of 100 EUT UART frames g) Evaluation 1) h) Repeat from step d) with next value of PSM i) Repeat from step c) with next values from COM and CQD |
| Test parameter | COM = {COM2, COM3}, CQD = {10 nF, 1 nF}, PSM = {PSMmin, PSMmax} (according to user manual) |
| Post condition | Memorize waveforms |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Determine tDR, tDF, VIHDMAX, V+D, V0D, VIldMIN in waveform |
| Test passed | For all monitored bits of the UART frames: tDR, tDF < 0,2 TBIT, and VIHDMAX – V+D < 1,0 V, and V0D – VIldMIN < 1,0 V |
| Test not passed (examples) | Any of the conditions in test passed is not met |
| Report | Bit eye-diagram @ maximum load (PSMmin): <yes/no> <ok nok> Bit eye-diagram @ maximum load (PSMmax): <yes/no> <ok nok> |

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647 **5.6.2 Bit eye-diagram with maximum load (Device)**

648 Table 39 defines the test conditions for this test case.

649 **Table 40 – Bit eye-diagram with maximum load (Device)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0294 |
| Name | | TCD_PHYL_INTF_BITEYEMAXLOAD |
| Purpose (short) | | Eye-diagram of 'low' and 'high' bits |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.2 |
| Category / type | | Device signal test: test to pass |
| Specification (clause) | | [7], see 5.3.3.2, Figure 22, Table 5, Table 9, |
| Configuration / setup | | Reference-Master connected to EUT (see Figure A.15 and clause A.1.5) |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | The waveform shall meet the requirements of the eye diagram under maximum load conditions. Test waveform for bits at C/Q input on the receiver side with a maximum permissible load applied. UART frames shall provide rising and falling edges at every bit position. |
| Precondition | | Reference-Master: PORT_INACTIVE EUT: SIO mode |
| Procedure | | a) Attach line simulation b) Attach Reference-Master with CQM = 1 nF c) Set VSM to first value d) Set Master to SDI mode, e.g. via SMI_PortConfiguration(ABPS_NO_TYPE_CHECK) e) Wait until OPERATE is reached to check for communication, e.g. via SMI services f) Record waveforms on Master side for a minimum of 100 EUT UART frames g) Evaluation 1) h) Repeat from step c) with next value of VSM |
| Test parameter | | VSM = {20V, 30V} |
| Post condition | | Memorize waveforms |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Determine tDR, tDF, VIHMMAX, V+M, V0M, VILMMIN in waveform |
| Test passed | | For all monitored bits of the UART frames: tDR, tDF < 0,2 TBIT, and VIHMMAX – V+M < 1,0 V, and V0M – VILMMIN < 1,0 V |
| Test not passed (examples) | | Any of the conditions in test passed is not met |
| Report | | Bit eye-diagram @ maximum load (VSM = 20 V): <yes/no> <ok nok> Bit eye-diagram @ maximum load (VSM = 30 V): <yes/no> <ok nok> |

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654 **5.6.3 Bit eye-diagram with minimum load (Master)**

655 Table 41 defines the test conditions for this test case.

656 **Table 41 – Bit eye-diagram with minimum load (Master)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0031 |
| Name | | TCM_PHYL_INTF_BITEYEMINLOAD |
| Purpose (short) | | Eye-diagram of 'low' and 'high' bits |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.2 |
| Category / type | | Master signal test: test to pass |
| Specification (clause) | | [7], see 5.3.3.2, Figure 22, Table 5, Table 9 |
| Configuration / setup | | EUT connected to Reference-Device without line simulation circuit (see A.1.5) |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | The waveform shall meet the requirements of the eye-diagram under minimum line load conditions. Test waveform for bits at the C/Q input on the receiver side with an applied minimum load. UART frames shall provide rising and falling edges at every bit position. | |
| Precondition | Reference-Device: disconnected EUT: PORT_INACTIVE | |
| Procedure | a) Attach Reference-Device with CQD = 500 pF and set first value of COM ; b) Apply first value of PSM to Master ; c) Set Master to communication, e.g. via SMI_PortConfiguration (ABPS_NO_TYPE_CHECK) d) Wait until OPERATE is reached to check for communication, e.g. via SMI services e) Record bit-waveforms on the Device side for a minimum of 100 EUT UART frames f) Evaluation 1) g) Repeat from step c) with next value of PSM h) Repeat from step b) with next value of COM | |
| Test parameter | COM= {COM2, COM3} PSM = {PSMmin, PSMmax} (according to user manual) | |
| Post condition | Memorize waveforms | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Determine tDR, tDF, VIHDMAX, V+D, V0D, VILDMIN in waveform | |
| Test passed | For all monitored bits of the UART frames: tDR, tDF < 0,2 TBIT, and VIHDMAX – V+D < 1,0 V, and V0D – VILDMIN < 1,0 V | |
| Test not passed (examples) | Any of the conditions in test passed is not met | |
| Report | Bit eye-diagram @ minimum load (PSMmin): <yes/no> Bit eye-diagram @ minimum load (PSMmax): <yes/no> | <ok nok> <ok nok> |

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661 **5.6.4 Bit eye-diagram with minimum load (Device)**

662 Table 41 defines the test conditions for this test case.

663 **Table 42 – Bit eye-diagram with minimum load (Device)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0295 |
| Name | | TCD_PHYL_INTF_BITEYEMINLOAD |
| Purpose (short) | | Eye-diagram of 'low' and 'high' bits |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.2 |
| Category / type | | Device signal test: test to pass |
| Specification (clause) | | [7], see 5.3.3.2, Figure 22, Table 5, Table 9 |
| Configuration / setup | | Reference-Master connected to EUT without line simulation (see A.1.5) |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | The waveform shall meet the requirements of the eye-diagram under minimum line load conditions. Test waveform for bits at C/Q input on the receiver side with an applied minimum line load. UART frames shall provide rising and falling edges at every bit position. |
| Precondition | | Reference-Master: PORT_INACTIVE EUT: SIO mode |
| Procedure | | a) Attach Reference-Master with CQM = 500pF b) Set VSM to first value c) Set Reference-Master to SDCI mode, e.g. via SMI_PortConfiguration(ABPS_NO_TYPE_CHECK) d) Wait until OPERATE to check for communication, e.g. via SMI services e) Record waveforms on the Master side for a minimum of 100 EUT UART frames f) Evaluation 1) g) Repeat from step c) with next value of VSM |
| Test parameter | | VSM = {20V, 30V} |
| Post condition | | Memorize waveforms |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Determine tDR, tDF, VIHMMAX, V+M, V0M, VILMMIN in waveform |
| Test passed | | For all monitored bits of the UART frames: tDR, tDF < 0,2 TBIT, and VIHMMAX – V+M < 1,0 V, and V0M – VILMMIN < 1,0 V |
| Test not passed (examples) | | Any of the conditions in test passed is not met |
| Report | | Bit eye-diagram @ minimum load (VSM = 20 V): <yes/no> <ok nok> Bit eye-diagram @ minimum load (VSM = 30 V): <yes/no> <ok nok> |

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668 **5.6.5 UART frame eye-diagram with maximum load (Master)**

669 Table 43 defines the test conditions for this test case.

670 **Table 43 – UART frame eye-diagram with maximum load (Master)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0032 |
| Name | | TCM_PHYL_INTF_UARTEYEMAXLOAD |
| Purpose (short) | | Eye-diagram of the UART frame |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.2 |
| Category / type | | Master signal test: test to pass |
| Specification (clause) | | [7], see 5.3.3.2, Figure 23, Table 9 |
| Configuration / setup | | EUT and Reference-Device using line simulation (see Figure A.15 and A.1.5) |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | The waveform shall meet the requirements of the eye-diagram under maximum line load conditions. Test waveform for UART frame at the C/Q input on the receiver side with an applied maximum permissible load. |
| Precondition | | Memorized bit waveforms from TC_0030 |
| Procedure | | – |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Apply mask with keep-out areas according to [7], Figure 23 to recorded UART frame waveforms of TC_0030 |
| Test passed | | UART frame waveforms do not enter keep-out areas |
| Test not passed (examples) | | Any UART frame waveform does enter keep-out areas |
| Report | | UART frame eye-diagram @ maximum load (PSMmin): <yes/no> <ok nok> UART frame eye-diagram @ maximum load (PSMmax): <yes/no> <ok nok> |

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675 **5.6.6 UART frame eye-diagram with maximum load (Device)**

676 Table 43 defines the test conditions for this test case.

677 **Table 44 – UART frame eye-diagram with maximum load (Device)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|---|---|
| Identification (ID) | | SDCI_TC_0296 |
| Name | | TCD_PHYL_INTF_UARTEYEMAXLOAD |
| Purpose (short) | | Eye-diagram of the UART frame |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.2 |
| Category / type | | Device signal test: test to pass |
| Specification (clause) | | [7], see 5.3.3.2, Figure 23, Table 9 |
| Configuration / setup | | Reference-Master connected to EUT (see Figure A.15 and A.1.5) |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | The waveform shall meet the requirements of the eye-diagram under maximum line load conditions. Test waveform for UART frame at the C/Q input on the receiver side with an applied maximum permissible line load. UART frames shall provide rising and falling edges at every bit position. | |
| Precondition | Memorized waveforms of TC_0294 | |
| Procedure | – | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Apply mask with keep-out areas according to [7], Figure 23 to recorded UART frame waveforms of TC_0294 | |
| Test passed | UART frame waveform does not enter keep-out areas | |
| Test not passed (examples) | Any UART frame waveform enters keep-out areas | |
| Report | UART frame eye-diagram @ maximum load (VSM = 20 V): <yes/no> <ok nok> UART frame eye-diagram @ maximum load (VSM = 30 V): <yes/no> <ok nok> | |

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5.6.7 UART frame eye-diagram with minimum load (Master)

Table 45 defines the test conditions for this test case.

Table 45 – UART frame eye-diagram with minimum load (Master)

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|---|------------|
| Identification (ID) | | SDCI_TC_0033 | |
| Name | | TCM_PHYL_INTF_UARTEYEMINLOAD | |
| Purpose (short) | | Eye-diagram of UART frame | |
| Equipment under test (EUT) | | Master | |
| Test case version | | 1.2 | |
| Category / type | | Master signal test: test to pass | |
| Specification (clause) | | [7], see 5.3.3.2, Figure 23, Table 9 | |
| Configuration / setup | | EUT and Reference-Device connected without line simulation (see A.1.5) | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | | The waveform shall meet the requirements of the eye-diagram under minimum line load conditions. Test waveform for UART frame at the C/Q input on the receiver side with a minimum load. UART frames shall provide rising and falling edges at every bit position. | |
| Precondition | | Memorized waveforms of TC_0031 | |
| Procedure | | – | |
| Test parameter | | – | |
| Post condition | | – | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | | 1) Apply mask with keep-out areas according to [7], Figure 23 to recorded UART frame waveforms of TC_0031 | |
| Test passed | | UART frame waveforms do not enter keep-out areas | |
| Test not passed (examples) | | Any UART frame waveform enters keep-out areas | |
| Report | | UART frame eye-diagram @ minimum load (PSMmin): <yes/no> | <ok nok> |
| | | UART frame eye-diagram @ minimum load (PSMmax): <yes/no> | <ok nok> |

689 **5.6.8 UART frame eye-diagram with minimum load (Device)**

690 Table 45 defines the test conditions for this test case.

691 **Table 46 – UART frame eye-diagram with minimum load (Device)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0297 |
| Name | TCD_PHYL_INTF_UARTEYEMINLOAD |
| Purpose (short) | Eye-diagram of UART frame |
| Equipment under test (EUT) | Device |
| Test case version | 1.2 |
| Category / type | Device signal test: test to pass |
| Specification (clause) | [7], see 5.3.3.2, Figure 23, Table 9 |
| Configuration / setup | Reference-Master connected to EUT without line simulation (see A.1.5) |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | The waveform shall meet the requirements of the eye-diagram under minimum line load conditions. Test waveform for UART frame at the C/Q input on the receiver side with a minimum load. UART frames shall provide rising and falling edges at every bit position. |
| Precondition | Memorized waveforms of TC_0295 |
| Procedure | – |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Apply mask with keep-out areas according to [7], Figure 23 to recorded UART frame waveforms of TC_0295 |
| Test passed | UART frame waveform is outside keep-out areas |
| Test not passed (examples) | Any UART frame waveform is inside keep-out areas |
| Report | UART frame eye-diagram @ minimum load (VSM = 20 V): <yes/no> <ok nok> UART frame eye-diagram @ minimum load (VSM = 30 V): <yes/no> <ok nok> |

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5.6.9 UART frame transmission delay of Master (Ports)

Table 47 defines the test conditions for this test case.

Table 47 – UART frame transmission delay of Master (Ports)

-CR103-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|---|----------------------------|
| Identification (ID) | SDCI_TC_0303 | |
| Name | TCM_PHYL_INTF_UARTTRANSDELAY | |
| Purpose (short) | UART frame transmission delay is within permitted range | |
| Equipment under test (EUT) | Master | |
| Test case version | 1.4 2 | |
| Category / type | Master signal test: test to pass | |
| Specification (clause) | [7], see A.3.3, equation (A.3) | |
| Configuration / setup | EUT with Reference-Device and C/Q line monitor (Figure A.16) | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | The delay time between two consecutive UART frames of a Master message is measured. | |
| Precondition | Reference-Device: Connected EUT: PORT_INACTIVE | |
| Procedure | a) Set Master to communication, e.g. via SMI_PortConfiguration(ABPS_NO_TYPE_CHECK) b) Record waveform at C/Q of at least 7 Master messages in STARTUP, PREOPERATE, and OPERATE c) Evaluation 1) | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Determine time tFRAME between the rising edges of start bits of consecutive UART frames for all recorded Master messages. Calculate UART frame transmission delay t1 for all evaluated UART frames with: $t1 = (tFRAME - 11 \text{ TBIT})$ Determine minimum and maximum values from all calculated delays t1 | |
| Test passed | For all values t1: $0 \text{ TBIT} \leq t1 \leq 1 \text{ TBIT}$ | |
| Test not passed (examples) | Any value t1: $t1 > 1 \text{ TBIT}$ | |
| Report | t1min: <minimum value of t1> t1max: <maximum value of t1> t1 within specified boundaries: <yes/no> | |
| | <ok nok> | |

704 **5.6.10 UART frame transmission delay of Device**

705 Table 48 defines the test conditions for this test case.

706 **Table 48 – UART frame transmission delay of Device**

707 **-CR103-**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|-----------------------------|---|
| Identification (ID) | SDCI_TC_0304 |
| Name | TCD_PHYL_INTF_UARTTRANSDELAY |
| Purpose (short) | UART frame transmission delay is within permitted range |
| Equipment under test (EUT) | Device |
| Test case version | 1.4 2 |
| Category / type | Device signal test: test to pass |
| Specification (clause) | [7], see A.3.4, equation (A.4) |
| Configuration / setup | Device connected to Reference-Master and C/Q line monitor (Figure A.16) |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | The delay time between two consecutive UART frames of a Device reply message is measured. |
| Precondition | Reference-Master: PORT_INACTIVE EUT: SIO mode |
| Procedure | a) Set Master to SDCI mode, e.g. via SMI_PortConfiguration(ABPS_NO_TYPE_CHECK) b) Monitor waveform of at least 7 Device reply messages with more than 1 UART frame in STARTUP, PREOPERATE, and OPERATE at C/Q c) Evaluation 1) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Determine time tFRAME between the rising edges of start bits of consecutive UART frames for all recorded Device reply messages. Calculate UART frame transmission delay t2 for all evaluated UART frames with: $t2 = (tFRAME - 11 \text{ TBIT})$ |
| Test passed | For all values t2: $0 \text{ TBIT} \leq t2 \leq 3 \text{ TBIT}$ |
| Test not passed (examples) | Any value t2: $t2 > 3 \text{ TBIT}$ |
| Report | t2min: <minimum value of t2> t2max: <maximum value of t2> t2 within specified boundaries: <yes/no> |
| | <ok nok> |

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712 **5.6.11 Response time of Device**

713 Table 49 defines the test conditions for this test case.

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Table 49 – Response time of Device

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0305 |
| Name | TCD_PHYL_INTF_RESPONSETIME |
| Purpose (short) | Device response time is within permitted range |
| Equipment under test (EUT) | Device |
| Test case version | 1.1 |
| Category / type | Device signal test: test to pass |
| Specification (clause) | [7], see A.3.5, equation (A.5) |
| Configuration / setup | Device connected to Reference-Master and C/Q line monitor (Figure A.16) |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | The delay time between Master messages to Device reply message (end of last UART frame to begin of first UART frame) is measured. |
| Precondition | Reference-Master: PORT_INACTIVE EUT: SIO mode |
| Procedure | a) Set Master to SDCI mode, e.g. via SMI_PortConfiguration(ABPS_NO_TYPE_CHECK) b) Monitor all M-sequences with Master Read messages in STARTUP c) Monitor all M-sequences with Master Write messages in STARTUP d) Monitor all M-sequences with Master Read messages in PREOPERATE e) Monitor all M-sequences with Master Write messages in PREOPERATE f) Monitor at least 100 M-sequences with Master Read messages in OPERATE g) Monitor at least 100 M-sequences with Master Write messages in OPERATE h) Monitor all M-sequences with 4 Device Events in OPERATE if applicable i) Evaluation 1) |
| Test parameter | Exemplary: Device test Events according to IODD |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | For all values tA: 1) Determine time tDELAY between the rising edges of the start bit of the last UART frame of the Master message to the start bit of the first UART frame of the Device reply message for all recorded M-sequences. Calculate response time of the Device tA for all evaluated M-sequences with: $tA = (tDELAY - 11 TBIT)$ |
| Test passed | All values tA: $1 \text{ TBIT} \leq tA \leq 10 \text{ TBIT}$ |
| Test not passed (examples) | Any value tA: $tA < 1 \text{ TBIT}$ OR $tA > 10 \text{ TBIT}$ |
| Report | tAmin: < minimum value of tA > tAmax: < maximum value of tA > tA within specified boundaries: <yes/no> |
| | <ok nok> |

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720 **5.6.12 Device response without transmission errors**

721 Table 50 defines the test conditions for this test case.

722 **Table 50 – Device response without transmission errors**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0319 |
| Name | | TCD_PHYL_INTF_TRANSMISSIONERRORS |
| Purpose (short) | | Device response without transmission errors @ standard noise-free test conditions |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.0 |
| Category / type | | Device signal test: test to pass |
| Specification (clause) | | [7], Annex I, Figure I.1 |
| Configuration / setup | | Reference-Master connected to EUT and C/Q line monitor (Figure A.16) |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Device response without transmission errors at standard noise-free test conditions: - Parity - Checksum - Missing Device response |
| Precondition | | Reference-Master: PORT_INACTIVE EUT: SIO mode |
| Procedure | | a) Set Master to SDCI mode, e.g. via SMI_PortConfiguration(ABPS_NO_TYPE_CHECK) b) Monitor all M-sequences with Master read messages in STARTUP c) Monitor all M-sequences with Master write messages in STARTUP d) Monitor all M-sequences with Master read messages in PREOPERATE e) Monitor all M-sequences with Master write messages in PREOPERATE f) Monitor at least 100 M-sequences with Master read messages in OPERATE g) Monitor at least 100 M-sequences with Master write messages in OPERATE h) Monitor all M-sequences with four Master Events in OPERATE if applicable j) Evaluation 1) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | Count transmission errors in all recorded Device responses |
| Test passed | | No transmission error detected |
| Test not passed (examples) | | Transmission error detected |
| Report | | Transmission errors: <yes/no> <ok nok> |

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727 **5.7 Test report template for PL tests**

728 Table 51 shows the template for the test report of the Physical Layer tests.

729 **Table 51 – Template for the test report of the Physical Layer tests**

| TEST CASE ID | TEST results | ok/ nok | Statement/ Exception |
|--------------|--|------------|-------------------------|
| SDCI_TC_0001 | VSM (PSMmin): <value> VSM (PSMmax): <value> Steady current flow: <yes/no> | | |
| SDCI_TC_0002 | QMI (PSMmin): <value> QMI (PSMmax): <value> | | |
| SDCI_TC_0003 | ILLM (VIM = 5 V, PSMmin): <value> ILLM (VIM = 5,1 V, PSMmin): <value> ILLM (VIM = 15 V, PSMmin): <value> ILLM (VIM = measured value of VSM, PSMmin): <value> ILLM (VIM = 5 V, PSMmax): <value> ILLM (VIM = 5,1 V, PSMmax): <value> ILLM (VIM = 15 V, PSMmax): <value> ILLM (VIM = measured value of VSM, PSMmax): <value> | | |
| SDCI_TC_0004 | VRQHM (PSMmin): <value> VRQHM (PSMmax): <value> | | |
| SDCI_TC_0005 | VRQLM (PSMmin): <value> VRQLM (PSMmax): <value> | | |
| SDCI_TC_0006 | VIM @ Transition 0→1 (PSMmin): <value> VIM @ Transition 0→1 (PSMmax): <value> | | |
| SDCI_TC_0007 | VIM @ Transition 1→0 (PSMmin): <value> VIM @ Transition 1→0 (PSMmax): <value> | | |
| SDCI_TC_0008 | VHYSM (PSMmin): <value> VHYSM (PSMmax): <value> | | |
| SDCI_TC_0299 | Communication established: <yes/no> | | |
| SDCI_TC_0310 | RIsom0: <value> RIsom1: <value> | | |
| SDCI_TC_0011 | ISDSIOMax (VSD = 18 V): <value/ n/a> ISDSIOMax (VSD = 30 V): <value/ n/a> ISDIOLmax (VSD = 18 V): <value> ISDIOLmax (VSD = 30 V): <value> | | Warning |
| SDCI_TC_0320 | Type of information: <value> | | Warning |
| SDCI_TC_0012 | QISD (VSD = 18 V): <value> STARTUP count (VSD = 18 V): <value> QISD (VSD = 30 V): <value> STARTUP count (VSD = 30 V): <value> | | |
| SDCI_TC_0013 | VCQ (VSD = 18 V): <value> VCQ (VSD = 30 V): <value> | | |
| SDCI_TC_0014 | VCQ (VSD = 18 V): <value> VCQ (VSD = 30 V): <value> | | |
| SDCI_TC_0015 | ICQ (VSD = 18 V, VID = 13V): <value> ICQ (VSD = 18 V, VID = VSD): <value> ICQ (VSD = 30 V, VID = 13V): <value> ICQ (VSD = 30 V, VID = VSD): <value> | | |
| SDCI_TC_0016 | VID @ Transition 0→1 (VSD = 18 V): <value> VID @ Transition 0→1 (VSD = 30 V): <value> | | |
| SDCI_TC_0017 | VID @ Transition 1→0 (VSD = 18 V): <value> VID @ Transition 1→0 (VSD = 30 V): <value> | | |
| SDCI_TC_0018 | VHYSD (VSD = 18 V): <value> VHYSD (VSD = 30 V): <value> | | |
| SDCI_TC_0300 | Communication established: <yes/no> | | |
| SDCI_TC_0311 | RIsod0: <value> RIsod1: <value> | | |

| TEST CASE ID | TEST results | ok/ nok | Statement/ Exception |
|--------------|--|------------|-------------------------|
| SDCI_TC_0021 | VIM @ WURQ (PSMmin): <value> VIM @ WURQ (PSMmax): <value> | | |
| SDCI_TC_0022 | tWUmin @ WURQ: <value> tWUmax @ WURQ: <value> | | |
| SDCI_TC_0023 | VIM @ WURQ (PSMmin): <value> VIM @ WURQ (PSMmax): <value> | | |
| SDCI_TC_0024 | tWUmin @ WURQ: <value> tWUmax @ WURQ: <value> | | |
| SDCI_TC_0025 | WURQ (VSD = 18 V): <yes/no> WURQ (VSD = 30 V): <yes/no> Proof of correct pulse detection: <yes/no> | | |
| SDCI_TC_0026 | WURQ (VSD = 18 V): <yes/no> WURQ (VSD = 30 V): <yes/no> Proof of correct pulse detection: <yes/no> | | |
| SDCI_TC_0027 | tREN @ C/Q = high: <value> | | |
| SDCI_TC_0028 | tREN @ C/Q = low: <value> | | |
| SDCI_TC_0029 | Response to first Wake-up request @TRDL: <yes/no> | | |
| SDCI_TC_0301 | tDSIomin: <value> tDSIomax: <value> tDSIO within specified boundaries: <yes/no> | | |
| SDCI_TC_0302 | tFBD @ OPERATE: <value> tFBD @ PREOPERATE: <value> | | |
| SDCI_TC_0030 | Bit eye-diagram @ maximum load (PSMmin): <yes/no> Bit eye-diagram @ maximum load (PSMmax): <yes/no> | | |
| SDCI_TC_0294 | Bit eye-diagram @ maximum load (VSM = 20 V): <yes/no> Bit eye-diagram @ maximum load (VSM = 30 V): <yes/no> | | |
| SDCI_TC_0031 | Bit eye-diagram @ minimum load (PSMmin): <yes/no> Bit eye-diagram @ minimum load (PSMmax): <yes/no> | | |
| SDCI_TC_0295 | Bit eye-diagram @ minimum load (VSM = 20 V): <yes/no> Bit eye-diagram @ minimum load (VSM = 30 V): <yes/no> | | |
| SDCI_TC_0032 | UART frame eye-diagram @ maximum load (PSMmin): <yes/no> UART frame eye-diagram @ maximum load (PSMmax): <yes/no> | | |
| SDCI_TC_0296 | UART frame eye-diagr. @ maximum load (VSM = 20 V): <yes/no> UART frame eye-diagr. @ maximum load (VSM = 30 V): <yes/no> | | |
| SDCI_TC_0033 | UART frame eye-diagram @ minimum load (PSMmin): <yes/no> UART frame eye-diagram @ minimum load (PSMmax): <yes/no> | | |
| SDCI_TC_0297 | UART frame eye-diagr. @ minimum load (VSM = 20 V): <yes/no> UART frame eye-diagr. @ minimum load (VSM = 30 V): <yes/no> | | |
| SDCI_TC_0303 | t1min: <minimum value of t1> t1max: <maximum value of t1> t1 within specified boundaries: <yes/no> | | |
| SDCI_TC_0304 | t2min: <minimum value of t2> t2max: <maximum value of t2> t2 within specified boundaries: <yes/no> | | |
| SDCI_TC_0305 | tAmin: < minimum value of tA > tAmax: < maximum value of tA > tA within specified boundaries: <yes/no>: | | |
| SDCI_TC_0319 | Transmission errors: <yes/no>: | | |

6 Device protocol test cases

6.1 General

-CR019-

735 The protocol tests can be performed almost automatically with the help of a Device-Tester as
736 defined in A.2.2. The test sequences are described in 4.4 together with a list of the relevant
737 test cases for Devices without ISDU support in Table 4, and a list of the relevant test cases for
738 Devices with ISDU support in Table 5. Supplementary requirements for Legacy-Devices beyond
739 the definitions in [5] are listed in Annex B.

740 Procedure results not mentioned in the evaluation part are assumed to be successful for pass-
741 ing the tests.

6.2 STARTUP

6.2.1 STARTUP cycle time

744 Table 52 defines the test conditions for this test case.

Table 52 – STARTUP cycle time

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|--|
| Identification (ID) | SDCI_TC_0034 | | |
| Name | TCD_DLPC_STUP_CYCTIME | | |
| Purpose (short) | Test STARTUP cycle time | | |
| Equipment under test (EUT) | Device | | |
| Test case version | 1.1 | | |
| Category / type | Device protocol test: test to pass | | |
| Specification (clause) | [7], see 7.3.2.5, 9.3.3.2, and A.2.6 | | |
| Configuration / setup | Device-Tester-Unit | | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | The Device shall perform in state STARTUP at any cycle time \geq 100 TBIT | | |
| Precondition | DTU: Wake-up and ComRequest are achieved until STARTUP is reached EUT: Device is in SDCI mode | | |
| Procedure | a) Master takes first value of CycTime in field "Test parameter" b) Master reads communication parameter (Direct Parameter 0x02 to 0x06) c) Master repeats at b) with next value of CycTime | | |
| Test parameter | CycTime {100 TBIT, 10 000 TBIT, 10 s} | | |
| Post condition | – | | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | 1) Check Device response after b) | | |
| Test passed | The Device responds to all read requests with valid (constant) data | | |
| Test not passed (examples) | No or incorrect response at any of the read requests | | |
| Report | Cycle time variation in STARTUP: <ok nok> | | |

750 6.2.2 From STARTUP to OPERATE

751 Table 53 defines the test conditions for this test case.

Table 53 – From STARTUP to OPERATE

753 -CR089-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|----------------------------|------------|
| Identification (ID) | SDCI_TC_0035 | | |
| Name | TCD_DLPC_STUP_STUOPER1 | | |
| Purpose (short) | Test state transition STARTUP to OPERATE | | |
| Equipment under test (EUT) | Device, except those with M-sequence TYPE_0 in OPERATE | | |
| Test case version | 1.2 3 | | |
| Category / type | Device protocol test: test to pass and test to fail | | |
| Specification (clause) | [7], see 7.2.3.5 7.3.2.5 , 9.3.3.2 | | |
| Configuration / setup | Device-Tester-Unit | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | <p>A Device supporting protocol revision V1.0 shall switch from STARTUP to OPERATE after receiving Master command 0x99. This transition is only used by Master supporting V1.0 according [5].</p> <p>A Device not supporting protocol revision V1.0 shall not switch from STARTUP to OPERATE after receiving Master command 0x99.</p> | | |
| Precondition | <p>DTU: Wake-up and ComRequest are achieved until STARTUP is reached</p> <p>EUT: Device is in SDCI mode</p> | | |
| Procedure | <ol style="list-style-type: none"> Master reads communication parameters (Direct Parameter 0x02 to 0x06) Master takes first value of MasterCycleTime in field "Test parameter" Master sends MasterCycleTime Master sends Master command 0x99 "DeviceOperate" Master sends ISDU "idle" request using the M-sequence TYPE for OPERATE Check Device response Master and Device switch to STARTUP Repeat from c) with next MasterCycleTime in field "Test parameter" | | |
| Test parameter | MasterCycleTime {MinCycleTime of Device, 0xBF (= 132,8 ms)} | | |
| Post condition | – | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | <ol style="list-style-type: none"> If Device supports protocol revision V1.0, check in step f) whether Device responds using M-Sequence TYPE for OPERATE If Device does not support protocol revision V1.0, check in step f) whether Device is not responding | | |
| Test passed | The Device responds correctly to any request according to its protocol support | | |
| Test not passed (examples) | The Device does not respond correctly to any request according to its protocol support or timeout | | |
| Report | Transition from STARTUP directly to OPERATE: | | <ok nok> |

758 **6.2.3 Master start-up with overwrite of the RID (compatible)**

759 Table 54 defines the test conditions for this test case.

760 **Table 54 – Master start-up with overwrite of the RID (compatible)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0306 |
| Name | | TCD_DLPC_CHCK_OVERRIDOK |
| Purpose (short) | | Check Device start-up behavior with overwrite of the Device RID (compatible) |
| Equipment under test (EUT) | | Device, except those not supporting protocol revision backward compatibility |
| Test case version | | 1.2 |
| Category / type | | Device protocol test: test to pass |
| Specification (clause) | | [7], 10.6.3 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Check Device start-up behavior with overwrite of the RevisionID (compatible). This test supposes the active switching to protocol revision 1.0. The Master overwrites the RID and the Device accepts the requested protocol version. |
| Precondition | | DTU: SIO mode; Port is configured to RevisionID 0x10 EUT: RevisionID is set to factory settings (0x11) |
| Procedure | | a) Master performs WURQ, ComRequest, Startup up to MasterIdent b) Master detects incorrect "RevisionID" c) Master overwrites the RevisionID with the requested legacy RevisionID d) Master writes MasterCommand 0x96 e) Master reads communication parameters again f) Master switches the "modified" Device into OPERATE mode |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) After step e), check RevisionID 2) After step f), check Device response |
| Test passed | | RevisionID (RID) = 0x10, and Device response with M-sequence TYPE for OPERATE |
| Test not passed (examples) | | No response, or Device provides RID = 0x11, or Incorrect Device response |
| Report | | Active switching to legacy protocol revision accepted: <ok nok> |

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766 **6.2.4 Illegal STARTUP to OPERATE**

767 Table 55 defines the test conditions for this test case.

768 **Table 55 – Illegal STARTUP to OPERATE**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0036 |
| Name | TCD_DLPC_STUP_STUOPER2 |
| Purpose (short) | Test illegal state transition STARTUP to OPERATE |
| Equipment under test (EUT) | Device, except those with M-sequence TYPE_0 in OPERATE |
| Test case version | 1.2 |
| Category / type | Device protocol test: test to pass |
| Specification (clause) | [7], see 7.2.3.5, 9.3.3.2 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | The Device shall not switch from STARTUP to OPERATE unless it receives a Master command 0x99. |
| Precondition | DTU: Wake-up and ComRequest are achieved until STARTUP is reached EUT: Device is in SDCI mode |
| Procedure | a) Master reads communication parameters (Direct Parameter 0x02 to 0x06) b) Master sends MasterCycleTime c) Master sends ISDU "idle" request using the M-sequence TYPE for OPERATE |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) After step c), check Device response |
| Test passed | No Device response |
| Test not passed (examples) | Any Device response |
| Report | Device does not leave STARTUP: <ok nok> |

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6.2.5 From OPERATE to STARTUP via Master command

Table 56 defines the test conditions for this test case.

Table 56 – From OPERATE to STARTUP via Master command

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|---|----------------------------|
| Identification (ID) | SDCI_TC_0037 | |
| Name | TCD_DLPC_OPER_OPERSTUP1 | |
| Purpose (short) | Test correct state transition from OPERATE to STARTUP | |
| Equipment under test (EUT) | Device, except those with M-sequence TYPE_0 in OPERATE | |
| Test case version | 1.2 | |
| Category / type | Device protocol test: test to pass | |
| Specification (clause) | [7], see 7.2.3.5, 9.3.3.2 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test the correct state transition from OPERATE to STARTUP via Master command | |
| Precondition | DTU: SDCI communication, OPERATE EUT: Device is in SDCI mode | |
| Procedure | a) Master sends MasterCommand 0x97 "DeviceStartup" b) Master sends ISDU "idle" request using the M-sequence TYPE for OPERATE c) Master reads Direct Parameter page address 0x02 using M-Sequence TYPE_0 | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) After step b), check Device response 2) After step c), check Device response | |
| Test passed | No response in 1), and Correct response in 2) | |
| Test not passed (examples) | Any response in 1), or Incorrect response in 2) | |
| Report | Transition from OPERATE state to STARTUP state: | <ok nok> |

780 6.2.6 From OPERATE to STARTUP via M-sequence TYPE_0

781 Table 57 defines the test conditions for this test case.

Table 57 – From OPERATE to STARTUP via M-sequence TYPE_0

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|--|
| Identification (ID) | | SDCI_TC_0038 | |
| Name | | TCD_DLPC_OPER_OPERSTAR2 | |
| Purpose (short) | | Test state transition OPERATE to STARTUP | |
| Equipment under test (EUT) | | Device, except those with M-sequence TYPE_0 in OPERATE | |
| Test case version | | 1.3 | |
| Category / type | | Device protocol test: test to pass (positive testing) | |
| Specification (clause) | | [7], see 7.2.3.5, 9.3.3.2; see NOTE in Table A.9 | |
| Configuration / setup | | Device-Tester-Unit | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | | Test state transition OPERATE to STARTUP | |
| Precondition | | DTU: SDCI communication, OPERATE EUT: Device is in SDCI mode | |
| Procedure | | a) Master sends M-sequence TYPE_0 to read Direct Parameter page address 0x02 b) Master sends M-sequence TYPE_0 to read Direct Parameter page address 0x02 c) Master sends ISDU "idle" request, using the M-sequence TYPE for OPERATE | |
| Test parameter | | – | |
| Post condition | | – | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | | 1) After step a), check Device response 2) After step b), check Device response 3) After step c), check Device response | |
| Test passed | | No response in 1), and Correct response in 2), and No response in 3) | |
| Test not passed (examples) | | Any response in 1), or Incorrect response in 2), or Any response in 3) | |
| Report | | Incorrect M-sequence in OPERATE state: <ok nok> | |

787 **6.3 PREOPERATE**

788 **6.3.1 From STARTUP to PREOPERATE Read**

789 Table 58 defines the test conditions for this test case.

790 **Table 58 – From STARTUP to PREOPERATE Read**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0039 |
| Name | TCD_DLPC_PROP_READPP1 |
| Purpose (short) | Switch Device from STARTUP to PREOPERATE and read DPP1. |
| Equipment under test (EUT) | Device |
| Test case version | 1.0 |
| Category / type | Device protocol test: test to pass, test to fail |
| Specification (clause) | [7], see 7.3.2.5, Figure 34, and Annex A.2, Table A.7 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Switch Device from STARTUP to PREOPERATE via Master command 0x9A and read DPP1. Device activates On-request Data, ISDU and Event handler and returns DL_Mode.ind (PREOPERATE). Device reply message to Master read message to be checked. |
| Precondition | - Initialize communication (WURQ) - Communication initialization successful (both in STARTUP state) - Save M-sequenceCapability, PDIn and PDOOut for later comparison |
| Procedure | a) DTU sends MasterCommand PREOPERATE (0x9A) b) DTU read message: Read DPP1 |
| Test parameter | M-sequenceCapability, PDIn, and PDOOut |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check whether MasterCommand 0x9A results in a correct reaction of the Device 2) Determine with saved settings on PDIn, PDOOut, and M-sequenceCapability the expected M-sequenceTYPE 3) Check whether the Device reply message has been received with the expected amount of On-request Data octets. 4) Check whether no process data has been transmitted. |
| Test passed | Device reply message has been received with the expected amount of On-request Data octets |
| Test not passed (examples) | In 1) MasterCommand 0x95 results in a state ≠ PREOPERATE, or In 3), 4) No or incorrect response from the Device |
| Report | Read of DPP1 in PREOPERATE state: <ok nok> |

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795 6.3.2 From STARTUP to PREOPERATE Write

796 Table 59 defines the test conditions for this test case.

Table 59 – From STARTUP to PREOPERATE Write

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|---|----------------------------|
| Identification (ID) | SDCI_TC_0040 | |
| Name | TCD_DLPC_PROP_WRITEDPP1 | |
| Purpose (short) | Switch Device from STARTUP to PREOPERATE and write DPP1. | |
| Equipment under test (EUT) | Device | |
| Test case version | 1.0 | |
| Category / type | Device protocol test: test to pass, test to fail | |
| Specification (clause) | [7], see 7.3.2.5, Figure 34, and Annex A.2, Table A.7 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Switch Device from STARTUP to PREOPERATE state via MasterCommand 0x9A and read DPP1. Master writes DPP1. Device reply message to Master read message to be checked. NOTE The number of octets to write depends on the used M-sequenceTYPE. The DPP1 will not be completely written, but a write request with a valid M-sequenceTYPE length will be accepted. | |
| Precondition | <ul style="list-style-type: none"> - Initialize communication (WURQ) - Communication initialization between Master and Device has been successful (both in STARTUP) - Save M-sequenceCapability, PDIn, and PDOOut for later comparison | |
| Procedure | <ol style="list-style-type: none"> a) DTU sends MasterCommand PREOPERATE (0x9A). b) Device acknowledges command c) DTU and Device changed to PREOPERATE d) Read DPP1 (one M-sequence) e) Save the Device's response On-request Data f) DTU builds a write message with the saved On-request Data ("mirror") g) DTU writes DPP1 (one message) in correct length h) Receive Device response | |
| Test parameter | M-sequenceCapability, PDIn and PDOOut | |
| Post condition | - | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | <ol style="list-style-type: none"> 1) Check whether MasterCommand 0x9A results in correct response of the Device 2) Determine with saved settings on PDIn, PDOOut, and M-sequenceCapability the expected M-sequenceTYPE 3) Check whether the Device reply message has been received and contains no On-request Data octets | |
| Test passed | DPP1 write command has been accepted | |
| Test not passed (examples) | In 1) MasterCommand 0x9A results in an incorrect response of the Device In 2), 3) No or incorrect response from the Device | |
| Report | Write of DPP1 in PREOPERATE state: | <ok nok> |

6.3.3 From STARTUP to PREOPERATE short message

Table 60 defines the test conditions for this test case.

Table 60 – From STARTUP to PREOPERATE short message

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|--|
| Identification (ID) | SDCI_TC_0041 | | |
| Name | TCD_DLPC_PROP_SHORTMESSAGE | | |
| Purpose (short) | Test behavior to truncated M-sequence request | | |
| Equipment under test (EUT) | Device | | |
| Test case version | 1.0 | | |
| Category / type | Device protocol test: test to fail | | |
| Specification (clause) | [7], see 7.3.2.5, Figure 34, and Annex A.2, Table A.7 | | |
| Configuration / setup | Device-Tester-Unit | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | Switch Device into PREOPERATE. To emulate message disturbances, caused for example by electromagnetic interference, DTU sends one octet less than required. The Device shall not respond to this truncated M-sequence request and respond to the following request without error. | | |
| Precondition | DTU and Device in PREOPERATE | | |
| Procedure | a) DTU writes to parameter "VendorID" in DPP1 (address 0x07/0x08) with one octet less than the normal request length b) DTU writes to parameter "VendorID" in DPP1 (address 0x07/0x08) after the shortest possible time (MinCycleTime, see Table A.9 and B.1.4) | | |
| Test parameter | – | | |
| Post condition | – | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | 1) Check response in a) 2) Check response in b) | | |
| Test passed | In 1) No response on the first request, and In 2) Response on the second request | | |
| Test not passed (examples) | In 1) Response on the first request, or In 2) No response to the second request | | |
| Report | First response: Second response: | <ok nok> <ok nok> | |

809 **6.3.4 From PREOPERATE to STARTUP via simulated reset**

810 Table 61 defines the test conditions for this test case.

811 **Table 61 – From PREOPERATE to STARTUP via simulated reset**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0043 |
| Name | | TCD_DLPC_PROP_SIMRESET |
| Purpose (short) | | Switch Device back to STARTUP from PREOPERATE via simulation of a reset |
| Equipment under test (EUT) | | Device in PREOPERATE |
| Test case version | | 1.2 |
| Category / type | | Device protocol test: test to pass, test to fail |
| Specification (clause) | | [7], see 7.3.2.5, Figure 34 (T12), and Annex A, Table A.7; see NOTE in Table A.9 on TYPE_0 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master and Device are in PREOPERATE. Master sends a TYPE_0 message (simulation of a Master reset – FHInfo_ILLEGAL_FRAMETYPE). The Device shall switch to STARTUP (deactivate On-request Data, ISDU and Event handler) and shall send a TYPE_0 response. |
| Precondition | | <ul style="list-style-type: none"> - Establish communication (WURQ) - Communication between DTU and Device successful (both in STARTUP) - Save M-sequenceCapability, PDIn, and PDOOut for later comparison - DTU sends MasterCommand PREOPERATE (0x9A) - DTU and Device in PREOPERATE |
| Procedure | | <ol style="list-style-type: none"> a) DTU checks usage of TYPE_0 in PREOPERATE. If yes, stop test and raise exception. Otherwise: b) DTU sends TYPE_0 Read request to get MinCycleTime c) DTU sends TYPE_0 read request to get MinCycleTime again |
| Test parameter | | M-sequenceCapability, PDIn, and PDOOut |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | <ol style="list-style-type: none"> 1) Check whether the Master TYPE_0 request in b) results in no response message from the Device 2) Check whether the Master TYPE_0 request in c) results in a response message of TYPE_0 with "MinCycleTime" from the Device |
| Test passed | | Received "MinCycleTime" with TYPE_0 message after second Read attempt |
| Test not passed (examples) | | Any response of the Device in procedure step b), or Device responds in procedure step c): <ul style="list-style-type: none"> - Device used incorrect M-sequence TYPE - No or incorrect response from Device |
| Report | | Received "MinCycleTime" in TYPE_0 Device message: <ok nok exception> |

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816 **6.3.5 From PREOPERATE to STARTUP with M-sequence fault**

817 Table 62 defines the test conditions for this test case.

818 **Table 62 – From PREOPERATE to STARTUP with M-sequence fault**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0044 |
| Name | | TCD_DLPC_PROP_FRAMEFAULT |
| Purpose (short) | | Force Device into STARTUP by sending the OPERATE M-sequence type |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.1 |
| Category / type | | Device protocol test: test to pass, test to fail |
| Specification (clause) | | [7], see 7.3.2.5, Figure 34 (T12), and Annex A, Table A.7; see NOTE in Table A.9 on TYPE_0 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Device shall not support another different M-sequence type while in PREOPERATE. The Device shall switch to STARTUP when detecting an illegal M-sequence type. Equal M-sequence types for PREOPERATE and OPERATE are legal, and M-sequence types TYPE_1_2 and TYPE_1_V are not treated as different. |
| Precondition | | Device in PREOPERATE |
| Procedure | | a) Determine expected M-sequence type and OD length from PDIn, PDOOut, and M-sequenceCapability b) Read parameter "MinCycleTime" with the OPERATE M-sequence types c) Read again parameter "MinCycleTime" with the PREOPERATE M-sequence types d) Read again parameter "MinCycleTime" with the STARTUP M-sequence type |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Read response in b) with respect to used M-sequence types 2) Check Read response in c) with respect to used M-sequence types 3) Check Read response in d) with respect to used M-sequence types |
| Test passed | | Case a: PREOPERATE = TYPE_0 and ≠ OPERATE M-sequence types: - No Device response at Read in b) - Correct data at Read in c) and d) - Implementation exception due to use of TYPE_0 Case b: PREOPERATE ≠ TYPE_0 and ≠ OPERATE M-sequence types: - No Device response at Read in b) and c) - Correct data at Read in d) Case c: PREOPERATE = TYPE_0 and = OPERATE M-sequence types: - Correct data at Read in b), c), and d) - Implementation exception due to use of TYPE_0 Case d: PREOPERATE ≠ TYPE_0 and = OPERATE M-sequence types: - No Device response at Read in d) |
| Test not passed (examples) | | Any evaluation failed |
| Report | | Tests in case a: Tests in case b: Tests in case c: Tests in case d: <ok nok exception> <ok nok > <ok nok exception> <ok nok > |

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827 **6.3.6 Minimum Recovery Time in PREOPERATE Mode**

828 -CR102-

829 Table 52317 defines the test conditions for this test case.

830 **Table 317 – From Minimum Recovery Time in PREOPERATE Mode**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0377 |
| Name | TCD_DLPC_PROP_RECOVERY_TIME |
| Purpose (short) | Check if Device works with minimum recovery time in PREOPERATE mode |
| Equipment under test (EUT) | Device with ISDU support |
| Test case version | 1.0 |
| Category / type | Device protocol test: test to pass |
| Specification (clause) | [7], Table A.8 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | The Master DTU shall use the minimum recovery time in PREOPERATE. The test case checks if the Device answers properly on each Master M-sequence. |
| Precondition | DTU: in PREOPERATE mode, DTU shall use minimum recovery time as specified in [7], Table A.8. |
| Procedure | a) DTU reads communication parameter (Direct Parameter 0x02 to 0x06) b) DTU writes to parameter A the value "test" defined by Parameter Set 1 c) DTU reads parameter A |
| Test parameter | parameter A: application specific tag (index 24) first parameter of "Parameter set 1" as defined in 6.7.1.1 |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check Device response in a) to c): Device must answer to any M-Sequence. No repetitions are allowed 2) Check after c) if read value equals the value written in b) if the device response is positive in step b) |
| Test passed | All evaluation steps ok. |
| Test not passed (examples) | Any evaluation step failed |
| Report | All evaluations <ok nok> |

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834 **6.4 OPERATE**

835 **6.4.1 From PREOPERATE to OPERATE Read**

836 Table 63 defines the test conditions for this test case.

837 **Table 63 – From PREOPERATE to OPERATE Read**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0045 |
| Name | TCD_DLPC_OPER_READ |
| Purpose (short) | Turn Master and Device into OPERATE via MasterCommand 0x99 and 0x98 |
| Equipment under test (EUT) | Device |
| Test case version | 1.0 |
| Category / type | Device protocol test: test to pass |
| Specification (clause) | [7], see 7.3.2.5, Figure 34, and Annex A.2, Table A.8 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master sends MasterCommand 0x99 and 0x98 and both (Device and Master) switch into OPERATE. |
| Precondition | <ul style="list-style-type: none"> - Establish a communication (WURQ) - Communication between Master and Device successful (both in STARTUP) - Save M-sequenceCapability, PDIn, and PDOOut for later comparison - DTU sends MasterCommand PREOPERATE (0x9A) - DTU and Device in PREOPERATE - Read DPP1 and save it in a variable for further use |
| Procedure | <ul style="list-style-type: none"> a) DTU sends MasterCommand 0x99 (OPERATE) followed by 0x98 (PD output valid) b) Read DPP1 for comparison with the appropriate M-sequence types for OPERATE |
| Test parameter | M-sequenceCapability, PDIn, and PDOOut |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | <ol style="list-style-type: none"> 1) Check reaction of Device upon MasterCommand 0x99 and 0x98 2) Determine M-sequence type via saved settings of M-sequenceCapability, PDIn, and PDOOut 3) Check whether DPP1 values were received completely (see "Test parameters") |
| Test passed | Device in OPERATE and DPP1 received correctly and no PD |
| Test not passed (examples) | <ul style="list-style-type: none"> - State ≠ OPERATE - No or incorrect response from Device - Device did not use the expected M-sequence type |
| Report | DPP1 received in OPERATE: <ok nok > |

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842 6.4.2 From PREOPERATE to OPERATE Write

843 Table 64 defines the test conditions for this test case.

Table 64 – From PREOPERATE to OPERATE Write

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|--|
| Identification (ID) | SDCI_TC_0046 | | |
| Name | TCD_DLPC_OPER_WRITE | | |
| Purpose (short) | Turn Device from PREOPERATE to OPERATE write | | |
| Equipment under test (EUT) | Device | | |
| Test case version | 1.0 | | |
| Category / type | Device protocol test: test to pass | | |
| Specification (clause) | [7], see 7.3.2.5, Figure 34, and Annex A.2, Table A.8 | | |
| Configuration / setup | Device-Tester-Unit | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | <p>Master sends MasterCommand 0x99 and 0x98 and both (Device and Master) switch to OPERATE. Master writes DPP1. Device reply message to Master write message to be checked.</p> <p>NOTE The number of octets to write depends on the used M-sequenceTYPE. The DPP1 will not be completely written, but a write request with a valid M-sequence type length will be accepted.</p> | | |
| Precondition | <ul style="list-style-type: none"> - Save M-sequenceCapability, PDIn, and PDOOut for later comparison - Master and Device in PREOPERATE state | | |
| Procedure | <ol style="list-style-type: none"> a) DTU sends MasterCommand 0x99 (OPERATE) followed by 0x98 (PD output valid) b) Master changes to OPERATE c) Read DPP1 (one M-sequence) d) Save On-request Data of the Device's response ("mirror") e) Master prepares a write message with saved On-request Data f) Master writes DPP1 (one M-sequence) with correct length | | |
| Test parameter | M-sequenceCapability, PDIn, and PDOOut | | |
| Post condition | – | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | <ol style="list-style-type: none"> 1) Check reaction of Device upon MasterCommand 0x99 and 0x98 2) Determine M-sequence type via saved settings of M-sequenceCapability, PDIn, and PDOOut 3) Check Device response (write DPP1) | | |
| Test passed | Device in OPERATE, and DPP1 accepted | | |
| Test not passed (examples) | <ul style="list-style-type: none"> - State ≠ OPERATE - No or incorrect response from Device - Device did not use the expected M-sequence type | | |
| Report | DPP1 write accepted in OPERATE: | <ok nok > | |

849 **6.4.3 From PREOPERATE to OPERATE negative Write**

850 Table 65 defines the test conditions for this test case.

851 **Table 65 – From PREOPERATE to OPERATE negative Write**

852 -CR029-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0047 |
| Name | TCD_DLPC_OPER_NEGWRITE |
| Purpose (short) | Switch Device from PREOPERATE to OPERATE and check negative write response |
| Equipment under test (EUT) | Device |
| Test case version | 1.0 1 |
| Category / type | Device protocol test: test to pass, test to fail |
| Specification (clause) | [7], see 7.3.2.5, Figure 34, and Annex A.2, Table A.8 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Switch Device from STARTUP PREOPERATE to OPERATE state via Master command 0x99 and 0x98. The Master writes DPP1 with one M-sequence and "parameter length underrun", i.e. one octet less than specified. Check whether the Device does not respond to this incomplete M-sequence. It is also a test purpose to send a correct M-sequence after the minimum cycle time of OPERATE and check the response. |
| Precondition | Master and Device in PREOPERATE state |
| Procedure | a) DTU sends MasterCommand 0x99 (OPERATE) followed by 0x98 (PD output valid) b) Master changes to OPERATE. c) Read DPP1 (one M-sequence) d) Save the On-request Data of the Device response e) Master prepares a write message with the saved On-request Data but one octet less than specified for the Master write message f) Master writes DPP1 (one M-sequence) with reduced length g) Master prepares a write message with the saved On-request Data in correct length h) Master writes DPP1 (one M-sequence) in correct length after the minimum cycle time of OPERATE |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check whether MasterCommand 0x99 results in a positive response of the Device 2) Check whether Device response (write DPP1 with one octet less than expected) results in no response 3) Check whether Device response (write DPP1 with correct length) results in an expected Device reply message |
| Test passed | All checks ok after using the incomplete M-sequence type |
| Test not passed (examples) | - OPERATE command results in a negative response, or - Device responds to message with incomplete M-sequence, or - Device did not use the expected M-sequence type, or - No Device response to the complete M-sequence |
| Report | DPP1 write only accepted with specified length in OPERATE: <ok nok > |

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857 **6.4.4 From OPERATE to STARTUP via simulated reset**

858 Table 66 defines the test conditions for this test case.

859 **Table 66 – From OPERATE to STARTUP via simulated reset**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0049 |
| Name | TCD_DLPC_OPER_SIMRESET |
| Purpose (short) | Switch Device from OPERATE back to STARTUP via a simulated reset |
| Equipment under test (EUT) | Device without TYPE_0 in OPERATE |
| Test case version | 1.2 |
| Category / type | Device protocol test: test to pass |
| Specification (clause) | [7], see 7.3.2.5, Figure 34 (T11), and Annex A, Table A.8; see NOTE in Table A.9 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master and Device are in OPERATE. Master sends a TYPE_0 message (simulation of a Master reset). Device shall switch to STARTUP (deactivate On-request Data, ISDU and Event handler) and send a TYPE_0 response. |
| Precondition | - Master and Device in PREOPERATE - Master sends MasterCommand OPERATE (0x99) - Master and Device in OPERATE |
| Procedure | a) Master sends TYPE_0 Read request for the MinCycleTime parameter b) Master sends TYPE_0 Read request for the MinCycleTime parameter again |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | Check whether the Master TYPE_0 request results in a Device TYPE_0 response message with the MinCycleTime parameter value |
| Test passed | Received the MinCycleTime parameter value at second TYPE_0 message |
| Test not passed (examples) | Any response of the Device in procedure step a) No or incorrect response from Device in procedure step b) |
| Report | Received MinCycleTime value at second TYPE_0 message: <ok nok > |

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6.4.5 Actuator behavior at PDOout invalid

Table 67 defines the test conditions for this test case.

Table 67 – Actuator behavior at PDOOut invalid

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|--|
| Identification (ID) | SDCI_TC_0312 | | |
| Name | TCD_DLPC_OPER_OUTINVALID | | |
| Purpose (short) | Failsafe reaction on PDOOut invalid | | |
| Equipment under test (EUT) | Device supporting PDOOut | | |
| Test case version | 1.0 | | |
| Category / type | Device protocol test: test to pass | | |
| Specification (clause) | [7], clause 10.2 | | |
| Configuration / setup | Device-Tester-Unit | | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Device shall detect the change of PDOOut validity state and react as described in the user manual | | |
| Precondition | Device is in OPERATE and PDOOut are marked as valid | | |
| Procedure | a) Write MasterCommand 0x99 (OPERATE) to Device ; <i>Process output data invalid</i> b) Observe Device reaction (failsafe state) | | |
| Test parameter | – | | |
| Post condition | – | | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | 1) Check whether Device acknowledged MasterCommand in a) 2) Check Device reaction against description in user manual in b) | | |
| Test passed | Device changes state as described in user manual | | |
| Test not passed (examples) | Device reaction deviates from expected reaction | | |
| Report | Actuator state at PDOOut invalid: <ok nok > | | |

871 6.4.6 Actuator behavior at communication loss

872 Table 68 defines the test conditions for this test case.

Table 68 – Actuator behavior at communication loss

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|----------------------------|
| Identification (ID) | SDCI_TC_0313 | |
| Name | TCD_DLPC_OPER_CONNECTIONLOSS | |
| Purpose (short) | Failsafe reaction on communication loss | |
| Equipment under test (EUT) | Device supporting PDOout | |
| Test case version | 1.0 | |
| Category / type | Device protocol test: test to pass | |
| Specification (clause) | [7], clause 7.3.3.5, 10.2 and 10.8.3 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | The Device shall detect the loss of communication and react as described in the user manual | |
| Precondition | Device is in communication mode and the PDOout are marked as valid | |
| Procedure | a) Communication stopped without MasterCommand "fallback", no further Wake-up b) Observe Device reaction (failsafe state) | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | Check Device reaction after communication stop against description in user manual | |
| Test passed | Device changes state as described in user manual | |
| Test not passed (examples) | Device reaction deviates from expected reaction | |
| Report | Actuator state at COMLOSS: <ok nok > | |

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6.4.7 PD Status for output Process Data only

-CR036-

Table 318 defines the test conditions for this test case.

Table 318 - PD Status for output Process Data only

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0376 |
| Name | | TCD_DLPC_OPER_PDVALIDITYINDICATION |
| Purpose (short) | | Check PD Status flag for Device output Process Data only |
| Equipment under test (EUT) | | Device with output Process Data only |
| Test case version | | 1.0 |
| Category / type | | Device protocol test; test to pass (positive testing) |
| Specification (clause) | | [7], A.1.5 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | A Device with no input Process Data but with output Process Data shall always indicate "Process Data valid" in the CKS octet |
| Precondition | | Device is in OPERATE and PDOOut are marked as invalid |
| Procedure | | a) Master reads Checksum / status (CKS) octet from Device b) Write MasterCommand 0x98 (ProcessDataOutputOperate) to Device c) Master reads Checksum / status (CKS) octet from Device |
| Test parameter | | - |
| Post condition | | - |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check after step a) that PD Status flag indicates "Process Data valid" 2) Check after step c) that PD Status flag indicates "Process Data valid" |
| Test passed | | All evaluation steps ok. |
| Test not passed (example) | | Any evaluation step failed |
| Report | | Device indicates "Process Data valid" <ok nok> |

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887 **6.5 ISDU (Indexed Service Data Unit)**

888 **6.5.1 Prearrangement measures and configuration**

889 **-CR029- -CR018- -CR027- -CR113- -CR066-**

890 The possibility of write operations is a precondition for the ISDU test cases. The only possible
891 writeable Index usable by all Device vendors is the "Application Specific Tag" parameter (Index
892 = 0x0018). However, this parameter is optional.

893 Therefore, the vendor shall provide the necessary Index information for ISDU write/read oper-
894 ations (Config 1, 2, 3, and 7) within the IODD of the Device:

895 • Config1 (8-bit Index without ExtLength): An 8-bit readable and writeable SDCL Index of the
896 Device that shall not provide data of type StringT and data length shall be less than 12
897 octets (ISDU read operation shall not use the "ExtLength").

898 • Config2 (16-bit Index ISDU access): If the Device supports 16-bit Indices, Config2 shall be
899 a readable and writeable 16-bit Index. If the Device does not support any 16-bit Index,
900 Config2 can be any 16-bit Index. The Device shall respond with correct ErrorCodes in case
901 this Index is addressed. Via this Index, the test system will check the 16-bit capabilities
902 (coping with the 16-bit ISDU addressing scheme) of the Device.

903 • Config3 (8-bit Index with ExtLength): An 8-bit readable SDCL Index of the Device providing
904 more than 42 **13** octets data for ISDU read operations with an "ExtLength" octet in an ISDU
905 read response.

906 • **Config4 A list of Block Parameter Indices which are accessed via block parameterization
907 (ListOfBlockParameters as UInt16). The list shall contain at least two entries. If the Device
908 supports only one parameter, an additional parameter shall be implemented for testing pur-
909 poses.**

910 • Config7 (IndexToGenerateEvent): This Index is a parameter for Devices supporting
911 Events including Data Storage Events. It can be used to stimulate up to two specific Test
912 Events within the Device. Four values shall be supported by the Device:

- EventA_Appear,
- EventA_Disappear,
- EventB_Appear, and
- EventB_Disappear.

A Write of this parameter causes the Device to stimulate the corresponding Event with the
corresponding Event mode. The data type of the parameter is UIntegerT, bitLength = 8.
There are Devices not supporting appearing and disappearing Events but supporting Notifications.
For the test of these kind of Events, the values for Event "appeared" and Event
"disappeared" shall be the same. The test system shall detect that the values are the
same and perform a Notification test.

923

924 **In addition to the information in the IODD the Test System will automatically generate a list of
925 block parameters based on the Paramter set 1, see 6.7.1.1.**

926

6.5.2 Availability of ISDU via M-sequence Capability

Table 69 defines the test conditions for this test case.

Table 69 – Availability of ISDU via M-sequence Capability

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|---|----------------------------|
| Identification (ID) | SDCI_TC_0052 | |
| Name | TCD_DLPC_ISDU_AVAILFSEQCAP | |
| Purpose (short) | Availability of ISDU via M-sequenceCapability in DPP1 | |
| Equipment under test (EUT) | Device | |
| Test case version | 1.0 | |
| Category / type | Device ISDU test: test to pass | |
| Specification (clause) | [7], see Annex B.1.4, Table B.3 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Master reads the Device's M-sequenceCapability via DPP1 and checks whether the ISDU data channel is supported. | |
| Precondition | <ul style="list-style-type: none"> - Establish communication (WURQ) - Establish communication into PREOPERATE or OPERATE respectively | |
| Procedure | <ol style="list-style-type: none"> a) Read M-sequenceCapability (DPP1, address 0x03) b) Check Bit "0" of the parameter M-sequenceCapability | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Received M-sequenceCapability 2) Bit "0" = 1 <i>;ISDU communication channel is supported</i> | |
| Test passed | Bit "0" = 1 | |
| Test not passed (examples) | <ul style="list-style-type: none"> - No response from the Device - Bit "0" = 0 <i>;ISDU communication channel is not supported</i> | |
| Report | Availability of the ISDU service: | |
| | <i><ok nok ></i> | |

934 **6.5.3 "Idle/Busy" check**

935 Table 70 defines the test conditions for this test case.

936 **Table 70 – "Idle/Busy" check**

937 -CR021-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0053 |
| Name | TCD_DLIC_ISDU_IDLEBUSYCHECK |
| Purpose (short) | Device response upon invalid FlowCtrl requests of the Master during "No Service" while in state "Idle_1" |
| Equipment under test (EUT) | Device |
| Test case version | 1.2 3 |
| Category / type | Device ISDU test: test to pass |
| Specification (clause) | [7], see 7.3.6.2, Table 52, and Annex A.5, Table A.12, Table A.14 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Device stays in responds with "No Service" after reception of an "Idle" request of the Master with invalid FlowCtrl contents. |
| Precondition | DTU: Communication without Parameter or Event access EUT: - |
| Procedure | a) DTU sends Read requests with channel = ISDU with "No Service", Length = 0, and FlowCtrl from 0x11 to 0x1F |
| Test parameter | - |
| Post condition | - |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check Device response in a) |
| Test passed | Device response contains "No Service" |
| Test not passed (examples) | No response from the Device, or Device response contains ≠ "No Service", or Communication error |
| Report | ISDU FlowCtrl ignores invalid contents: <ok nok > |

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942 **6.5.4 Read 8-bit Index**

943 Table 71 defines the test conditions for this test case.

944

Table 71 – Read 8-bit Index

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0054 |
| Name | TCD_DLIC_ISDU_READINDEX8 |
| Purpose (short) | Device response to an ISDU Read request with 8-bit Index |
| Equipment under test (EUT) | Device |
| Test case version | 1.0 |
| Category / type | Device ISDU test: test to pass |
| Specification (clause) | [7], see 7.3.6.4, Figure 52, and Annex A.2, Table A.10 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master sends ISDU read request for VendorName (0x10, mandatory). Device responds with expected VendorName. |
| Precondition | Master in PREOPERATE or OPERATE respectively |
| Procedure | a) Master: Sends ISDU Read request to Index 0x10 b) Receive Read response "busy" (0x01) until Device is ready c) Check and save Read response ("temp") d) Save I-Service, Length, Data and Checksum in variables and save ISDU Read response M-sequence COUNT |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check whether the I-Service code of the positive Read response = 0b1101 2) Compare Length variable with the actual received M-sequence COUNT 3) Check "temp" 4) Calculate checksum and compare with saved checksum |
| Test passed | "temp" received is complete as expected as vendorName from IODD, and I-Service, Length and Checksum are correct |
| Test not passed (examples) | No, negative or wrong response from the Device |
| Report | "VendorName" read correctly from Device: <ok nok > |

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949 **6.5.5 Read 8-bit Index with ExtLength**

950 Table 72 defines the test conditions for this test case.

951 **Table 72 – Read 8-bit Index with ExtLength**

952 -CR027-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0055 |
| Name | TCD_DLIC_ISDU_READ8EXTLENGTH |
| Purpose (short) | Read request with 8-bit Index and Read response with ExtLength |
| Equipment under test (EUT) | Device |
| Test case version | 1.1 |
| Category / type | Device ISDU test: test to pass |
| Specification (clause) | [7], see 7.3.6.4, Annex A.5.3 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master sends ISDU Read request using "Config3". Device responds according "Config3" (ISDU response with ExtLength octet possible). |
| Precondition | - Device in PREOPERATE or OPERATE respectively - DTU in PREOPERATE or OPERATE respectively - Variable size to be set to > 42 13 octets |
| Procedure | a) DTU: Sends ISDU Read request to Index defined in "Config3" b) Receive Read response "busy" (0x01) until Device is ready c) Save I-Service, Length, Data and Checksum in variables and save ISDU Read response M-sequence COUNT |
| Test parameter | "Config3" according to 6.5.1 |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check whether the I-Service code of the positive Read response = 0b1101 2) Length = 0b0001 3) Compare ExtLength variable with M-sequence COUNT 4) Calculate checksum and compare with saved Checksum |
| Test passed | Response correct according to "Config3", and I-Service, Length, ExtLength and Checksum are correct |
| Test not passed (examples) | No, negative or wrong response from the Device |
| Report | "Config3" read correctly from Device: <ok nok > |

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6.5.6 Write 8-bit Index

Table 73 defines the test conditions for this test case.

Table 73 – Write 8-bit Index

-CR018-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|----------------------------|--|
| Identification (ID) | SDCI_TC_0056 | | |
| Name | TCD_DLIC_ISDU_WRITE8 | | |
| Purpose (short) | Write request with 8-bit Index is possible | | |
| Equipment under test (EUT) | Device | | |
| Test case version | 1.2 | | |
| Category / type | Device ISDU test: test to pass | | |
| Specification (clause) | [7], see 7.3.6.4 | | |
| Configuration / setup | Device-Tester-Unit | | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Master sends ISDU write request according "Config1". Check whether the Write request has been successful. | | |
| Precondition | <ul style="list-style-type: none"> - Device in PREOPERATE or OPERATE respectively - DTU in PREOPERATE or OPERATE respectively | | |
| Procedure | <ul style="list-style-type: none"> a) DTU sends ISDU Write request using "Config1" b) Receive Write response "busy" (0x01) until Device is ready c) Receive Write response d) DTU sends ISDU Read request on Index of "Config1" e) Save received data as "temp" | | |
| Test parameter | "Config1" according to 6.5.1. Manufacturer/vendor is responsible for choosing a variable for the test not changing value after Write. | | |
| Post condition | – | | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | <ol style="list-style-type: none"> 1) Check ISDU response in c) 2) Check received data in e) | | |
| Test passed | Positive Write response or ErrorType ≠ "Index not available", and "temp" = Config1 from IODD or ErrorType ≠ "Index not available" | | |
| Test not passed (examples) | Negative Write response ≠ "Index not available", or "temp" ≠ Config1 from IODD | | |
| Report | 8-bit Write request: <ok nok > | | |

965 **6.5.7 Read 8-bit Index reserved**

966 Table 74 defines the test conditions for this test case.

967 **Table 74 – Read 8-bit Index reserved**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0057 |
| Name | | TCD_DLIC_ISDU_READ8RESERVED |
| Purpose (short) | | Device response "Index not available" upon Read of 8-bit reserved Index |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.0 |
| Category / type | | Device ISDU test: test to fail |
| Specification (clause) | | [7], see 7.3.6, and Annex C, Table C.1 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master sends ISDU Read request for Index = 0xFF (reserved) and receives "Index not available". |
| Precondition | | - Device in PREOPERATE or OPERATE respectively - DTU in PREOPERATE or OPERATE respectively |
| Procedure | | a) DTU sends ISDU Read request on Index 0xFF, Subindex "0" b) Receive Read response "busy" (0x01) until Device is ready c) Receive Read response when ready |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Read response in c) |
| Test passed | | Negative Read response (I-Service: 0b1100, Length: 0b0100) with ErrorCode = 0x80, and AdditionalCode = 0x11 "Index not available" |
| Test not passed (examples) | | Positive response from Device or incorrect ErrorCode or AdditionalCode |
| Report | | Negative read response upon reserved 8-bit Index: <ok nok > |

970

971

972 **6.5.8 Read 8-bit Index with unavailable Subindex**

973 Table 75 defines the test conditions for this test case.

974 **Table 75 – Read 8-bit Index with unavailable Subindex**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0058 |
| Name | TCD_DLIC_ISDU_READ8NOSUBINDEX |
| Purpose (short) | 8-bit Read response when Subindex not available |
| Equipment under test (EUT) | Device |
| Test case version | 1.0 |
| Category / type | Device ISDU test: test to fail |
| Specification (clause) | [7], see 7.3.6, and Annex C, Table C.1 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master sends ISDU Read request for VendorName (Index = 0x10, mandatory, StringT) and Subindex = 0x02. This results in a negative Read response, "Subindex not available". |
| Precondition | - Device in PREOPERATE or OPERATE respectively - DTU in PREOPERATE or OPERATE respectively |
| Procedure | a) DTU sends ISDU Read request on Index 0x10, Subindex 2 b) Receive Read response "busy" (0x01) until Device is ready c) Receive Read response when ready |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check Read response in c) |
| Test passed | Negative Read response (I-Service: 0b1100, Length: 0b0100) with ErrorCode = 0x80, and AdditionalCode = 0x12 "Subindex not available" |
| Test not passed (examples) | Positive response from Device or incorrect ErrorCode or AdditionalCode |
| Report | Negative read response upon unavailable Subindex: <ok nok > |

977

978

979 **6.5.9 Read 16-bit Index**

980 Table 76 defines the test conditions for this test case.

981 **Table 76 – Read 16-bit Index**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0059 |
| Name | TCD_DLIC_ISDU_READ16 |
| Purpose (short) | Read response with 16-bit Index using "Config2" |
| Equipment under test (EUT) | Device |
| Test case version | 1.0 |
| Category / type | Device ISDU test: test to pass |
| Specification (clause) | [7], see 7.3.6.4, Figure 52, and Annex A.2, Table A.10 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master sends ISDU read request using "Config2". Device responds according "Config2". If the Device does not support 16-bit Indices, access shall be rejected with the correct ErrorType. |
| Precondition | - DTU in PREOPERATE or OPERATE respectively |
| Procedure | a) DTU sends ISDU Read request to Index defined in "Config2" b) Receive Read response "busy" (0x01) until Device is ready c) Save I-Service, Length, Data and Checksum in variables and save ISDU Read response |
| Test parameter | "Config2" in 6.5.1 |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check response |
| Test passed | Positive read response or ErrorType "Index not available", and I-Service, Length and Checksum are correct |
| Test not passed (examples) | Any other negative response or no response |
| Report | "Config2" read correctly from Device: <ok nok > |

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6.5.10 Write 16-bit Index

Table 77 defines the test conditions for this test case.

Table 77 – Write 16-bit Index**-CR018-**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0060 |
| Name | | TCD_DLIC_ISDU_WRITE16 |
| Purpose (short) | | 16-bit Write request is possible |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.1 |
| Category / type | | Device ISDU test: test to pass |
| Specification (clause) | | [7], see 7.3.6.4 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master sends 16-bit ISDU Write request using "Config2". Check whether the Write request was successful. If the Device does not support 16 bit addressing, the access shall be rejected with the correct ErrorCode. |
| Precondition | | - Device in PREOPERATE or OPERATE respectively - DTU in PREOPERATE or OPERATE respectively |
| Procedure | | a) DTU sends 16-bit ISDU Write request using "Config2" b) Receive response "busy" (0x01) until Device is ready c) Receive Write response d) DTU sends ISDU Read request using "Config2" e) Save received data in "temp" |
| Test parameter | | "Config2" according to 6.5.1. Manufacturer/vendor is responsible for choosing a variable for the test not changing value after Write. |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check ISDU response in c) 2) Check received data in e) |
| Test passed | | Positive Write response or ErrorType ≠ "Index not available", and "temp" = Config2 from IODD or ErrorType = "Index not available" |
| Test not passed (examples) | | Negative write response ≠ "Index not available", or "temp" ≠ Config2 from IODD |
| Report | | "Config2" changed after Write request: <ok nok > |

992

993

994 **6.5.11 Read 16-bit Index reserved**

995 Table 78 defines the test conditions for this test case.

996 **Table 78 – Read 16-bit Index reserved**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0061 |
| Name | | TCD_DLIC_ISDU_READ16RESERVED |
| Purpose (short) | | Device response "Index not available" upon Read to 16-bit reserved Index |
| Equipment under test (EUT) | | Device supporting 16-bit Indices |
| Test case version | | 1.0 |
| Category / type | | Device ISDU test: test to fail |
| Specification (clause) | | [7], see 7.3.6, and Annex C, Table C.1 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master sends ISDU Read request to Index = 0x7F32 (reserved) and receives a negative response with "Index not available" |
| Precondition | | - Device in PREOPERATE or OPERATE respectively - DTU in PREOPERATE or OPERATE respectively |
| Procedure | | a) DTU sends ISDU Read request to Index 0x7F32, Subindex "0" b) Receive Read response "busy" (0x01) until Device is ready c) Receive Read response when ready |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Read response in c) |
| Test passed | | Negative Read response (I-Service: 0b1100, Length: 0b0100) with ErrorCode = 0x80, and AdditionalCode = 0x11 "Index not available" |
| Test not passed (examples) | | Positive response from Device or incorrect ErrorCode or AdditionalCode |
| Report | | Negative Read response upon reserved 16-bit Index: <ok nok > |

999

1000

1001 **6.5.12 Read 16-bit Index with unavailable Subindex**

1002 Table 79 defines the test conditions for this test case.

1003 **Table 79 – Read 16-bit Index with unavailable Subindex**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0062 |
| Name | | TCD_DLIC_ISDU_READ16NOSUBINDEX |
| Purpose (short) | | 16-bit Read response when Subindex not available |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.1 |
| Category / type | | Device ISDU test: test to fail |
| Specification (clause) | | [7], see 7.3.6, and Annex C, Table C.1 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master sends ISDU read request for Config2 with Subindex "0" and Subindex "2" (not implemented). This results in a negative read response depending on Subindex. |
| Precondition | | - Device in PREOPERATE or OPERATE respectively - DTU in PREOPERATE or OPERATE respectively |
| Procedure | | a) DTU sends ISDU Read request with Index in "Config2" and Subindex "0" b) Receive Read response "busy" (0x01) until Device is ready c) Receive and save Read response in "Sub0" d) DTU sends ISDU Read request with Index in Config2 and Subindex = "2" e) Receive Read response "busy" (0x01) until Device is ready f) Receive and save read response in "Sub2" |
| Test parameter | | "Config2" in 6.5.1 |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response combinations - Sub0 = Sub2 = ErrorType "Index not available" - Sub0 = positive response AND Sub2 = ErrorType "SubIndex not available" |
| Test passed | | If exactly one of the evaluations is correct |
| Test not passed (examples) | | None of the evaluations are correct |
| Report | | Negative Read response upon unavailable Subindex: <ok nok > |

1006

1007

6.5.13 Write 8-bit Index with data length overrun

1009 Table 80 defines the test conditions for this test case.

Table 80 – Write 8-bit Index with data length overrun

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|-------------|
| Identification (ID) | SDCI_TC_0063 | | |
| Name | TCD_DLIC_ISDU_WRITE8LENOVERRUN | | |
| Purpose (short) | Response of 8-bit Write request with 70 octets when 64 are permitted | | |
| Equipment under test (EUT) | Device | | |
| Test case version | 1.0 | | |
| Category / type | Device ISDU test: test to fail | | |
| Specification (clause) | [7], see 7.3.6, and Annex C, Table C.1 | | |
| Configuration / setup | Device-Tester-Unit | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | Master sends Write request with 70 octets for "Config1" (maximum of 64 octets). Write Request with ExtLength. Check whether the Write request was denied with "Parameter length overrun". | | |
| Precondition | <ul style="list-style-type: none"> - Device in PREOPERATE state - DTU in PREOPERATE state | | |
| Procedure | <ul style="list-style-type: none"> a) DTU sends ISDU read request with Config1 b) Receive and save ISDU response in "temp1" c) Master: Send ISDU Write request to Index with Config1 containing 70 octets length and different content from "temp1" d) Receive Write response "busy" (0x01) until Device is ready e) Receive Write response f) DTU sends ISDU Read request with Config1 g) Receive and save ISDU response in "temp2" | | |
| Test parameter | "Config1" in 6.5.1 | | |
| Post condition | – | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | <ol style="list-style-type: none"> 1) Check ISDU response from e) 2) Check received data from g) | | |
| Test passed | ErrorType "Parameter length overrun" received "temp1" = "temp2" | | |
| Test not passed (examples) | Positive Write response or different ErrorType from Device "temp1" ≠ "temp2" | | |
| Report | Negative Read response upon length overrun: | | <ok nok > |

1015 **6.5.14 Write 8-bit Index with data length underrun**

1016 Table 80 defines the test conditions for this test case.

1017 **Table 81 – Write 8-bit Index with with data length underrun**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0064 |
| Name | | TCD_DLIC_ISDU_WRITE8WRONGLEN |
| Purpose (short) | | Response of 8-bit Write request with one octet less than expected |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.0 |
| Category / type | | Device ISDU test: test to fail |
| Specification (clause) | | [7], see 7.3.6, and Annex C, Table C.1 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master sends Write request with one octet less than the "m" expected octets for Config1. Check whether the Write request was denied with "Parameter length underrun". |
| Precondition | | - Device in PREOPERATE state - DTU in PREOPERATE state |
| Procedure | | a) DTU sends ISDU read request with Config1 b) Receive and save ISDU response in "temp1" c) DTU sends ISDU Write request to Index with Config1 containing one octet less length and different content from "temp1" d) Receive Write response "busy" (0x01) until Device is ready e) Receive Write response f) DTU sends ISDU Read request with Config1 g) Receive and save ISDU response in "temp2" |
| Test parameter | | "Config1" in 6.5.1 |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check ISDU response in e) 2) Check received data in g) |
| Test passed | | ErrorType "Parameter length underrun" received, and "temp1" = "temp2" |
| Test not passed (examples) | | Positive Write response or different ErrorType from Device, or "temp1" ≠ "temp2" |
| Report | | Negative read response upon length underrun: <ok nok > |

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1022 **6.5.15 Read 8-bit Index with incorrect Checksum value**

1023 Table 80 defines the test conditions for this test case.

1024 **Table 82 – Read 8-bit Index with incorrect Checksum value**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0065 |
| Name | | TCD_DLIC_ISDU_WRITE8WRONGCHECKSUM |
| Purpose (short) | | Response of 8-bit Read request with incorrect checksum value |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.1 |
| Category / type | | Device ISDU test: test to fail |
| Specification (clause) | | [7], see 7.3.6, Annex A.5, Table A.12, and Table A.14 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master sends 8-bit Read request with an incorrect Checksum value to get Vendor-Name (0x10). The correct Checksum value is 0x8B, the value in use is 0xFF. A negative Read response "No Service" is expected. |
| Precondition | | - Device in PREOPERATE state or OPERATE respectively - DTU in PREOPERATE state or OPERATE respectively |
| Procedure | | a) DTU sends ISDU Read request on Index 0x10 with incorrect checksum 0xFF b) Receive response "busy" (0x01) until Device is ready c) Receive Read response when ready |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Read response in c) |
| Test passed | | Negative Read response with I-Service = 0b0000 ("No Service") |
| Test not passed (examples) | | Positive response from Device, or ErrorType with not permitted AdditionalCode |
| Report | | Read response "No Service" upon incorrect Checksum value: <ok nok > |

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6.5.16 Write 8-bit Index on read only Index

1030 Table 83 defines the test conditions for this test case.

Table 83 – Write 8-bit Index on read only Index

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|-------------|
| Identification (ID) | SDCI_TC_0066 | | |
| Name | TCD_DLIC_ISDU_WRITE8ROINDEX | | |
| Purpose (short) | Response of 8-bit Write request upon read only Index | | |
| Equipment under test (EUT) | Device | | |
| Test case version | 1.0 | | |
| Category / type | Device ISDU test: test to fail | | |
| Specification (clause) | [7], see 7.3.6, and Annex C, Table C.1; see 10.3.4 and Table 97 | | |
| Configuration / setup | Device-Tester-Unit | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | Master sends 8-bit Write request on read only index "VendorName". A negative Write response "Access denied" is expected. | | |
| Precondition | <ul style="list-style-type: none"> - Device in PREOPERATE or OPERATE respectively - DTU in PREOPERATE or OPERATE respectively | | |
| Procedure | <ol style="list-style-type: none"> a) DTU sends ISDU Write request on Index 0x10 with 1 octet data length b) Receive response "busy" (0x01) until Device is ready c) Receive response when ready | | |
| Test parameter | - | | |
| Post condition | - | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | 1) Check Write response in c) | | |
| Test passed | Negative Write response with ErrorCode = 0x80 and AdditionalCode = 0x23 "Access denied" | | |
| Test not passed (examples) | Negative response ≠ "Access denied", or Positive Write response | | |
| Report | Negative Write response upon read only Index: | | <ok nok > |

1036 **6.5.17 Read 8-bit Index with aborted request**

1037 Table 84 defines the test conditions for this test case.

1038 **Table 84 – Read 8-bit Index with aborted request**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0067 |
| Name | | TCD_DLIC_ISDU_ABORTREADREQ |
| Purpose (short) | | Response of aborted 8-bit Read request |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.1 |
| Category / type | | Device ISDU test: test to pass |
| Specification (clause) | | [7], see 7.3.6.4, Figure 52 (T9; for Devices with more than two octets On-request Data within one message: T10 or T11), and Annex A.2, Table A.10 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master sends and aborts an 8-bit Read request for "VendorName" (0x10). Device switches to Idle mode. |
| Precondition | | DTU in PREOPERATE or OPERATE respectively |
| Procedure | | a) DTU sends first ISDU segment in first message b) DTU sends ISDU abort (R, FlowCTRL = ABORT = 0x1F, ISDU) in next message c) DTU sends idle message (R, FlowCTRL = IDLE 1 = 0x11, ISDU) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Read response |
| Test passed | | Read response with I-Service = 0b0000 ("No Service") |
| Test not passed (examples) | | Incorrect Device response to incomplete ISDU |
| Report | | Device works properly after aborted Read request: <ok nok > |

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6.5.18 Read 8-bit Index with aborted response

Table 85 defines the test conditions for this test case.

Table 85 – Read 8-bit Index with aborted response

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0068 |
| Name | | TCD_DLIC_ISDU_ABORTREADRESP |
| Purpose (short) | | Reaction of aborted 8-bit Read response |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.1 |
| Category / type | | Device ISDU test: test to pass |
| Specification (clause) | | [7], see 7.3.6.4, Figure 52 (T11), Table 50, and Annex A.2, Table A.10 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master sends Read request for VendorName (0x0010) and receives from the Device the expected "VendorName". Master aborts reading the complete "VendorName". |
| Precondition | | DTU in PREOPERATE or OPERATE respectively |
| Procedure | | <ul style="list-style-type: none"> a) DTU sends ISDU Read request to Index 0x0010 (16) b) Receive response "BUSY" (0x01) until Device is ready c) Receive first ISDU segment of the Read response "VendorName" d) DTU sends ISDU abort (R, FlowCTRL = ABORT = 0x1F, ISDU) e) DTU sends idle message (R, FlowCTRL = IDLE 1 = 0x11, ISDU) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Read response |
| Test passed | | Read response with I-Service = 0b0000 ("No Service") |
| Test not passed (examples) | | Incorrect Device reply message to the incomplete Read response |
| Report | | Device works properly after the aborted Read response: <ok nok > |

1048

1049

1050 **6.5.19 Master retries when ISDU transfer failed**

1051 Table 86 defines the test conditions for this test case.

1052 **Table 86 – Master retries when ISDU transfer failed**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0309 |
| Name | TCD_DLIC_ISDU_ELEMENT_RETRY |
| Purpose (short) | Behavior of Device if an ISDU segment is being repeated |
| Equipment under test (EUT) | Device |
| Test case version | 1.1 |
| Category / type | Device ISDU test: test to pass |
| Specification (clause) | [7], 7.3.6, Table 52 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | If the transmission of a single M-sequence has been corrupted, the Master can send up to three retries requesting the same ISDU segment. Thus, the Device shall repeat the segment and correctly continue the transmission of the ISDU response afterwards. The correct behavior shall be tested sending an ISDU read request using "Config3". NOTE: If the read result of the ISDU contained in "Config 3" is transmitted in less than three M-sequences, as many segments as possible shall be repeated during the test. |
| Precondition | - Device in PREOPERATE or OPERATE respectively - DTU in PREOPERATE or OPERATE respectively |
| Procedure | a) DTU sends ISDU Read request using "Config3" b) Receive Read response "busy" (0x01) until Device is ready c) Receive first segment of ISDU Read response ;FlowCTRL = 0x10 d) DTU repeats the first segment e) DTU continues reading the next segment ;FlowCTRL = 0x01 f) DTU repeats the second segment g) DTU continues reading until the last segment h) DTU repeats the last segment i) DTU sends idle message (R, FlowCTRL=IDLE 1=0x11, ISDU) to finalize transfer j) DTU sends ISDU Read request using "Config3" without retries |
| Test parameter | "Config3" in 6.5.1 |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check Read response in i) 2) Check Length in i) 3) Compare element ExtLength with element COUNT in i) 4) Calculate checksum and compare with saved checksum in i) 5) Compare data in i) and j) |
| Test passed | Positive Read response with I-Service = 0b1101 ("Read response (+)") Length = 0b0001 ;see ExtLength ExtLength corresponds to COUNT Correct checksum Both data are identical |
| Test not passed (examples) | No, negative or incorrect response from the Device |
| Report | "Config3" received correctly from Device: <ok nok > |

1055

1056 **6.6 Events**1057 **6.6.1 General**

1058 -CR093- -CR066- -CR105-

1059 Any of the Device applications can generate predefined "status" information when SDCI operations fail, or "technology specific" information (diagnosis) as a result from technology specific
1060 diagnostic methods. This information can be communicated via SDCI Event to upper level systems of different capability. Thus, the following tests can only verify the conformity to the SDCI
1061 standard [7] in terms of Event handling mechanisms.

1064 Event test cases shall be executed if the Device supports any one or more Events (EventCol-
1065 lection in IODD is not empty) or Data Storage. The Number of supported events is defined by
1066 the number of entries of EventCollection in IODD. Test cases use Test Events A and B stimu-
1067 lated by ISDU Write to the Index defined in Config7. For each of the Test Events, Config7
1068 defines a value EventA_Appear/EventB_Appear that stimulates "Event Appear" and a value
1069 EventA_Disappear/EventB_Disappear that stimulates "Event Disappear" of the corresponding
1070 Event.

1071 It is mandatory for a Device to implement the required test Events. EventCodes and Event type
1072 are vendor specific. Event Type shall be error and corresponding device status shall be "4-
1073 failure". EventCodes are Vendor specific. EventCodes for Event A and Event B shall be differ-
1074 ent. If the Device supports only Notifications, the test Events shall be Notifications and the
1075 Event mode is "Event single shot". The Test systems shall wait 5 seconds after initiating of the
1076 event until a timeout is shown. Even if there is no time specified in [7], the assumption is that
1077 an event should not be delayed more than 5 seconds.

1078 **Event Test Procedures**

1079 In general a device is allowed to have initial events at the beginning of a test process. It is not
1080 allowed to activate additional unexpected application specific events during the test run.
1081 Event related tests focus on testing of the change of diagnosis during the test run. IO-Link
1082 Test Master reads out the activated events 1s after the precondition is reached startup and
1083 acknowledges all events. Later on the IO-Link Test Master only checks for changes in the di-
1084 agnosis channel.

1085

1086 At the end of each test case, the Device-Tester-Unit shall clean-up the test Events. For stimu-
1087 lated Events, the corresponding EventA_Disappear or EventB_Disappear command shall be
1088 sent, and all Events shall be acknowledged. A pause of 1 s shall be added at the end of the
1089 test to ensure the Event can be stimulated again without delay within the next test case.

1090

1091 **6.6.2 Single Event while in OPERATE state**
 1092 Table 87 defines the test conditions for this test case. For Notification test see 6.5.1.

1093 **Table 87 – Single Event while in OPERATE state**

1094 -CR066-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0069 |
| Name | | TCD_DLIC_EVNT_OPERSINGLLEVENT |
| Purpose (short) | | Test of single Event processing while in OPERATE state. |
| Equipment under test (EUT) | | Device supporting more than one Event |
| Test case version | | 1.4 5 |
| Category / type | | Device Event test: test to pass |
| Specification (clause) | | [7], see 7.3.8.2 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Check if Event flag and Event buffer is serviced as specified: - Event Flag is raised once an Event occurred - StatusCode Type 2 is set respectively - Event page is frozen while Event is pending - Events are cleared as specified - Event Type & Code match |
| Precondition | | DTU: SDCI communication in state OPERATE EUT: is free of Events; no incidents in application, no Events in communication DTU: Communication EUT: OPERATE |
| Procedure | | a) Device-Tester to read StatusCode. Save value in tester variable "SCa". b) Write EventA_Appear to index in Config7 c) Device-Tester to read StatusCode. Save value in tester variable "SCc". d) Write EventB_Appear to index in Config7 e) Device-Tester to read StatusCode. Save value in tester variable "SCe". f) Device-Tester to read EventQualifier. g) Device-Tester to read EventCode. h) Device-Tester to write "0xFF" to StatusCode. i) Wait until Event flag is set (again). j) Device-Tester to read StatusCode. k) Device-Tester to read EventQualifier. l) Device-Tester to read EventCode. m) Device-Tester to write "0xFF" to StatusCode. n) Device-Tester to read StatusCode. Save value in tester variable "SCn". |
| Test parameter | | Config7 (Event A and B) in 6.5.1 |
| Post condition | | EUT is free of events once test is completed. Test Events A and B are reset once the test is completed |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check after step b) that Event Flag is set 2) Check after step c) that content of "SCa" and "SCc" are different 3) Check after step c) that "SCc" indicates one Event 4) Check after step e) that content of "SCc" and "SCe" is equal 5) Check after step f) that Event Type equals Event Type of test Event A 6) Check after step g) that Event Code equals Event Code of test Event A 7) Check after step k) that Event Type equals Event Type of test Event B 8) Check after step l) that Event Code equals Event Code of test Event B 9) Check after step m) that Event Flag is cleared 10) Check after step n) that SCn is clear = no events |
| Test passed | | All evaluation steps ok. |

| TEST CASE RESULTS | CHECK / REACTION | |
|----------------------------|---|--|
| Test not passed (examples) | Any evaluation step failed | |
| Report | Deviations in evaluations: <yes/no> a) Event Flag set: b) Content of "SCa" and "SCc" are different: c) Content of "SCa": d) Event Type & Code: e) Event Flag is cleared: | <ok nok> <ok nok> <ok nok> <ok nok> <ok nok> <ok nok> |

1097

1098

1099 6.6.3 Single Event while in PREOPERATE state

Table 88 defines the test conditions for this test case. For Notification test see 6.5.1.

Table 88 – Single Event while in PREOPERATE

1102 -CR066-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|----------------------------|
| Identification (ID) | SDCI_TC_0070 | |
| Name | TCD_DLIC_EVNT_PROPSINGLEEVENT | |
| Purpose (short) | Test of single Event processing while in PREOPERATE state | |
| Equipment under test (EUT) | Device, supporting more than one Event | |
| Test case version | 1.4 | |
| Category / type | Device Event test: test to pass | |
| Specification (clause) | [7], see 7.3.8.2 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Check if Event flag and Event buffer is serviced as specified: - Event flag is raised once Event has occurred - StatusCode Type 2 is set respectively - Event page is frozen while event is pending - Events are cleared as specified | |
| Precondition | DTU: SDCI communication in state PREOPERATE EUT: is free of Events; no incidents in application, no Events in communication DTU: Communication EUT: PREOPERATE | |
| Procedure | a) Device-Tester to read StatusCode. Save value in tester variable "SCa". b) Write EventA_Appear to index in Config7 c) Device-Tester to read StatusCode. Save value in tester variable "SCc". d) Write EventB_Appear to index in Config7 e) Device-Tester to read StatusCode. Save value in tester variable "SCe". f) Device-Tester to read EventQualifier. g) Device-Tester to read EventCode. h) Device-Tester to write "0xFF" to StatusCode. i) Wait until Event flag is set (again). j) Device-Tester to read StatusCode. k) Device-Tester to read EventQualifier. l) Device-Tester to read EventCode. m) Device-Tester to write "0xFF" to StatusCode. n) Device-Tester to read StatusCode. Save value in tester variable "SCn". | |
| Test parameter | Config7 (Event A and B) in 6.5.1 | |
| Post condition | EUT is free of events once test is completed. Test Events A and B are reset once the test is completed | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check after step b) that Event Flag is set 2) Check after step c) that content of "SCa" and "SCc" are different 3) Check after step c) that "SCc" indicates one Event 4) Check after step e) that content of "SCc" and "SCe" is equal 5) Check after step f) that Event Type equals Event Type of test Event A 6) Check after step g) that Event Code equals Event Code of test Event A 7) Check after step k) that Event Type equals Event Type of test Event B 8) Check after step l) that Event Code equals Event Code of test Event B 9) Check after step m) that Event Flag is cleared 10) Check after step n) that SCn is clear = no events | |
| Test passed | All evaluation steps ok. | |
| Test not passed (examples) | Any evaluation step failed | |

| TEST CASE RESULTS | CHECK / REACTION |
|-------------------|--|
| Report | Deviations in evaluations: <yes/no> a) Event Flag set: <ok nok> b) Content of "SCa" and "SCc" are different: <ok nok> c) Content of "SCa": <ok nok> d) Event Type & Code: <ok nok> e) Event Flag is cleared: <ok nok> |

1105

1106 **6.6.4 Event clearance in OPERATE state**

1107 Table 89 defines the test conditions for this test case.

1108 **Table 89 – Event clearance in OPERATE state**

1109 -CR105- -CR066-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0071 |
| Name | TCD_DLIC_EVNT_OPEREVENTCLEAR |
| Purpose (short) | Test of Event clearance while in OPERATE state. |
| Equipment under test (EUT) | Device supporting one or more Events |
| Test case version | 1.3 4 |
| Category / type | Device Event test: test to pass |
| Specification (clause) | [7], see 7.3.8.2 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | <p>Check if Event flag is serviced as specified, i.e. Event is cleared with any value written back into the StatusCode</p> <p>Check if Event flag and Event buffer is serviced as specified:</p> <ul style="list-style-type: none"> - Event Flag is raised once an Event occurred - Events are cleared with any value written back into the StatusCode |
| Precondition | <p>DTU: SDCI communication in state OPERATE</p> <p>EUT: is free of Events; no incidents in application, no Events in communication</p> <p>DTU: Communication</p> <p>EUT: OPERATE</p> |
| Procedure | <ol style="list-style-type: none"> a) Write EventA_Appear to index in Config7. b) Device-Tester to write StatusCode "0x00". c) Wait 50 ms d) Write EventA_Disappear to index in Config7. e) Device-Tester to write StatusCode "0xAA". f) Wait 1 s g) Write EventA_Appear to index in Config7. h) Device-Tester to read StatusCode. Save value in tester variable "SCf". i) Device-Tester to write StatusCode with value of tester variable "SCf". |
| Test parameter | Config7 (Event A) in 6.5.1 |
| Post condition | <p>EUT is free of Events once test is completed</p> <p>Test Events A and B are reset once the test is completed</p> |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | <ol style="list-style-type: none"> 1) Check after step b) that Event Flag is cleared 2) Check after step e) that Event Flag is cleared 3) Check after step i) that Event Flag is cleared |
| Test passed | All evaluation steps ok |
| Test not passed (examples) | Any evaluation step failed |
| Report | <p>Deviations in evaluations: <yes/no></p> <p>a) Event Flag in procedure step b: <ok nok></p> <p>b) Event Flag in procedure step e: <ok nok></p> <p>c) Event Flag in procedure step i: <ok nok></p> |

1112

1113

1114 **6.6.5 Event handling while communication interruption**

1115 Table 90 defines the test conditions for this test case. For Events of type Notification, which
 1116 usually are not acknowledged, it should be noted that the same rules apply as for Warnings and
 1117 Errors: The Event shall be resent.

1118 **Table 90 – Event handling while communication interruption**

1119 -CR066-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0072 |
| Name | TCD_DLIC_EVNT_OPERCOMMINTERRUPT |
| Purpose (short) | Test of Event handling while communication is interrupted. |
| Equipment under test (EUT) | Device supporting one or more Events |
| Test case version | 1.4 5 |
| Category / type | Device Event test: test to pass |
| Specification (clause) | [7], see 10.9.2-10.10.2 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Check if Event is handled as specified once communication is cancelled or interrupted. |
| Precondition | DTU: SDCI communication in state OPERATE EUT: is free of Events; no incidents in application, no Events in communication DTU: Communication EUT: OPERATE |
| Procedure | a) Write EventA_Appear to index in Config7 b) DTU to read StatusCode. Save value in tester variable "SCb". c) DTU to read the indicated EventQualifier ("Event appears"). Save value in tester variable "SCc". d) DTU to read the indicated EventCode. Save value in tester variable "SCd". e) DTU performs reset f) Pause of 2 s g) DTU to wake-up Device to OPERATE state h) Read out and acknowledge Events until expected Event occurred (timeout = 15 s) |
| Test parameter | Config7 (Event A) Hint: Messages with transmission errors shall be repeated or dropped. |
| Post condition | EUT is free of Events once test is completed Test Events A and B are reset once the test is completed |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check after step g) that Event Flag is set because the error cause from step a) was not cleared before communication was lost. 2) Check after step h): that one Event received corresponds to tester variable "SCc", and "SCd". |
| Test passed | All evaluation steps ok |
| Test not passed (examples) | Any evaluation step failed, OR timeout in h) |
| Report | Deviations in evaluations: <yes/no> a) Event Flag in procedure step g: <ok nok> b) Read value in step h: <ok nok> |

1122

1123

1124 6.6.6 Event handling while power supply interruption

1125 Table 91 defines the test conditions for this test case. This test case can be skipped in case of
1126 Notifications.

Table 91 – Event handling while power supply interruption

1128 -CR066-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|----------------------------|
| Identification (ID) | SDCI_TC_0073 | |
| Name | TCD_DLIC_EVNT_OPERPOWERINTERRUPT | |
| Purpose (short) | Test of Event handling while power supply of communication is interrupted. | |
| Equipment under test (EUT) | Device supporting Events of type Warning or Error | |
| Test case version | 1.4-5 | |
| Category / type | Device Event test: test to pass | |
| Specification (clause) | [7], see 7.3.8.2 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Check if Event modes are handled as specified when power supply of the Device is interrupted: The "Event appears" and "Event disappears" flow must be correct and start with "Event appears" after communication is restarted. Events that are no longer active after communication restart shall not be reported with "Event disappears". | |
| Precondition | DTU: SDCI communication in state OPERATE EUT: is free of Events; no incidents in application, no Events in communication DTU: Communication EUT: OPERATE | |
| Procedure | a) Write EventA_Appear to Index in Config7 b) Device-Tester to read StatusCode c) Device-Tester to read the indicated EventQualifier d) Device-Tester to read the EventCode. Save value in tester variable "SCd" e) Power-down of the Device (disconnect from Device-Tester) f) Pause of 15 sec g) Re-connect Device h) Device-Tester to wake-up Device to OPERATE state i) Read out and acknowledge Events (timeout = 15 s) | |
| Test parameter | Config7 (Event A) in 6.5.1 | |
| Post condition | EUT is free of Events once test is completed Test Events A and B are reset once the test is completed | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check after step d) that one entry of SCd equals EventCode of Event A 2) Check in step i) that Event A is not read with mode "Event disappear" | |
| Test passed | All evaluation steps ok, or timeout | |
| Test not passed (examples) | Any evaluation step failed | |
| Report | Event appears after power off/on cycle: <yes/no> Deviations in evaluations: <yes/no> a) Read value in step i): | |
| | <ok nok> | |
| | <ok nok> | |

1133 **6.6.7 Event appears/disappears**

1134 Table 92 defines the test conditions for this test case.

1135 **Table 92 – Event appears/disappears**

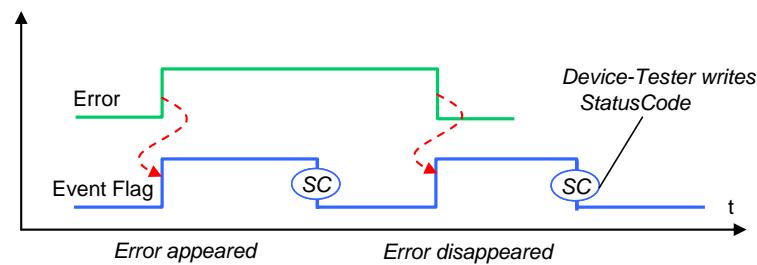
1136 -CR066-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0074 |
| Name | | TCD_DLIC_EVNT_OPERAPPEARDISAPPEAR |
| Purpose (short) | | Test of Event handling with Errors appearing and disappearing. |
| Equipment under test (EUT) | | Device, supporting one or more Events, test Event is of type Error or Warning |
| Test case version | | 1.3 4 |
| Category / type | | Device Event test: test to pass |
| Specification (clause) | | [7], see 7.3.8.2 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Check if Event modes are handled as specified in Figure 11 |
| Precondition | | DTU: SDCI communication in state OPERATE EUT: is free of Events; no incidents in application, no Events in communication DTU: Communication EUT: OPERATE |
| Procedure | | a) Write EventA_Appear to Index in Config7 b) Device-Tester to read StatusCode c) Device-Tester to read EventQualifier. Save value in tester variable "SCc". d) Device-Tester to read EventCode. Save value in tester variable "SCd". e) Device-Tester to write StatusCode "0xFF". f) Wait 50 ms g) Write EventA_Disappear to Index in Config7 h) Device-Tester to read StatusCode. i) Device-Tester to read EventQualifier. Save value in tester variable "SCh". j) Device-Tester to read EventCode. Save value in tester variable "SCI". k) Device-Tester to write StatusCode "0xFF". |
| Test parameter | | Config7 (Event A) in 6.5.1 |
| Post condition | | EUT is free of events once test is completed Test Events A and B are reset once the test is completed |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check after step a) that Event Flag is set 2) Check after step c) that value read shows mode = "Event appeared" 3) Check after step e) that Event Flag is cleared 4) Check after step g) that Event Flag is set 5) Check after step i) that value read shows mode = "Event disappeared" 6) Check after step j) that value of "SCI" equals value of "SCd" (EventCodes). 7) Check after step k) that Event Flag is cleared |
| Test passed | | All evaluation steps ok |
| Test not passed (examples) | | Any evaluation step failed |
| Report | | Deviations in evaluations: <yes/no> a) Event Flag in procedure step a: <ok nok> b) Value in procedure step c: <ok nok> c) Event Flag in procedure step e: <ok nok> d) Event Flag in procedure step g: <ok nok> e) Value in procedure step i: <ok nok> f) EventCodes in procedure step j: <ok nok> g) Event Flag in procedure step k: <ok nok> |

1139

1140

1141 Figure 11 shows the relationship of an Error and the Event Flag and its appearance and dis-
1142 pearance.



1143

1144

Figure 11 – Relationship of an Error and the Event Flag

1145

1146 **6.6.8 Multi Event handling**

1147 Table 93 defines the test conditions for this test case.

1148 **Table 93 – Multi Event handling**

1149 -CR066-

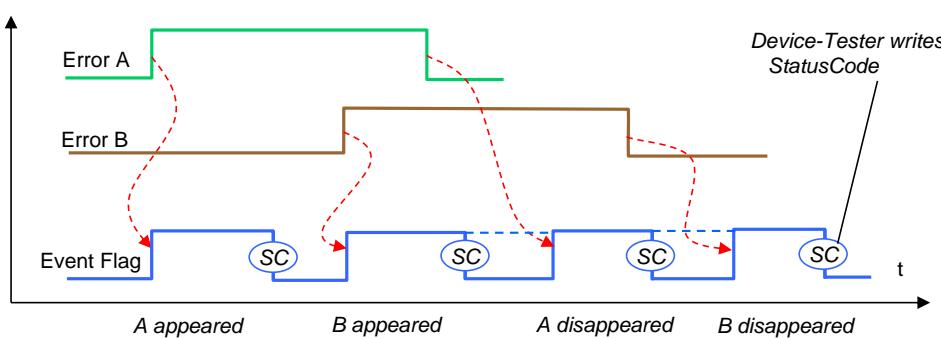
| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0075 |
| Name | | TCD_DLIC_EVNT_OPERMULTEVENT |
| Purpose (short) | | Test of Event handling with multiple Events. |
| Equipment under test (EUT) | | Device supporting more than one Event |
| Test case version | | 1.4 5 |
| Category / type | | Device Event test: test to pass |
| Specification (clause) | | [7], see 7.3.8.2 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Check if Event modes are handled as specified in Figure 12 |
| Precondition | | DTU: SDI-1 communication in state OPERATE EUT: is free of Events; no incidents in application, no Events in communication DTU: Communication EUT: OPERATE |
| Procedure | | a) Write EventA_Appear to index in Config7 b) Device-Tester to read StatusCode c) Device-Tester to read EventQualifier. Save value in tester variable "SCc". d) Device-Tester to read EventCode. Save value in tester variable "SCd". e) Device-Tester to write Status Code "0xFF". f) Write EventB_Appear to index in Config7 g) Device-Tester to read StatusCode h) Wait 50 ms i) Write EventA_Disappear to index in Config7 j) Device-Tester to read EventQualifier. Save value in tester variable "SCj". k) Device-Tester to read EventCode. Save value in tester variable "SCk". l) Device-Tester to write Status Code "0xFF". m) Device-Tester to read StatusCode n) Write EventB_Disappear to index in Config7 o) Device-Tester to read EventQualifier. Save value in tester variable "SCo". p) Device-Tester to read EventCode. Save value in tester variable "SCp". q) Device-Tester to write StatusCode "0xFF". r) Device-Tester to read StatusCode s) Device-Tester to read EventQualifier. Save value in tester variable "SCs". t) Device-Tester to read EventCode. Save value in tester variable "SCt". u) Device-Tester to write StatusCode "0xFF". |
| Test parameter | | Config7 (Event A and B) in 6.5.1 |
| Post condition | | EUT is free of events once test is completed Test Events A and B are reset once the test is completed |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check after step c) that value read shows mode = "Event appeared" or "Event single shot" in case of Notification 2) Check after step d) that SCd equals EventCode of Event A 3) Check after step d) that Event Flag is set 4) Check after step e) that Event Flag is cleared 5) Check after step f) that Event Flag is set 6) Check after step j) that value read shows mode = "Event appeared" or "Event single shot" in case of Notification 7) Check after step k) that SCk equals EventCode of Event B 8) Check after step k) that Event Flag is set 9) Check after step o) that value read shows mode = "Event disappeared" or |

| | |
|----------------------------|---|
| | "Event single shot" in case of Notification 10) Check after step p) that SCp equals EventCode of Event A 11) Check after step p) that Event Flag is set 12) Check after step s) that value read shows mode = "Event disappeared" or "Event single shot" in case of Notification 13) Check after step t) that SCt equals EventCode of Event B 14) Check after step t) that Event Flag is set 15) Check after step u) that Event Flag is cleared |
| Test passed | All evaluation steps ok |
| Test not passed (examples) | Any evaluation step failed |
| Report | Deviations in evaluations: <yes/no> <ok nok> |

1152

1153 Figure 12 shows the correlation of two Errors and the Event Flag and its appearance and disappearance. In case of Notifications the rising and falling edges define the time the Event is
 1154 stimulated.

1155



1156

1157

Figure 12 – Correlation of two Errors and the Event Flag

1158

1159 **6.6.9 Short time Events**

1160 Table 94 defines the test conditions for this test case.

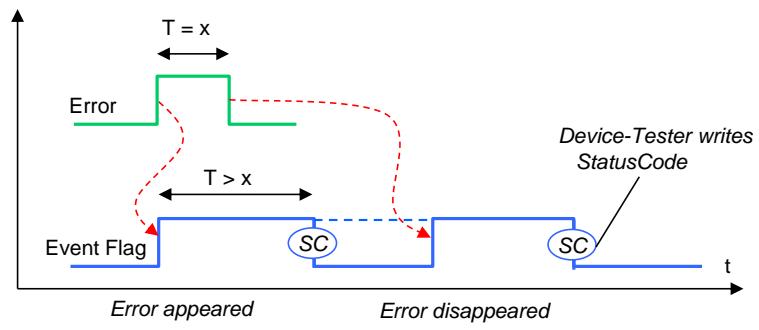
1161 **Table 94 – Short time Events**

1162 -CR066- -CR029-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0076 |
| Name | TCD_DLIC_EVNT_OPERSHORTEVENT |
| Purpose (short) | Test of the Event handling of short time errors. |
| Equipment under test (EUT) | Device, supporting one or more Events, test Event is of type Error or Warning |
| Test case version | 1.2 3 |
| Category / type | Device Event test: test to pass |
| Specification (clause) | [7], see 7.3.8.2 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Event handling of short time Errors according Figure 13. "Short time Error" means that the cause of the Error is no more existent, when the acknowledgement from the Master for the appearance occurred (Write access to StatusCode (SC)). The Device shall send "Event disappeared" in this case after the acknowledgement. |
| Precondition | DTU: SDCI-communication in state OPERATE EUT: is free of Events; no incidents in application, no Events in communication DTU: Communication EUT: OPERATE |
| Procedure | a) Write EventA_Appear to index in Config7. b) Write EventA_Disappear to index in Config7 c) Device-Tester to write StatusCode "0xFF". d) Wait for 50 ms or two times MasterCycleTime whichever is longer e) Device-Tester to write StatusCode "0xFF" |
| Test parameter | Config7 (Event A) in 6.5.1 and MasterCycleTime |
| Post condition | EUT is free of events once test is completed Test Events A and B are reset once the test is completed |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check after step a) that Event Flag is set 2) Check after step e) d) that Event Flag is set 3) Check after step e) that Event Flag is cleared |
| Test passed | All evaluation steps ok |
| Test not passed (examples) | Any evaluation step failed |
| Report | Deviations in evaluations: <yes/no> Event has been latched: <ok nok> |

1165

1166 Figure 13 shows the timings of a short time error and the Event flag.



1167

1168

1169

Figure 13 – Timings of a short time Error and the Event flag

6.6.10 Interconnection active Event/Device Status

Table 140319 defines the test conditions for this test case.

Table 319 - Interconnection active Event/Device Status/Detailed Device Status**-CR066-**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|---|-----------------------------------|
| Identification (ID) | SDCI_TC_0373 | |
| Name | TCD_DLIC_DEF_P_EVENTDEVSTAT | |
| Purpose (short) | Check correct interconnection between Event and (detailed) Device Status | |
| Equipment under test (EUT) | Device supporting Events of type Warning or Error And Parameters Device Status and Detailed Device Status | |
| Test case version | 1.0 | |
| Category / type | Device application test: test to pass | |
| Specification (clause) | [7], see Annex B.2.17 B.2.20 and B.2.21 and Table D.1 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Test correct behavior regarding the interconnection of an active Event and the resulting content of parameter Device Status and Detailed Device Status. | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | a) Read Parameter Device Status and store value in "devStatBase" b) Read Parameter Detailed Device Status, parse result from beginning to end in steps of 3 octets and store values in "detDevStatBase" c) Write EventA_Appear to index in Config7 d) Read Parameter Device Status e) Read Parameter Detailed Device Status, parse result from beginning to end in steps of 3 octets f) Write EventA_Disappear to index in Config7 g) Read Parameter Device Status h) Read Parameter Detailed Device Status, parse result from beginning to end in steps of 3 octets | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | 1) Check values at step d) 2) Check values at step e) 3) Check values at step g) 4) Check values at step h) | |
| Test passed | 1) Device Status = 4 (failure) 2) Check Detailed Device Status: One entry must be the Event Code given in Config 7 3) Device Status must be the same as stored in a) ("devStatBase") 4) Detailed Device Status Entry given in config 7 has been deleted, content matches stored values in b) ("detDevStatBase") | |
| Test not passed (examples) | Any evaluation failed | |
| Report | All evaluations | <ok nok> |

1177 **6.7 Data Storage (DS)**

1178 **6.7.1 General**

1179 **6.7.1.1 Checks on Data Storage Index**

1180 -CR038- -CR113-

1181 Checks on different states/values shall be performed according to the notes in the "Evaluation"
1182 and "Report" field of the test cases:

1183 • State_Property
1184 - value of "State of Data Storage"
1185 - value of "DS_UPLOAD_FLAG"

1186 • Data_Storage_Size
1187 - shall be ~~larger or equal to the actual memory size for the current "Index_List" and current~~
1188 ~~object values of the objects in the Index List~~, as described in "Structure of the stored DS
1189 data objects"
1190 - check after Upload

1191 • Parameter_checksum
1192 - This value shall be changed after modification of parameters listed for data storage
1193 - Check after parameter modification

1194 These states are specified in [7], 10.4.2 (Data Storage state machine), and B.2.3 (Data Storage
1195 Index).

1196 "Parameter set 1" and "Parameter set 2" are used as placeholders for two parameter sets ful-
1197 filling the following conditions:

1198 • "Parameter set 1" and "Parameter set 2" contain parameters listed for data storage
1199 • "Parameter set 1" and "Parameter set 2" are different in parameter values listed for data
1200 storage
1201 • "Parameter set 1" and the parameter set of the delivered Device are different in values

1202 **6.7.1.2 Generation of "DS_UPLOAD_REQ"**

1203 It would be possible to test the generation of "DS_UPLOAD_REQ" in separate test cases. But
1204 these tests are already performed within the test cases for Upload and Download.

1205 **6.7.1.3 Different Upload test cases**

1206 Upload is tested in different states of the Device.

1207 **6.7.1.4 Different Download test cases**

1208 Download is only checked with "DS_UPLOAD_REQ" flag = "0" (false).

1209

1210

1211 **6.7.2 Upload without DS_UPLOAD_FLAG notification**

1212 Table 95 defines the test conditions for this test case.

1213 **Table 95 – Upload without DS_UPLOAD_FLAG notification**

1214 -CR023- -CR038- -CR039-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | | | | | | | | | | | | | | | | | | |
|---|--|--|------------|---|------------|--|------------|--|------------|---|------------|---|------------|--|------------|---|------------|---|------------|
| Identification (ID) | SDCI_TC_0077 | | | | | | | | | | | | | | | | | | |
| Name | TCD_APPS_DSUP_NOFLAG | | | | | | | | | | | | | | | | | | |
| Purpose (short) | Explicit upload without DS_UPLOAD_FLAG notification | | | | | | | | | | | | | | | | | | |
| Equipment under test (EUT) | Device Device with Datastorage support | | | | | | | | | | | | | | | | | | |
| Test case version | 1.01 | | | | | | | | | | | | | | | | | | |
| Category / type | Device DS test: test to pass | | | | | | | | | | | | | | | | | | |
| Specification (clause) | [7], see 10.4.2, Table B.11, Figure 90 | | | | | | | | | | | | | | | | | | |
| Configuration / setup | Device-Tester-Unit | | | | | | | | | | | | | | | | | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | | | | | | | | | | | | | | | | | |
| Purpose (detailed) | Test covers upload of Data Storage contents (parameter set) without DS_UPLOAD_FLAG notification | | | | | | | | | | | | | | | | | | |
| Precondition | <ul style="list-style-type: none"> - Device in PREOPERATE or OPERATE mode - Device DS activated - DS_UPLOAD_FLAG is not set - Device parameterized (manufacturer to define parameter set) | | | | | | | | | | | | | | | | | | |
| Procedure | <p>Perform upload completely as defined in DTU DS state machine:</p> <ol style="list-style-type: none"> a) Switch DTU DS from deactivated to activated state. b) Stimulate upload using DS_Commands "DS_UploadStart" and "DS_UploadEnd" | | | | | | | | | | | | | | | | | | |
| Test parameter | Parameter set (manufacturer to define parameter set) | | | | | | | | | | | | | | | | | | |
| Post condition | – | | | | | | | | | | | | | | | | | | |
| TEST CASE RESULTS | CHECK / REACTION | | | | | | | | | | | | | | | | | | |
| Evaluation | <p>Check whether parameter set is read without errors through Data Storage Index. Upon each of the following actions:</p> <ol style="list-style-type: none"> 1) After call of the DS_UploadStart command 2) After reading/uploading the parameters 3) After call of the DS_UploadEnd command <p>check the following:</p> <ol style="list-style-type: none"> 4) State of Data Storage is correct 5) DS_UPLOAD_FLAG is not set 6) Parameter_checksum does not change <p>7) Verify that the value of DS Size matches with the size of the uploaded data + 4 * number of entries in Index List (see IO-Link System Spec. Annex G)</p> | | | | | | | | | | | | | | | | | | |
| st passed | All three checks during the three actions described in evaluation are positive | | | | | | | | | | | | | | | | | | |
| Test not passed (examples) | Any check in evaluation failed | | | | | | | | | | | | | | | | | | |
| Report | <table border="0" style="width: 100%;"> <tr> <td style="width: 70%;">Result of evaluation action 1) and check 4): <state></td> <td style="width: 30%;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 1) and check 5): <flag></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 1) and check 6: <checksum></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 2) and check 4): <state></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 2) and check 5): <flag></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 2) and check 6): <checksum></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 3) and check 4): <state></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 3) and check 5): <flag></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 3) and check 6): <checksum></td> <td><ok nok></td> </tr> </table> | Result of evaluation action 1) and check 4): <state> | <ok nok> | Result of evaluation action 1) and check 5): <flag> | <ok nok> | Result of evaluation action 1) and check 6: <checksum> | <ok nok> | Result of evaluation action 2) and check 4): <state> | <ok nok> | Result of evaluation action 2) and check 5): <flag> | <ok nok> | Result of evaluation action 2) and check 6): <checksum> | <ok nok> | Result of evaluation action 3) and check 4): <state> | <ok nok> | Result of evaluation action 3) and check 5): <flag> | <ok nok> | Result of evaluation action 3) and check 6): <checksum> | <ok nok> |
| Result of evaluation action 1) and check 4): <state> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 1) and check 5): <flag> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 1) and check 6: <checksum> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 2) and check 4): <state> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 2) and check 5): <flag> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 2) and check 6): <checksum> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 3) and check 4): <state> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 3) and check 5): <flag> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 3) and check 6): <checksum> | <ok nok> | | | | | | | | | | | | | | | | | | |

1219 **6.7.3 Upload via ParamDownloadStore**

1220 Table 96 defines the test conditions for this test case.

1221 **Table 96 – Upload via ParamDownloadStore**

1222 -CR023- -CR024-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | | | | | | | | | | | | | | | | | | |
|---|--|--|------------|---|------------|---|------------|--|------------|---|------------|---|------------|--|------------|---|------------|---|------------|
| Identification (ID) | SDCI_TC_0078 | | | | | | | | | | | | | | | | | | |
| Name | TCD_APPS_DSUP_VIADOWNLOADSTORE | | | | | | | | | | | | | | | | | | |
| Purpose (short) | Explicit upload via SystemCommand "ParamDownloadStore" | | | | | | | | | | | | | | | | | | |
| Equipment under test (EUT) | Device with Block Parameterization support Device with Datastorage support | | | | | | | | | | | | | | | | | | |
| Test case version | 1.1 | | | | | | | | | | | | | | | | | | |
| Category / type | Device DS test: test to pass | | | | | | | | | | | | | | | | | | |
| Specification (clause) | [7], see 10.4.2, Tables B.8, B.9, B.11, and D.1, Figure 90 | | | | | | | | | | | | | | | | | | |
| Configuration / setup | Device-Tester-Unit | | | | | | | | | | | | | | | | | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | | | | | | | | | | | | | | | | | |
| Purpose (detailed) | Test covers parameterization (parameter set 2) of a Device and upload of this set into the Master DS per SystemCommand "ParamDownloadStore". Manufacturer is responsible for the definition of two possible "parameter sets". | | | | | | | | | | | | | | | | | | |
| Precondition | <ul style="list-style-type: none"> - Device in PREOPERATE or OPERATE mode - Device-DS-activated - Parameter set 1 stored within Device (manufacturer to define parameter set 1) - DS_UPLOAD_FLAG is not set - Test preparation e.g. using DS_Command "DS_UploadStart", upload of parameter set 1" using the Index List (upload), followed by a "DS_UploadEnd" | | | | | | | | | | | | | | | | | | |
| Procedure | <ol style="list-style-type: none"> a) Call SystemCommand "ParamDownloadStart" if Device supports Block Parameterization b) Write different parameter set 2 into the Device c) Call SystemCommand "ParamDownloadStore" (causes Event DS_UPLOAD_REQ) d) Wait for event DS_UPLOAD_REQ e) Perform Upload (Data Storage) completely as defined in the Master state machine (switch Master DS from deactivated to activated) | | | | | | | | | | | | | | | | | | |
| Test parameter | Parameter set 1 and parameter set 2 (defined by manufacturer) | | | | | | | | | | | | | | | | | | |
| Post condition | – | | | | | | | | | | | | | | | | | | |
| TEST CASE RESULTS | CHECK / REACTION | | | | | | | | | | | | | | | | | | |
| Evaluation | <p>Check whether parameter set 2 is read without errors through Parameter_checksum. Upon each of the following actions:</p> <ol style="list-style-type: none"> 1) After call of the DS_UploadStart command 2) After reading/uploading the parameters 3) After call of the DS_UploadEnd command <p>check the following:</p> <ol style="list-style-type: none"> 4) State of Data Storage is 0b00 (Inactive) State of Data Storage is correct (active after DS_UploadStart, inactive after DS_UploadEnd) 5) DS_UPLOAD_FLAG is not set DS_UPLOAD_FLAG is correct (set after "ParamDownloadStore" and cleared after DS_UploadEnd) 6) Parameter_checksum has changed to that of parameter set 2 | | | | | | | | | | | | | | | | | | |
| Test passed | All three checks during the three actions described in evaluation are positive | | | | | | | | | | | | | | | | | | |
| Test not passed (examples) | Any check in evaluation failed | | | | | | | | | | | | | | | | | | |
| Report | <table border="0" style="width: 100%;"> <tr> <td>Result of evaluation action 1) and check 4): <state></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 1) and check 5): <flag></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 1) and check 6): <checksum></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 2) and check 4): <state></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 2) and check 5): <flag></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 2) and check 6): <checksum></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 3) and check 4): <state></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 3) and check 5): <flag></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 3) and check 6): <checksum></td> <td style="text-align: right;"><ok nok></td> </tr> </table> | Result of evaluation action 1) and check 4): <state> | <ok nok> | Result of evaluation action 1) and check 5): <flag> | <ok nok> | Result of evaluation action 1) and check 6): <checksum> | <ok nok> | Result of evaluation action 2) and check 4): <state> | <ok nok> | Result of evaluation action 2) and check 5): <flag> | <ok nok> | Result of evaluation action 2) and check 6): <checksum> | <ok nok> | Result of evaluation action 3) and check 4): <state> | <ok nok> | Result of evaluation action 3) and check 5): <flag> | <ok nok> | Result of evaluation action 3) and check 6): <checksum> | <ok nok> |
| Result of evaluation action 1) and check 4): <state> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 1) and check 5): <flag> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 1) and check 6): <checksum> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 2) and check 4): <state> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 2) and check 5): <flag> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 2) and check 6): <checksum> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 3) and check 4): <state> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 3) and check 5): <flag> | <ok nok> | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 3) and check 6): <checksum> | <ok nok> | | | | | | | | | | | | | | | | | | |

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1227 **6.7.4 Upload via ParamDownloadStore without write calls**

1228 Table 97 defines the test conditions for this test case.

1229 **Table 97 – Upload via ParamDownloadStore without write calls**

1230 -CR023- -CR025-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | | | | | | | | |
|-------------------------------------|---|-------------------------------------|------------|---------------------------------|------------|---------------------------------|------------|-------------------------------------|------------|
| Identification (ID) | SDCI_TC_0079 | | | | | | | | |
| Name | TCD_APPS_DSUP_VIADOWNLOADSTORENOWRITE | | | | | | | | |
| Purpose (short) | Explicit upload via "ParamDownloadStore" without write calls | | | | | | | | |
| Equipment under test (EUT) | Device Device with Datastorage support | | | | | | | | |
| Test case version | 1.4 2 | | | | | | | | |
| Category / type | Device DS test: test to pass | | | | | | | | |
| Specification (clause) | [7], see 10.4.2, Tables B.8, B.11, and D.1, Figure 90 | | | | | | | | |
| Configuration / setup | Device-Tester-Unit | | | | | | | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | | | | | | | |
| Purpose (detailed) | Test covers parameterization (parameter set 2) of a Device and upload of this set into the Master DS per SystemCommand "ParamDownloadStore". Manufacturer is responsible for the definition of two possible "parameter sets". | | | | | | | | |
| Precondition | <ul style="list-style-type: none"> - Device in PREOPERATE or OPERATE mode - Device-DS-activated - Parameter set 1 stored within Device (manufacturer to define parameter set 1) - DS_UPLOAD_FLAG is not set - Test preparation e.g. using DS_Command "DS_UploadStart", upload of parameter set 1" using the Index List (upload), followed by a "DS_UploadEnd" | | | | | | | | |
| Procedure | <ol style="list-style-type: none"> a) Write different parameter set 2 into the Device b) Wait 1 s for event DS_UPLOAD_REQ c) Call SystemCommand "ParamDownloadStart" via ISDU (w/o writing parameters), if Device supports Block Parameterization d) Initiate upload via SystemCommand "ParamDownloadStore" e) Wait for Event DS_UPLOAD_REQ f) Perform upload (Data Storage) completely as defined in the Master state machine (switch Master DS from deactivated to activated) | | | | | | | | |
| Test parameter | Parameter set 1 and 2 (manufacturer to define possible parameter sets) | | | | | | | | |
| Post condition | – | | | | | | | | |
| TEST CASE RESULTS | CHECK / REACTION | | | | | | | | |
| Evaluation | <ol style="list-style-type: none"> 1) Check whether parameter set 2 is written without errors 2) Check whether Event DS_UPLOAD_REQ was not raised after changing parameters (parameter set 2) 3) Check whether Event DS_UPLOAD_REQ was raised by the Device after SystemCommand "ParamDownloadStore" 4) Check whether parameter set 2 is read without errors through Parameter_checksum <p>Upon each of the following actions:</p> <ol style="list-style-type: none"> 5) After call of the DS_UploadStart command 6) After reading/uploading the parameters 7) After call of the DS_UploadEnd command <p>check via Data Storage Index the following:</p> <ol style="list-style-type: none"> 8) State of Data Storage is correct 9) DS_UPLOAD_FLAG is not set DS_UPLOAD_FLAG is correct (set after "ParamDownloadStore" and cleared after DS_UploadEnd) 10) Parameter_checksum has changed only after "Write parameter set 2" | | | | | | | | |
| Test passed | All checks in 1) to 4) and all three checks during the three actions described in evaluation are positive | | | | | | | | |
| Test not passed (examples) | Any check in evaluation failed | | | | | | | | |
| Report | <table style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 70%;">Result of evaluation 1): <checksum></td> <td style="text-align: right; width: 30%;"><ok nok></td> </tr> <tr> <td>Result of evaluation 2): <flag></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation 3): <flag></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation 4): <checksum></td> <td style="text-align: right;"><ok nok></td> </tr> </table> | Result of evaluation 1): <checksum> | <ok nok> | Result of evaluation 2): <flag> | <ok nok> | Result of evaluation 3): <flag> | <ok nok> | Result of evaluation 4): <checksum> | <ok nok> |
| Result of evaluation 1): <checksum> | <ok nok> | | | | | | | | |
| Result of evaluation 2): <flag> | <ok nok> | | | | | | | | |
| Result of evaluation 3): <flag> | <ok nok> | | | | | | | | |
| Result of evaluation 4): <checksum> | <ok nok> | | | | | | | | |

| TEST CASE RESULTS | CHECK / REACTION | |
|-------------------|--|------------|
| | Result of evaluation action 5) and check 8): <state> | <ok nok> |
| | Result of evaluation action 5) and check 9): <flag> | <ok nok> |
| | Result of evaluation action 5) and check 10): <checksum> | <ok nok> |
| | Result of evaluation action 6) and check 8): <state> | <ok nok> |
| | Result of evaluation action 6) and check 9): <flag> | <ok nok> |
| | Result of evaluation action 6) and check 10): <checksum> | <ok nok> |
| | Result of evaluation action 7) and check 8): <state> | <ok nok> |
| | Result of evaluation action 7) and check 9): <flag> | <ok nok> |
| | Result of evaluation action 7) and check 10): <checksum> | <ok nok> |

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1235 **6.7.5 Upload via local parameter modification**

1236 Table 98 defines the test conditions for this test case.

1237 **Table 98 – Upload via local parameter modification**

1238 -CR023- -CR025-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | | | | | | | | | | | | | | | | | | |
|---|------------|--|---------------------------------|------------|-------------------------------------|------------|--|------------|---|------------|---|------------|--|------------|---|------------|---|------------|--|------------|
| Identification (ID) | | SDCI_TC_0080 | | | | | | | | | | | | | | | | | | |
| Name | | TCD_APPS_DSUP_VIALOCALCHANGE | | | | | | | | | | | | | | | | | | |
| Purpose (short) | | Implicit upload after local parameter modification | | | | | | | | | | | | | | | | | | |
| Equipment under test (EUT) | | Device with local parameterization such as teach-in or panel as indicated in IODD and with Datastorage support | | | | | | | | | | | | | | | | | | |
| Test case version | | 1.0 1 | | | | | | | | | | | | | | | | | | |
| Category / type | | Device DS test: test to pass | | | | | | | | | | | | | | | | | | |
| Specification (clause) | | [7], see 10.4.2, Tables B.8, B.11, and D.1, Figure 90 | | | | | | | | | | | | | | | | | | |
| Configuration / setup | | Device-Tester-Unit | | | | | | | | | | | | | | | | | | |
| TEST CASE | | CONDITIONS / PERFORMANCE | | | | | | | | | | | | | | | | | | |
| Purpose (detailed) | | Test covers local parameter changes of a Device and implicit upload of the parameter set into the Master DS. Manufacturer is responsible for the definition of two possible "parameter sets". | | | | | | | | | | | | | | | | | | |
| Precondition | | <ul style="list-style-type: none"> - Device in PREOPERATE or OPERATE mode - Device DS deactivated - Parameter set 1 stored within Device (manufacturer to define parameter set 1) - DS_UPLOAD_FLAG is not set - Test preparation e.g. using DS_Command "DS_UploadStart", upload of parameter set 1" using the Index List (upload), followed by a "DS_UploadEnd" | | | | | | | | | | | | | | | | | | |
| Procedure | | <ol style="list-style-type: none"> a) Change parameter value(s) locally in the Device, e.g. via local menu or teach-in b) Wait for Event DS_UPLOAD_REQ c) Perform upload (Data Storage) completely as defined in the Master state machine (switch Master DS from deactivated to activated) | | | | | | | | | | | | | | | | | | |
| Test parameter | | Parameter set 1 (manufacturer to define the possible parameter set) | | | | | | | | | | | | | | | | | | |
| Post condition | | – | | | | | | | | | | | | | | | | | | |
| TEST CASE RESULTS | | CHECK / REACTION | | | | | | | | | | | | | | | | | | |
| Evaluation | | <ol style="list-style-type: none"> 1) Check whether Event DS_UPLOAD_REQ was raised automatically by the Device after local parameter modification 2) Check whether parameter set 2 is read without errors through Parameter_checksum <p>Upon each of the following actions:</p> <ol style="list-style-type: none"> 3) After call of the DS_UploadStart command 4) After reading/uploading the parameters 5) After call of the DS_UploadEnd command <p>check via Data Storage Index the following:</p> <ol style="list-style-type: none"> 6) State of Data Storage is correct 7) DS_UPLOAD_FLAG is not set DS_UPLOAD_FLAG is correct (set after local change of parameter values and cleared after DS_UploadEnd) 8) Parameter_checksum has changed only after 'local change of parameter values' | | | | | | | | | | | | | | | | | | |
| Test passed | | All checks in 1), 2), and all three checks during the three actions described in evaluation are positive | | | | | | | | | | | | | | | | | | |
| Test not passed (examples) | | Any check in evaluation failed | | | | | | | | | | | | | | | | | | |
| Report | | <table border="0"> <tr> <td>Result of evaluation 1): <flag></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation 2): <checksum></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 3) and check 6): <state></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 3) and check 7): <flag></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 3) and check 8): <checksum></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 4) and check 6): <state></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 4) and check 7): <flag></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 4) and check 8): <checksum></td> <td><ok nok></td> </tr> <tr> <td>Result of evaluation action 5) and check 6): <state></td> <td><ok nok></td> </tr> </table> | Result of evaluation 1): <flag> | <ok nok> | Result of evaluation 2): <checksum> | <ok nok> | Result of evaluation action 3) and check 6): <state> | <ok nok> | Result of evaluation action 3) and check 7): <flag> | <ok nok> | Result of evaluation action 3) and check 8): <checksum> | <ok nok> | Result of evaluation action 4) and check 6): <state> | <ok nok> | Result of evaluation action 4) and check 7): <flag> | <ok nok> | Result of evaluation action 4) and check 8): <checksum> | <ok nok> | Result of evaluation action 5) and check 6): <state> | <ok nok> |
| Result of evaluation 1): <flag> | <ok nok> | | | | | | | | | | | | | | | | | | | |
| Result of evaluation 2): <checksum> | <ok nok> | | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 3) and check 6): <state> | <ok nok> | | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 3) and check 7): <flag> | <ok nok> | | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 3) and check 8): <checksum> | <ok nok> | | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 4) and check 6): <state> | <ok nok> | | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 4) and check 7): <flag> | <ok nok> | | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 4) and check 8): <checksum> | <ok nok> | | | | | | | | | | | | | | | | | | | |
| Result of evaluation action 5) and check 6): <state> | <ok nok> | | | | | | | | | | | | | | | | | | | |

| TEST CASE RESULTS | CHECK / REACTION | |
|-------------------|--|--------------------------|
| | Result of evaluation action 5) and check 7): <flag> Result of evaluation action 5) and check 8): <checksum> | <ok nok> <ok nok> |

1241

1242 **6.7.6 Call ParamBreak in different states of Upload**

1243 Table 99 defines the test conditions for this test case.

1244 **Table 99 – Call ParamBreak in different states of Upload**

1245 -CR023-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0081 |
| Name | | TCD_APPS_DSUP_PARABREAKABORT |
| Purpose (short) | | Upload abort via SystemCommand "ParamBreak" in different states |
| Equipment under test (EUT) | | Device with Block Parameterization support Device with Datastorage and Block Parameterization support |
| Test case version | | 1.3 |
| Category / type | | Device DS test: test to pass |
| Specification (clause) | | [7], see 10.4.2, Tables B.8, B.11, and D.1, Figure 90 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test covers Upload aborts via SystemCommand "ParamBreak" in different states. Manufacturer is responsible for the definition of two possible "parameter sets". |
| Precondition | | <ul style="list-style-type: none"> - Device in PREOPERATE or OPERATE mode - Device DS activated - Parameter set 1 stored within Device (manufacturer to define parameter set 1) - DS_UPLOAD_FLAG is not set - Test preparation e.g. using DS_Command "DS_UploadStart", upload of parameter set 1" using the Index List (upload), followed by a "DS_UploadEnd" |
| Procedure | | <ol style="list-style-type: none"> a) Call SystemCommand "ParamDownloadStart" b) Write different parameter set 2 into the Device c) Call SystemCommand "ParamDownloadStore" (causes Event DS_UPLOAD_REQ) d) Wait for Event DS_UPLOAD_REQ e) Start Upload via SystemCommand "ParamUploadStart" f) Call SystemCommand "ParamBreak" directly after "ParamUploadStart" g) Start Upload via SystemCommand "ParamUploadStart" h) Transmit first Block Parameter object of Config4 i) Call SystemCommand "ParamBreak" j) Start Upload via SystemCommand "ParamUploadStart" k) Transmit all Block Parameter objects of Config4 l) Call SystemCommand "ParamBreak" m) Perform upload (Data Storage) completely as defined in the Master state machine (switch Master DS from deactivated to activated) |
| Test parameter | | Parameter set 1 and 2 |
| Post condition | | - |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | <ol style="list-style-type: none"> 1) Check whether Event DS_UPLOAD_REQ was raised automatically by the Device 2) Check whether parameter set 2 is read without errors through Parameter_checksum <p>Upon each of the following actions:</p> <ol style="list-style-type: none"> 3) After call of each SystemCommand "ParamUploadStart" (3x) 4) After call of each SystemCommand "ParamBreak" (3x) <p>check via Data Storage Index the following:</p> <ol style="list-style-type: none"> 5) State of Data Storage is 0b00 (inactive) 6) DS_UPLOAD_FLAG is set 7) Parameter_checksum has changed only after 'write parameter set 2' 8) Check whether the Upload has been completed without errors |
| Test passed | | All checks in 1), 2), 8), and all three checks during the two actions described in evaluation are positive |
| Test not passed (examples) | | Any check in evaluation failed |
| Report | | Result of evaluation 1): <flag> <ok nok> Result of evaluation 2): <checksum> <ok nok> Result of evaluation action 3) and check 5): <state> <ok nok> |

| TEST CASE RESULTS | CHECK / REACTION | |
|-------------------|---|------------|
| | Result of evaluation action 3) and check 6): <flag> | <ok nok> |
| | Result of evaluation action 3) and check 7): <checksum> | <ok nok> |
| | Result of evaluation action 4) and check 5): <state> | <ok nok> |
| | Result of evaluation action 4) and check 6): <flag> | <ok nok> |
| | Result of evaluation action 4) and check 7): <checksum> | <ok nok> |
| | Result of evaluation 8): | <ok nok> |

1248

1249 **6.7.7 Check structure of Data Storage Index List**

1250 Table 320 defines the test conditions for this test case.

1251 **Table 320 – Check structure of Data Storage Index List**

1252 -CR070-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0378 |
| Name | | TCD_APPS_DSUP_INDEXLIST |
| Purpose (short) | | Check structure of Data Storage Index List |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.0 |
| Category / type | | Device DS test: test to pass |
| Specification (clause) | | B.2.3, Table B.11 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Check structure of Index_List and concatenated Index_Lists if available |
| Precondition | | DTU: Communication EUT: PREOPERATE |
| Procedure | | a) Read Index 3, extract Index_List (Subindex 5) b) Store length of Index_List (number of octets) in <len> c) Calculate and store <EntryCount> = (<len>-2) / 3 d) Store termination marker in <term> e) If <term> is not equal 0x00 0x00 read next Index_List from index referenced by <term> and repeat from step b) |
| Input parameter | | |
| Post condition | | - |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | For each loop cycle check: 1) After step c) check: <EntryCount> must be an integer value in range 0 to 70 2) After step d) check if <EntryCount> is less than 70, <term> must equal 0x00 0x00 1) TODO: optional: check if each index referenced by the index list is greater than 23 |
| Test passed | | All evaluations with positive result |
| Test failed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

1255

1256 **6.7.8 Download after modification of parameters**

1257 Table 100 defines the test conditions for this test case.

1258 **Table 100 – Download after modification of parameters**

1259 -CR023-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|---|-----------------------------------|
| Identification (ID) | SDCI_TC_0082 | |
| Name | TCD_APPS_DSDN_PARAMODIFICATION | |
| Purpose (short) | Download after modification of parameters | |
| Equipment under test (EUT) | Device with Block Parameterization support Device with Datastorage and Block Parameterization support | |
| Test case version | 1.1 2 | |
| Category / type | Device DS test: test to pass | |
| Specification (clause) | [7], see 10.4.2, Tables B.8, B.11, and D.1, Figure 90 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | After changing parameters in Device without storing them in DS, download a different parameter set into the Device. | |
| Precondition | <ul style="list-style-type: none"> - Device in PREOPERATE or OPERATE mode - Device_DS_activated - Parameter set 1 stored within Device (manufacturer to define parameter set 1) - DS_UPLOAD_FLAG is not set - Test preparation e.g. using DS_Command "DS_UploadStart", upload of parameter set 1" using the Index List (upload), followed by a "DS_UploadEnd" | |
| Procedure | <ol style="list-style-type: none"> a) Call SystemCommand "ParamDownloadStart" via ISDU b) Write different parameter set 2 into the Device c) Call SystemCommand "ParamDownloadEnd" d) Perform Download (restore) of parameter set 1 completely as defined in the Master state machine only if the DS_UPLOAD_FLAG is not set (switch Master DS from deactivated to activated) | |
| Test parameter | Parameter set 1 and 2 | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check whether Event DS_UPLOAD_REQ was not raised by the Device Upon each of the following actions: 2) After call of SystemCommand "ParamDownloadStart" 3) After call of SystemCommand "ParamDownloadEnd" 4) After execution of the complete Download check via Data Storage Index the following: 5) State of Data Storage is 0b00 (inactive) 6) DS_UPLOAD_FLAG is not set 7) Parameter_checksum has changed only after 'write parameter set 2' 8) Check whether the Download has been completed without errors | |
| Test passed | All checks in 1), 8), and all three checks during the three actions described in evaluation are positive | |
| Test not passed (examples) | Any check in evaluation failed | |
| Report | Result of evaluation 1): <flag> <ok nok> Result of evaluation action 2) and check 5): <state> <ok nok> Result of evaluation action 2) and check 6): <flag> <ok nok> Result of evaluation action 2) and check 7): <checksum> <ok nok> Result of evaluation action 3) and check 5): <state> <ok nok> Result of evaluation action 3) and check 6): <flag> <ok nok> Result of evaluation action 3) and check 7): <checksum> <ok nok> Result of evaluation action 4) and check 5): <state> <ok nok> Result of evaluation action 4) and check 6): <flag> <ok nok> Result of evaluation action 4) and check 7): <checksum> <ok nok> Result of evaluation 8): <ok nok> | |

1262

1263

1264 **6.7.9 Download into the Device after reset**

1265 Table 101 defines the test conditions for this test case.

1266 **Table 101 – Download into the Device after reset**

1267 -CR023-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | | | | | | | | | | |
|---|---|---------------------------------|------------|--|------------|---|------------|---|------------|--------------------------|------------|
| Identification (ID) | SDCI_TC_0083 | | | | | | | | | | |
| Name | TCD_APPS_DSDN_FACTORYRESET | | | | | | | | | | |
| Purpose (short) | Download into the Device after reset to factory settings | | | | | | | | | | |
| Equipment under test (EUT) | Device with "Reset to factory settings" support and with Datastorage support | | | | | | | | | | |
| Test case version | 1.0 | | | | | | | | | | |
| Category / type | Device DS test: test to pass | | | | | | | | | | |
| Specification (clause) | [7], see 10.4.2, 10.7, Tables B.8, B.11, and D.1, Figure 90 | | | | | | | | | | |
| Configuration / setup | Device-Tester-Unit | | | | | | | | | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | | | | | | | | | |
| Purpose (detailed) | Test of Download of the stored parameter set into the Device after reset to factory settings. Manufacturer to provide parameter set 1 different to factory settings. | | | | | | | | | | |
| Precondition | <ul style="list-style-type: none"> - Device in PREOPERATE or OPERATE mode - Device DS activated - Parameter set 1 stored within Device (manufacturer to define parameter set 1) - DS_UPLOAD_FLAG is not set - Test preparation e.g. using DS_Command "DS_UploadStart", upload of parameter set 1" using the Index List (upload), followed by a "DS_UploadEnd" | | | | | | | | | | |
| Procedure | <ol style="list-style-type: none"> a) Call SystemCommand "Restore factory settings" via ISDU b) Perform Download (restore) of parameter set 1 completely as defined in the Master state machine only if the DS_UPLOAD_FLAG is not set (switch Master DS from deactivated to activated) | | | | | | | | | | |
| Test parameter | Parameter set 1 | | | | | | | | | | |
| Post condition | – | | | | | | | | | | |
| TEST CASE RESULTS | CHECK / REACTION | | | | | | | | | | |
| Evaluation | <ol style="list-style-type: none"> 1) After "Restore factory settings" check whether Event DS_UPLOAD_REQ was not raised by the Device. Upon the following action: 2) After "Restore factory settings" check via Data Storage Index the following: 3) State of Data Storage is correct 4) DS_UPLOAD_FLAG is not set 5) Parameter_checksum has changed 6) Check whether the Download has been completed without errors | | | | | | | | | | |
| Test passed | All checks in 1), 6), and all three checks during the action described in evaluation are positive | | | | | | | | | | |
| Test not passed (examples) | Any check in evaluation failed | | | | | | | | | | |
| Report | <table style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 70%;">Result of evaluation 1): <flag></td> <td style="width: 30%; text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 2) and check 3): <state></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 2) and check 4): <flag></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation action 2) and check 5): <checksum></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Result of evaluation 6):</td> <td style="text-align: right;"><ok nok></td> </tr> </table> | Result of evaluation 1): <flag> | <ok nok> | Result of evaluation action 2) and check 3): <state> | <ok nok> | Result of evaluation action 2) and check 4): <flag> | <ok nok> | Result of evaluation action 2) and check 5): <checksum> | <ok nok> | Result of evaluation 6): | <ok nok> |
| Result of evaluation 1): <flag> | <ok nok> | | | | | | | | | | |
| Result of evaluation action 2) and check 3): <state> | <ok nok> | | | | | | | | | | |
| Result of evaluation action 2) and check 4): <flag> | <ok nok> | | | | | | | | | | |
| Result of evaluation action 2) and check 5): <checksum> | <ok nok> | | | | | | | | | | |
| Result of evaluation 6): | <ok nok> | | | | | | | | | | |

1270

1271

1272 **6.7.10 Call ParamBreak in different states of Download**

1273 Table 102 defines the test conditions for this test case.

1274 **Table 102 – Call ParamBreak in different states of Download**

1275 -CR023-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0084 |
| Name | TCD_APPS_DSDN_PARABREAKABORT |
| Purpose (short) | Download abort via SystemCommand "ParamBreak" in different states |
| Equipment under test (EUT) | Device with Block Parameterization support Device with Datastorage and Block Parameterization support |
| Test case version | 1.2.3 |
| Category / type | Device DS test: test to pass |
| Specification (clause) | [7], see 10.4.2, Tables B.8, B.11, and D.1, Figure 90 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Test covers Download aborts via SystemCommand "ParamBreak" in different states. Manufacturer is responsible for the definition of two possible "parameter sets". |
| Precondition | <ul style="list-style-type: none"> - Device in PREOPERATE or OPERATE mode - Device_DS activated - Parameter set 1 stored within Device (manufacturer to define parameter set 1) - DS_UPLOAD_FLAG is not set - Test preparation e.g. using DS_Command "DS_UploadStart", upload of parameter set 1" using the Index List (upload), followed by a "DS_UploadEnd" |
| Procedure | <ol style="list-style-type: none"> a) Start Download via SystemCommand "ParamDownloadStart" b) Call SystemCommand "ParamBreak" directly after "ParamDownloadStart" c) Start Download via SystemCommand "ParamDownloadStart" d) Transmit first Block Parameter object of Config4 with data of parameter set 2 e) Call SystemCommand "ParamBreak" f) Start Download via SystemCommand "ParamDownloadStart" g) Transmit all Block Parameter objects of Config4 with data of parameter set 2 h) Call SystemCommand "ParamBreak" i) Perform Download of parameter set 2 completely as defined in the Master state machine only if the DS_UPLOAD_FLAG is not set in the Device (switch Master DS from deactivated to activated) |
| Test parameter | Parameter set 1 and 2 |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | <p>After call of each SystemCommand "ParamBreak" (3x) check via Data Storage Index the following:</p> <ol style="list-style-type: none"> 1) State of Data Storage is 0b00 (inactive) 2) DS_UPLOAD_FLAG is not set 3) Parameter_checksum has not changed <p>After i):</p> <ol style="list-style-type: none"> 4) Check whether the Download has been completed without errors |
| Test passed | All checks during the actions described in evaluation are positive |
| Test not passed (examples) | Any check in evaluation failed |
| Report | All evaluations: <ok nok> |

1278

1279 **6.7.11 Parameter Manager – Single Parameter and DownloadStore**

1280 Table 103 defines the test conditions for this test case.

1281 **Table 103 – Parameter Manager – Single Parameter and DownloadStore**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0321 |
| Name | TCD_DSBD_APPL_DSSINGLEPARAM |
| Purpose (short) | Test of single parameter write in Parameter Manager Idle |
| Equipment under test (EUT) | Device with Data Storage as indicated in IODD |
| Test case version | 1.0 |
| Category / type | Device DS test: test to pass |
| Specification (clause) | [7], 10.3.2 and 10.3.4 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Device shall not invoke DataStorage if parametrized via single parameter accesses. Device shall invoke DataStorage after receiving a SystemCommand "ParamDownloadStore". |
| Precondition | DTU: Communication EUT: No Event pending or active DataStorage of the Device is inactive and DS_UPLOAD_FLAG is "0" |
| Procedure | a) Write test parameter with different content than stored in Device b) Wait for DS_UPLOAD_REQ Event with a timeout of 1 s c) Read DataStorage state property: Index 3, Subindex 2 d) Write SystemCommand "ParamDownloadStore" e) Wait for DS_UPLOAD_REQ Event with a timeout of 1 s f) Read Data Storage state property: Index 3, Subindex 2 g) Write DS_Command "DS_UploadEnd" |
| Test parameter | One parameter of the parameter sets defined in 6.7.1.1 |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) After step b), check that timeout occurred and no Event with code "DS_UPLOAD_REQ" has been received 2) After step c), check that State_Property.DS_UPLOAD_FLAG = "0" 3) After step e), check that no timeout occurred and Event with code "DS_UPLOAD_REQ" has been received 4) After step f), check that State_Property.DS_UPLOAD_FLAG = "1" |
| Test passed | All evaluations with positive result |
| Test not passed (examples) | No response or any evaluation failed |
| Report | Single Parameter without DS activity DS_DownloadStore in ParameterManager state "Idle_0" <ok nok> <ok nok> |

1285 **6.7.12 Clear DS_UPLOAD_FLAG after DS_Up/DownloadEnd**

1286 Table 104 defines the test conditions for this test case.

1287 **Table 104 – Clear DS_UPLOAD_FLAG after DS_Up/DownloadEnd**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0322 |
| Name | | TCD_DS_APP_IDLEFLAGCLEAR |
| Purpose (short) | | DS_UPLOAD_FLAG is cleared after TransmissionEnd while in DSIdle_2 |
| Equipment under test (EUT) | | Device with Data Storage indicated in IODD |
| Test case version | | 1.0 |
| Category / type | | Device DS test: Test to pass |
| Specification (clause) | | [7], see 10.4.2, Table B.11, Table D.2, Figure 90 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | DS_UPLOAD_FLAG is cleared when DS_UploadEnd or DS_DownloadEnd command is received while Data Storage state machine is in state DSIdle_2 (Transition T11) | |
| Precondition | DTU: OPERATE EUT: DS state machine is in state DSIdle_2 | |
| Procedure | a) Write SystemCommand "ParamDownloadStore" b) Read DataStorageIndex c) Write DS Command "DS_UploadEnd" d) Read DataStorageIndex e) Write SystemCommand "ParamDownloadStore" f) Read DataStorageIndex g) Write DS Command "DS_DownloadEnd" h) Read DataStorageIndex | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check "DS_UPLOAD_FLAG" in step b), d), f), and h) | |
| Test passed | In b) = "1" In d) = "0" In f) = "1" In h) = "0" | |
| Test not passed (examples) | Any check failed | |
| Report | In b): <flag> | <ok nok> |
| | In d): <flag> | <ok nok> |
| | In f): <flag> | <ok nok> |
| | In h): <flag> | <ok nok> |

1289

1291 **6.7.13 Storage of DS_UPLOAD_FLAG in non volatile memory**

1292 -CR043-

1293 Table 104321 defines the test conditions for this test case.

1294 **Table 321 – Storage of DS_UPLOAD_FLAG in non volatile memory**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0374 |
| Name | TCD_DS_APP_UPLOAD_FLAG_NON_VOLATILE |
| Purpose (short) | Storage of DS_UPLOAD_FLAG in non volatile memory |
| Equipment under test (EUT) | Device with Block Parameterization Data Storage support |
| Test case version | 1.0 |
| Category / type | Device DS test: test to pass |
| Specification (clause) | [7], see 10.4.2, Tables B.8, B.9, B.11, and D.1, Figure 90 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Test covers parameterization (parameter set 2) of a Device and initiation of the Upload via SystemCommand "ParamDownloadStore". Device shall store the DS_UPLOAD_FLAG in non volatile memory |
| Precondition | <ul style="list-style-type: none"> - Device in PREOPERATE mode - Parameter set 1 stored within Device (manufacturer to define parameter set 1) - DS_UPLOAD_FLAG is not set - Test preparation e.g. using DS_Command "DS_UploadStart", upload of parameter set 1" using the Index List (upload), followed by a "DS_UploadEnd" |
| Procedure | <ol style="list-style-type: none"> a) Call SystemCommand "ParamDownloadStart" if Device supports Block Parameterization b) Write different parameter set 2 into the Device a) Call SystemCommand "ParamDownloadStore" (causes Event DS_UPLOAD_REQ) b) Wait for event DS_UPLOAD_REQ c) Check DS_UPLOAD_FLAG in parameter DataStorageIndex d) Apply power cycle (power off, wait 5 s, power on: Port remains in communication) e) Check if a communication startup sequence has been triggered, and Device is in PREOPERATE f) Check DS_UPLOAD_FLAG in parameter DataStorageIndex g) Reset the DS_UPLOAD_FLAG with the call of the System Command "DS_UploadStart", followed by the system command "DSUploadEnd" h) Check DS_UPLOAD_FLAG in parameter DataStorageIndex |
| Test parameter | Parameter set 1 and parameter set 2 (defined by manufacturer) |
| Post condition | - |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | <ol style="list-style-type: none"> 1) Check whether Event DS_UPLOAD_REQ was raised automatically by the Device after b) 2) check via Data Storage Index: the DS_UPLOAD_FLAG is set after c) 3) Startup Sequence has been detected in e), and Device is in PREOPERATE state 4) Value of procedure f) (DS_UPLOAD_FLAG) = "1" (active DS_UPLOAD_REQ) 5) Value of procedure h) (DS_UPLOAD_FLAG) = "0" (no active DS_UPLOAD_REQ) |
| Test passed | All checks are positive |

| TEST CASE RESULTS | CHECK / REACTION |
|------------------------|--|
| Test failed (examples) | Any of the checks failed |
| Report | Device has stored the DS_UPLOAD_FLAG non volatile: <yes/no> <ok nok> |

1297

1298

1299 6.8 Operation with a legacy Master ("Master 1.0")**1300 6.8.1 General**

1301 Designers of Devices according to [7] ("Device 1.1") should be aware of the possibility that such
1302 a Device in the field can be connected to a Master ("Master 1.0") designed according to a
1303 previous specification [5]. Therefore, the conformity class requirements and the associated test
1304 cases are specified within the following clauses. It should be noted that the IODD of such a
1305 Device plays an important role in establishing the right behavior in respect to Process Data
1306 exchange and cycle times (interleave mode). The compatibility rules for IODDs are defined in
1307 [3].

1308 6.8.2 Conformity classes**1309 6.8.2.1 Master conformity**

1310 The "Masters 1.0" in the field are supposed to be conform with [5]. By design according to [1],
1311 the "Masters 1.1" shall be compatible to any legacy "Device 1.0". Therefore, no special com-
1312 patibility rules are required for Master and no conformity classes.

1313 6.8.2.2 "Device 1.1" without backward compatibility

1314 The Device requires features that only a Master provides, which is designed according to [7] or
1315 a later version. Thus, usually it can deny SDCI communication with a "Master 1.0". Example is
1316 a Device with large Process Data (PD). If this Device would be used with a "Master 1.0" and an
1317 M-sequence TYPE_1, the Process Data cycle could last much longer than with a "Master 1.1"
1318 (see Annex B.5).

1319 6.8.2.3 "Device 1.1" compatible with a "Master 1.0"

1320 There exist two main possibilities to design a "Device 1.1" compatible to a "Master 1.0".

- 1321 • A "Device 1.1" can be adjusted to a behavior according to [5] through setting of a specific
1322 parameter using ISDU services ("Device 1.0"). In this case no new test cases are required
1323 due to an SDCI communication compatible to [5].
- 1324 • A "Device 1.1" will automatically detect connection to a "Master 1.0" and switch to an SDCI
1325 communication compatible to [5]. For this case, the restrictions for "Master 1.0" and "Device
1326 1.1" are defined in the following.

1327 The compatibility restrictions or constraints for a "Master 1.0" being able to support automatic
1328 SDCI communication version detection are:

- 1329 • As defined in the state machines of [7], the "Device 1.1" will send the protocol version 1.1
1330 (or a later one) via parameter 0x04 (RevisionID) to the "Master 1.0" during the startup
1331 phase. The "Master 1.0" ignores this version number. If the "Master 1.0" insists in protocol
1332 version 1.0, the "Device 1.1" cannot be used with this Master.
- 1333 • During reading of the parameters 0x02 to 0x06 (Direct Parameter page 1) in the
1334 STARTUP phase, the "Device 1.1" cannot detect the Master version. For this reason,
1335 some of the reserved bits in the parameter 0x03 (M-sequence Capability) in [5] are set in
1336 the "Device 1.1". The "Master 1.0" ignores these bits. Otherwise, the "Device 1.1" cannot
1337 be used with this "Master 1.0".

1340 **6.8.3 From STARTUP to OPERATE (V1.0)**

1341 Table 105 defines the test conditions for this test case.

1342 **Table 105 – From STARTUP to OPERATE (V1.0)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0085 |
| Name | | TCD_DLIC_COMP_STARTUP |
| Purpose (short) | | Establish a connection from Wakeup to OPERATE according to V1.0 SDCI protocol |
| Equipment under test (EUT) | | Device with "V1.0" support |
| Test case version | | 1.2 |
| Category / type | | Device legacy Master test: test to pass |
| Specification (clause) | | [5] |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Establish a connection from Wakeup to OPERATE in V1.0 way of SDCI protocol. The Device-Tester initiates a Wakeup request, reads out the parameter 0x02 – 0x06 (DPP1) and then tries to turn the Device in OPERATE mode. After this, the Device shall be able to exchange Process Data and accept ISDU services. This test shall ensure that a V1.1 Device can be accessed from a V1.0 Master. |
| Precondition | | – |
| Procedure | | <ul style="list-style-type: none"> a) Master initiates a Wakeup (with reading of parameter 0x02) b) After the transmission rate detection the Master reads parameter 0x03 – 0x06 c) After reading the parameter it will write the MasterCycleTime d) Master sends MasterCommand 0x99 (OPERATE) e) Master switches to target M-sequence type and exchanges Process Data f) Master initiates a Read or Write to DPP1 to ensure response g) Master initiates an ISDU Read or Write to test the Device capability (only in case of ISDU support) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | <ul style="list-style-type: none"> 1) Check if Device responds with the correct values during STARTUP 2) Check if the Device responds with the correct M-sequence type after OPERATE 3) Check if the Device supports ISDU (highly recommended) 4) Check if the ISDU Read or Write is responded (only if ISDU is supported) |
| Test passed | | Evaluations 1), 2), and 4) successful |
| Test not passed (examples) | | Evaluations 1), 2), or 4) failed |
| Report | | Exchange of PD: <yes/no> ISDU is working: <yes/no> No ISDU support: <yes/no> |
| | | <ok nok> <ok nok> <exception> |

1345

1346

1347 **6.8.4 From STARTUP to OPERATE – interleave (V1.0)**

1348 Table 106 defines the test conditions for this test case.

1349 **Table 106 – From STARTUP to OPERATE - interleave (V1.0)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|-----------------------------|--|---|---|
| Identification (ID) | | SDCI_TC_0086 | |
| Name | | TCD_DLIC_COMP_TYPE1INTERLEAVE | |
| Purpose (short) | | Interleave test | |
| Equipment under test (EUT) | | Device with "V1.0" support | |
| Test case version | | 1.2 | |
| Category / type | | Device legacy Master test: test to pass | |
| Specification (clause) | | [5] | |
| Configuration / setup | | Device-Tester-Unit | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | | Interleave test. In V1.1 the SDCI protocol defines new M-sequence types for large Process Data transfers (more than 2 octets). In Version V1.0, SDCI communication uses the TYPE_1_x M-sequences with interleaving of PD and OD. A compatible Device shall be able to switch to the interleave mode (TYPE_1_x) during communication with the Device-Tester. | |
| Precondition | | Device supports more than 2 octets of Process Data | |
| Procedure | | a) Master initiates a Wakeup request (with reading of parameter 0x02) b) After detection of the transmission rate the Master reads parameter 0x03 – 0x06 c) After reading the parameter it will write the MasterCycleTime to 0x01 d) Master sends MasterCommand 0x99 (OPERATE) e) Master switches to M-sequence TYPE_1_1/2 and exchanges Process Data f) Master initiates a Read or Write DPP1 to ensure a response from the Device g) Master initiates an ISDU Read or Write to ensure a response from the Device (only in case of ISDU support) | |
| Test parameter | | "PD size" taken from the IODD | |
| Post condition | | – | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | | 1) Check if Device responds with the correct values during STARTUP 2) Check if the Device responds with the correct M-sequence type after OPERATE 3) Check if the Read or Write to DPP1 is responded 4) Check if the ISDU Read or Write is responded | |
| Test passed | | Evaluations 1), 2), and 4) successful | |
| Test not passed (examples) | | Evaluations 1), 2), or 4) failed | |
| Report | | Exchange of PD in interleave mode: <yes/no> Read or Write to DPP1 is working: <yes/no> ISDU is working: <yes/no> No ISDU support: <yes/no> | <ok nok> <ok nok> <ok nok> <exception> |

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1354 **6.8.5 Events – PDInvalid / PDValid (V1.0)**

1355 Table 107 defines the test conditions for this test case.

1356 **Table 107 – Events – PDInvalid / PDValid (V1.0)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0087 |
| Name | | TCD_DLIC_COMP_PDINVALIDEVENT |
| Purpose (short) | | Send Event for PDVALID/INVALID |
| Equipment under test (EUT) | | Device NOTE For Devices without PDInvalid Flag support, this test case can be skipped. No test interface required. |
| Test case version | | 1.1 |
| Category / type | | Device legacy Master test: test to pass |
| Specification (clause) | | [5] |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Send Event for PDVALID/INVALID. This test to ensure that a Device can indicate the validity of the Process Data inputs GOOD or BAD via an Event in a V1.0 SDCI communication (In V1.0, the Master does not interpret the bit in the Process Data). |
| Precondition | | Communication is established |
| Procedure | | a) Stimulate an error in the Device, which leads to a Process Data failure b) The Device shall send this status change via an Event |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | Check if the Device sent an Event with PDValid/Invalid to the Master |
| Test passed | | DTU received an Event for the validity change of Process Data (GOOD and BAD) |
| Test not passed (examples) | | Device did not send an Event |
| Report | | Device sent "GOOD/BAD" Event: <yes/no> <ok nok> |

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1361 **6.9 Direct Parameter page 1**1362 **6.9.1 MasterCycleTime**

1363 Table 108 defines the test conditions for this test case.

1364 **Table 108 – MasterCycleTime**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|---|---|
| Identification (ID) | SDCI_TC_0089 | |
| Name | TCD_DLPC_STDP_MASTERCYCLETIME | |
| Purpose (short) | Correct value of MasterCycleTime | |
| Equipment under test (EUT) | Device | |
| Test case version | 1.1 | |
| Category / type | Device DPP test: test to pass | |
| Specification (clause) | [7], see B.1.3 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test the correct value of MasterCycleTime in DPP1. The value shall match the value transmitted by the Master (DTU). | |
| Precondition | DTU: Port inactive EUT: – | |
| Procedure | a) Set DTU to communication b) Read DPP1.MasterCycleTime | <i>;save MasterCycleTime(Master) ;returns MasterCycleTime(Device)</i> |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) After b), compare MasterCycleTime(Master) with MasterCycleTime(Device) | |
| Test passed | Values match | |
| Test not passed (examples) | Mismatch of values | |
| Report | MasterCycleTime(Master): <value> MasterCycleTime(Device): <value> | <ok nok> |

1367

1368

1369 6.9.2 MinCycleTime

1370 Table 109 defines the test conditions for this test case.

Table 109 – MinCycleTime

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|----------------------------|--|
| Identification (ID) | SDCI_TC_0090 | | |
| Name | TCD_DLPC_STDP_MINCYCLETIME | | |
| Purpose (short) | Correct setting of MinCycleTime as indicated in IODD | | |
| Equipment under test (EUT) | Device | | |
| Test case version | 1.2 | | |
| Category / type | Device DPP test: test to pass | | |
| Specification (clause) | [7], see B.1.3, Figure B.2, Table B.3 | | |
| Configuration / setup | Device-Tester-Unit | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | Test value of MinCycleTime. The value shall match the Device specific default settings as indicated in IODD and it shall be valid according to specified coding. | | |
| Precondition | DTU: Communication EUT: OPERATE | | |
| Procedure | a) Read DPP1.MinCycleTime ; <i>returns MinCycleTime(Device)</i> | | |
| Test parameter | MinCycleTimeIODD = node PhysicalLayer, attribute minCycleTime in IODD | | |
| Post condition | – | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | 1) After a), compare MinCycleTime(Device) with MinCycleTimeIODD | | |
| Test passed | MinCycleTime(Device) = MinCycleTimeIODD and Time Base < 3 | | |
| Test not passed (examples) | MinCycleTime(Device) ≠ MinCycleTimeIODD or Time Base = 3 | | |
| Report | MinCycleTimeIODD: <value> MinCycleTime(DEVICE): <value> Time Base: <value> | | |
| | <ok nok> | | |

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1375

1376 6.9.3 M-sequenceCapability

1377 Table 110 defines the test conditions for this test case.

1378

Table 110 – M-sequence Capability

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | SDCI_TC_0091 | |
| Name | TCD_DLPC_STDP_FSEQCAPABILITY | |
| Purpose (short) | Correct M-sequence type entries as indicated in IODD | |
| Equipment under test (EUT) | Device | |
| Test case version | 1.2 | |
| Category / type | Device DPP test: test to pass | |
| Specification (clause) | [7], see B.1.4, Figure B.3 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test parameter M-sequenceCapability for a valid value according to specified coding. Values shall match the Device specific settings as specified in IODD. | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | a) Read DPP1.M-sequenceCapability | <i>;returns M-sequenceCapability(Device)</i> |
| Test parameter | M-sequenceCapabilityIODD = node PhysicalLayer, attribute mSequenceCapability | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) After a), check value of M-sequenceCapability | |
| Test passed | M-sequenceCapability(Device) = M-sequenceCapabilityIODD and bit 6,7 = "0" | |
| Test not passed (examples) | M-sequenceCapability(Device) ≠ M-sequenceCapabilityIODD or bit 6,7 ≠ "0" | |
| Report | M-sequenceCapabilityIODD: <value> M-sequenceCapability(Device): <value> | <ok nok> |

1381

1382

1383 **6.9.4 RevisionID**

1384 Table 111 defines the test conditions for this test case.

1385

Table 111 – RevisionID

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0092 |
| Name | TCD_DLPC_STDP_REVISIONID |
| Purpose (short) | Correct default protocol revision as indicated in IODD |
| Equipment under test (EUT) | Device |
| Test case version | 1.1 |
| Category / type | Device DPP test: test to pass |
| Specification (clause) | [7], see B.1.5, Figure B.4 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Test value of the protocol revision of Device. Value shall match the revision defined in IODD. |
| Precondition | DTU: Communication EUT: OPERATE |
| Procedure | a) Read DPP1.RevisionID <i>;returns RevisionID(Device)</i> |
| Test parameter | ProtocolRevisionIODD = node CommNetworkProfile, attribute iolinkRevision |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) After a), check RevisionID(Device) |
| Test passed | RevisionID(Device) = ProtocolRevisionIODD |
| Test not passed (examples) | RevisionID(Device) does not match |
| Report | ProtocolRevisionIODDD: <value> RevisionID(Device): <value> <i><ok nok></i> |

1388

1389

6.9.5 ProcessDataIn

1391 Table 112 defines the test conditions for this test case.

Table 112 – ProcessDataIn

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|---|---------------------------------------|
| Identification (ID) | SDCI_TC_0093 | |
| Name | TCD_DLPC_STDP_PDIN | |
| Purpose (short) | Correct default ProcessDataInput value as indicated in IODD | |
| Equipment under test (EUT) | Device | |
| Test case version | 1.1 | |
| Category / type | Device DPP test: test to pass | |
| Specification (clause) | [7], see B.1.6, Figure B.5, Table B.5, Table B.6 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test the values of ProcessDataInput. The value shall match the value as specified in the IODD. | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | a) Read DPP1.ProcessDataIn | <i>;returns ProcessDataIn(Device)</i> |
| Test parameter | ProcessDataInIODD = node ProcessData.ProcessDataIn, attribute bitlength SIOsupportIODD = node PhysicalLayer, attribute sioSupported | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) After a), check ProcessDataIn(Device) | |
| Test passed | Process Data length and SIO bit match specified values, and Process Data length unit is a valid value, and Bit 5 is "0", and ProcessDataIn(Device) = ProcessDataInIODD | |
| Test not passed (examples) | Any of the evaluations failed | |
| Report | ProcessDataInIODD: <value> SIOsupportIODD: <value> ProcessDataIn(Device): <value> | <ok nok> |

1397 **6.9.6 ProcessDataOut**

1398 Table 113 defines the test conditions for this test case.

1399

Table 113 – ProcessDataOut

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | SDCI_TC_0094 | |
| Name | TCD_DLPC_STDP_PDOUT | |
| Purpose (short) | Correct default ProcessDataOutput value as indicated in IODD | |
| Equipment under test (EUT) | Device | |
| Test case version | 1.1 | |
| Category / type | Device DPP test: test to pass | |
| Specification (clause) | [7], see B.1.7, Figure B.5, Table B.6 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test the values of Process Data Output. The value shall match the value as specified in the IODD. | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | a) Read DPP1.ProcessDataOut | <i>;returns ProcessDataOut(Device)</i> |
| Test parameter | ProcessDataOutIODD = node ProcessData.ProcessDataOut, attribute bitLength | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) After a), check ProcessDataOut(Device) | |
| Test passed | Process Data length match specified values, and Process Data length unit is a valid value, and Bit 5 and 6 are "0", and ProcessDataOut(Device) = ProcessDataOutIODD | |
| Test not passed (examples) | Any of the evaluations failed | |
| Report | ProcessDataOutIODD: <value> ProcessDataOut(Device): <value> | |
| | <ok nok> | |

1402

1403

6.9.7 VendorID

1405 Table 114 defines the test conditions for this test case.

Table 114 – VendorID

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|---|----------------------------|
| Identification (ID) | SDCI_TC_0095 | |
| Name | TCD_DLPC_STDP_VENDORID | |
| Purpose (short) | Correct VendorID as indicated in IODD | |
| Equipment under test (EUT) | Device | |
| Test case version | 1.1 | |
| Category / type | Device DPP test: test to pass | |
| Specification (clause) | [7], see B.1.8 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test the value of the VendorID. The value shall match the unique ID assigned to the vendor and the value specified in the IODD. | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | a) Read DPP1.VendorID1 ; <i>returns VendorID1</i> b) Read DPP1.VendorID2 ; <i>returns VendorID2</i> c) Combine VendorID1 and VendorID2 to VendorID(Device) | |
| Test parameter | VendorIDIODD = node DeviceIdentity, attribute vendorid VendorIDAssigned = VendorID @ (https://iolinek.com/share/Downloads/Vendor_ID_Table.xml) | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) After c), check VendorID(Device) | |
| Test passed | VendorID(Device) = VendorIDIODD, and VendorID(Device) = VendorIDAssigned | |
| Test not passed (examples) | Any of the evaluations failed | |
| Report | VendorIDIODD: <value> VendorIDAssigned: <value> VendorID(Device): <value> | |
| | <ok nok> | |

1411 6.9.8 DeviceID

1412 Table 115 defines the test conditions for this test case.

Table 115 – DeviceID

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|---|----------------------------|
| Identification (ID) | SDCI_TC_0096 | |
| Name | TCD_DLPC_STDP_DEVICEID | |
| Purpose (short) | Correct default DeviceID as indicated in IODD | |
| Equipment under test (EUT) | Device | |
| Test case version | 1.1 | |
| Category / type | Device DPP test: test to pass | |
| Specification (clause) | [7], see B.1.9 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test the value of the DeviceID. The value shall match the ID assigned by the vendor and the value specified in the IODD. | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | a) Read DPP1.DeviceID1 ;returns DeviceID1 b) Read DPP1.DeviceID2 ;returns DeviceID2 c) Read DPP1.DeviceID3 ;returns DeviceID3 d) Combine DeviceID1, and DeviceID2, and DeviceID3 to DeviceID(Device) | |
| Test parameter | DeviceIDIODD = node DeviceIdentity, attribute deviceid | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) After d), check DeviceID(Device) | |
| Test passed | DeviceID(Device) = DeviceIDIODD, and DeviceID(Device) > 0 | |
| Test not passed (examples) | Any of the evaluations failed | |
| Report | DeviceIDIODD: <value> DeviceID(Device): <value> | |
| | <ok nok> | |

1418 **6.9.9 FunctionID**

1419 Table 116 defines the test conditions for this test case.

1420

Table 116 – FunctionID

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0097 |
| Name | TCD_DLPC_STDP_FUNCTIONID |
| Purpose (short) | Correct FunctionID (reserved) |
| Equipment under test (EUT) | Device |
| Test case version | 1.1 |
| Category / type | Device DPP test: test to pass |
| Specification (clause) | [7], see B.1.10 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Test the value of the FunctionID. The FunctionID is not used and shall contain the default value. |
| Precondition | DTU: Communication EUT: OPERATE |
| Procedure | a) Read DPP1.FunctionID1 ;returns FunctionID1 b) Read DPP1.FunctionID2 ;returns FunctionID2 c) Combine FunctionID1 and FunctionID2 to FunctionID(Device) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) After c), check FunctionID(Device) |
| Test passed | FunctionID(Device) = "0" |
| Test not passed (examples) | FunctionID(Device) ≠ "0" |
| Report | FunctionID(Device): <value> <ok nok> |

1423

1424

1425 **6.9.10 Reserved parameter – Read/Write**

1426 Table 117 defines the test conditions for this test case.

1427

Table 117 – Reserved parameter – Read/Write

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0101 |
| Name | | TCD_DLPC_STDP_WRITERESPAR |
| Purpose (short) | | Test reserved Direct Parameter write behavior |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.0 |
| Category / type | | Device DPP test: test to pass |
| Specification (clause) | | [7], see B.1.1 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test the Device behavior and read result after write access to a reserved Direct Parameter |
| Precondition | | Device is in SDI communication mode |
| Procedure | | Write values 0x00 to 0xFF via the Device-Tester to reserved parameters on Direct Parameter page 1 (Address 0x0E) |
| Input parameter | | - |
| Post condition | | - |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | Check validity of a Write access to reserved Direct Parameter. |
| Test passed | | If no communication errors occurred |
| Test failed (examples) | | If communication errors or Events occurred |
| Report | | Communication errors: <no/yes> <passed/failed> |

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1431 **6.9.11 Validity of MinCycleTime**

1432 -CR094-

1433 Table 322 defines the test conditions for this test case.

1434 **Table 322 – Validity of MinCycleTime**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0375 |
| Name | | TCD_DLPC_STDP_MINCYCLETIME_VALID |
| Purpose (short) | | Check validity of MinCycleTime against best case timing and allowed ranges |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.0 |
| Category / type | | Device DPP test, test to pass |
| Specification (clause) | | B.1.3 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test value of MinCycleTime against best case timing, means the provided time shall not be lower than the shortest possible timing calculated according clauses A.3.4 to A.3.6 with t_1 , t_2 , t_{idle} equal zero T_{BIT} and t_A equal one T_{BIT} . Further the ranges of Table B.3 are checked for violations. |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | <ul style="list-style-type: none"> a) Read DPP1.MinCycleTime b) Read DPP1.M-sequenceCapability c) Read DPP1.ProcessDataIn d) Read DPP1.ProcessDataOut |
| Input parameter | | - |
| Post condition | | - |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | <ul style="list-style-type: none"> 2) After reading the communication parameters, calculate best timing with t_1, t_2, t_{idle} equal zero and t_A equal one based on the proposed M-sequence type and process data width. 3) Check MinCycleTime against allowed ranges defined in Table B.3 |
| Test passed | | MinCycleTime equal or greater than best timing from 1) MinCycleTime does not violate allowed ranges according 2) |
| Test failed (examples) | | Min CycleTime lower than best timing or violating ranges according 2) |
| Report | | MinCycleTime in range <ok nok> |

1437

1438 **6.10 Predefined Device parameters**

1439 **6.10.1 General rules**

1440 Predefined parameters shall be tested in any case. The following rules apply:

1441 They shall be tested as specified within the test cases if they are defined within the IODD.

1442 They shall *not* be tested as specified within the test cases if they are *not* defined within the
1443 IODD.

1444 All optional test cases for Predefined Parameters shall be handled according to rule b)

1445

1446

1447 **6.10.2 System command – reserved commands**

1448 Table 118 defines the test conditions for this test case.

1449 **Table 118 – System command – reserved commands**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0104 |
| Name | | TCD_DLIC_DEF_P_SYSCMDRES |
| Purpose (short) | | SystemCommand behavior upon reserved commands (via ISDU) |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.1 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see B.2.2, and Annex C.2.1, Table C.1 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | The test verifies the correct response values upon usage of reserved and unused SystemCommands. |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Write subsequently the following values to parameter SystemCommand: - 0x00 - 0x01 to 0x04, if Block Parameter transfer is not supported - 0x05, if neither Data Storage nor Block Parameter transfer is supported - 0x06, if Block Parameter transfer is not supported - 0x07 to 0x3F - 0x40 to 0x7F, if no Profile is supported - 0x80 to 0x83, if not referenced in IODD - 0x84 to 0x9F - 0xA0 to 0xFF, if not referenced in IODD |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check each Write response in a) |
| Test passed | | All Write error responses = FUNC_NOTAVAIL (0x8035) If Write error response ≠ FUNC_NOTAVAIL (0x8035), indicate value and warning |
| Test not passed (examples) | | Positive or no Write response |
| Report | | Write response (reserved SystemCommand): <value> <ok nok> |

1452

1453 **6.10.3 Data Storage Index – entire parameter structure**

1454 Table 119 defines the test conditions for this test case.

1455 **Table 119 – Data Storage Index – entire parameter structure**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0107 |
| Name | | TCD_DLIC_DEF_P_DSINDEX |
| Purpose (short) | | Behavior of parameter DataStorageIndex |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.1 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.3, Table B.9; see B.2.3 (records without gaps) |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | The test verifies correct implementation of parameter DataStorageIndex. Devices without Data Storage support shall support the entire parameter structure. |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read parameter DataStorageIndex (Index 0x03) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response of Read access 2) Check parameter length 3) Calculate <index entries> = (parameter length – 12)/3 |
| Test passed | | No negative response, and <index entries> has a positive integer value in the range ≥ 0 and ≤ 70 |
| Test not passed (examples) | | Negative response, or <index entries> outside the permitted range |
| Report | | Data Storage Index, length: <index entries> <ok nok> |

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1459

6.10.4 Data Storage Index – record items

1461 Table 120 defines the test conditions for this test case.

1462

Table 120 – DataStorageIndex – record items

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|--|
| Identification (ID) | SDCI_TC_0108 | | |
| Name | TCD_DLIC_DEFP_DSRECORD | | |
| Purpose (short) | Behavior of parameter DataStorageIndex record items | | |
| Equipment under test (EUT) | Device | | |
| Test case version | 1.0 | | |
| Category / type | Device application test: test to pass | | |
| Specification (clause) | [7], see Annex B.2.3, Table B.9 | | |
| Configuration / setup | Device-Tester-Unit | | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | The test verifies the correct structure of parameter and record items of the DataStorageIndex. | | |
| Precondition | DTU: Communication EUT: OPERATE | | |
| Procedure | a) Read subsequently Subindex 1 to 5 of DataStorageIndex (Index 0x03) | | |
| Test parameter | – | | |
| Post condition | – | | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | 1) Check response of Read access 2) Check record item length 3) Check value of record item | | |
| Test passed | No negative response on record item Read access, and Subindex 1 has a length of 1 octet and value is within range ≥ 0 to ≤ 5 Subindex 2 has a length of 1 octet and value of bit 0 and bit 3 - 6 is "0" Subindex 3 has a length of 4 octets and value is within range 0 to 2048 Subindex 4 has a length of 4 octets Subindex 5 has a length of ≥ 2 octets in increments of 3 (2,5,8,11,14, until 212) | | |
| Test not passed (examples) | Record items are deviating in length or value range | | |
| Report | DataStorageIndex, Subindex 1: <length, value> | <ok nok> | |
| | DataStorageIndex, Subindex 2: <length, value> | <ok nok> | |
| | DataStorageIndex, Subindex 3: <length, value> | <ok nok> | |
| | DataStorageIndex, Subindex 4: <length> | <ok nok> | |
| | DataStorageIndex, Subindex 5: <length> | <ok nok> | |

1465

1466 6.10.5 Data Storage Index – termination marker

1467 Table 120 defines the test conditions for this test case.

1468 **Table 121 – DataStorageIndex – termination marker**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|----------------------------|--|
| Identification (ID) | SDCI_TC_0323 | | |
| Name | TCD_DLIC_DEFP_DSRECORDMARKER | | |
| Purpose (short) | Behavior of parameter DataStorageIndex record items – Termination marker | | |
| Equipment under test (EUT) | Device without DS support | | |
| Test case version | 1.0 | | |
| Category / type | Device application test: test to pass | | |
| Specification (clause) | [7], see Annex B.2.3, Table B.9, and 10.4.5 | | |
| Configuration / setup | Device-Tester-Unit | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | The test verifies the correct entries in items Data_Storage_Size and DS Index_List of the parameter DataStorageIndex. Both items shall be "0". | | |
| Precondition | DTU: Communication EUT: OPERATE | | |
| Procedure | a) Read subsequently Subindex 1 to 5 of DataStorageIndex (Index 0x03) | | |
| Test parameter | – | | |
| Post condition | – | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | 1) Check response of Read access 2) Check record item length 3) Check value of record item | | |
| Test passed | No negative response on record item Read access, and Subindex 1 has a length of 1 octet and value is within range ≥ 0 to ≤ 5 Subindex 2 has a length of 1 octet and value of bit 0 and bit 3 - 6 is "0" Subindex 3 has a length of 4 octets and value = "0" Subindex 4 has a length of 4 octets Subindex 5 has a length of 2 octets and value = "0" | | |
| Test not passed (examples) | Record items are deviating in length or value range | | |
| Report | DataStorageIndex, Subindex 1: <length, value> | <ok nok> | |
| | DataStorageIndex, Subindex 2: <length, value> | <ok nok> | |
| | DataStorageIndex, Subindex 3: <length, value> | <ok nok> | |
| | DataStorageIndex, Subindex 4: <length, value> | <ok nok> | |
| | DataStorageIndex, Subindex 5: <length, value > | <ok nok> | |

1471

1472

1473 **6.10.6 Device Access Locks – valid**

1474 Table 122 defines the test conditions for this test case.

1475 **Table 122 – Device Access Locks – valid**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|--|--|---|
| Identification (ID) | | SDCI_TC_0109 |
| Name | | TCD_DLIC_DEF_P_ACCESSLOCKSVAL |
| Purpose (short) | | Behavior of DeviceAccessLocks with valid values |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.1 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], 10.6.5, 10.6.6, Annex B.2.4, Table B.12 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | The test verifies that all implemented values for DeviceAccessLocks are stored and responded correctly. |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Write value to DeviceAccessLocks with "1" at every bit position marked as implemented and "0" at the remaining bits. b) Read value DeviceAccessLocks c) Write value 0x0000 to DeviceAccessLocks d) Read value DeviceAccessLocks |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check for response on Read and Write access 2) Set warning flag, if a positive response is received for a write access with "1" at bit positions "0" or "1" 3) Compare response value from step b) with written value from step a) 4) Compare response value from step d) with written value from step c) |
| Test passed | | No negative response on Read or Write access, and Evaluations 3) and 4) show matching values |
| Test not passed (examples) | | No matching values |
| Report | | DeviceAccessLocks implemented: <written/read values> <ok nok> DeviceAccessLocks 0x0000: <written/read values> <ok nok> Warning "Locking implemented" (see NOTE): <exception> |
| NOTE If warning flag is set, text shall be displayed: "It is highly recommended not to implement the features "parameter access locking" or "Data Storage locking" since they will be removed in future releases of the specification. Vendor to inform user". | | |

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1479

1480 **6.10.7 Device Access Locks – invalid**

1481 Table 123 defines the test conditions for this test case.

1482 **Table 123 – Device Access Locks – invalid**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0110 |
| Name | | TCD_DLIC_DEF_P_ACCESSLOCKSINVAL |
| Purpose (short) | | Behavior of DeviceAccessLocks with invalid values |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.0 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.4, Table B.11 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | The test verifies that all reserved or unused values for DeviceAccessLocks are responded correctly. |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Write to DeviceAccessLocks subsequently the value "1" at a single bit position, which is marked as reserved and a value "0" at the remaining bit positions b) Read value DeviceAccessLocks c) Repeat from a) with next bit position |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check responses in step a) 2) Check response values in step b) |
| Test passed | | Each response in 1) = PAR_VALOUTOFRNG (0x8030), and Each value = 0x0000 |
| Test not passed (examples) | | No negative response Any value ≠ 0x0000 |
| Report | | Device Access Locks reserved: <written/read values> Device Access Locks 0x0000: <written/read values> |
| | | <ok nok> <ok nok> |

1485

1486

1487 **6.10.8 Profile Characteristic**

1488 Table 124 defines the test conditions for this test case.

1489

Table 124 – Profile Characteristic

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--------------------------|
| Identification (ID) | SDCI_TC_0111 | |
| Name | TCD_DLIC_DEF_PPROFILCHARAC | |
| Purpose (short) | Behavior of parameter ProfileCharacteristic | |
| Equipment under test (EUT) | Device without supported profiles | |
| Test case version | 1.2 | |
| Category / type | Device application test: test to pass | |
| Specification (clause) | [7], see Annex B.2.5; [3] | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test for implementation of parameter ProfileCharacteristic | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | a) Read parameter ProfileCharacteristic (Index 0x000D) | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check response | |
| Test passed | Negative response with ErrorType = 0x8011 – <i>Index not available</i> | |
| Test not passed (examples) | Different ErrorType or positive response | |
| Report | Response: <negative/positive> ErrorType: <value> | <ok nok> <ok nok> |

1492

1493

1494 **6.10.9 PD Input Descriptor**

1495 Table 125 defines the test conditions for this test case.

1496

Table 125 – PD Input Descriptor

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--------------------------|
| Identification (ID) | SDCI_TC_0112 | |
| Name | TCD_DLIC_DEF_PDIDESC | |
| Purpose (short) | Behavior of parameter PDInputDescriptor | |
| Equipment under test (EUT) | Device without supported profiles | |
| Test case version | 1.3 | |
| Category / type | Device application test: test to pass | |
| Specification (clause) | [7], see Annex B.2.6; [3] | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test for implementation of parameter PDInputDescriptor | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | a) Read parameter PDInputDescriptor (Index 0x000E) | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check response | |
| Test passed | Negative response with ErrorType 0x8011 – <i>Index not available</i> | |
| Test not passed (examples) | Different ErrorType or positive response | |
| Report | Response: <negative/positive> ErrorType: <value> | <ok nok> <ok nok> |

1499

1500

1501 **6.10.10 PD Output Descriptor**

1502 Table 126 defines the test conditions for this test case.

1503

Table 126 – PD Output Descriptor

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0113 |
| Name | | TCD_DLIC_DEF_PDOOUTDESC |
| Purpose (short) | | Behavior of parameter PDOOutputDescriptor |
| Equipment under test (EUT) | | Device without supported profiles |
| Test case version | | 1.2 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.7; [3] |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test for implementation of parameter PDOOutputDescriptor |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read parameter PDOOutputDescriptor (Index 0x000F) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response |
| Test passed | | Negative response with ErrorType 0x8011 – <i>Index not available</i> |
| Test not passed (examples) | | Different ErrorType or positive response |
| Report | | Response: <negative/positive> ErrorType: <value> |
| | | <ok nok> <ok nok> |

1506

1507

1508 **6.10.11 Vendor Name**

1509 Table 127 defines the test conditions for this test case.

1510

Table 127 – Vendor Name

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0114 |
| Name | | TCD_DLIC_DEF_P_VENDORMAM |
| Purpose (short) | | Behavior of parameter VendorName |
| Equipment under test (EUT) | | Device with ISDU support |
| Test case version | | 1.2 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.6 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test the correct contents and coding of parameter VendorName |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read parameter VendorName (Index 0x0010) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response 2) Check coding of parameter 3) Check parameter length 4) Check contents of parameter |
| Test passed | | No negative response, and Parameter coded in UTF8, and Parameter length ≤ 64 octets, and Contents matches registered vendor for VendorID (VID) |
| Test not passed (examples) | | Any of the evaluations fails |
| Report | | VendorName response: <negative/positive> VendorName UTF8 coding: <yes/no> VendorName length: <value> VendorName registration: <yes/no> |
| | | <ok nok> <ok nok> <ok nok> <ok nok> |

1513

1514

1515 **6.10.12 Vendor Text**

1516 Table 128 defines the test conditions for this test case.

1517 **Table 128 – Vendor Text**

1518 -CR117-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0115 |
| Name | | TCD_DLIC_DEF_P_VENDORTEXT |
| Purpose (short) | | Behavior of parameter VendorText |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.1 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.7 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test the correct contents and coding of parameter VendorText |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read parameter VendorText (Index 0x0011) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response on Read access 2) Check coding of parameter 3) Check parameter length 4) Check contents of parameter if default value is present in IODD. |
| Test passed | | No negative response, and Parameter coded in UTF8, and Parameter length ≤ 64 octets, and Contents matches vendor / Device specific information |
| Test not passed (examples) | | Any of the evaluations fails |
| Report | | VendorText response: <negative/positive> VendorText UTF8 coding: <yes/no> VendorText length: <value> VendorText adequate: <yes/no> |
| | | <ok nok> <ok nok> <ok nok> <ok nok> |

1521

1522

1523 **6.10.13 Product Name**

1524 Table 129 defines the test conditions for this test case.

1525 **Table 129 – Product Name**

1526 -CR117-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|---|--|
| Identification (ID) | SDCI_TC_0116 | |
| Name | TCD_DLIC_DEF_P_PRODUCTNAM | |
| Purpose (short) | Behavior of parameter ProductName | |
| Equipment under test (EUT) | Device with ISDU support | |
| Test case version | 1.1 | |
| Category / type | Device application test: test to pass | |
| Specification (clause) | [7], see Annex B.2.8 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test the correct contents and coding of parameter ProductName | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | Read parameter ProductName (Index 0x0012) | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check response 2) Check coding of parameter 3) Check parameter length 4) Check contents of parameter if default value is present in IODD. | |
| Test passed | No negative response, and Parameter coded in UTF8, and Parameter length ≤ 64 octets, and Contents matches vendor / Device specific information | |
| Test not passed (examples) | Any of the evaluations fails | |
| Report | ProductName response: <negative/positive> ProductName UTF8 coding: <yes/no> ProductName length: <value> ProductName adequate: <yes/no> | <ok nok> <ok nok> <ok nok> <ok nok> |

1529

1530

1531 **6.10.14 Product ID**

1532 Table 130 defines the test conditions for this test case.

1533 **Table 130 – Product ID**

1534 -CR117-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0117 |
| Name | | TCD_DLIC_DEFP_PRODUCTID |
| Purpose (short) | | Behavior of parameter ProductID |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.1 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.9 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test the correct contents and coding of parameter ProductID. |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | Read parameter Product ID (Index 0x0013) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response 2) Check coding of parameter 3) Check parameter length 4) Check contents of parameter if default value is present in IODD. |
| Test passed | | No negative response, and Parameter coded in UTF8, and Parameter length ≤ 64 octets, and Contents matches vendor / Device specific information |
| Test not passed (examples) | | Any of the evaluations fails |
| Report | | ProductID response: <negative/positive> ProductID UTF8 coding: <yes/no> ProductID length: <value> ProductID adequate: <yes/no> |
| | | <ok nok> <ok nok> <ok nok> <ok nok> |

1537

1538

1539 **6.10.15 Product Text**

1540 Table 131 defines the test conditions for this test case.

1541 **Table 131 – Product Text**

1542 -CR117-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|---|--|
| Identification (ID) | SDCI_TC_0118 | |
| Name | TCD_DLIC_DEF_P PRODUCTTEXT | |
| Purpose (short) | Behavior of parameter ProductText | |
| Equipment under test (EUT) | Device with adequate reference in IODD | |
| Test case version | 1.1 | |
| Category / type | Device application test: test to pass | |
| Specification (clause) | [7], see Annex B.2.10 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test the correct contents and coding of parameter ProductText | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | Read parameter Product Text (Index 0x0014) | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check response 2) Check coding of parameter 3) Check parameter length 4) Check contents of parameter if default value is present in IODD. | |
| Test passed | No negative response, and Parameter coded in UTF8, and Parameter length ≤ 64 octets, and Contents matches vendor / Device specific information | |
| Test not passed (examples) | Any of the evaluations fails | |
| Report | ProductText response: <negative/positive> ProductText UTF8 coding: <yes/no> ProductText length: <value> ProductText adequate: <yes/no> | <ok nok> <ok nok> <ok nok> <ok nok> |

1545

1546

1547 **6.10.16 Serial Number**

1548 Table 132 defines the test conditions for this test case.

1549 **Table 132 – SerialNumber**

1550 -CR123-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0119 |
| Name | | TCD_DLIC_DEFP_SERNUM |
| Purpose (short) | | Behavior of parameter SerialNumber |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.2 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.11 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test the correct contents and coding of parameter SerialNumber |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read parameter SerialNumber (Index 0x0015) |
| Test parameter | | SerialNumber of the EUT provided by the manufacturer |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response 2) Check coding of parameter 3) Check parameter length 4) Check contents of parameter |
| Test passed | | No negative response, and Parameter coded in UTF8, and Parameter length ≤ 16 octets, and Contents matches vendor / Device specific information |
| Test not passed (examples) | | Any of the evaluation steps fails |
| Report | | SerialNumber response: <negative/positive> SerialNumber UTF8 coding: <yes/no> SerialNumber length: <value> SerialNumber adequate: <yes/no> |
| | | <ok nok> <ok nok> <ok nok> <ok nok> |

1553

1554

1555 **6.10.17 Hardware Revision**

1556 Table 133 defines the test conditions for this test case.

1557 **Table 133 – HardwareRevision**

1558 -CR123-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0120 |
| Name | | TCD_DLIC_DEF_P_HARDREV |
| Purpose (short) | | Test of parameter HardwareRevision |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.2 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.12 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test the correct contents and coding of parameter HardwareRevision |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read parameter HardwareRevision (Index 0x0016) |
| Test parameter | | HardwareRevision of the EUT provided by the manufacturer |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response 2) Check coding of parameter 3) Check parameter length 4) Check contents of parameter |
| Test passed | | No negative response, and Parameter coded in UTF8, and Parameter length ≤ 64 octets, and Contents matches vendor / Device specific information |
| Test not passed (examples) | | Any of the evaluations fails |
| Report | | HardwareRevision response: <negative/positive> HardwareRevision UTF8 coding: <yes/no> HardwareRevision length: <value> HardwareRevision adequate: <yes/no> |
| | | <ok nok> <ok nok> <ok nok> <ok nok> |

1561

1562

1563 **6.10.18 Firmware Revision**

1564 Table 134 defines the test conditions for this test case.

1565 **Table 134 – Firmware Revision**

1566 -CR123-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0121 |
| Name | | TCD_DLIC_DEFP_FIRMREV |
| Purpose (short) | | Behavior of parameter Firmware Revision |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.2 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.13 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test the correct contents and coding of parameter FirmwareRevision |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read parameter FirmwareRevision (Index 0x0017) |
| Test parameter | | FirmwareRevision of the EUT provided by the manufacturer |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response 2) Check coding of parameter 3) Check parameter length 4) Check contents of parameter |
| Test passed | | No negative response, and Parameter coded in UTF8, and Parameter length ≤ 64 octets, and Contents matches vendor / Device specific information |
| Test not passed (examples) | | Any of the evaluations fails |
| Report | | FirmwareRevision response: <negative/positive> FirmwareRevision UTF8 coding: <yes/no> FirmwareRevision length: <value> FirmwareRevision adequate: <yes/no> |
| | | <ok nok> <ok nok> <ok nok> <ok nok> |

1569

1570

1571 **6.10.19 Application Specific Tag – valid**

1572 Table 135 defines the test conditions for this test case.

1573 **Table 135 – Application Specific Tag – valid**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0122 |
| Name | | TCD_DLIC_DEF_P_TAGVALID |
| Purpose (short) | | Behavior of parameter ApplicationSpecificTag – valid strings |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.2 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.16, 10.3.4, and 10.3.5, Table 98, rule 6 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test the correct behavior for write and read access to parameter ApplicationSpecific-Tag |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Write a random text string with length <specified fixed length> to parameter ApplicationSpecificTag (Index 0x0018) b) Read parameter ApplicationSpecificTag (Index 0x0018) c) Power OFF/ON of the Device d) Read parameter ApplicationSpecificTag (Index 0x0018) |
| Test parameter | | Random text string with <specified fixed length> = manufacturer dependent (minimum 16 octets, maximum 32 octets). |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response of Read and Write access 2) Compare contents and length of reading in step b) to written string in step a) 3) Compare contents and length of reading in step b) and step d) |
| Test passed | | No negative responses, and String lengths in 2) = string lengths in 3) Contents in 2) = Contents in 3) |
| Test not passed (examples) | | Negative response or comparison fails |
| Report | | ApplicationSpecificTag string length: <ok nok> ApplicationSpecificTag content: <ok nok> |

1576

1577

1578 **6.10.20 Application Specific Tag – invalid**

1579 Table 136 defines the test conditions for this test case.

1580 **Table 136 – Application Specific Tag – invalid**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0123 |
| Name | | TCD_DLIC_DEF_P_TAGINVALID |
| Purpose (short) | | Behavior of parameter ApplicationSpecificTag – invalid string length |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.2 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.14 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test the correct behavior for Write and Read access with invalid string length to parameter ApplicationSpecificTag. |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read parameter ApplicationSpecificTag (Index 0x0018) b) Write a random string with length <specified fixed length + 1> to parameter Application Specific Tag (Index 0x0018) c) Read parameter ApplicationSpecificTag (Index 0x0018) |
| Test parameter | | Random text string with <specified fixed length> = manufacturer dependent (minimum 16 octets, maximum 32 octets) |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Read responses 2) Check Write response 3) Compare contents and length of reading in step a) and step c) |
| Test passed | | No negative Read responses, and Negative Write response = VAL_LENOVRRUN (0x8033), and Values in 3) are matching |
| Test not passed (examples) | | No response |
| Report | | ApplicationSpecificTag negative Write response: <yes/no> <ok nok> ApplicationSpecificTag contents match: <yes/no> <ok nok> |

1583

1584

1585 **6.10.21 Error Count**

1586 Table 137 defines the test conditions for this test case.

1587 **Table 137 – Error Count**

1588 -CR066-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|---|---|
| Identification (ID) | SDCI_TC_0124 | |
| Name | TCD_DLIC_DEF_P_ERRCOUNT | |
| Purpose (short) | Behavior of parameter ErrorCount | |
| Equipment under test (EUT) | Device with adequate reference in IODD (stimulation of ErrorCount possible) | |
| Test case version | 1.2 3 | |
| Category / type | Device application test: test to pass | |
| Specification (clause) | [7], see Annex B.2.15 B.2.19 | |
| Configuration / setup | Device-Tester-Unit; user interaction for stimulation is required | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test the correct contents and coding of parameter ErrorCount | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | a) Read parameter ErrorCount (Index 0x0020) b) Stimulate error within Device specific technology (registered for ErrorCount) c) Read parameter ErrorCount (Index 0x0020) d) Power OFF/ON of the Device ;reset of ErrorCount e) Read parameter ErrorCount (Index 0x0020) | |
| Test parameter | Manufacturer defined stimulation of an error | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check Read responses 2) Check parameter length 3) Compare values from step a) and step c) if stimulation is possible 4) Check value of step e) | |
| Test passed | No negative Read responses, and Parameter length = 2 octets, and ErrorCount in c) = ErrorCount in a) + 1, and ErrorCount in e) = 0x0000 | |
| Test not passed (examples) | Any of the evaluations fails | |
| Report | ErrorCount: <length> ErrorCount: <increment> ErrorCount: <value> No stimulation possible: | <ok nok> <ok nok> <ok nok> <Exception> |

1591

1592

1593 **6.10.22 Device Status**

1594 Table 138 defines the test conditions for this test case.

1595 **Table 138 – DeviceStatus**

1596 -CR066-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0128 |
| Name | | TCD_DLIC_DEF_P_DEVSTAT |
| Purpose (short) | | Behavior of parameter DeviceStatus |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.4 2 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.16 B.2.20 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test the correct contents and coding of parameter DeviceStatus |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read parameter DeviceStatus (Index 0x0024) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response 2) Check parameter length 3) Check parameter value |
| Test passed | | No negative response, and Parameter length = 1 octet, and "0" ≤ value ≤ 4 |
| Test not passed (examples) | | No response |
| Report | | DeviceStatus response: <positive/negative> DeviceStatus length: <value> DeviceStatus: <value> |
| | | <ok nok> <ok nok> <ok nok> |

1599

1600

1601 **6.10.23 Detailed Device Status – complete object**

1602 Table 139 defines the test conditions for this test case.

1603 **Table 139 – Detailed Device Status – complete object**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0129 |
| Name | | TCD_DLIC_DEF_P_DETAILDEVSTAT |
| Purpose (short) | | Behavior of entire parameter DetailedDeviceStatus |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.2 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.17 and [4] |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test of the correct length of parameter DetailedDeviceStatus |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read parameter DetailedDeviceStatus (Index 0x0025) |
| Test parameter | | <record item count> |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check response 2) Check parameter length 3) Calculate <record item count> = parameter length / 3 |
| Test passed | | No negative response, and Parameter length ≤ 64 x 3 octets, and 1 ≤ record item count is an integer value ≤ 64 |
| Test not passed (examples) | | No response |
| Report | | DetailedDeviceStatus response: <positive/negative> DetailedDeviceStatus length: <value> DetailedDeviceStatus: <value> |
| | | <ok nok> <ok nok> <ok nok> |

1606

1607

1608 **6.10.24 Detailed Device Status – Event inactive**

1609 Table 140 defines the test conditions for this test case.

1610 **Table 140 – Detailed Device Status – Event inactive**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0130 |
| Name | | TCD_DLIC_DEF_P_DETAILDEVSTATINACTIVE |
| Purpose (short) | | Record contents in parameter DetailedDeviceStatus without active Events |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.2 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.17 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test correct contents of the parameter record DetailedDeviceStatus and initialization of the values. |
| Precondition | | DTU: Communication EUT: OPERATE, no active Event |
| Procedure | | a) Read record of parameter DetailedDeviceStatus b) Parse result from beginning to end in steps of 3 octets and store values |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check values at each step b) |
| Test passed | | Value at each step = "0x000000" |
| Test not passed (examples) | | No response or value ≠ "0x000000" |
| Report | | DetailedDeviceStatus Event inactive: <ok nok> |

1613

1614

1615 **6.10.25 Detailed Device Status – Event active**

1616 Table 141 defines the test conditions for this test case.

1617 **Table 141 – Detailed Device Status – Event active**

1618 -CR066-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0131 |
| Name | | TCD_DLIC_DEF_P_DETAILDEVSTATACTIVE |
| Purpose (short) | | Record contents in parameter DetailedDeviceStatus with active Event |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.2 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.17 B.2.21 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test of correct entry of active Events in parameter DetailedDeviceStatus |
| Precondition | | DTU: Communication EUT: OPERATE, no active Event |
| Procedure | | a) Stimulate an incident in Device's specific technology causing an Event , using config7 (error or warning) b) Read record of parameter DetailedDeviceStatus c) Parse result from beginning to end in steps of 3 octets and store value d) Power OFF/ON of the Device e) Read record of parameter DetailedDeviceStatus f) Parse result from beginning to end in steps of 3 octets and store value |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check value at each procedure step c) 2) Check value at each procedure step f) |
| Test passed | | Evaluation 1) provides exactly one value ≠ "0x000000", and This value matches the transferred Event in EventCode/EventQualifier, and Every value in evaluation 2) = "0x000000" Evaluation 1) One of the parsed Events equals the initiated Event of Step a) Evaluation 2) Check parsed values of Detailed Device Status against the active Events |
| Test not passed (examples) | | – Incorrect values or no response – an initiated event does not appear in the Detailed Device Status |
| Report | | DetailedDeviceStatus Event active: <ok nok> |

1621

1622

1623 **6.10.26 Process Data Input**

1624 Table 142 defines the test conditions for this test case.

1625 **Table 142 – Process Data Input**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0132 |
| Name | | TCD_DLIC_DEF_P DIN |
| Purpose (short) | | Behavior of parameter ProcessDataInput |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.1 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.18 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test the correct contents and coding of parameter ProcessDataInput |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read parameter ProcessDataInput (Index 0x0028) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Read response 2) Check parameter length 3) Check parameter contents |
| Test passed | | No negative response, and Parameter length matches parameter ProcessDataIn (DPP1, address 0x05), and Unused bits = "0" |
| Test not passed (examples) | | No response |
| Report | | ProcessDataInput response: <positive/negative> ProcessDataInput length: <value> ProcessDataInput unused bits = "0": <yes/no> |
| | | <ok nok> <ok nok> <ok nok> |

1628

1629

1630 **6.10.27 Process Data Output**

1631 Table 143 defines the test conditions for this test case.

1632 **Table 143 – Process Data Output**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0133 |
| Name | | TCD_DLIC_DEF_PDOOUT |
| Purpose (short) | | Behavior of parameter ProcessDataOutput |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.1 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.19 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test of the correct contents and coding of parameter ProcessDataOutput |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | Read parameter ProcessDataOutput (Index 0x0029) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Read response 2) Check parameter length 3) Check parameter contents |
| Test passed | | No negative response, and Parameter length matches parameter ProcessDataOut (DPP1, address 0x06), and Unused bits = "0" |
| Test not passed (examples) | | No response |
| Report | | ProcessDataOutput response: <positive/negative> ProcessDataOutput length: <value> ProcessDataOutput unused bits = "0": <yes/no> |
| | | <ok nok> <ok nok> <ok nok> |

1635

1636

1637 **6.10.28 Offset Time – valid**

1638 Table 144 defines the test conditions for this test case.

1639

Table 144 – Offset Time – valid

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0134 |
| Name | | TCD_DLIC_DEFP_OFFSETIMEVALID |
| Purpose (short) | | Behavior of OffsetTime with valid values |
| Equipment under test (EUT) | | Device with adequate reference in IODD |
| Test case version | | 1.1 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2.20, Table B.11 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | The test verifies whether the value range for OffsetTime is correct. |
| Precondition | | DTU: Communication EUT: OPERATE at maximum MasterCycleTime |
| Procedure | | a) Write OffsetTime with "0" for time base and for multiplier (Index 0x0030) b) Read OffsetTime c) Repeat step a) and step b) with multiplier = "63" d) Repeat step a) to step c) with time base = "1" and time base = "2" |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Write response in a) and Read response in b) 2) Compare written value in a) with response value in b) |
| Test passed | | No negative responses, and Values in 2) are matching |
| Test not passed (examples) | | No response |
| Report | | For all three settings: OffsetTime valid response: <positive/negative> OffsetTime valid matching values: <yes/no> |
| | | <ok nok> <ok nok> |

1642

1643 **6.10.29 Profile Parameter – Read access**

1644 Table 145 defines the test conditions for this test case.

1645 **Table 145 – Profile Parameter – Read access**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0136 |
| Name | | TCD_DLIC_DEF_P_PROFILEPARREAD |
| Purpose (short) | | Behavior of unexpected profile parameter Read access |
| Equipment under test (EUT) | | Device supporting no profile: IODD attribute "features/ProfileCharacteristic" is not implemented within the IODD or contains no entries |
| Test case version | | 1.2 |
| Category / type | | Device application test: test to fail |
| Specification (clause) | | [7], see Annex B.2.21 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test of Read access to Profile specific parameters |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) Read Profile parameters from Index 0x0031 to 0x003F |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check each Read response |
| Test passed | | Negative response = IDX_NOTAVAIL (0x8011) upon each profile parameter |
| Test not passed (examples) | | No negative response on profile parameters, or Negative response ≠ IDX_NOTAVAIL (0x8011) |
| Report | | For all Read responses: Profile parameter response: <negative/positive> |
| | | <ok nok> |

1648

1649

6.10.30 Profile Parameter – Write access

1651 Table 146 defines the test conditions for this test case.

Table 146 – Profile Parameter – Write access

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|---|----------------------------|
| Identification (ID) | SDCI_TC_0137 | |
| Name | TCD_DLIC_DEFP_PROFILEPARWRITE | |
| Purpose (short) | Behavior of unexpected profile parameter Write access | |
| Equipment under test (EUT) | Device supporting no profile: IODD attribute "features/ProfileCharacteristic" is not implemented within the IODD or contains no entries | |
| Test case version | 1.2 | |
| Category / type | Device application test: test to fail | |
| Specification (clause) | [7], see Annex B.2.21 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test of Write access to Profile specific parameters | |
| Precondition | DTU: Communication EUT: OPERATE | |
| Procedure | a) Write profile parameters from index 0x0031 to 0x003F with <values> | |
| Test parameter | <values>: 0x0000 | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check each Write response | |
| Test passed | Negative response = IDX_NOTAVAIL (0x8011) upon each profile parameter | |
| Test not passed (examples) | No negative response on profile parameters, or Negative response ≠ IDX_NOTAVAIL (0x8011) | |
| Report | For all Write responses: Profile Parameter used response: <negative/positive> | <ok nok> |

1657 **6.10.31 Write access – Read only parameter**

1658 Table 147 defines the test conditions for this test case.

1659 **Table 147 – Write access – Read only parameter**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0140 |
| Name | | TCD_DLIC_DEF_P_WRITETOREADONLY |
| Purpose (short) | | Write access to Read only standard parameter |
| Equipment under test (EUT) | | Device with ISDU support and with adequate parameter reference in IODD |
| Test case version | | 1.3 |
| Category / type | | Device application test: test to fail |
| Specification (clause) | | [7], see Annex B.2 and Annex C.2.8 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test that Write access to a Read only standard parameter shows the correct response behavior |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) First standard parameter marked "Read Only" b) Read standard parameter <i>:provides parameter length</i> c) Write <value> to standard parameter d) Repeat at b) with next standard parameter marked "Read Only" |
| Test parameter | | <value>: any standard parameter in IODD marked as "Read Only" |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Write responses |
| Test passed | | Negative response = IDX_NOT_ACCESSIBLE (0x8023) |
| Test not passed (examples) | | No response |
| Report | | Upon all Write accesses to Read Only parameters: Parameter Read Only response: <ErrorType> <i><ok nok></i> |

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1663

1664 **6.10.32 Write access – Length too short**

1665 Table 148 defines the test conditions for this test case.

1666 **Table 148 – Write access – Length too short**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0141 |
| Name | | TCD_DLIC_DEF_P_WRITETOOSHORT |
| Purpose (short) | | Write access with invalid length (too short) to writable standard parameter |
| Equipment under test (EUT) | | Device with ISDU support and writeable standard parameters are referenced within the IODD |
| Test case version | | 1.1 |
| Category / type | | Device application test: test to fail |
| Specification (clause) | | [7], see Annex B.2 and Annex C.2.13 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test that Write access to a writable standard parameter with a too short parameter length shows the correct response behavior |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) First standard parameter with no data type StringT and length > 1 octet b) Read standard parameter <i>;provides parameter length</i> c) Write <value> with reduced length to standard parameter d) Repeat at b) with next standard parameter with no StringT and length > 1 octet |
| Test parameter | | <value>: any writable standard parameter in IODD |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Write responses |
| Test passed | | Negative response = VAL_LENUNDRUN (0x8034) |
| Test not passed (examples) | | No response or incorrect ErrorType |
| Report | | Upon all Write accesses with too short length to writable parameters: Parameter Write response: <ErrorType> <i><ok nok></i> |

1669

1670

1671 **6.10.33 Write access – Length too long**

1672 Table 149 defines the test conditions for this test case.

1673 **Table 149 – Write access – Length too long**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0142 |
| Name | | TCD_DLIC_DEF_P_WRITETOOLONG |
| Purpose (short) | | Write access with invalid length (too long) to writable standard parameter |
| Equipment under test (EUT) | | Device with ISDU support and writeable standard parameters are referenced within the IODD |
| Test case version | | 1.1 |
| Category / type | | Device application test: test to pass |
| Specification (clause) | | [7], see Annex B.2, and Annex C.2.8 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Test that Write access to a writable standard parameter with a too long parameter length shows the correct response behavior |
| Precondition | | DTU: Communication EUT: OPERATE |
| Procedure | | a) First standard parameter with no data type StringT and length > 1 octet b) Read standard parameter <i>:provides parameter length</i> c) Write <value> with extended length to standard parameter d) Repeat at b) with next standard parameter with no StringT and length > 1 octet |
| Test parameter | | <value>: any writable standard parameter in IODD |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check Write responses |
| Test passed | | Negative response = VAL_LENOVRRUN (0x8033) |
| Test not passed (examples) | | No response or incorrect ErrorType |
| Report | | Upon all Write accesses with too long length to writeable parameters: Parameter Write response: <ErrorType> <i><ok nok></i> |

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1683 **6.11 Block parameter**1684 **6.11.1 General**1685 The manufacturer/vendor of a Device shall provide information about a possible Block Parameter set enabling the performance of the following tests. This Block Parameter set shall comply
1686 with the requirements of the test cases 6.11.2 through 6.11.7.
1687

1688

1689 **6.11.2 Block parameter – Download**

1690 Table 150 defines the test conditions for this test case.

1691 **Table 150 – Block parameter – Download**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|---|--|
| Identification (ID) | SDCI_TC_0143 | |
| Name | TCD_DSBP_APPL_BPDOWNLOAD | |
| Purpose (short) | Test of Block parameter Download | |
| Equipment under test (EUT) | Device with option "blockParameter" indicated in IODD | |
| Test case version | 1.1 | |
| Category / type | Device Block parameter test: test to pass | |
| Specification (clause) | [7], 10.3.2, 10.3.5, Table 97, Table 98, Table B.9 | |
| Configuration / setup | Device-Tester-Unit | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Test of Block parameter Download | |
| Precondition | DTU: SDCI communication EUT: No Block parameterization is active | |
| Procedure | a) Write SystemCommand "ParamDownloadStart" b) Write Block parameters defined in field Test parameter c) Write SystemCommand "ParamDownloadEnd" | |
| Test parameter | Parameter set defined in 6.7.1.1 | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check after step a) that no ErrorType has been received 2) Check during step b) that no ErrorType has been received 3) Check after step c) that no ErrorType has been received | |
| Test passed | All evaluation steps with positive result | |
| Test not passed (examples) | No response or any evaluation negative | |
| Report | Write "ParamDownloadStart" Write Block parameter Write "ParamDownloadEnd" | <ok nok> <ok nok> <ok nok> |

1694

1695

1696 **6.11.3 Block parameter – Break by command**

1697 Table 151 defines the test conditions for this test case.

1698 **Table 151 – Block parameter – Break by command**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0144 |
| Name | | TCD_DSBP_APPL_BPBREAKCMD |
| Purpose (short) | | Test break of Block parameter transfer per command |
| Equipment under test (EUT) | | Device with option "blockParameter" indicated in IODD |
| Test case version | | 1.1 |
| Category / type | | Device Block parameter test: test to pass |
| Specification (clause) | | [7], 10.3.2, 10.3.5, Table 97, Table 98, Table B.9 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Device shall discard any change of parameters when receiving a SystemCommand "ParamDownloadBreak" |
| Precondition | | DTU: SDCI communication EUT: no Block parameterization is active |
| Procedure | | a) Read one parameter (see field Test parameter) and buffer it as <value1> b) Write SystemCommand "ParamDownloadStart" c) Write parameter from step a) with <value2> ≠ <value1> d) Write SystemCommand "ParamDownloadBreak" e) Read parameter from step a) f) Write SystemCommand "ParamDownloadEnd" g) Read parameter from step a) |
| Test parameter | | Parameter set defined in 6.7.1.1 |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check after step b) that no ErrorType has been received 2) Check after step d) that no ErrorType has been received 3) Check after step e) that received value matches <value1> 4) Check after step f) that ErrorType 0x8036 has been received 5) Check after step g) that received value matches <value1> |
| Test passed | | All evaluation steps with positive result |
| Test not passed (examples) | | No response or any evaluation negative |
| Report | | Write "ParamDownloadBreak" <ok nok> Rollback to previous value after break <ok nok> Write "ParamDownloadEnd" <ok nok> Non-volatile storage after ParamDownloadEnd <ok nok> |

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1703 **6.11.4 Block parameter – Break by reset**

1704 Table 152 defines the test conditions for this test case.

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Table 152 – Block parameter – Break by reset

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0145 |
| Name | TCD_DSBD_APPL_BPBREAKRESET |
| Purpose (short) | Test break of Block parameter transfer per reset |
| Equipment under test (EUT) | Device with option "blockParameter" indicated in IODD |
| Test case version | 1.1 |
| Category / type | Device Block parameter test: test to pass |
| Specification (clause) | [7], 10.3.2, 10.3.5, Table 97, Table 98, Table B.9 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Device shall discard any change of parameters if a reset occurs during parameterization |
| Precondition | DTU: SDCI communication EUT: No Block parametrization is active |
| Procedure | a) Read one Parameter (see field Test parameter) and buffer it as <value1> b) Write SystemCommand "ParamDownloadStart" c) Write parameter from step a) with <value2> ≠ <value1> d) Reset the Device either (descending priority based on availability) - using MasterCommand "Fallback" or - using SystemCommand "DeviceReset" or - using power off/on cycle e) Set Device into SDCI communication f) Read Parameter from step a) g) Write SystemCommand "ParamDownloadEnd" h) Read Parameter from step a) |
| Test parameter | Parameter set defined in 6.7.1.1 |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check after step b) that no ErrorType has been received 2) Check after step e) that Device communication is active 3) Check after step f) that received value matches <value1> 4) Check after step g) that ErrorType 0x8036 has been received 5) Check after step h) that received value matches <value1> |
| Test passed | All evaluation steps with positive result |
| Test not passed (examples) | No response or any evaluation negative |
| Report | Write "ParamDownloadBreak" <ok nok> SDCI restart <ok nok> Rollback to previous value after communication restart <ok nok> Write "ParamDownloadEnd" <ok nok> Non-volatile storage after ParamDownloadEnd <ok nok> |

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1710 **6.11.5 Block parameter – Illegal parameter write**

1711 Table 153 defines the test conditions for this test case.

1712 **Table 153 – Block parameter – Illegal parameter write**

1713 -CR029-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0146 |
| Name | | TCD_DSBP_APPL_BPBREAKILLPARAM |
| Purpose (short) | | Test break of Block parameter transfer by illegal parameter |
| Equipment under test (EUT) | | Device with option "blockParameter" indicated in IODD |
| Test case version | | 1.4 2 |
| Category / type | | Device Block parameter test: test to pass |
| Specification (clause) | | [7], 10.3.2, 10.3.5, Table 97, Table 98, Table B.9 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Device shall discard any change of parameters if an illegal parameter occurs during parameterization |
| Precondition | | DTU: SDCI communication EUT: no Block parametrization is active |
| Procedure | | a) Read one parameter (see Test parameter) and buffer it as <value1> b) Write SystemCommand "ParamDownloadStart" c) Write parameter from step a) with <value2> ≠ <value1> d) Write another parameter using an illegal structure (incorrect data length) e) Write SystemCommand "ParamDownloadEnd" f) Read parameter from step a) |
| Test parameter | | Parameter set defined in 6.7.1.1 |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check after step b) that no ErrorType has been received 2) Check after step e) d) that ErrorType 0x8033 or 0x8034 has been received 3) Check after step d) e) that ErrorType 0x8041 has been received 4) Check after step f) that received parameter matches <value1> |
| Test passed | | All evaluation steps with positive result |
| Test not passed (examples) | | No response or any evaluation negative |
| Report | | Write "ParamDownloadStart" <ok nok> Device behavior upon illegal structure <ok nok> Write "ParamDownloadEnd" <ok nok> Rollback to previous value after inconsistent parameter block <ok nok> |

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1718 **6.11.6 Block parameter – Break by double download**

1719 Table 154 defines the test conditions for this test case.

1720 **Table 154 – Block parameter – Break by double download**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0147 |
| Name | | TCD_DSBP_APPL_BPBREAK2DOWNLOADS |
| Purpose (short) | | Test break of Block Parameter transfer by double SystemCommand "ParamDownloadStart" |
| Equipment under test (EUT) | | Device with option "blockParameter" indicated in IODD |
| Test case version | | 1.1 |
| Category / type | | Device Block parameter test: test to pass |
| Specification (clause) | | [7], 10.3.2, 10.3.5, Table 97, Table 98, Table B.9 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Device shall discard any change of parameters if Block parameterization is restarted via a new "ParamDownloadStart" during a running Block parameter transfer |
| Precondition | | DTU: SDCI communication EUT: no block parametrization is active |
| Procedure | | a) Read one parameter (see field Test parameter) and buffer it as <value1> b) Write SystemCommand "ParamDownloadStart" c) Write parameter from step a) with <value2> ≠ <value1> d) Write SystemCommand "ParamDownloadStart" e) Write all parameters in field Test parameter, except those used in step a) f) Write SystemCommand "ParamDownloadEnd" g) Read parameter from step a) |
| Test parameter | | Parameter set defined in 6.7.1.1 |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check after step b) that no ErrorType has been received 2) Check after step d) that no ErrorType has been received 3) Check during step e) that no ErrorType has been received 4) Check after step f) that no ErrorType has been received 5) Check after step g) that received value does not match <value1> |
| Test passed | | All evaluation steps with positive result |
| Test not passed (examples) | | No response or any evaluation negative |
| Report | | Write "ParamDownloadStart" <ok nok> Write second "ParamDownloadStart" while block is unfinished <ok nok> Write Block parameter <ok nok> Write "ParamDownloadEnd" <ok nok> Rollback to previous values via second "ParamDownloadStart" <ok nok> |

1723

1724

1725 **6.11.7 Block parameter – local locking**

1726 Table 155 defines the test conditions for this test case.

1727 **Table 155 – Block parameter – local locking**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0148 |
| Name | | TCD_DSBD_APPL_BPBREAKLOCALLOCK |
| Purpose (short) | | Test locking of local parametrization during Block parameter transfer |
| Equipment under test (EUT) | | Device with option "blockParameter" indicated in IODD, and local parameterization capability (on-board) |
| Test case version | | 1.1 |
| Category / type | | Device Block parameter test: test to pass |
| Specification (clause) | | [7], 10.3.2, 10.3.5, Table 97, Table 98, Table B.9 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Local access and change of parameterization shall be locked during Block parameterization |
| Precondition | | DTU: SDCI communication EUT: no block parametrization is active |
| Procedure | | a) Read one parameter from A) and buffer it as <value1> b) Read parameter B) and buffer it as <value2> c) Write SystemCommand "ParamDownloadStart" d) Write parameter from step a) with <value2> ≠ <value1> e) Try to change parameter B) via local parameterization f) Write SystemCommand "ParamDownloadEnd" g) Read parameter from step a) h) Read parameter B) |
| Test parameter | | A) Parameter set defined in 6.7.1.1 B) Parameter in A) that can be changed by local parametrization (on-board) and via SDCI communication |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check after step c) that no ErrorType has been received 2) Check during step e) that the Device denies the trial of local parameterization 3) Check after step f) that no ErrorType has been received 4) Check after step g) that received value does not match <value1> 5) Check after step h) that received value matches <value2> |
| Test passed | | All evaluation steps with positive result |
| Test not passed (examples) | | No response or any evaluation negative |
| Report | | Write "ParamDownloadStart" <ok nok> Inhibited local parametrization <ok nok> Write "ParamDownloadEnd" <ok nok> Non-volatile storage after "ParamDownloadEnd" <ok nok> Rejection of local changes <ok nok> |

1730

1731 **6.11.8 ParameterManager – Unexpected commands in Idle**

1732 Table 156 defines the test conditions for this test case.

1733 **Table 156 – ParameterManager – Unexpected commands in Idle**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0324 |
| Name | | TCD_DSBP_APPL_UNEXPECTEDINIDLE |
| Purpose (short) | | Test of unexpected commands in state Idle of ParameterManager |
| Equipment under test (EUT) | | Device |
| Test case version | | 1.0 |
| Category / type | | Device Block parameter test: test to pass |
| Specification (clause) | | [7], 10.3.2, 10.3.5, 10.6.11, Table 97, Table 98, Table B.9 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Device shall issue the correct ErrorType after receiving an unexpected block ending command while ParameterManager is in state Idle. |
| Precondition | | DTU: SDCI communication EUT: No block parametrization is active |
| Procedure | | Write SystemCommand "ParamUploadEnd" Write SystemCommand "ParamBreak" Write SystemCommand "ParamDownloadEnd" |
| Test parameter | | "blockParameter" <true / false> indicated in IODD |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | After steps a) to c), check received ErrorType |
| Test passed | | ErrorType = 0x8036 if blockParameter <true>, OR ErrorType = 0x8035 if blockParameter <false> |
| Test not passed (examples) | | No response or incorrect ErrorTypes |
| Report | | Unexpected actions in ParameterManager state Idle <ok nok> |

1736

1737 **6.11.9 ParameterManager – Write request during Upload**

1738 Table 157 defines the test conditions for this test case.

1739 **Table 157 – ParameterManager – Write request during Upload**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0325 |
| Name | | TCD_DSBP_APPL_WRITEINUPLOAD |
| Purpose (short) | | Test of reaction on write accesses during an active Block Upload |
| Equipment under test (EUT) | | Device with option "blockParameter" indicated in IODD |
| Test case version | | 1.0 |
| Category / type | | Device Block parameter test: test to pass |
| Specification (clause) | | [7], 10.3.2, 10.3.5, 10.6.11, Table 97, Table 98, Table B.9 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Device shall not accept any write accesses to parameters except via SystemCommands during an active Block Upload. The SystemCommand is already tested in other test cases. |
| Precondition | | DTU: SDCL communication EUT: No block parametrization is active |
| Procedure | | a) Write SystemCommand "ParamUploadStart" b) Write any parameter which is not excluded from DataStorage c) Write SystemCommand "ParamUploadEnd" d) Write any parameter which is not excluded from DataStorage |
| Test parameter | | One parameter of the parameter sets defined in 6.7.1.1 |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check after step b) that ErrorType 0x8022 has been received 2) Check after step d) that no ErrorType has been received |
| Test passed | | All evaluation steps with positive result |
| Test not passed (examples) | | No response or any evaluation negative |
| Report | | Write restriction during Block parameter Upload <ok nok> |

1742

1743 **6.11.10 ParameterManager – Read requests during Download**

1744 Table 158 defines the test conditions for this test case.

1745 **Table 158 – ParameterManager – Read requests during Download**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0326 |
| Name | | TCD_DSBP_APPL_READINDOWNLOAD |
| Purpose (short) | | Test of reaction on read accesses during active Download |
| Equipment under test (EUT) | | Device with option "blockParameter" indicated in IODD |
| Test case version | | 1.0 |
| Category / type | | Device Block parameter test: test to pass |
| Specification (clause) | | [7], 10.3.2, 10.3.5, 10.6.11, Table 97, Table 98, Table B.9 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Device shall not accept any Read accesses to parameters during an active Block Download. |
| Precondition | | DTU: SDCI communication EUT: No Block parametrization is active |
| Procedure | | a) Write SystemCommand "ParamDownloadStart" b) Read Test parameter c) Read DataStorageIndex, Index 3, SubIndex 0 d) Write SystemCommand "ParamDownloadEnd" e) Read Test parameter |
| Test parameter | | One parameter of the parameter sets defined in 6.7.1.1 |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check after step b) that ErrorType 0x8022 has been received 2) Check after step c) that no ErrorType has been received 3) Check after step e) that no ErrorType has been received |
| Test passed | | All evaluation steps with positive result |
| Test not passed (examples) | | No response or any evaluation negative |
| Report | | Read restriction during Block parameter Download <ok nok> |

1748

1749 **6.11.11 ParameterManager – Unexpected commands during Upload**

1750 Table 159 defines the test conditions for this test case.

1751 **Table 159 – ParameterManager – Unexpected commands during Upload**

| Identification (ID) | SDCI_TC_0327 |
|----------------------------|---|
| Name | TCD_DSBP_APPL_UNEXPINUPLOAD |
| Purpose (short) | Test of reaction on unexpected SystemCommands during active Upload |
| Equipment under test (EUT) | Device with option "blockParameter" indicated in IODD |
| Test case version | 1.0 |
| Category / type | Device Block parameter test: test to pass |
| Specification (clause) | [7], 10.3.2, 10.3.5, 10.6.11, Table 97, Table B.9 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | During an active Block Upload, a Device shall react on unexpected SystemCommands, abort the ongoing process and switch to the requested state. |
| Precondition | DTU: SDCI communication EUT: - No Event pending or active - DataStorage of the Device is inactive and DS_UPLOAD_FLAG is "0" - No Block parametrization is active |
| Procedure | a) Write SystemCommand "ParamUploadStart" b) Write Test parameter A) c) Write SystemCommand "ParamUploadStart" d) Write Test parameter A) e) Write SystemCommand "ParamDownloadEnd" f) Write Test parameter A) If "dataStorage" = <true> g) Write SystemCommand "ParamUploadStart" h) Write SystemCommand "ParamDownloadStore" i) Wait for Event (max 1s) and read DataStorage Index j) Write DS_Command "DS_UploadEnd" |
| Test parameter | A) One parameter of the parameter sets defined in 6.7.1.1 B) dataStorage <true / false> indicated in IODD |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check after step b) that ErrorType 0x8022 has been received 2) Check after step d) that ErrorType 0x8022 has been received 3) Check after step f) that no ErrorType has been received If "dataStorage" = <true> 4) Check after step i) that Event with code DS_UPLOAD_REQ has been received and DS_UPLOADREQ = "1" |
| Test passed | All evaluation steps with positive result |
| Test not passed (examples) | No response or any evaluation negative |
| Report | Reaction on unexpected commands in Upload <ok nok> |

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1755 **6.11.12 ParameterManager – Unexpected switches Upload/Download**

1756 Table 160 defines the test conditions for this test case.

1757 **Table 160 – ParameterManager – Unexpected switches Upload/Download**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0328 |
| Name | | TCD_DSBP_APPL_SWITCHSTATES |
| Purpose (short) | | Test of reaction on unexpected switches between Upload and Download |
| Equipment under test (EUT) | | Device with option "blockParameter" indicated in IODD |
| Test case version | | 1.0 |
| Category / type | | Device Block parameter test: test to pass |
| Specification (clause) | | [7], 10.3.2, 10.3.5, 10.6.11, Table 97, Table 98, Table B.9 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Any Upload or Download shall be interrupted by the start of the opposite action. |
| Precondition | | DTU: SDCI communication EUT: No Block parameterization is active |
| Procedure | | a) Write SystemCommand "ParamUploadStart" b) Write Test parameter c) Write SystemCommand "ParamDownloadStart" d) Read Test parameter e) Write SystemCommand "ParamUploadStart" f) Write Test parameter g) Write SystemCommand "ParamUploadEnd" |
| Test parameter | | One parameter of the parameter sets defined in 6.7.1.1 |
| Post condition | | - |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check after step b) that ErrorType 0x8022 has been received 2) Check after step d) that ErrorType 0x8022 has been received 3) Check after step f) that ErrorType 0x8022 has been received |
| Test passed | | All evaluation steps with positive result |
| Test not passed (examples) | | No response or any evaluation negative |
| Report | | Switching between Upload and Download |
| | | <ok nok> |

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1761 **6.11.13 ParameterManager – Upload interrupted by reset**

1762 Table 161 defines the test conditions for this test case.

1763 **Table 161 – ParameterManager – Upload interrupted by reset**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0329 |
| Name | TCD_DSBP_APPL_UPBREAKRESET |
| Purpose (short) | Test of Block Parameter Upload transfer interrupted per reset |
| Equipment under test (EUT) | Device with option "blockParameter" indicated in IODD |
| Test case version | 1.0 |
| Category / type | Device Block parameter test: test to pass |
| Specification (clause) | [7], 10.3.2, 10.3.5, 10.6.11, Table 97, Table 98, Table B.9 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Any Upload can be interrupted by a communication reset and Block parameterization shall be aborted in this case. |
| Precondition | DTU: SDCI communication EUT: No block parametrization is active |
| Procedure | a) Write SystemCommand "ParamUploadStart" b) Write Test parameter c) Reset the Device either (descending priority based on availability) - using MasterCommand "Fallback" or - using SystemCommand "DeviceReset" or - using power off/on cycle reset d) Set Device to SDCI communication e) Write Test parameter |
| Test parameter | One parameter of the parameter sets defined in 6.7.1.1 |
| Post condition | - |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check after step b) that ErrorType 0x8022 has been received 2) Check after step e) that no ErrorType has been received |
| Test passed | All evaluation steps with positive result |
| Test not passed (examples) | No response or any evaluation negative |
| Report | Communication interruption during Upload <ok nok> |

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1767 **6.11.14 ParameterManager – UploadEnd during Download**

1768 Table 162 defines the test conditions for this test case.

1769 **Table 162 – ParameterManager – UploadEnd during Download**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0330 |
| Name | TCD_DSBP_APPL_DNENDBYUPLOAD |
| Purpose (short) | Reaction on Upload commands while in Download, discarding written parameter |
| Equipment under test (EUT) | Device with option "blockParameter" indicated in IODD |
| Test case version | 1.0 |
| Category / type | Device Block parameter test: test to pass |
| Specification (clause) | [7], 10.3.2, 10.3.5, 10.6.11, Table 97, Table 98, Table B.9 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Parameter values of any Download shall be discarded when receiving an Upload-Start or UploadEnd command. |
| Precondition | DTU: SDCI communication EUT: No Block parameterization is active |
| Procedure | a) Read Test parameter A) b) Write SystemCommand "ParamDownloadStart" c) Write Test parameter value A) or B), whichever is different from step a) d) Write SystemCommand "ParamUploadStart" e) Read parameter from c) f) Write SystemCommand "ParamDownloadStart" g) Write Test parameter value A) or B), whichever is different from step a) h) Write SystemCommand "ParamUploadEnd" i) Read parameter from c) |
| Test parameter | A) One parameter of the parameter sets defined in 6.7.1.1 with value of set 1 B) Same as parameter in A) with value of set 2 |
| Post condition | - |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check after step e) that read value equals original value of step a) 2) Check after step i) that read value equals original value of step a) |
| Test passed | All evaluation steps with positive result |
| Test not passed (examples) | No response or any evaluation negative |
| Report | Download break by any Upload command <ok nok> |

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1779 **6.12 Test report summary of the Device protocol tests**

1780 The template is defined by the Device-Tester. The complete test report shall present at least
1781 the information of the report fields of the test cases for the Device protocol tests.

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1784 **7 IODD-related tests**

1785 **7.1 Overview**

1786 The IODD test focuses on four major issues. The first issue is the test of a Device's IODD file
1787 with the help of a so-called IODD checker tool. IO-Link defines the parsers such an IODD
1788 checker tool shall use for IODD schema consistency checks. It also defines a set of business
1789 rules for the IODD check (see 7.2.1).

1790 The second issue focuses on the IODD interpreter tool. This test shall ensure, that the "Port
1791 and Device Configuration Tool" (PDCT) of the Master is able to provide all the IODD definitions
1792 in the correct manner (see 7.2.2).

1793 The third issue is the test whether the parameters defined in the IODD are accessible within
1794 the Device (parameter verification test). These test cases are specified in 7.3.

1795 The fourth issue is the test of complex system functions such as diverse reset possibilities that
1796 are indicated within the IODD. These test cases are specified in 7.4.

1797 For all these tests, the Master shall be configured with inspection level "type compatible".

1798 **7.2 Schema test via an IODD checker tool and IODD interpreter tests**

1799 **7.2.1 IODD Checker**

1800 The organization referenced in Annex D makes available an IODD checker tool ("Checker") for
1801 free download from its web server. It is mandatory for each and every IODD associated with a
1802 Device to pass the test with this Checker. The Device's manufacturer declaration shall state the
1803 successful result of the test.

1804 The requirements for IODD testing had been specified in previous versions of this document
1805 but was shifted to the IODD specification [3] for practical reasons.

1806 **7.2.2 IODD interpreter tool**

1807 A Master-Tester-System shall provide a so-called fictive IODD with critical constellations of
1808 parameters, which are supported by the Master-Tester-Unit (MTU) playing the role of a Device.
1809 The IODD interpreter tools associated or related to a particular Master can be tested with the
1810 help of this IODD. Clause 4.5 describes how these tests can be performed.

1811

1812 **7.3 Parameter verification test**

1813 **7.3.1 IODD identification**

1814 Table 163 defines the test conditions for this test case.

1815 **Table 163 – IODD identification**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0149 |
| Name | TCD_IODD_PARV_IDENT |
| Purpose (short) | Device matches the associated IODD |
| Equipment under test (EUT) | Device and associated IODD |
| Test case version | 1.0 |
| Category / type | IODD parameter verification test: test to pass |
| Specification (clause) | [3], 7.4 and 7.4.1; [7], B.1.8, B.1.9 and B.2.11 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Verify that Device matches the associated IODD. DTU reads Device parameters VendorID, DeviceID, and ProductID, and compares with IODD node descriptions. For further tests, read of DeviceID and ProductID are sufficient for an IODD association check |
| Precondition | DTU: SDCI communication EUT: Device is communicating, associated IODD available in machine readable form |
| Procedure | a) Read VendorID, DeviceID, ProductID from DPP1 of the Device b) Read corresponding entries from IODD c) Read DeviceVariantCollection from IODD <i>;see Test parameter ;see Test parameter</i> |
| Test parameter | IODD: DeviceIdentity/@vendorId, DeviceIdentity/@deviceId, DeviceVariant/@productId |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check if IDs match the entries in IODD's Device identity after b) 2) Check if ProductID is listed in the DeviceVariantCollection of the IODD after c) |
| Test passed | All IDs from Device found in IODD |
| Test not passed (examples) | Any of the ID from Device not found in IODD (not matching) |
| Report | VendorID: <value> <ok nok> DeviceID: <value> <ok nok> ProductID: <value> <ok nok> ProductID listed in DeviceVariantCollection: <yes/no> <ok nok> |

1820 **7.3.2 IODD communication parameter verification**

1821 Table 164 defines the test conditions for this test case.

1822 **Table 164 – IODD communication parameter verification**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0150 |
| Name | | TCD_IODD_PARV_COMPROFILE |
| Purpose (short) | | Device's communication parameters match corresponding values in IODD |
| Equipment under test (EUT) | | Device and associated IODD |
| Test case version | | 1.0 |
| Category / type | | IODD parameter verification test: test to pass |
| Specification (clause) | | [3], 7.6; [7], B.1.3, B.1.5 and B.1.6 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Verify that Device's communication parameters match values within the associated IODD. DTU reads Device parameters MinCycleTime, RevisionID, and ProcessDataIn and compares with IODD node descriptions. |
| Precondition | | DTU: SDCI communication EUT: Device is communicating; associated IODD available in machine readable form VendorID and ProductID of the Device match values in IODD |
| Procedure | | a) Read MinCycleTime, RevisionID, ProcessDataIn (address 0x05, bit 6 – SIO supported) from DPP1 of the Device b) Read corresponding entries from IODD <i>;see Test parameter</i> |
| Test parameter | | IODD: CommNetworkProfile/@iolinkRevision, TransportLayers/PhysicalLayer/@minCycleTime, PhysicalLayer/@sioSupported |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Compare values in DPP1 with corresponding entries in IODD after b) |
| Test passed | | Values are matching |
| Test not passed (examples) | | Values do not match |
| Report | | MinCycleTime: <value> <ok nok> RevisionID: <value> <ok nok> SIO supported: <yes/no> <ok nok> |

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1827 **7.3.3 IODD parameter read verification**

1828 Table 165 defines the test conditions for this test case.

1829 **Table 165 – IODD parameter read verification**

1830 -CR031- -CR034-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | | | | | | | | |
|--|--|--------------------|------------|------------------------------|------------|----------------------------------|------------|--|--|
| Identification (ID) | SDCI_TC_0151 | | | | | | | | |
| Name | TCD_IODD_PARV_READVERIFY | | | | | | | | |
| Purpose (short) | Verify access rights, structures, and data contents of Read parameters | | | | | | | | |
| Equipment under test (EUT) | Device and associated IODD | | | | | | | | |
| Test case version | 1.0 1 | | | | | | | | |
| Category / type | IODD parameter verification test: test to pass | | | | | | | | |
| Specification (clause) | [3], 7.5.4; [7], Table C.1, C.2.2 to C.2.19, F.2.2 to F.2.9, F.3.2, F.3.3 | | | | | | | | |
| Configuration / setup | Device-Tester-Unit | | | | | | | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | | | | | | | |
| Purpose (detailed) | <p>Verify that all parameters in the IODD with Read access can be read from the Device, have a correct structure and valid data content. The length of an acquired parameter is used as measure for its structure since the lengths of parameters depend on their data. The validity of the data content is only checked for parameters of type StringT.</p> <p>The Tests shall be done by access with sub index == 0, and by subindex >>0 if the type of the variable is Record_T, regardless if subindexAccessSupported is true or false.</p> | | | | | | | | |
| Precondition | <p>DTU: SDCI communication</p> <p>EUT: Device is communicating; associated IODD available in machine readable form; VendorID and ProductID of the Device match values in IODD</p> | | | | | | | | |
| Procedure | <p>a) Get first parameter with Read access from IODD</p> <p>b) Read parameter with Read access according to the IODD</p> <p>c) Repeat from b) with next parameter with Read access from IODD until last one</p> | | | | | | | | |
| Test parameter | – | | | | | | | | |
| Post condition | – | | | | | | | | |
| TEST CASE RESULTS | CHECK / REACTION | | | | | | | | |
| Evaluation | <p>For each acquired parameter:</p> <ol style="list-style-type: none"> 1) Check ErrorType after b) 2) Check length after b) 3) Check data content in case of data type StringT after b) | | | | | | | | |
| Test passed | <p>In case of no ErrorType: Length matches IODD entry, and Data has only one or more "0x00" at the end of the StringT</p> <p>In case of no ErrorType: If the data type is not StringT, the Length must match the IODD entry If the data type is StringT, the following checks will be done: - The length must match the IODD entry, or may be less than the max. length (condensed string). - If condensed, the string may not contain trailing zeros - The string may not contain zero values followed by a non zero value</p> <p>In case of ErrorTypes: only 0x8020, 0x8021, or 0x8022 permitted In case of Error Types: only 0x8020, 0x8021, or 0x8022 permitted, or 0x8012 in case of subindex access when subindexAccessSupported="false"</p> | | | | | | | | |
| Test not passed (examples) | Any evaluation failed | | | | | | | | |
| Report | <p>For each and every parameter with Read access in the IODD:</p> <table style="width: 100%; border-collapse: collapse;"> <tr> <td>No Error: <yes/no></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>Permitted Error: <ErrorType></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td>StringT without "0x00": <yes/no></td> <td style="text-align: right;"><ok nok></td> </tr> <tr> <td colspan="2" style="text-align: center;">String content check OK (if applicable)</td> </tr> </table> | No Error: <yes/no> | <ok nok> | Permitted Error: <ErrorType> | <ok nok> | StringT without "0x00": <yes/no> | <ok nok> | String content check OK (if applicable) | |
| No Error: <yes/no> | <ok nok> | | | | | | | | |
| Permitted Error: <ErrorType> | <ok nok> | | | | | | | | |
| StringT without "0x00": <yes/no> | <ok nok> | | | | | | | | |
| String content check OK (if applicable) | | | | | | | | | |

1833

1834

1835 **7.3.4 IODD parameter write verification**

1836 Table 166 defines the test conditions for this test case.

1837 **Table 166 – IODD parameter write verification**

1838 -CR034- -CR073-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | | | | |
|------------------------------|------------|--|--------------------|------------|------------------------------|------------|
| Identification (ID) | | SDCI_TC_0152 | | | | |
| Name | | TCD_IODD_PARV_WRITEVERIFY | | | | |
| Purpose (short) | | Test verifies index space and value ranges defined within the Device's IODD | | | | |
| Equipment under test (EUT) | | Device and associated IODD | | | | |
| Test case version | | 1.1 | | | | |
| Category / type | | IODD parameter verification test: test to pass | | | | |
| Specification (clause) | | [3], 7.5.4; [7], Table C.1, C.2.2 to C.2.19, F.2.2 to F.2.9, F.3.2, F.3.3 | | | | |
| Configuration / setup | | Device-Tester-Unit | | | | |
| TEST CASE | | CONDITIONS / PERFORMANCE | | | | |
| Purpose (detailed) | | <p>The Device-Tester writes dedicated IODD parameters to the Device. Verify that all parameters in the IODD can be accessed. Test for semantics (device specific technology) is not included. The individual rules for applicable values to be written are defined depending on the data types (for example string, integer, enum), see section "Test parameter".</p> <p>The Tests shall be done by access with sub index == 0, and by subindex >>0 if the type of the variable is Record_T, regardless if subindexAccessSupported is true or false.</p> | | | | |
| Precondition | | <p>DTU: SDCI communication</p> <p>EUT: Device is communicating; associated IODD available in machine readable form VendorID and ProductID of the Device match values in IODD</p> | | | | |
| Procedure | | <p>a) Identify parameter with Write access in the associated IODD.</p> <p>b) Identify a valid <value> for the Write access (see field "Test parameter").</p> <p>c) Write parameter according to IODD including Subindices.</p> | | | | |
| Test parameter | | <p>Write only parameters are excluded.</p> <p>For every <value> to be written, the following rules for the data types shall apply:</p> <ul style="list-style-type: none"> - String: filled with blanks - INT, UINT, FLOAT: maximum value of the permitted range minus one unit - BOOL: true - Time: 2011-04-18 12:00:00 UTC - Timespan: 1 s - Enum (single value): first single value | | | | |
| Post condition | | Original parameter contents shall be stored and rewritten before the end of the test-case | | | | |
| TEST CASE RESULTS | | CHECK / REACTION | | | | |
| Evaluation | | <p>For each written parameter:</p> <ol style="list-style-type: none"> 1) Check for ErrorType according Table C.1 after c) 2) Check Device behavior | | | | |
| Test passed | | <p>Either no ErrorType or none of 0x8011, 0x8012, 0x8023, 0x8033, and 0x8034</p> <p>Device is communicating</p> <p>Either no ErrorType or none of 0x8011, 0x8023, 0x8033, and 0x8034, 0x8012 shall be used in case of subindex access when subindexAccessSupported="false" and Device is communicating</p> | | | | |
| Test not passed (examples) | | Any evaluation failed | | | | |
| Report | | <p>For every parameter with Write access in the IODD:</p> <table style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 60%;">No Error: <yes/no></td> <td style="width: 40%; text-align: right;"><ok nok></td> </tr> <tr> <td>Permitted Error: <ErrorType></td> <td style="text-align: right;"><ok nok></td> </tr> </table> | No Error: <yes/no> | <ok nok> | Permitted Error: <ErrorType> | <ok nok> |
| No Error: <yes/no> | <ok nok> | | | | | |
| Permitted Error: <ErrorType> | <ok nok> | | | | | |

1842 **7.3.5 IODD parameter Index/Subindex consistency**

1843 Table 167 defines the test conditions for this test case.

1844 **Table 167 – IODD parameter Index/Subindex consistency**

1845 -CR033-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0157 |
| Name | TCD_IODD_PARV_INDEXCONSISTENT |
| Purpose (short) | Test the consistency between Indices and Subindices for IODD parameters |
| Equipment under test (EUT) | Device and associated IODD |
| Test case version | 1.0-1 |
| Category / type | IODD parameter verification test: test to pass |
| Specification (clause) | [3], 7.5.4; [7], A.5.4, F.3.2, F.3.3 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | <p>The Device-Tester tests if reading or writing parameters via Subindex has the same result as reading or writing via Index. Test shall be repeated for all parameters which are:</p> <ul style="list-style-type: none"> - not dynamic - readable and writeable - subindex access is allowed <p>For each parameter, test shall be repeated for all subindices which are read-able and writeable</p> |
| Precondition | <p>DTU: SDCI communication</p> <p>EUT: Device is communicating; associated IODD available in machine readable form VendorID and ProductID of the Device match values in IODD</p> <p>This test only for non-dynamic parameters with complex data type and "subindexAccessSupported = true" within the IODD</p> |
| Procedure | <p>a) Identify parameter from IODD (Index, particular Subindex)</p> <p>b) Identify a valid <value1> to write</p> <p>c) Write <value1> to parameter (Index)</p> <p>d) Read parameter (Index, Subindex "0x00")</p> <p>e) Read <value2> of particular Subindex of Index</p> <p>f) Write <value2> into Subindex of the same parameter</p> <p>g) Read parameter (Index, Subindex "0x00")</p> <p>h) Determine <value3> from particular Subindex of Index</p> <p>a) Find a valid value <value1> for subindex 0</p> <p>b) Write <value1> to subindex 0</p> <p>c) Read subindex 0 and store it to <value2></p> <p>d) Extract value of subindex n from <value1> and store it to <value3></p> <p>e) Read subindex n and store it to <value4></p> <p>f) Find valid value <value5> for subindex n which is different to <value3></p> <p>g) Write <value5> to subindex n</p> <p>h) Read subindex 0 and store it to <value6></p> <p>i) Extract value of subindex n from <value6> and store it to <value7></p> <p>j) Read subindex n and store it to <value8></p> |
| Test parameter | <p><value1> to be defined by manufacturer</p> <p>For <value1> and <value5> use values from parameter sets defined in 6.7.1.1</p> |
| Post condition | - |

| TEST CASE RESULTS | CHECK / REACTION |
|----------------------------|---|
| Evaluation | <p>a) Check whether <value2> fits into <value1> after e) b) Check whether <value2> matches <value3> after h)</p> <p>After step c) compare <value1> with <value2>. Values must be equal. After step e) compare <value3> with <value4>. Values must be equal. After step i) compare <value5> with <value7>. Values must be equal. After step j) compare <value5> with <value8>. Values must be equal.</p> |
| Test passed | All evaluations are positive |
| Test not passed (examples) | Any evaluation failed |
| Report | <p>For every parameter with Subindex access in the IODD:</p> <p>Parameter consistency: <value2/value1> <ok nok> Parameter consistency: <value2/value3> <ok nok></p> |

1848

1849 **7.4 Functional system tests (IODD indication)**

1850 **7.4.1 General**

1851 The availability of some more complex system functions of a Device is indicated in its IODD.
1852 The corresponding functional system tests are specified in this clause.

1853

1854 **7.4.2 IODD – functional verification of "Parameter (write) access lock"**

1855 Table 168 defines the test conditions for this test case.

1856 **Table 168 – IODD – functional verification of "Parameter (write) access lock"**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0156 |
| Name | | TCD_IODD_PARV_ACCESSLOCK |
| Purpose (short) | | Test functional behavior of parameter access locking (conditional) |
| Equipment under test (EUT) | | Device with feature "Parameter (write) access" indicated within IODD |
| Test case version | | 1.1 |
| Category / type | | IODD functional system test: test to pass |
| Specification (clause) | | [7], 10.6.5, B.2.4, C.2.1, Table C.1 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Access to parameter write values is locked if feature "Device Access Lock" is implemented. Only parameters with attribute: accessRights = "rw" or accessRights = "wo" in IODD are tested. |
| Precondition | | DTU: OPERATE EUT: Device is in SDCI communication mode, VendorID and DeviceID match with IODD |
| Procedure | | a) Write value "0x0001" to Index "DeviceAccessLocks" (= parameter access locked) b) Select parameter with Write access within IODD c) Write <value> (see Test parameter) to selected parameter in b) d) Write value "0x0000" to Index "DeviceAccessLocks" |
| Test parameter | | <value> to be defined by manufacturer |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Response is negative and ErrorType = 0x8023 (= access denied) 2) Procedure d) results in a positive response |
| Test passed | | Evaluations 1) and 2) are true |
| Test not passed (example) | | Evaluation 1) or 2) are false |
| Report | | Parameter (from evaluation 1): <index>, <ErrorType> DeviceAccessLocks (from evaluation 2) <ok nok> Warning: <yes/no> <ok nok> |

1859

| | | |
|---|---|--|
| 1860 | 7.4.3 IODD – functional verification of "Device reset" | |
| 1861 | Table 169 defines the test conditions for this test case. | |
| Table 169 – IODD – functional verification of "Device reset" | | |
| -CR078- -CR026- -CR020- | | |
| 1864 | TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
| | Identification (ID) | SDCI_TC_0316 |
| | Name | TCD_IODD_PARV_DEVICERESET |
| | Purpose (short) | Test functional behavior of SystemCommand "Device reset" (conditional) |
| | Equipment under test (EUT) | Device with feature "Device reset" indicated in IODD |
| | Test case version | 1.0-1 |
| | Category / type | IODD functional system test: test to pass |
| | Specification (clause) | [7], 10.7.2, Table 101, B.2.2 |
| | Configuration / setup | Device-Tester-Unit |
| | TEST CASE | CONDITIONS / PERFORMANCE |
| | Purpose (detailed) | Parameter and reset behavior shall be as specified after a reset triggered by the SystemCommand "Device reset". |
| | Precondition | DTU: OPERATE EUT: Device is in SDCI communication mode; VendorID and DeviceID match IODD |
| | Procedure | <p>a) Provide input field or configuration option for variable <time> representing the maximum Device startup time after reset or power off/on cycle</p> <p>representing the maximum Device time after System command Device Reset to restart communication (in seconds)</p> <p>b) Select parameter from IODD fulfilling the conditions in "Test parameter"</p> <p>c) Read selected parameter from b) and store values in array <parvalue_a></p> <p>d) Read DID (Device ID) and store value in <didvalue_a></p> <p>e) Write SystemCommand "Device reset" (128 / 0x80)</p> <p>f) Wait <time></p> <p>g) Check if a communication startup sequence has been triggered</p> <p>h) Read RID (RevisionID)</p> <p>i) Read DID (DeviceID) and store value in <didvalue_b></p> <p>j) Check if an Event has been triggered (mode "Event appears")</p> <p>k) Read parameter DeviceStatus and store value to <status_b> if DeviceStatus is marked as implemented in IODD</p> <p>l) Read selected parameter from b) and store values in array <parvalue_b></p> |
| | Test parameter | Only parameters in IODD are tested - with attribute "accessRights = "rw", and - which are "excludedFromDataStorage" (= "true") which are not marked with "excludedFromDataStorage="true" in the IODD |
| | Post condition | – |
| | TEST CASE RESULTS | CHECK / REACTION |
| | Evaluation | <p>1) Procedure g) shows exactly one communication startup sequence</p> <p>2) Result of procedure h) matches with IODD (CommNetworkProfile: iolinkRevision = "Vx.x")</p> <p>3) Values of <didvalue_a> match values of <didvalue_b></p> <p>4) Procedure j) shows at least one event of mode "Event appears" or value of <status_b> is equal '0 (0x00)' (Skip this step, if DeviceStatus is not marked as implemented in IODD)</p> <p>For each received parameter (from procedure b):</p> <p>5) Response is positive</p> <p>6) Values of <parvalue_a> match values of <parvalue_b></p> |
| | Test passed | All evaluations 1) to 6) are true |
| | Test not passed (example) | Any of the evaluations 1) to 6) is false |
| | Report | Communication from evaluation 1): <value> RevisionID from evaluation 2): <value> |

| | | |
|--|---|--|
| | DeviceID from evaluation 3): <value> DeviceStatus: <value> (from procedure k), <event> (from procedure j) For each received parameter (from evaluation 5) and 6): Parameter: <Index>, <parvalue_a>, <parvalue_b> | <ok nok> <ok nok> <ok nok> |
|--|---|--|

1866

1867 **7.4.4 IODD – functional verification of "Application reset"**

1868 Table 170 defines the test conditions for this test case.

1869 **Table 170 – IODD – functional verification of "Application reset"**

1870 -CR104- -CR121- -CR040- -CR017- -CR097-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0317 |
| Name | TCD_IODD_PARV_APPLRESET |
| Purpose (short) | Test functional behavior of SystemCommand "Application reset" (conditional) |
| Equipment under test (EUT) | Device with feature "Application reset" indicated in IODD |
| Test case version | 1.0 1 |
| Category / type | IODD functional system test: test to pass |
| Specification (clause) | [7], 10.7.3, Table 101, B.2.2 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Parameter and reset behavior shall be as specified after a reset triggered by the SystemCommand "Application reset" |
| Precondition | DTU: Data storage is disabled EUT: Device is in SDCI communication mode, VendorID and DeviceID match IODD |
| Procedure | a) Select parameter from IODD fulfilling the conditions in "Test parameter" and excluding parameter ApplicationSpecificTag, FunctionTag, LocationTag b) If supported, read parameter ApplicationSpecificTag, FunctionTag and LocationTag and store responses in <tagvalue_a> c) Read parameter DID (DeviceID) and RID (RevisionID) and store values in <idvalue_a> d) Write SystemCommand "Application reset" (129 / 0x81) e) Wait 5 s f) Check if a communication startup sequence has been triggered g) Wait for event DS_UPLOAD_REQ h) Check DS_UPLOAD_FLAG in parameter DataStorageIndex i) Read parameter DID (Device ID) and RID (Revision ID) and store values in <idvalue_b> j) If supported, read parameter ApplicationSpecificTag, FunctionTag and LocationTag and store responses in <tagvalue_b> k) Read selected parameter from a) and store values in array <parvalue_b> l) Write 0x04 (DS_DownloadEnd) to Index 3, subindex 1 |
| Test parameter | Only technology specific parameters in IODD are tested - with attribute "accessRights = "rw", - with attribute "defaultValue="" |
| Post condition | - |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Procedure f) shows no communication startup sequence 2) Values of <idvalue_a> and <idvalue_b> are equal 3) Values of <tagvalue_a> and <tagvalue_b> are equal 4) Check whether Event DS_UPLOAD_REQ was raised after SystemCommand "Application reset" 5) Value of procedure h) (DS_UPLOAD_FLAG) is equal '1' (DS_UPLOAD_REQ pending) if DS is supported, or is eq '0' if DS is not supported For each received parameter (from procedure a)): 6) Response is positive 7) Values of <parvalue_b> match corresponding assigned "defaultValue" if available in IODD Hint evaluation 7) : Results are only logged |
| Test passed | All evaluations 1) to 6) are true |
| Test not passed (example) | At least one of the evaluations 1) to 6) is false |

| TEST CASE RESULTS | CHECK / REACTION |
|-------------------|--|
| Report | Communication (from evaluation 1)) RevisionID/DeviceID (from evaluation 2)) Identification (from evaluation 3)) DataStorage (from evaluation 4)) For each received parameter (from evaluation 5) and 6): Parameter: <Index>, <parvalue_a>, <parvalue_b> <ok nok> <ok nok> <ok nok> <ok nok> <ok nok> |

1873

| 1874 | 7.4.5 IODD – functional verification of "Restore factory settings" | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
|--|--|----------------------|----------------------------|---------------------|---|--------------|---|---------------------------|--|----------------------------|---|-------------------|--------------|-----------------|---|------------------------|-------------------------------|-----------------------|--------------------|--|--|-----------|--------------------------|--------------------|--|--------------|---|-----------|--|----------------|---|----------------|---|------|--|-------------------|------------------|------------|---|-------------|--|---------------------------|---|
| 1875 | Table 171 defines the test conditions for this test case. | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Table 171 – IODD – functional verification of "Restore factory settings" | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| -CR071- -CR042- -CR017- -CR028- | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 1878 | <table border="1"> <thead> <tr> <th>TEST CASE ATTRIBUTES</th><th>IDENTIFICATION / REFERENCE</th></tr> </thead> <tbody> <tr> <td>Identification (ID)</td><td>SDCI_TC_0155</td></tr> <tr> <td>Name</td><td>TCD_IODD_PARV_FACTORYSETTINGS</td></tr> <tr> <td>Purpose (short)</td><td>Test functional behavior of SystemCommand "Restore factory settings" (conditional)</td></tr> <tr> <td>Equipment under test (EUT)</td><td>Device with feature "Restore factory settings" indicated in IODD</td></tr> <tr> <td>Test case version</td><td>1.4 2</td></tr> <tr> <td>Category / type</td><td>IODD functional system test: test to pass</td></tr> <tr> <td>Specification (clause)</td><td>[7], 10.7.4, Table 101, B.2.2</td></tr> <tr> <td>Configuration / setup</td><td>Device-Tester-Unit</td></tr> <tr> <td colspan="2"> <table border="1"> <thead> <tr> <th>TEST CASE</th><th>CONDITIONS / PERFORMANCE</th></tr> </thead> <tbody> <tr> <td>Purpose (detailed)</td><td>Parameter and reset behavior shall be as specified after a reset triggered by the SystemCommand "Restore factory settings"</td></tr> <tr> <td>Precondition</td><td>DTU: Data storage is disabled , Inspection level is set to "compatible" EUT: Device is in SDCI communication mode, VendorID and DeviceID match IODD</td></tr> <tr> <td>Procedure</td><td> a) Select parameter from IODD, which fulfill the conditions in "Test parameter" b) Read parameter DeviceStatus and store value in <status_a> c) Write SystemCommand " ParamDownloadStore" (5 / 0x05) d) Write SystemCommand "Restore factory setting" (130 / 0x82) e) Check if an Event has been triggered (mode "Event disappears") f) Wait 5 seconds g) Check if a communication startup sequence has been triggered h) Check DS_UPLOAD_FLAG in parameter DataStorageIndex i) Read parameter DID (DeviceID) and RID (RevisionID) and store to <idvalue_b> j) Check if an Event has been triggered (mode "Event appears") k) Read parameter DeviceStatus and store value in <status_b> l) Read selected parameter from a) and store values in array <parvalue_b> </td></tr> <tr> <td>Test parameter</td><td>Only parameters in IODD are tested - with attribute "accessRights = "rw", and - which are "excludedFromDataStorage", - which are not "excludedFromDataStorage" and - with attribute: defaultValue="<value>"</td></tr> <tr> <td>Post condition</td><td>–</td></tr> </tbody> </table> </td></tr> <tr> <td>1879</td><td> <table border="1"> <thead> <tr> <th>TEST CASE RESULTS</th><th>CHECK / REACTION</th></tr> </thead> <tbody> <tr> <td>Evaluation</td><td> 1) Procedure f) g) shows no or exactly one communication startup sequence 2) If <status_a> is ≠ "0 (0x00)", procedure d) e) shows at least one Event of mode "Event disappears" (If a communication startup occurred skip this evaluation) 3) Values of <idvalue_b> match default values of IODD RID: (CommNetworkProfile→iolinkRevisions="Vx.x") 4) Value of procedure g) h) (DS_UPLOAD_FLAG) = "0" (no DS_UPLOAD_REQ) 5) Procedure i) j) shows at least one Event of mode "Event appears" or value of <status_b> = "0 (0x00)" For each received parameter (from procedure a)): 6) Response is positive 7) Values of <parvalue_b> match corresponding assigned "defaultValue" if available in IODD </td></tr> <tr> <td>Test passed</td><td>All evaluations 1) to 7) are true (if a communication startup occurred skip evaluation 2)</td></tr> <tr> <td>Test not passed (example)</td><td>At least one of the evaluations 1) to 7) is false</td></tr> </tbody> </table> </td></tr> </tbody></table> | TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | Identification (ID) | SDCI_TC_0155 | Name | TCD_IODD_PARV_FACTORYSETTINGS | Purpose (short) | Test functional behavior of SystemCommand "Restore factory settings" (conditional) | Equipment under test (EUT) | Device with feature "Restore factory settings" indicated in IODD | Test case version | 1.4 2 | Category / type | IODD functional system test: test to pass | Specification (clause) | [7], 10.7.4, Table 101, B.2.2 | Configuration / setup | Device-Tester-Unit | <table border="1"> <thead> <tr> <th>TEST CASE</th><th>CONDITIONS / PERFORMANCE</th></tr> </thead> <tbody> <tr> <td>Purpose (detailed)</td><td>Parameter and reset behavior shall be as specified after a reset triggered by the SystemCommand "Restore factory settings"</td></tr> <tr> <td>Precondition</td><td>DTU: Data storage is disabled , Inspection level is set to "compatible" EUT: Device is in SDCI communication mode, VendorID and DeviceID match IODD</td></tr> <tr> <td>Procedure</td><td> a) Select parameter from IODD, which fulfill the conditions in "Test parameter" b) Read parameter DeviceStatus and store value in <status_a> c) Write SystemCommand " ParamDownloadStore" (5 / 0x05) d) Write SystemCommand "Restore factory setting" (130 / 0x82) e) Check if an Event has been triggered (mode "Event disappears") f) Wait 5 seconds g) Check if a communication startup sequence has been triggered h) Check DS_UPLOAD_FLAG in parameter DataStorageIndex i) Read parameter DID (DeviceID) and RID (RevisionID) and store to <idvalue_b> j) Check if an Event has been triggered (mode "Event appears") k) Read parameter DeviceStatus and store value in <status_b> l) Read selected parameter from a) and store values in array <parvalue_b> </td></tr> <tr> <td>Test parameter</td><td>Only parameters in IODD are tested - 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| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Identification (ID) | SDCI_TC_0155 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Name | TCD_IODD_PARV_FACTORYSETTINGS | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Purpose (short) | Test functional behavior of SystemCommand "Restore factory settings" (conditional) | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Equipment under test (EUT) | Device with feature "Restore factory settings" indicated in IODD | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Test case version | 1.4 2 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Category / type | IODD functional system test: test to pass | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Specification (clause) | [7], 10.7.4, Table 101, B.2.2 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Configuration / setup | Device-Tester-Unit | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
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| TEST CASE | CONDITIONS / PERFORMANCE | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Purpose (detailed) | Parameter and reset behavior shall be as specified after a reset triggered by the SystemCommand "Restore factory settings" | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Precondition | DTU: Data storage is disabled , Inspection level is set to "compatible" EUT: Device is in SDCI communication mode, VendorID and DeviceID match IODD | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Procedure | a) Select parameter from IODD, which fulfill the conditions in "Test parameter" b) Read parameter DeviceStatus and store value in <status_a> c) Write SystemCommand " ParamDownloadStore" (5 / 0x05) d) Write SystemCommand "Restore factory setting" (130 / 0x82) e) Check if an Event has been triggered (mode "Event disappears") f) Wait 5 seconds g) Check if a communication startup sequence has been triggered h) Check DS_UPLOAD_FLAG in parameter DataStorageIndex i) Read parameter DID (DeviceID) and RID (RevisionID) and store to <idvalue_b> j) Check if an Event has been triggered (mode "Event appears") k) Read parameter DeviceStatus and store value in <status_b> l) Read selected parameter from a) and store values in array <parvalue_b> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
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| Post condition | – | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
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| TEST CASE RESULTS | CHECK / REACTION | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Evaluation | 1) Procedure f) g) shows no or exactly one communication startup sequence 2) If <status_a> is ≠ "0 (0x00)", procedure d) e) shows at least one Event of mode "Event disappears" (If a communication startup occurred skip this evaluation) 3) Values of <idvalue_b> match default values of IODD RID: (CommNetworkProfile→iolinkRevisions="Vx.x") 4) Value of procedure g) h) (DS_UPLOAD_FLAG) = "0" (no DS_UPLOAD_REQ) 5) Procedure i) j) shows at least one Event of mode "Event appears" or value of <status_b> = "0 (0x00)" For each received parameter (from procedure a)): 6) Response is positive 7) Values of <parvalue_b> match corresponding assigned "defaultValue" if available in IODD | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Test passed | All evaluations 1) to 7) are true (if a communication startup occurred skip evaluation 2) | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Test not passed (example) | At least one of the evaluations 1) to 7) is false | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |

| TEST CASE RESULTS | CHECK / REACTION | |
|-------------------|---|--|
| Report | Communication (from evaluation 1)) Diagnosis clear (from evaluation 2)) RevisionID/DeviceID (from evaluation 3)) DataStorage (from evaluation 4)) DeviceStatus (from evaluation 5)): <value>, <event> For each received parameter (from evaluation 6) and 7)): Parameter: <Index>, <parvalue_a>, <parvalue_b> | <ok nok> <ok nok> <ok nok> <ok nok> <ok nok> <ok nok> |

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1882 **7.4.6 IODD – functional verification of "Back-to-box"**

1883 Table 172 defines the test conditions for this test case.

1884 **Table 172 – IODD – functional verification of "Back-to-box"**

1885 -CR071- -CR042- -CR017- -CR078-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0318 |
| Name | TCD_IODD_PARV_BACKTOBOX |
| Purpose (short) | Test functional behavior of SystemCommand "Back-to-box" (conditional) |
| Equipment under test (EUT) | Device with feature "Back-to-box" indicated in IODD |
| Test case version | 1.0 [1] |
| Category / type | IODD functional system test: test to pass |
| Specification (clause) | [7], 10.7.5, Table 101, B.2.2 |
| Configuration / setup | Device-Tester-Unit In case of the Deviceld is not equal to the DefaultDeviceld (see System Spec Table 101) , the DefaultIODD must be provided |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Parameter and reset behavior shall be as specified after a reset triggered by the SystemCommand "Back-to-box" |
| Precondition | DTU: Data storage is disabled EUT: Device is in SDCI communication mode, VendorID and DevicID match IODD |
| Procedure | <p>a) Provide input field or configuration option for variable <time> representing the maximum Device startup time after reset or power off/on cycle (in seconds)</p> <p>b) a) Select parameter from <Default>IODD fulfilling the conditions in "Test parameter"</p> <p>b) Call SystemCommand "ParamDownloadStart" if Device supports Block Parameterization</p> <p>c) Write parameter set 1 into the Device because it is different to factory reset</p> <p>d) Write SystemCommand " ParamDownloadStore" (5 / 0x05)</p> <p>e) e) Write SystemCommand "Back-to-box" (131 / 0x83)</p> <p>f) f) Wait 5 s</p> <p>e) g) Check communication</p> <p>f) h) Apply power cycle (power off, wait 5 s, power on: Port remains in communication)</p> <p>g) i) Wait <time> Wait 1s to ensure that the Wakeup mechanism has been started again</p> <p>h) j) Check if a communication startup sequence has been triggered</p> <p>i) k) Check DS_UPLOAD_FLAG in parameter DataStorageIndex</p> <p>j) l) Read parameter DID (Device ID) and RID (Revision ID) and store to <idvalue_b></p> <p>k) m) Check if an Event has been triggered (mode "Event appears")</p> <p>l) n) Read parameter DeviceStatus and store value to <status_b></p> <p>m) o) Read selected parameter from a) and store values in array <parvalue_b></p> |
| Test parameter | <p>Only parameters in IODD are tested</p> <ul style="list-style-type: none"> - with attribute "accessRights = "rw", and - which are not "excludedFromDataStorage", — which are not "excludedFromDataStorage", and - with attribute: defaultValue="<value>" <p>In case of the Deviceld is not equal to the DefaultDeviceld, the Test system needs the following information in addition</p> <ul style="list-style-type: none"> - the DefaultDeviceld to which the device is switched back - the default parameter from the DefaultIODD - The Testparameter must be taken from the DefaultIODD for comparison |
| Post condition | – |

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| TEST CASE RESULTS | CHECK / REACTION |
|-------------------|--|
| Evaluation | <p>1) Procedure e) shows communication interruption and procedure h) shows exactly one communication startup sequence</p> <p>2) Values of <idvalue_b> match the default values of the IODD RID: (CommNetworkProfile: iolinkRevision = "Vx.x")</p> <p>3) Value of procedure i) (DS_UPLOAD_FLAG) = "0" (no DS_UPLOAD_REQ)</p> <p>4) Procedure k) shows at least one Event of mode "Event appears" or value of <status_b> = "0 (0x00)"</p> <p>For each read parameter (from procedure a)):</p> <p>5) Response is positive</p> <p>6) Values of <parvalue_b> match assigned "defaultValue" if available in IODD</p> |
| Test passed | All evaluations 1) to 6) are true |
| Test not passed | At least one of the evaluations 1) to 6) is false |
| Report | <p>Communication from evaluation 1): <ok nok></p> <p>RevisionID/DeviceID from evaluation 2): <ok nok></p> <p>DataStorage from evaluation 3): <ok nok></p> <p>DeviceStatus from evaluation 4): <value>, <event> <ok nok></p> <p>For each received parameter (from evaluation 5) and 6)): <value>, <event> <ok nok></p> <p>Parameter: <Index>, <parvalue_a>, <parvalue_b> <ok nok></p> |

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1890 **7.4.7 IODD – Write alternative valid DeviceID**

1891 Table 173 defines the test conditions for this test case.

1892 **Table 173 – IODD – Write alternative valid DeviceID**

1893 -CR068-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0314 |
| Name | TCD_DLPC_DID_OVERWRITE_COMP |
| Purpose (short) | Device behavior with overwrite of the DeviceID (compatible) |
| Equipment under test (EUT) | Device with support of an additional compatible DeviceID |
| Test case version | 1.4 2 |
| Category / type | IODD functional system test: test to pass |
| Specification (clause) | [7], 10.6.2, B.1.9 |
| Configuration / setup | Device-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Check Device behavior with overwrite of the DeviceID with a compatible DeviceID as listed in the IODD. Master overwrites the DeviceID and the Device accepts the requested DeviceID. After a power off/on, Master checks if the previously written DeviceID has been stored in non-volatile memory in the Device. |
| Precondition | DTU: SIO mode EUT: Device set to factory settings (original "DID-0") |
| Procedure | a) DTU establishes communication b) DTU reads DeviceID from Device (EUT) c) DTU overwrites original DeviceID with the additional DeviceID ("DID-2") c) DTU overwrites the DeviceID with the DeviceID ("DID-2") by using the complete mechanism written in [19], Figure 76, including Restart d) Device (EUT) power switched off and on again e) DTU re-establishes communication f) DTU reads DeviceID from Device (EUT) g) DTU overwrites the DeviceID ("DID-2") with "DID-0" to return to the previous settings for the next test by using the complete mechanism written in [19], Figure 76, including Restart |
| Test parameter | IODD: DeviceIdentity/@deviceID, memorized as "DID-0" DeviceIdentity/@additionalDeviceIDs, one of the DeviceIDs memorized as "DID-2" |
| Post condition | - |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check acquired DeviceID after b) 2) Compare "DID-0" with acquired DeviceID in b) 3) 2) Check acquired DeviceID after f) |
| Test passed | DeviceID = "DID-1" "DID-0" in 1) DeviceID from IODD ("DID-0") = "DID-1" in 2) DeviceID = "DID-2" in 3) 2) |
| Test not passed (examples) | Any of the checks failed. It can be assumed that Device does not store the DeviceID in non-volatile memory if DeviceID = "DID-1" in 3). |
| Report | Additional DeviceID stored in non-volatile memory: <yes/no> <ok nok> |

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7.4.8 IODD – Write alternative invalid DeviceID

Table 174 defines the test conditions for this test case.

Table 174 – IODD – Write alternative invalid DeviceID**-CR067-**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0315 |
| Name | | TCD_DLPC_DID_OVERRIDE_INCOMP |
| Purpose (short) | | Device behavior with overwrite of the DeviceID (incompatible) |
| Equipment under test (EUT) | | Device with or without support of an additional incompatible DeviceID |
| Test case version | | 1.1 2 |
| Category / type | | IODD functional system test: test to fail |
| Specification (clause) | | [7], 10.6.2 |
| Configuration / setup | | Device-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Check Device behavior at overwrite of the DeviceID with incompatible value. Master overwrites the DeviceID and the Device rejects the requested DeviceID. |
| Precondition | | DTU: SIO mode EUT: Device set to factory settings (original "DID-1") Device set to ("DID-0") |
| Procedure | | a) DTU establishes communication b) DTU reads DeviceID from Device (EUT) c) DTU overwrites original DeviceID with any DeviceID (# "DID-1" or "DID-2") c) DTU overwrites the DeviceID with any DeviceID (# "DID-0" or "DID-x") by using the complete mechanism written in [7], Figure 76, including Restart d) DTU reads DeviceID from Device (EUT) d) e) Device (EUT) power switched off and on again e) f) DTU re-establishes communication f) g) DTU reads DeviceID from Device (EUT) |
| Test parameter | | IODD: DeviceIdentity/@deviceId, memorized as "DID-0" DeviceIdentity/@additionalDeviceIds, memorized as "DID-2" DeviceIdentity@additionalDeviceIds = "DID-x", the additional DeviceIDs in the IODD |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check acquired DeviceID after b) 2) Compare "DID-0" with acquired DeviceID in b) 2) Check acquired DeviceID after d) 3) Check acquired DeviceID after g) |
| Test passed | | DeviceID = "DID-1" "DID-0" in 1) DeviceID from IODD ("DID-0") = "DID-1" in 2) DTU receives Port error with EventCode = 0x1803 (Incorrect DeviceID) in 3) DeviceID = "DID-0" in 2) DeviceID = "DID-0" in 3) |
| Test not passed (examples) | | Any of the checks failed or Device (EUT) returned incorrect DeviceID in 3) Any of the evaluation failed |
| Report | | Port error with EventCode 0x1803 occurred: <yes/no> <ok nok> Device don't change to invalid DeviceID: <yes/no> <ok nok> |

1904

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1908 **7.5 Test report summary of the IODD based Device tests**

1909 The template is defined by the Device-Tester-System. The test report shall present at least the
1910 results of the test cases for the IODD based Device tests.

1911

1912 8 Master protocol tests

1913 8.1 General

1914 -CR019-

1915 The protocol tests can be performed almost automatically with the help of a Master-Tester-
 1916 System as defined in A.3. The test sequences are described in 4.5 together with a list of the
 1917 relevant test cases for Master in Table 6. Supplementary requirements for Legacy-Masters be-
 1918 yond the definitions in [5] are listed in Annex B.

1919 Procedure results not mentioned in the evaluation part are assumed to be successful for pass-
 1920 ing the tests.

1921 Master test cases are specified using appropriate types of macros as defined in Annex A.4.

1922 8.2 Timings

1923 8.2.1 Delay times after WURQ and Master messages (TDMT)

1924 Table 175 defines the test conditions for this test case.

1925 **Table 175 – Delay times after WURQ and Master messages (TDMT)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0158 |
| Name | TCM_PHYL_TIME_TDMT |
| Purpose (short) | Check delay times after WURQ and Master messages |
| Equipment under test (EUT) | Master |
| Test case version | 1.1 |
| Category / type | Master protocol test: test to pass |
| Specification (clause) | [7], 7.3.2.2, Table 42 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Measuring the delays between WURQ and first request (230,4 kbit/s) or between the requests in the individual transmission rates, respectively. Check if TDMT is within the tolerance of 27 to 37 TBIT of the subsequent transmission rate. |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | a) MTU_State_Deactivate b) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) b) MTU_Timing_Startup ;returning TDMT(COM3), TDMT(COM2), TDMT(COM1) c) Evaluation 1) d) Evaluation 2) e) Evaluation 3) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check TDMT(COM3) ;See Figure 31 in [7], time from begin WURQ to begin start bit of COM3 minus TREN with 500 µs 2) Check TDMT(COM2) ;See Figure 31 in [7], time from begin stop bit COM3 to begin start bit COM2 minus 1 TBIT(COM3) 3) Check TDMT(COM1) ;See Figure 31 in [7], time from begin stop bit COM2 to begin start bit COM1 minus 1 TBIT(COM2) |
| Test passed | In 1) 27 TBIT ≤ TDMT(COM3) ≤ 37 TBIT ;TBIT = 4,34 µs In 2) 27 TBIT ≤ TDMT(COM2) ≤ 37 TBIT ;TBIT = 26,04 µs In 3) 27 TBIT ≤ TDMT(COM1) ≤ 37 TBIT ;TBIT = 208,33 µs |

| TEST CASE RESULTS | CHECK / REACTION |
|----------------------------|---|
| Test not passed (examples) | Any TDMT out of tolerance |
| Report | TDMT(COM3): <value> TDMT(COM2): <value> TDMT(COM1): <value> |

1928

1929 **8.2.2 Delay time between three WURQs (TDWU)**

1930 Table 176 defines the test conditions for this test case.

1931 **Table 176 – Delay time between three WURQs (TDWU)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0159 |
| Name | | TCM_PHYL_TIME_TDWFU |
| Purpose (short) | | Check whether delay time between wake-up retries is within tolerance |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.1 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 7.3.2.2, Table 42 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Measuring the times between the three Wake-up retries. Master-Tester-Unit shall detect the beginning of all Wake-up requests and measure the time in between. It shall not react to requests. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_Deactivate a) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) b) MTU_Timing_Startup <i>;returning TDWU12 and TDWU23</i> c) Evaluation 1) d) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check interval between first and second Wake-up: TDWU12 2) Check interval between second and third Wake-up: TDWU23 |
| Test passed | | 30 ms ≤ TDWU12 ≤ 50 ms, and 30 ms ≤ TDWU23 ≤ 50 ms |
| Test not passed (examples) | | TDWU12 or TDWU23 out of tolerance |
| Report | | TDWU12 (interval between first and second): <value> <i><ok nok></i> TDWU23 (interval between second and third): <value> <i><ok nok></i> |

1934

1935

1936 **8.2.3 Number of WURQs**

1937 Table 177 defines the test conditions for this test case.

1938 **Table 177 – Number of WURQs**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0160 |
| Name | | TCM_PHYL_TIME_NUMOFWURQS |
| Purpose (short) | | Check number of Wake-up retries |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.1 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 7.3.2.2, Table 42 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | The number of WURQs during one Wake-up sequence is counted. The number of retries shall be exactly 2 (total number 3). Master-Tester-Unit shall detect the start of the first WURQ and then start time measurement. Another 2 WURQs shall follow within the next 100 ms. No further requests except these 3 WURQs shall follow within 500 ms after start of the first WURQ. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_Deactivate a) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) b) MTU_Timing_Startup <i>;returning WURQ and WURQ101-500 counts</i> c) Evaluation 1) d) Evaluation 2) |
| Test parameter | | — |
| Post condition | | — |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check number of WURQs within first 100 ms: WURQ 2) Check number of WURQs within 101 ms to 500 ms: WURQ101-500 |
| Test passed | | WURQ = 3, and WURQ101-500 = 0 |
| Test not passed (examples) | | WURQ ≠ 3, or WURQ101-500 > 0 |
| Report | | WURQ: <value> WURQ101-500: <value> |
| | | <ok nok> <ok nok> |

1941

1942

8.2.4 Delay time between WURQ retry sequences (TSD)

1944 Table 178 defines the test conditions for this test case.

Table 178 – Delay time between WURQ retry sequences (TSD)

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|----------------------------|
| Identification (ID) | SDCI_TC_0161 | |
| Name | TCM_PHYL_TIME_TSD | |
| Purpose (short) | Check time between two WURQs is between 0,5 s and 1 s. | |
| Equipment under test (EUT) | Master | |
| Test case version | 1.1 | |
| Category / type | Master protocol test: test to pass | |
| Specification (clause) | [7], 7.3.2.2, Table 42 | |
| Configuration / setup | Master-Tester-System | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | The time between start of two Wake-up sequences is measured. Master-Tester-Unit shall detect start of the first WURQ and start time measurement. Two more WURQs shall follow within the next 100 ms. No further requests except these 3 WURQs shall follow within 500 ms after start of the first WURQ. At the latest 1 s after the first WURQ, the Master shall start a new Wake-up sequence. Master-Tester-Unit shall check these times. | |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | |
| Procedure | a) MTU_State_Deactivate a) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) b) MTU_Timing_Startup <i>;returning TSD</i> c) Evaluation 1) | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check TSD | |
| Test passed | 0,5 s ≤ TSD ≤ 1 s | |
| Test not passed (examples) | TSD > 1 s | |
| Report | TSD: <value> <ok nok> | |

1950 **8.2.5 Delay time between two Master messages at STARTUP (TINITCYC)**

1951 Table 179 defines the test conditions for this test case.

1952 **Table 179 – Delay time between two Master messages at STARTUP (TINITCYC)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0162 |
| Name | | TCM_PHYL_TIME_TINITCYC |
| Purpose (short) | | STARTUP: The time between two message beginnings shall be ≥ 100 TBIT. |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.1 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 7.3.3.3, A.2.6, Table A.7 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | In state STARTUP, the time between two Master message beginnings is measured. This is repeated for all transmission rates supported by the Master. Master-Tester-Unit detects the start of each Master message and measures the time in between. These times shall be ≥ 100 TBIT. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) Assign first value to "com" (Test parameter) b) MTU_Timing_SetCommunicationMode = "com" c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) d) TM_AWAIT_PORT_STATUS(OPERATE) e) MTU_Timing_GetTinitcyInStartup <i>:returning TINITCYC</i> f) Evaluation 1) g) SMI_PortConfiguration(ABPS_PORTINACTIVE) h) Repeat from b) with next "com" |
| Test parameter | | com = {COM1, COM2, COM3} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check TINITCYC |
| Test passed | | Minimum of TINITCYC (COM1) ≥ 100 TBIT, and Minimum of TINITCYC (COM2) ≥ 100 TBIT, and Minimum of TINITCYC (COM3) ≥ 100 TBIT |
| Test not passed (examples) | | Any of the minima of TINITCYC is < 100 TBIT |
| Report | | Minimum of TINITCYC (COM1): <value> Minimum of TINITCYC (COM2): <value> Minimum of TINITCYC (COM3): <value> <i><ok nok></i> |

1955

1956

1957 **8.2.6 Delay time of Master messages with 2 octets OD in PREOP (TINITCYC)**

1958 Table 180 defines the test conditions for this test case.

1959 **Table 180 – Delay time of Master messages with 2 octets OD in PREOP (TINITCYC)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0331 |
| Name | | TCM_PHYL_TIME_TINITCYC_PREOP_2 |
| Purpose (short) | | PREOPERATE: TINITCYC of messages with 2 octets OD shall be \geq 100 TBIT |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.0 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 7.3.3.3, A.2.6, Table A.8 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | In state PREOPERATE, the time between the start of two Master messages with 2 octets On-request Data is measured. This is repeated for all transmission rates supported by the Master. Master-Tester-Unit detects the start of each Master message and measures the time in between. These times shall be \geq 100 TBIT. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE ; <i>2 octets OD</i> |
| Procedure | | a) Assign first value to "com" (Test parameter) b) MTU_Timing_SetCommunicationMode = "com" c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) d) TM_AWAIT_PORT_STATUS(OPERATE) e) MTU_Timing_GetTinitcyclnPreoperate ; <i>returning TINITCYC</i> f) Evaluation 1) g) SMI_PortConfiguration(ABPS_PORTINACTIVE) h) Repeat from b) with next "com" |
| Test parameter | | com = {COM1, COM2, COM3} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check TINITCYC |
| Test passed | | Minimum of TINITCYC (COM1) \geq 100 TBIT, and Minimum of TINITCYC (COM2) \geq 100 TBIT, and Minimum of TINITCYC (COM3) \geq 100 TBIT |
| Test not passed (examples) | | Any of the minima of TINITCYC is at least < 100 TBIT |
| Report | | Minimum of TINITCYC (COM1): <value> Minimum of TINITCYC (COM2): <value> Minimum of TINITCYC (COM3): <value> <ok nok> |

1962

1963

1964 **8.2.7 Delay time of Master messages with 8 octets OD in PREOP (TINITCYC)**

1965 Table 181 defines the test conditions for this test case.

1966 **Table 181 – Delay time of Master messages with 8 octets OD in PREOP (TINITCYC)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0332 |
| Name | | TCM_PHYL_TIME_TINITCYC_PREOP_8 |
| Purpose (short) | | PREOPERATE: TINITCYC of messages with 8 octets OD shall be \geq 210 TBIT |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.0 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 7.3.3.3, A.2.6, Table A.8 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | In state PREOPERATE, the time between the start of two Master messages with 8 octets On-request Data is measured. This is repeated for all transmission rates supported by the Master. Master-Tester-Unit detects the start of each Master message and measures the time in between. These times shall be \geq 210 TBIT. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) Assign first value to "com" (Test parameter) b) MTU_Timing_SetCommunicationMode = "com" c) MTU_DPP1_Set(M-sequenceCapability) = 0x21 d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) e) TM_AWAIT_PORT_STATUS(OPERATE) f) MTU_Timing_GetTinitcyInPreoperate ; <i>8 octets On-request Data returning TINITCYC</i> g) Evaluation 1) h) SMI_PortConfiguration(ABPS_PORTINACTIVE) i) Repeat from b) with next "com" |
| Test parameter | | com = {COM1, COM2, COM3} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check TINITCYC |
| Test passed | | Minimum of TINITCYC (COM1) \geq 210 TBIT, and Minimum of TINITCYC (COM2) \geq 210 TBIT, and Minimum of TINITCYC (COM3) \geq 210 TBIT |
| Test not passed (examples) | | Any of the minima of TINITCYC is at least < 210 TBIT |
| Report | | Minimum of TINITCYC (COM1): <value> Minimum of TINITCYC (COM2): <value> Minimum of TINITCYC (COM3): <value> |
| | | <ok nok> |

1969

1970

1971 **8.2.8 Delay time of Master messages with 32 octets OD in PREOP (TINITCYC)**

1972 Table 182 defines the test conditions for this test case.

1973 **Table 182 – Delay time of Master messages with 32 octets OD in PREOP (TINITCYC)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0333 |
| Name | | TCM_PHYL_TIME_TINITCYC_PREOP_32 |
| Purpose (short) | | PREOPERATE: TINITCYC of messages with 32 octets OD shall be \geq 550 TBIT |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.0 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 7.3.3.3, A.2.6, Table A.8 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | In state PREOPERATE, the time between the start of two Master messages with 32 octets On-request Data is measured. This is repeated for all transmission rates supported by the Master. Master-Tester-Unit detects the start of each Master message and measures the time in between. These times shall be \geq 550 TBIT. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) Assign first value to "com" (Test parameter) b) MTU_Timing_SetCommunicationMode = "com" c) MTU_DPP1_Set(M-sequenceCapability) = 0x31 d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) e) TM_AWAIT_PORT_STATUS(OPERATE) f) MTU_Timing_GetTinitcyInPreoperate <i>;32 octets On-request Data ;returning TINITCYC</i> g) Evaluation 1) h) SMI_PortConfiguration(ABPS_PORTINACTIVE) i) Repeat from b) with next "com" |
| Test parameter | | com = {COM1, COM2, COM3} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check TINITCYC |
| Test passed | | Minimum of TINITCYC (COM1) \geq 550 TBIT, and Minimum of TINITCYC (COM2) \geq 550 TBIT, and Minimum of TINITCYC (COM3) \geq 550 TBIT |
| Test not passed (examples) | | Any of the minima of TINITCYC is at least < 550 TBIT |
| Report | | Minimum of TINITCYC (COM1): <value> Minimum of TINITCYC (COM2): <value> Minimum of TINITCYC (COM3): <value> <ok nok> |

1976

1977

1978 **8.2.9 Adjustment of the MasterCycleTime**

1979 Table 183 defines the test conditions for this test case.

1980 **Table 183 – Adjustment of the MasterCycleTime**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0163 |
| Name | | TCM_PHYL_TIME_MASTERCYCLETIME |
| Purpose (short) | | The Master shall adapt correctly to a too short MinCycleTime of the Device |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.1 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], B.1.3 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master-Tester-Unit shall suggest the M-sequence type for a too small MinCycleTime value. The Master shall not accept this time and shall write back a feasible Master-Cycle time. The same applies if the MinCycleTime value is "0". At each M-sequence type, MTU starts with the MinCycleTime value "0" and with times below the time the Master can achieve. The Master shall correct these times by writing back a possible MasterCycleTime value. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) Assign first value to "com", "minCT" (Test parameter) b) MTU_Timing_SetCommunicationMode = "com" ;"Device" uses COMx c) MTU_DPP1_Set(MinCycleTime) = "minCT" ;"Device" uses too small minCT d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;Master corrects value e) TM_AWAIT_PORT_STATUS(OPERATE) f) MTU_DPP1_Get(MasterCycleTime) ;returning mstCT g) Evaluation 1) h) SMI_PortConfiguration(ABPS_PORTINACTIVE) i) Repeat from b) with next "com", "minCT" |
| Test parameter | | com = {COM1, COM1, COM2, COM2, COM3, COM3} minCT = {0x00, 0x52 (13,6 ms), 0x00, 0x11 (1,7 ms), 0x00, 0x03 (0,3 ms)} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check all mstCT |
| Test passed | | COM1, minCT = 0x00: mstCT ≥ 0x5B (17,2 ms) COM1, minCT = 0x52: mstCT ≥ 0x53 (14,0 ms) COM2, minCT = 0x00: mstCT ≥ 0x16 (2,2 ms) COM2, minCT = 0x11: mstCT ≥ 0x12 (1,8 ms) COM3, minCT = 0x00: mstCT ≥ 0x04 (0,4 ms) COM3, minCT = 0x03: mstCT ≥ 0x04 (0,4 ms) |
| Test not passed (examples) | | Any of the mstCT values < Master limits (see Test passed) |
| Report | | mstCT (COM1, minCT = 0x00): <value> <ok nok> mstCT (COM1, minCT = 0x52): <value> <ok nok> mstCT (COM2, minCT = 0x00): <value> <ok nok> mstCT (COM2, minCT = 0x11): <value> <ok nok> mstCT (COM3, minCT = 0x00): <value> <ok nok> mstCT (COM3, minCT = 0x03): <value> <ok nok> |

1983

1984

8.2.10 Written MasterCycleTime corresponds to real cycle time

Table 184 defines the test conditions for this test case. It should be noted that communication load at other Ports can interfere with the performance of this test.

Table 184 – Written MasterCycleTime corresponds to real cycle time

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|----------------------------|--|
| Identification (ID) | SDCI_TC_0164 | | |
| Name | TCM_PHYL_TIME_MASTERCYCLETIMEREAL | | |
| Purpose (short) | Written MasterCycleTime matches real cycle time | | |
| Equipment under test (EUT) | Master | | |
| Test case version | 1.1 | | |
| Category / type | Master protocol test: test to pass | | |
| Specification (clause) | [7], 7.3.3.3, A.2.6, Table A.11 | | |
| Configuration / setup | Master-Tester-System | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | The Master shall read the MinCycleTime value from Master-Tester-Unit and shall write back its MasterCycleTime value. This time shall be checked by the Master-Tester-Unit. To do so, Master-Tester-Unit shall start several times with different MinCycleTimes and then check them. Master-Tester-Unit receives different values in the Direct Parameter page 1 for the MinCycleTime and carries out a start-up to state OPERATE. In this state the MasterCycleTime is checked. | | |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | | |
| Procedure | a) Assign first value to "com", "minCT" b) MTU_Timing_SetCommunicationMode = "com" ;"Device" uses COMx c) MTU_DPP1_Set(MinCycleTime) = "minCT" ;"Device" uses too small minCT d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;Master corrects value e) TM_AWAIT_PORT_STATUS(OPERATE) f) MTU_DPP1_Get(MasterCycleTime) ;returning Texp g) MTU_Timing_GetTcycleInOperate ;returning TCYC h) Evaluation 1) j) SMI_PortConfiguration(ABPS_PORTINACTIVE) k) Repeat from b) with next "com", "minCT" | | |
| Test parameter | com = {COM1, COM1, COM1, COM1, COM1, COM1, COM2, COM2, COM2, COM2, COM2, COM2, COM2, COM3, COM3, COM3, COM3, COM3, COM3, COM3 } minCT = {0x00, 0x5D, 0x7F, 0x80, 0xBF, 0x00, 0x17, 0x3F, 0x40, 0x7F, 0x80, 0xBF, 0x00, 0x04, 0x3F, 0x40, 0x7F, 0x80, 0xBF} ;see Table A.11 in [7] for recommended MinCycleTimes and Table B.3 in [7] for crossover values | | |
| Post condition | - | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | 1) Check TCYC and Texp | | |
| Test passed | Minimum of TCYC \geq Texp - 1% Maximum of TCYC \leq Texp +10% | | |
| Test not passed (examples) | Minimum of TCYC < Texp - 1% Maximum of TCYC > Texp +10% | | |
| Report | Minimum of TCYC: <value> Maximum of TCYC: <value> | | |
| | <ok nok> <ok nok> | | |

1993 **8.2.11 Master tolerates different Device response times**

1994 Table 185 defines the test conditions for this test case.

1995 **Table 185 – Master tolerates different Device response times**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0165 |
| Name | | TCM_PHYL_TIME_DEVRESPTIMES |
| Purpose (short) | | Master tolerates different Device response times |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.2 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], A.3.5 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master-Tester-Unit shall answer with different response times after receiving the Master message for all transmission rates COM1, COM2, and COM3. The Master shall be able to handle deviations (jitter). Master-Tester-Unit responds with different response times between 1 and 10 TBIT. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) Assign first value to "com" (Test parameter) b) MTU_Timing_SetCommunicationMode = "com" c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) d) TM_AWAIT_PORT_STATUS(OPERATE) e) Assign first value to "TA" (Test parameter) f) MTU_Timing_SetReplyMessageDelay(TA) = "TA" g) MTU_State_GetMasterRetryCTViolCount ; <i>clear RETRIES, CTVIOLS</i> h) SMI_Device Read(ABPS_DEVICEREAD(Index=16)) ; <i>Vendor-Name</i> i) MTU_State_GetMasterRetryCTViolCount ; <i>returning RETRIES, CTVIOLS</i> j) Evaluation 1) k) Repeat from f) with next "TA" l) SMI_PortConfiguration(ABPS_PORTINACTIVE) m) Repeat from b) with next "com" |
| Test parameter | | com = {COM1, COM2, COM3} TA = {1 TBIT, 5 TBIT, 10 TBIT} ; <i>1 TBIT or as fast as possible</i> |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check RETRIES, CTVIOLS |
| Test passed | | RETRIES = 0 and CTVIOLS = 0 |
| Test not passed (examples) | | RETRIES > 0 or CTVIOLS > 0 |
| Report | | CTVIOLS: <value> RETRIES: <value> |
| | | <ok nok> <ok nok> |

1998

1999

2000 **8.2.12 Master tolerates different UART frame delay times (T2)**

2001 Table 186 defines the test conditions for this test case.

2002 **Table 186 – Master tolerates different UART frame delay times (T2)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0166 |
| Name | | TCM_PHYL_TIME_UARTT2 |
| Purpose (short) | | Master tolerates different UART frame delay times (T2) of the Device. |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.2 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], A.3.4 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master-Tester-Unit shall respond with different delays between the octets at all transmission rates COM1, COM2, and COM3. The Master shall be able to handle this variation. Master-Tester-Unit responds with different delays between 0 and 3 TBIT. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) Assign first value to "com" (Test parameter) b) MTU_Timing_SetCommunicationMode = "com" c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) d) TM_AWAIT_PORT_STATUS(OPERATE) e) Assign first value to "T2" (Test parameter) f) MTU_Timing_SetReplyMessageDelay(T2) = "T2" g) MTU_State_GetMasterRetryCTViolCount ; <i>clear RETRIES, CTVIOLS</i> h) SMI_Device Read(ABPS_DEVICEREAD(Index=16)) ; <i>Vendor-Name</i> i) MTU_State_GetMasterRetryCTViolCount ; <i>returning RETRIES, CTVIOLS</i> j) Evaluation 1) k) Repeat from f) with next "T2" l) SMI_PortConfiguration(ABPS_PORTINACTIVE) m) Repeat from b) with next "com" |
| Test parameter | | com = {COM1, COM2, COM3} T2 = {0 TBIT, 1 TBIT, 2 TBIT, 3 TBIT} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check RETRIES, CTVIOLS |
| Test passed | | RETRIES = 0 and CTVIOLS = 0 |
| Test not passed (examples) | | RETRIES > 0 or CTVIOLS > 0 |
| Report | | CTVIOLS: <value> RETRIES: <value> |
| | | <ok nok> <ok nok> |

2005

2006

2007 **8.2.13 Master sends UART frames within tolerated times (T1)**

2008 Table 187 defines the test conditions for this test case.

2009 **Table 187 – Master sends UART frames within tolerated times (T1)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0167 |
| Name | | TCM_PHYL_TIME_UARTT1 |
| Purpose (short) | | Master sends UART frames within tolerated times (T1) |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.2 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], A.3.3 |
| Configuration / setup | | Master-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Measuring the delays between the UART octets for all transmission rates COM1, COM2, and COM3. Master-Tester-Unit shall measure the delays between the end of the stop bit and the beginning of the start bit of the next octet. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) Assign first value to "com" (Test parameter) b) MTU_Timing_SetCommunicationMode = "com" c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) d) TM_AWAIT_PORT_STATUS(O PERATE) e) MTU_Timing_Get_T1 f) Evaluation 1) g) SMI_PortConfiguration(ABPS_PORTINACTIVE) h) Repeat from b) with next "com" <div style="float: right; color: blue; font-size: small;">;returning T1</div> |
| Test parameter | | com = {COM1, COM2, COM3} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check T1 |
| Test passed | | Maximum of T1 ≤ 1 TBIT |
| Test not passed (examples) | | Maximum of T1 > 1 TBIT |
| Report | | Maximum of T1: <value> <ok nok> |

2012

2013

2014 **8.3 Process Data (PD)**2015 **8.3.1 TYPE_2_1 for 8 bit PD input**

2016 Table 188 defines the test conditions for this test case.

2017 **Table 188 – TYPE_2_1 for 8 bit PD input**

2018 -CR086- -CR072-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0168 |
| Name | | TCM_DLPD_CYCC_TYPE21BIT8IN |
| Purpose (short) | | Master uses M-sequence TYPE_2_1 for 8 bit Process Data input |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.4 2 |
| Category / type | | Master M-sequence test: test to pass |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (row 5) |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master reads PD input length = 8 bit and output length = 0 bit during STARTUP from Device. Master shall select M-sequence TYPE_2_1 in OPERATE and propagate this information to SMI_PDin, SMI_PDIInOut and SMI_PortStatus services. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | <p>a) MTU_DPP1_Set(M-sequenceCapability) = 0x11 ;see B.1.4 in [7] b) MTU_DPP1_Set(PDIn length) = 0x08 ;"8" Bit c) MTU_DPP1_Set(PDOut length) = 0x00 ;"0" Bit d) MTU_PD_Set = 0x12 ;PDIn = 0x12 e) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;Switch to OPERATE f) TM_GET_PORT_STATUS(OPERATE) TM_AWAIT_PORT_STATUS(OPERATE) ;Wait for OPERATE g) MTU_State_CheckOperate ;returns "MTU in OPERATE" h) Evaluation 1) i) SMI_PDIn ;returns "ArgBlock PDIn" j) Evaluation 2) ;returns "ArgBlock PDIInOut" k) SMI_PDIInOut l) Evaluation 3) m) SMI_PortStatus ;returns "ArgBlock PortStatusList" n) Evaluation 4) o) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) p) Evaluation 5)</p> |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | <p>1) Check "MTU in OPERATE" 2) Check "ArgBlock PDIn" 3) Check "ArgBlock PDIInOut" 4) Check "ArgBlock PortStatusList" 5) Check <vendorname></p> |
| Test passed | | <p>"MTU in OPERATE" = TRUE, and PDIn: PQI = 0xA0, InputDataLength = 1, PDI0 = [0x12], and PDIInOut: PQI = 0xA0, OE = 0x00, InputDataLength = 1, PDI0 = [0x12], OutputDataLength = 0, and PortStatusList: PortQualityInfo = 0x04 0x02, RevisionID = 0x11, InputDataLength = 1, OutputDataLength = 0, and <vendorname> = IO-Link Community</p> |
| Test not passed (examples) | | Any of the checks in Test passed failed or communication error |

| TEST CASE RESULTS | CHECK / REACTION |
|-------------------|--|
| Report | <vendorname> correct: <yes/no> <ok nok> |

2021

2022 **8.3.2 TYPE_2_2 for 16 bit PD input**

2023 Table 189 defines the test conditions for this test case.

2024 **Table 189 – TYPE_2_2 for 16 bit PD input**

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| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0169 |
| Name | | TCM_DLPD_CYCC_TYPE22BIT16IN |
| Purpose (short) | | Master uses M-sequence TYPE_2_2 for 16 bit Process Data input |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master M-sequence test: test to pass |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (row 6) |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master reads PD input length = 16 bit and output length = 0 bit during STARTUP from Device. Master shall select M-sequence TYPE_2_2 in OPERATE and propagate this information to SMI_PDin, SMI_PDIInOut and SMI_PortStatus services. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x11 ;see B.1.4 in [7] b) MTU_DPP1_Set(PDIn length) = 0x10 ;"16" Bit c) MTU_DPP1_Set(PDOut length) = 0x00 ;"0" Bit d) MTU_PD_Set = 0x1234 ;PDIn = 0x1234 e) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;Switch to OPERATE f) TM_GET_PORT_STATUS TM_AWAIT_PORT_STATUS (OPERATE) <i>;Wait for OPERATE</i> g) MTU_State_CheckOperate ;returns "MTU in OPERATE" h) Evaluation 1) i) SMI_PDIn ;returns "ArgBlock PDIn" j) Evaluation 2) k) SMI_PDIInOut ;returns "ArgBlock PDIInOut" l) Evaluation 3) m) SMI_PortStatus ;returns "ArgBlock PortStatusList" n) Evaluation 4) o) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) p) Evaluation 5) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check "ArgBlock PDIn" 3) Check "ArgBlock PDIInOut" 4) Check "ArgBlock PortStatusList" 5) Check <vendorname> |
| Test passed | | "MTU in OPERATE" = TRUE, and PDIn: PQI = 0xA0, InputDataLength = 2, PDI = [0x12, 0x34], and PDIInOut: PQI = 0xA0, OE = 0x00, InputDataLength = 2, PDI = [0x12, 0x34], OutputDataLength = 0, and PortStatusList: PortQualityInfo= 0x01 0x02, RevisionID = 0x11, InputDataLength = 2, OutputDataLength = 0, and <vendorname> = "IO-Link Community" |
| Test not passed (examples) | | Any of the checks in Test passed failed or communication error |
| Report | | <vendorname> correct: <yes/no> <ok nok> |

2028

2029 **8.3.3 TYPE_2_3 for 8 bit PD output**

2030 Table 190 defines the test conditions for this test case.

2031 **Table 190 – TYPE_2_3 for 8 bit PD output**

2032 -CR072-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0170 |
| Name | | TCM_DLPD_CYCC_TYPE23BIT8OUT |
| Purpose (short) | | Master uses M-sequence TYPE_2_3 for 8 bit Process Data output |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.4 2 |
| Category / type | | Master M-sequence test: test to pass |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (row 7) |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master reads PD input length = 0 bit and output length = 8 bit during STARTUP from Device. Master shall select M-sequence TYPE_2_3 in OPERATE and propagate this information to SMI_PDIn, SMI_PDIInOut and SMI_PortStatus services. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x11 ;see B.1.4 in [7] b) MTU_DPP1_Set(PDIn length) = 0x00 ;"0" Bit c) MTU_DPP1_Set(PDOut length) = 0x08 ;"8" Bit d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;Switch to OPERATE e) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE state f) MTU_State_CheckOperate ;returns "MTU in OPERATE" g) Evaluation 1) h) SMI_PDOOut(ABPS_PDOOUT<PDO0=0x12>) ;PDO0 = 0x12 i) SMI_PDIInOut ;returns "ArgBlock PDIInOut" j) Evaluation 2) k) MTU_PD_Get ;returns "PDOut values" l) Evaluation 3) m) SMI_PortStatus ;returns "ArgBlock PortStatusList" n) Evaluation 4) o) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) p) Evaluation 5) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check "ArgBlock PDIInOut" 3) Check "PDOut values" 4) Check "ArgBlock PortStatusList" 5) Check <vendorname> |
| Test passed | | "MTU in OPERATE" = TRUE, and PDIInOut: PQI = 0x20 0xA0 , OE = 1, InputDataLength = 0, OutputDataLength = 1, PDO0 = [0x12], and "PDout values" = 0x12, and PortStatusList: PortQualityInfo= 0x02 0x00 , RevisionID = 0x11, InputDataLength = 0, OutputDataLength = 1, and <vendorname> = "IO-Link Community" |
| Test not passed (examples) | | Any of the checks in Test passed failed or communication error |
| Report | | <vendorname> correct: <yes/no> <ok nok> |

2035

2036 **8.3.4 TYPE_2_4 for 16 bit PD output**

2037 Table 191 defines the test conditions for this test case.

2038 **Table 191 – TYPE_2_4 for 16 bit PD output**

2039 -CR072-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0171 |
| Name | | TCM_DLPD_CYCC_TYPE24BIT16OUT |
| Purpose (short) | | Master uses M-sequence TYPE_2_4 for 16 bit Process Data output |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.4 2 |
| Category / type | | Master M-sequence test: test to pass |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (row 8) |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master reads PD input length = 0 bits, Output length = 16 bit during STARTUP from Device. Master shall select M-sequence TYPE_2_4 in OPERATE and propagate this information to SMI_PDIn, SMI_PDIInOut and SMI_PortStatus services. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x11 ;see B.1.4 in [7] b) MTU_DPP1_Set(PDIn length) = 0x00 ;"0" Bit c) MTU_DPP1_Set(PDOut length) = 0x10 ;"16" Bit d) SMI_PortConfiguration (ABPS_NOTYPE_CHECK) ;switch to OPERATE e) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE f) MTU_State_CheckOperate ;returns "MTU in OPERATE" g) Evaluation 1) h) SMI_PDOOut(ABPS_PDOOUT<PDO0=0x12, PDO1=0x34>) ;set PDOut = 0x1234 i) SMI_PDIInOut ;returns "ArgBlock PDIInOut" j) Evaluation 2) k) MTU_PD_Get ;returns "PDOut values" l) Evaluation 3) m) SMI_PortStatus ;returns "ArgBlock PortStatusList" n) Evaluation 4) o) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check "ArgBlock PDIInOut" 3) Check "PDOut values" 4) Check "ArgBlock PortStatusList" 5) Check <vendorname> |
| Test passed | | "MTU in OPERATE" = TRUE, and PDIInOut: PQI = 0x20 0xA0 , OE = 1, InputDataLength = 0, OutputDataLength = 2, PDO = [0x12, 0x34], and "PDOut values" = 0x12, 0x34, and PortStatusList: PortQualityInfo= 0x02 0x00 , RevisionID = 0x11, InputDataLength = 0, OutputDataLength = 2, and <vendorname> = "IO-Link Community" |
| Test not passed (examples) | | Any of the checks in Test passed failed or communication error |
| Report | | <vendorname> correct: <yes/no> <ok nok> |

2043 **8.3.5 TYPE_2_5 for 8/8 bit PD in/output**

2044 Table 192 defines the test conditions for this test case.

2045 **Table 192 – TYPE_2_5 for 8/8 bit PD in/output**

2046 -CR072-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0172 |
| Name | | TCM_DLPD_CYCC_TYPE25BIT8INBIT8OUT |
| Purpose (short) | | Master uses M-sequence TYPE_2_5 for 8/8 bit Process Data in/output |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.4 2 |
| Category / type | | Master M-sequence test: test to pass |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (row 9) |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master reads PD input length = 8 bits, Output length = 8 bit during STARTUP from Device. Master shall select M-sequence TYPE_2_5 in OPERATE and propagate this information to the SMI_PDIn, SMI_PDIOut and SMI_PortStatus services. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x11 ;see B.1.4 in [7] b) MTU_DPP1_Set(PDIn length) = 0x08 ;"8" Bit c) MTU_DPP1_Set(PDOut length) = 0x08 ;"8" Bit d) MTU_PD_Set = 0x12 ;PDIn = 0x12 e) SMI_PortConfiguration (ABPS_NOTYPE_CHECK) ;Switch to OPERATE f) TM_AWAIT_PORT_STATUS(OPERATE) ;Wait for OPERATE g) MTU_State_CheckOperate ;returns "MTU in OPERATE" h) Evaluation 1) i) SMI_PDIOut(ABPS_PDOOUT<PDO0=0x34>) ;PDO0 = 0x34 j) SMI_PDIn ;returns "ArgBlock PDIn" k) Evaluation 2) l) SMI_PDIOut ;returns "ArgBlock PDIOut" m) Evaluation 3) n) MTU_PD_Get ;returns "PDOut values" o) Evaluation 4) p) SMI_PortStatus ;returns "ArgBlock PortStatusList" q) Evaluation 5) r) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) s) Evaluation 6) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check "ArgBlock PDIn" 3) Check "ArgBlock PDIOut" 4) Check "PDout values" 5) Check "ArgBlock PortStatusList" 6) Check <vendorname> |
| Test passed | | "MTU in OPERATE" = TRUE, and PDIn: PQI = 0xA0, InputDataLength = 1, PDI0 = [0x12], and PDIOut: PQI = 0xA0, OE = 1, InputDataLength = 1, PDI0 = [0x12], OutputDataLength = 1, PDO0 = [0x34], and "PDout values" = 0x34, and PortStatusList: PortQualityInfo=0x03 0x00 , RevisionID = 0x11, InputDataLength = 1, OutputDataLength = 1, and <vendorname> = "IO-Link Community" |
| Test not passed (examples) | | Any of the checks in Test passed failed or communication error |

| TEST CASE RESULTS | CHECK / REACTION | |
|-------------------|--------------------------------|------------|
| Report | <vendorname> correct: <yes/no> | <ok nok> |

2049

2050 **8.3.6 TYPE_2_V for 16/16 bit PD in/output and 1 octet OD**

2051 Table 192 defines the test conditions for this test case.

2052 **Table 193 – TYPE_2_V for 16/16 bit PD in/output and 1 octet OD**

2053 -CR072-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0298 |
| Name | | TCM_DLPD_CYCC_TYPE2VBIT16INBIT16OUT |
| Purpose (short) | | Master uses M-sequence TYPE_2_V for 16/16 bit Process Data in/output |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.4 2 |
| Category / type | | Master M-sequence test: test to pass |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (row 10 and 11) |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master reads PD input length = 16 bit, Output length = 16 bit during STARTUP from Device. Master shall select M-sequence TYPE_2_V with 1 octet OD in OPERATE and propagate information to SMI_PDIn, SMI_PDIOut, and SMI_PortStatus. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x11 ;see B.1.4 in [7] b) MTU_DPP1_Set(PDIn length) = 0x10 ;"16" Bit c) MTU_DPP1_Set(PDOut length) = 0x10 ;"16" Bit d) MTU_PD_Set = 0x1234 ;PDIn = 0x1234 e) SMI_PortConfiguration (ABPS_NOTYPE_CHECK) ;switch to OPERATE f) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE g) MTU_State_CheckOperate ;returns "MTU in OPERATE" h) Evaluation 1) i) SMI_PDIOut(ABPS_PDOOUT<PDO0=0x56, PDO1=0x78>) ;PDO = 0x5678 j) SMI_PDIn ;returns "ArgBlock PDIn" k) Evaluation 2) l) SMI_PDIOut ;returns "ArgBlock PDIOut" m) Evaluation 3) n) MTU_PD_Get ;returns "PDOut values" o) Evaluation 4) p) SMI_PortStatus ;returns "ArgBlock PortStatusList" q) Evaluation 5) r) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) s) Evaluation 6) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check "ArgBlock PDIn" 3) Check "ArgBlock PDIOut" 4) Check "PDOut values" 5) Check "ArgBlock PortStatusList" 6) Check <vendorname> |
| Test passed | | "MTU in OPERATE" = TRUE, and PDIn: PQI = 0xA0, InputDataLength = 2, PDI = [0x12, 0x34], and PDIOut: PQI = 0xA0, OE = 0x01, InputDataLength = 2, PDI = [0x12, 0x34], OutputDataLength = 2, PDO = [0x56, 0x78], and "PDOut values" = 0x56, 0x78, and PortStatusList: PortQInfo = 0x03 0x00 , RevID = 0x11, InDLen = 2, OutDLen = 2, and <vendorname> = "IO-Link Community" |

| TEST CASE RESULTS | CHECK / REACTION |
|----------------------------|--|
| Test not passed (examples) | Any of the checks in Test passed failed or communication error |
| Report | <vendorname> correct: <yes/no> <ok nok> |

2056

2057 **8.3.7 TYPE_1_1 for 32 octets PD in and 2 octets OD**

2058 Table 194 defines the test conditions for this test case.

2059 **Table 194 – TYPE_1_1 for 32 octets PD in and 2 octets OD**

2060 -CR072-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|---|--|
| Identification (ID) | | SDCI_TC_0173 | |
| Name | | TCM_DLPD_CYCC_TYPE1OCTET32IN | |
| Purpose (short) | | Master uses M-sequence TYPE_1_1 for 32/0 octets PD input and 2 octets OD | |
| Equipment under test (EUT) | | Master + Port | |
| Test case version | | 1.4 2 | |
| Category / type | | Master M-sequence test: test to pass | |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (row 3) | |
| Configuration / setup | | Master-Tester-System | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | | Master reads PD input length = 256 bits, Output length = 0 bit during STARTUP from Device. Master shall select M-sequence TYPE_1_1 with 2 octets OD in OPERATE and propagate this information to SMI_PDIn, SMI_PDIOut and SMI_PortStatus services. | |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x13 ;see B.1.4 in [7] b) MTU_DPP1_Set(RevisionID) = 0x10 ;see B.1.1 in [7] c) MTU_DPP1_Set(PDIn length) = 0x100 ;"256" Bit = 32 octets d) MTU_DPP1_Set(PDOOut length) = 0x00 ;"0" Bit e) MTU_PD_Set = 2^256-1 ;all Bits "1" f) SMI_PortConfiguration (ABPS_NOTYPE_CHECK) ;switch to OPERATE g) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE h) MTU_State_CheckOperate ;returns "MTU in OPERATE" i) Evaluation 1) j) SMI_PDIn ;returns "ArgBlock PDIn" k) Evaluation 2) l) SMI_PDIOut ;returns "ArgBlock PDIOut" m) Evaluation 3) n) SMI_PortStatus ;returns "ArgBlock PortStatusList" o) Evaluation 4) p) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) q) Evaluation 5) | |
| Test parameter | | – | |
| Post condition | | – | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check "ArgBlock PDIn" 3) Check "ArgBlock PDIOut" 4) Check "ArgBlock PortStatusList" 5) Check <vendorname> | |
| Test passed | | "MTU in OPERATE" = TRUE, and PDIn: PQI = 0xA0, InputDataLength = 0x20, PDI[0 ... 31] = 0xFF, and PDIOut: PQI = 0xA0, OE = 0 0x00 , InputDataLength = 0x20, PDI[0 ... 31] = 0xFF, OutputDataLength = 0, and PortStatusList: PortQualityInfo = 0x04 0x02 , RevisionID = 0x10, InputDataLength = 0x20, OutputDataLength = 0, and <vendorname> = "IO-Link Community" | |
| Test not passed (examples) | | Any of the checks in Test passed failed or communication error | |

| TEST CASE RESULTS | CHECK / REACTION | |
|-------------------|--------------------------------|------------|
| Report | <vendorname> correct: <yes/no> | <ok nok> |

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2065 **8.3.8 TYPE_2_V for 0/32 octets PD in/out and variable octets OD**
2066 Table 195 defines the test conditions for this test case.

2067 **Table 195 – TYPE_2_V for 0/32 octets PD in/out and variable octets OD**

2068 -CR072-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0334 |
| Name | | TCM_DLPD_CYCC_TYPE2VOD1IN0OUT32OCTET |
| Purpose (short) | | Master uses M-sequence TYPE_2_V for 0/32 octets PD in/out and variable ODs |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.4 2 |
| Category / type | | Master M-sequence test: test to pass |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (rows 12, 15, 17, and 19) |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master reads OD length = 1 and PD input length = 0 bits, Output length = 256 bits during STARTUP from Device. Master shall select M-sequence TYPE_2_V in OPERATE and propagate this information to SMI_PDIIn, SMI_PDIInOut and SMI_PortStatus services. Different OD lengths are tested within the test procedure loop (TPL). |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) Assign first value to "Mscap" (Test parameter) b) MTU_DPP1_Set(M-sequenceCapability) = "Mscap" ;see B.1.4 in [7] c) MTU_DPP1_Set(PDIIn length) = 0x00 ;"0" Bit d) MTU_DPP1_Set(PDOut length) = 0x100 ;"256" Bit e) SMI_PortConfiguration (ABPS_NOTYPE_CHECK) ;switch to OPERATE f) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE g) MTU_State_CheckOperate ;returns "MTU in OPERATE" h) Evaluation 1) i) SMI_PDOOut(ABPS_PDOOUT<PDO[0..31]=0xFF>) ;PDO all bits "1" j) SMI_PDIInOut ;returns "ArgBlock PDIInOut" k) Evaluation 2) l) MTU_PD_Get ;returns "PDOut values" m) Evaluation 3) n) SMI_PortStatus ;returns "ArgBlock PortStatusList" o) Evaluation 4) p) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) q) Evaluation 5) r) SMI_PortConfiguration (ABPS_PORT_INACTIVE) ;SIO mode s) Repeat from b) with "Mscap" = next value from Test parameter |
| Test parameter | | Mscap = {0x19, 0x1B, 0x1D, 0x1F} ;M-sequence capability |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | For all TPL: 1) Check "MTU in OPERATE" 2) Check "ArgBlock PDIInOut" 3) Check "PDout values" 4) Check "ArgBlock PortStatusList" 5) Check <vendorname> |
| Test passed | | "MTU in OPERATE" = TRUE, and PDIIn: PQI = 0x20 0xA0 , OE = 0x01, InputDataLength = 0x00, OutputDataLength = 0x20, PDO[0 ... 31] = 0xFF, and PortStatusList: PortQualityInfo = 0x02 0x00 , RevisionID = 0x11, InputDataLength = 0x20, OutputDataLength = 0, and <vendorname> = "IO-Link Community" |
| Test not passed (examples) | | Any of the checks in Test passed failed or communication error |
| Report | | <vendorname> correct: <yes/no> <ok nok> |

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| | 8.3.9 TYPE_2_V for 32/0 octets PD in/out and variable octets OD | | | | | | | | | | | | | | | | | | |
|---|--|----------------------|----------------------------|---------------------|--|--------------|---|-----------------|--|----------------------------|--|-------------------|--------------|-----------------|--------------------------------------|------------------------|---|-----------------------|----------------------|
| 2073 | Table 196 defines the test conditions for this test case. | | | | | | | | | | | | | | | | | | |
| Table 196 – TYPE_2_V for 32/0 octets PD in/out and variable octets OD | | | | | | | | | | | | | | | | | | | |
| 2074 | -CR072- | | | | | | | | | | | | | | | | | | |
| <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th style="text-align: left; padding: 2px;">TEST CASE ATTRIBUTES</th><th style="text-align: left; padding: 2px;">IDENTIFICATION / REFERENCE</th></tr> </thead> <tbody> <tr> <td style="padding: 2px;">Identification (ID)</td><td style="padding: 2px;">SDCI_TC_0335</td></tr> <tr> <td style="padding: 2px;">Name</td><td style="padding: 2px;">TCM_DLPD_CYCC_TYPE2VOD1IN32OUT0OCTET</td></tr> <tr> <td style="padding: 2px;">Purpose (short)</td><td style="padding: 2px;">Master uses M-sequence TYPE_2_V for 32/0 octets PD in/out and variable ODs</td></tr> <tr> <td style="padding: 2px;">Equipment under test (EUT)</td><td style="padding: 2px;">Master + Port</td></tr> <tr> <td style="padding: 2px;">Test case version</td><td style="padding: 2px;">1.4 2</td></tr> <tr> <td style="padding: 2px;">Category / type</td><td style="padding: 2px;">Master M-sequence test: test to pass</td></tr> <tr> <td style="padding: 2px;">Specification (clause)</td><td style="padding: 2px;">[7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (rows 13, 14, 16, and 18)</td></tr> <tr> <td style="padding: 2px;">Configuration / setup</td><td style="padding: 2px;">Master-Tester-System</td></tr> </tbody> </table> | | TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | Identification (ID) | SDCI_TC_0335 | Name | TCM_DLPD_CYCC_TYPE2VOD1IN32OUT0OCTET | Purpose (short) | Master uses M-sequence TYPE_2_V for 32/0 octets PD in/out and variable ODs | Equipment under test (EUT) | Master + Port | Test case version | 1.4 2 | Category / type | Master M-sequence test: test to pass | Specification (clause) | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (rows 13, 14, 16, and 18) | Configuration / setup | Master-Tester-System |
| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | | | | | | | | | | | | | | | | | | |
| Identification (ID) | SDCI_TC_0335 | | | | | | | | | | | | | | | | | | |
| Name | TCM_DLPD_CYCC_TYPE2VOD1IN32OUT0OCTET | | | | | | | | | | | | | | | | | | |
| Purpose (short) | Master uses M-sequence TYPE_2_V for 32/0 octets PD in/out and variable ODs | | | | | | | | | | | | | | | | | | |
| Equipment under test (EUT) | Master + Port | | | | | | | | | | | | | | | | | | |
| Test case version | 1.4 2 | | | | | | | | | | | | | | | | | | |
| Category / type | Master M-sequence test: test to pass | | | | | | | | | | | | | | | | | | |
| Specification (clause) | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (rows 13, 14, 16, and 18) | | | | | | | | | | | | | | | | | | |
| Configuration / setup | Master-Tester-System | | | | | | | | | | | | | | | | | | |
| <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th style="text-align: left; padding: 2px;">TEST CASE</th><th style="text-align: left; padding: 2px;">CONDITIONS / PERFORMANCE</th></tr> </thead> <tbody> <tr> <td style="padding: 2px;">Purpose (detailed)</td><td style="padding: 2px;">Master reads OD length = 1 and PD input length = 256 bits, Output length = 0 bit during STARTUP from Device. Master shall select M-sequence TYPE_2_V in OPERATE and propagate this information to SMI_PDIn, SMI_PDIInOut, and SMI_PortStatus services. Different OD lengths are tested within the test procedure loop (TPL).</td></tr> <tr> <td style="padding: 2px;">Precondition</td><td style="padding: 2px;">EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE</td></tr> <tr> <td style="padding: 2px;">Procedure</td><td style="padding: 2px;"> a) Assign first value to "Mscap" (Test parameter) b) MTU_DPP1_Set(M-sequenceCapability) = "Mscap" ;see B.1.4 in [7] c) MTU_DPP1_Set(PDIn length) = 0x100 ;"256" Bit d) MTU_DPP1_Set(PDOut length) = 0x00 ;"0" Bit e) MTU_PD_Set = 2^256-1 ;PDIn = all bits set f) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;switch to OPERATE g) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE h) MTU_State_CheckOperate ;returns "MTU in OPERATE" i) Evaluation 1) j) SMI_PDIn ;returns "ArgBlock PDIn" k) Evaluation 2) l) SMI_PDIInOut ;returns "ArgBlock PDIInOut" m) Evaluation 3) n) SMI_PortStatus ;returns "ArgBlock PortStatusList" o) Evaluation 4) p) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) q) Evaluation 5) r) SMI_PortConfiguration (ABPS_PORT_INACTIVE) ;SIO mode s) Repeat from b) with "Mscap" = next value from Test parameter </td></tr> <tr> <td style="padding: 2px;">Test parameter</td><td style="padding: 2px;">Mscap = {0x19, 0x1B, 0x1D, 0x1F} ;M-sequence capability</td></tr> <tr> <td style="padding: 2px;">Post condition</td><td style="padding: 2px;">–</td></tr> </tbody> </table> | | TEST CASE | CONDITIONS / PERFORMANCE | Purpose (detailed) | Master reads OD length = 1 and PD input length = 256 bits, Output length = 0 bit during STARTUP from Device. Master shall select M-sequence TYPE_2_V in OPERATE and propagate this information to SMI_PDIn, SMI_PDIInOut, and SMI_PortStatus services. Different OD lengths are tested within the test procedure loop (TPL). | Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | Procedure | a) Assign first value to "Mscap" (Test parameter) b) MTU_DPP1_Set(M-sequenceCapability) = "Mscap" ;see B.1.4 in [7] c) MTU_DPP1_Set(PDIn length) = 0x100 ;"256" Bit d) MTU_DPP1_Set(PDOut length) = 0x00 ;"0" Bit e) MTU_PD_Set = 2^256-1 ;PDIn = all bits set f) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;switch to OPERATE g) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE h) MTU_State_CheckOperate ;returns "MTU in OPERATE" i) Evaluation 1) j) SMI_PDIn ;returns "ArgBlock PDIn" k) Evaluation 2) l) SMI_PDIInOut ;returns "ArgBlock PDIInOut" m) Evaluation 3) n) SMI_PortStatus ;returns "ArgBlock PortStatusList" o) Evaluation 4) p) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) q) Evaluation 5) r) SMI_PortConfiguration (ABPS_PORT_INACTIVE) ;SIO mode s) Repeat from b) with "Mscap" = next value from Test parameter | Test parameter | Mscap = {0x19, 0x1B, 0x1D, 0x1F} ;M-sequence capability | Post condition | – | | | | | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | | | | | | | | | | | | | | | | | |
| Purpose (detailed) | Master reads OD length = 1 and PD input length = 256 bits, Output length = 0 bit during STARTUP from Device. Master shall select M-sequence TYPE_2_V in OPERATE and propagate this information to SMI_PDIn, SMI_PDIInOut, and SMI_PortStatus services. Different OD lengths are tested within the test procedure loop (TPL). | | | | | | | | | | | | | | | | | | |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | | | | | | | | | | | | | | | | | | |
| Procedure | a) Assign first value to "Mscap" (Test parameter) b) MTU_DPP1_Set(M-sequenceCapability) = "Mscap" ;see B.1.4 in [7] c) MTU_DPP1_Set(PDIn length) = 0x100 ;"256" Bit d) MTU_DPP1_Set(PDOut length) = 0x00 ;"0" Bit e) MTU_PD_Set = 2^256-1 ;PDIn = all bits set f) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;switch to OPERATE g) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE h) MTU_State_CheckOperate ;returns "MTU in OPERATE" i) Evaluation 1) j) SMI_PDIn ;returns "ArgBlock PDIn" k) Evaluation 2) l) SMI_PDIInOut ;returns "ArgBlock PDIInOut" m) Evaluation 3) n) SMI_PortStatus ;returns "ArgBlock PortStatusList" o) Evaluation 4) p) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) q) Evaluation 5) r) SMI_PortConfiguration (ABPS_PORT_INACTIVE) ;SIO mode s) Repeat from b) with "Mscap" = next value from Test parameter | | | | | | | | | | | | | | | | | | |
| Test parameter | Mscap = {0x19, 0x1B, 0x1D, 0x1F} ;M-sequence capability | | | | | | | | | | | | | | | | | | |
| Post condition | – | | | | | | | | | | | | | | | | | | |
| <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th style="text-align: left; padding: 2px;">TEST CASE RESULTS</th><th style="text-align: left; padding: 2px;">CHECK / REACTION</th></tr> </thead> <tbody> <tr> <td style="padding: 2px;">Evaluation</td><td style="padding: 2px;"> For all TPL: 1) Check "MTU in OPERATE" 2) Check "ArgBlock PDIn" </td></tr> <tr> <td style="padding: 2px;"></td><td style="padding: 2px;"> 3) Check "ArgBlock PDIInOut" 4) Check "ArgBlock PortStatusList" 5) Check <vendorname> </td></tr> <tr> <td style="padding: 2px;">Test passed</td><td style="padding: 2px;"> "MTU in OPERATE" = TRUE, and PDIn: PQI = 0xA0, InputDataLength = 0x20, PDI[0 ... 31] = 0xFF, and PDIInOut: PQI = 0xA0, OE = 0x00, InputDataLength = 0x20, PDI[0 ... 31] = 0xFF, OutputDataLength = 0, and PortStatusList: PortQualityInfo=0x04 0x02, RevisionID = 0x11, InputDataLength = 0x20, OutputDataLength = 0, and <vendorname> = "IO-Link Community" </td></tr> <tr> <td style="padding: 2px;">Test not passed (examples)</td><td style="padding: 2px;">Any of the checks in Test passed failed or communication error</td></tr> </tbody> </table> | | TEST CASE RESULTS | CHECK / REACTION | Evaluation | For all TPL: 1) Check "MTU in OPERATE" 2) Check "ArgBlock PDIn" | | 3) Check "ArgBlock PDIInOut" 4) Check "ArgBlock PortStatusList" 5) Check <vendorname> | Test passed | "MTU in OPERATE" = TRUE, and PDIn: PQI = 0xA0, InputDataLength = 0x20, PDI[0 ... 31] = 0xFF, and PDIInOut: PQI = 0xA0, OE = 0x00, InputDataLength = 0x20, PDI[0 ... 31] = 0xFF, OutputDataLength = 0, and PortStatusList: PortQualityInfo=0x04 0x02 , RevisionID = 0x11, InputDataLength = 0x20, OutputDataLength = 0, and <vendorname> = "IO-Link Community" | Test not passed (examples) | Any of the checks in Test passed failed or communication error | | | | | | | | |
| TEST CASE RESULTS | CHECK / REACTION | | | | | | | | | | | | | | | | | | |
| Evaluation | For all TPL: 1) Check "MTU in OPERATE" 2) Check "ArgBlock PDIn" | | | | | | | | | | | | | | | | | | |
| | 3) Check "ArgBlock PDIInOut" 4) Check "ArgBlock PortStatusList" 5) Check <vendorname> | | | | | | | | | | | | | | | | | | |
| Test passed | "MTU in OPERATE" = TRUE, and PDIn: PQI = 0xA0, InputDataLength = 0x20, PDI[0 ... 31] = 0xFF, and PDIInOut: PQI = 0xA0, OE = 0x00, InputDataLength = 0x20, PDI[0 ... 31] = 0xFF, OutputDataLength = 0, and PortStatusList: PortQualityInfo=0x04 0x02 , RevisionID = 0x11, InputDataLength = 0x20, OutputDataLength = 0, and <vendorname> = "IO-Link Community" | | | | | | | | | | | | | | | | | | |
| Test not passed (examples) | Any of the checks in Test passed failed or communication error | | | | | | | | | | | | | | | | | | |

| TEST CASE RESULTS | CHECK / REACTION |
|-------------------|--|
| Report | <vendorname> correct: <yes/no> <ok nok> |

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2080 **8.3.10 Master reads mirrored PD in/out from Device**

2081 Table 197 defines the test conditions for this test case.

2082 **Table 197 – Master reads mirrored PD in/out from Device**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|--|
| Identification (ID) | | SDCI_TC_0176 | |
| Name | | TCM_DLPD_CYCC_MIRROREDPD | |
| Purpose (short) | | Master reads mirrored Process Data in/out from Device | |
| Equipment under test (EUT) | | Master + Port | |
| Test case version | | 1.1 | |
| Category / type | | Master M-sequence test: test to pass | |
| Specification (clause) | | [7], 7.3.3.2, 9.2.3.5 | |
| Configuration / setup | | Master-Tester-System | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | | Device (MTU) mirrors its PD such that the Master can check consistency. | |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x11 ;see B.1.4 in [7] b) MTU_DPP1_Set(PDIn length) = 0x10 ;"16" Bit c) MTU_DPP1_Set(PDOut length) = 0x10 ;"16" Bit d) SMI_PortConfiguration (ABPS_NOTYPE_CHECK) ;switch to OPERATE e) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE f) MTU_State_MirrorPD ;perform PD mirroring g) SMI_PDOOut(ABPS_PDOOUT<OutputDataLength=2, PDO0=0x12, PDO1=0x34>) ;returns "ArgBlock PDIn1" h) SMI_PDIn i) Evaluation 1) j) SMI_PDOOut (ABPS_PDOOUT<OutputDataLength=2, PDO0=0x56, PDO1=0x78>) ;returns "ArgBlock PDIn2" k) SMI_PDIn l) Evaluation 2) | |
| Test parameter | | – | |
| Post condition | | – | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | | 1) Check "ArgBlock PDIn1" 2) Check "ArgBlock PDIn2" | |
| Test passed | | PDIn1: PDI = [0x12, 0x34], and PDIn2: PDI = [0x56, 0x78] | |
| Test not passed (examples) | | Inconsistency between transmitted and received process data | |
| Report | | Sent and received PD match: <ok nok> | |

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2087 **8.3.11 Master propagates "PD invalid" indication in a correct manner**

2088 Table 198 defines the test conditions for this test case.

2089 **Table 198 – Master propagates "PD invalid" indication in a correct manner**

2090 -CR063-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0177 |
| Name | TCM_DLPD_CYCC_PDINVALID |
| Purpose (short) | Master propagates "PD invalid" indication in a correct manner |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.4 2 |
| Category / type | Master M-sequence test: test to pass |
| Specification (clause) | [7], A.1.5 and Table A.5 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | PDValid – PDInvalid transition reported correctly. |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | a) MTU_DPP1_Set(RevisionID) = 0x11 ;see B.1.1 in [7] b) a) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;switch to OPERATE c) b) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE d) c) SMI_PDI ;returns "ArgBlock PDI_1" f) d) Evaluation 1) e) SMI_PortStatus ;returns "ArgBlock PortStatusList_1" f) Evaluation 2) g) MTU_State_SetPDValidity(INVALID) ;PD invalid h) SMI_PDI ;returns "ArgBlock PDI_2" f) Evaluation 3) i) SMI_PortStatus ;returns "ArgBlock PortStatusList_2" j) Evaluation 4) k) SMI_PortConfiguration(ABPS_PORTINACTIVE) ;switch to Deactivated l) MTU_State_SetPDValidity(VALID) ;PD valid |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "ArgBlock PDI_1" 2) Check "ArgBlock PortStatusList_1" 3) Check "ArgBlock PDI_2" 4) Check "ArgBlock PortStatusList_2" |
| Test passed | PDI_1: PQI = 0xA0, and PortStatusList_1: PortQualityInfo.Bit0 = VALID, and PDI_2: PQI = 0x20, and PortStatusList_2: PortQualityInfo.Bit0 = INVALID |
| Test not passed (examples) | Master defines PDI_1 in upper-level system as invalid and/or Master defines PDI_2 in upper-level system as valid |
| Report | "PDValidity" propagated correctly to upper-level system: <ok nok> |

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2095 **8.3.12 Master propagates "PD valid" indication in a correct manner**

2096 Table 199 defines the test conditions for this test case.

2097 **Table 199 – Master propagates "PD valid" indication in a correct manner**

2098 -CR064-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|--|
| Identification (ID) | | SDCI_TC_0178 | |
| Name | | TCM_DLPD_CYCC_PDVALID | |
| Purpose (short) | | Master propagates "PD Valid" indication in a correct manner | |
| Equipment under test (EUT) | | Master + Port | |
| Test case version | | 1.4 2 | |
| Category / type | | Master M-sequence test: test to pass | |
| Specification (clause) | | [7], A.1.5 and Table A.5 | |
| Configuration / setup | | Master-Tester-System | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | | PDIInvalid – PDValid transition reported correctly. | |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | |
| Procedure | | a) MTU_DPP1_Set(RevisionID) = 0x11 ;see B.1.1 in [7] b) a) MTU_State_SetPDValidity(INVALID) ;PD invalid c) b) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;switch to OPERATE d) c) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE e) d) MTU_State_SetPDValidity(VALID) ;PD valid f) e) SMI_PDIIn ;returns "ArgBlock PDIIn" g) f) Evaluation 1 h) g) SMI_PortStatus ;returns "ArgBlock PortStatusList" i) h) Evaluation 2 | |
| Test parameter | | – | |
| Post condition | | – | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | | 1) Check "ArgBlock PDIIn" 2) Check "ArgBlock PortStatusList" | |
| Test passed | | PDIIn: PQI = 0xA0, and PortStatusList: PortQualityInfo.Bit0 = VALID | |
| Test not passed (examples) | | Master defines the PD in the upper-level system as invalid | |
| Report | | "PDIInvalid" = "0" propagated to upper-level system: | |

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2102

2103 **8.4 On-request Data (OD)**

2104 **8.4.1 TYPE_2_V for different PD in/out and 1 octet OD**

2105 Table 200 defines the test conditions for this test case.

2106 **Table 200 – TYPE_2_V for different PD in/out and 1 octet OD**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0179 |
| Name | | TCM_DLOD_CYCC_TYPE2VPDXOD1 |
| Purpose (short) | | Master uses TYPE_2_V for different PD in/out and 1 octet OD |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.2 |
| Category / type | | Master M-sequence test: test to pass |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.4, A.2.6, B.1.4, E.4, E.10, E.11, E.12, Table A.10 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Check whether Master uses TYPE_2_V for several different PD in/out combinations and 1 octet OD. The Master receives the information about the target M-sequence type via address 0x03 (M-sequenceCapability), 0x05 (ProcessDataIn), and 0x06 (ProcessDataOut) out of DPP1. Different PD lengths are tested within a test procedure loop (TPL). |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_ISDU_Add(64, 0, 0x00) ;ISDU with value 1 x "0" b) Assign first value to "pdinlen", "pdoutlen", "mseq" ;Test parameter c) MTU_DPP1_Set(M-sequenceCapability) = "mseq" ;Test parameter d) MTU_DPP1_Set(PDIn length) = "pdinlen" ;"16" Bit e) MTU_DPP1_Set(PDOut length) = "pdoutlen" ;"0" Bit f) MTU_PD_Set = [0x5A,..., "pdinlen"-times] ;set "PDin" in MTU g) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;switch to OPERATE h) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE i) MTU_State_CheckOperate ;returns "MTU in OPERATE" j) Evaluation 1) k) SMI_PDOut(ABPS_PDOOUT<"pdoutlen", PDO0=0x5A>) ;set "PDout" l) SMI_DeviceWrite(ABPS_DEVICEWRITE<Index=64, OD=0xBF>) m) SMI_DeviceRead(ABPS_DEVICEREAD<Index=64>) ;returns "ArgBlock OD" n) Evaluation 2) o) MTU_PD_Get ;returns "PDOOut values" p) Evaluation 3) q) SMI_PDid ;returns "ArgBlock PDIn" r) Evaluation 4) s) SMI_PortConfiguration(ABPS_PORTINACTIVE) ;deactivate Port t) Repeat from c) with next values of "pdinlen", "pdoutlen", "mseq" |
| Test parameter | | pdinlen = {1, 3, 32, 6, 0}, pdoutlen = {3, 1, 32, 0, 20} ;variable PD lengths mseq = {0x11, 0x11, 0x19, 0x19, 0x19} ;M-sequenceCapability |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | For all TPL: 1) Check "MTU in OPERATE" 2) Check "ArgBlock OD" 3) Check "PDInOut values" 4) Check "ArgBlock PDin" |
| Test passed | | "MTU in OPERATE" = TRUE, and On-request Data = 0xBF, and PDout length = pdoutlen, all "PDOOut values" = "0x5A", and PDid.InputDataLength = pdinlen, all PDid.PDIx = "0x5A" |
| Test not passed (examples) | | Any of the checks in Test passed failed or communication error |
| Report | | All M-sequence TYPES (PD combinations): <ok nok> |

2111 **8.4.2 TYPE_2_V for different PD in/out and 2 octets OD**

2112 Table 201 defines the test conditions for this test case.

2113 **Table 201 – TYPE_2_V for different PD in/out and 2 octets OD**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|--|
| Identification (ID) | | SDCI_TC_0180 | |
| Name | | TCM_DLOD_CYCC_TYPE2VPDXOD2 | |
| Purpose (short) | | Master uses TYPE_2_V for different PD in/out and 2 octets OD | |
| Equipment under test (EUT) | | Master + Port | |
| Test case version | | 1.1 | |
| Category / type | | Master M-sequence test: test to pass | |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.4, A.2.6, B.1.4, E.4, E.10, E.11, E.12, Table A.10 | |
| Configuration / setup | | Master-Tester-System | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | | Check whether Master uses TYPE_2_V for several different PD in/out combinations and 2 octets OD. The Master receives the information about the target M-sequence type via address 0x03 (M-sequenceCapability), 0x05 (ProcessDataIn), and 0x06 (ProcessDataOut) out of DPP1. Different PD lengths are tested within a test procedure loop (TPL). | |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x2B ;see B.1.4 in [7] b) MTU_ISDU_Add(64, 0, [0x00, 0x00]) ;ISDU with values 2 x "0" c) Assign first value to "pdinlen" and "pdoutlen" ;Test parameter d) MTU_DPP1_Set(PDIn length) = "pdinlen" × 8 ;in Bits e) MTU_DPP1_Set(PDOut length) = "pdoutlen" × 8 ;in Bits f) MTU_PD_Set = [0x5A,..., "pdinlen"-times] ;set "PDin" in MTU g) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;switch to OPERATE h) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE i) MTU_State_CheckOperate ;returns "MTU in OPERATE" j) Evaluation 1) k) SMI_PDOut(ABPS_PDOOUT<"pdoutlen", PDO0=0x5A>) ;set "PDout" l) SMI_DeviceWrite(ABPS_DEVICEWRITE<Index=64, OD=[0xAA, 0xBF]>) m) SMI_DeviceRead(ABPS_DEVICEREAD<Index=64>);returns "ArgBlock OD" n) Evaluation 2) o) MTU_PD_Get ;returns "PDInOut values" p) Evaluation 3) q) SMI_PDin ;returns "ArgBlock PDIn" r) Evaluation 4) s) SMI_PortConfiguration(ABPS_PORTINACTIVE) ;deactivate Port t) Repeat from d) with next values of "pdinlen", "pdoutlen" ;Test parameter | |
| Test parameter | | pdinlen = {1, 32, 6, 0}, pdoutlen = {3, 32, 0, 20} ;variable PD lengths in octets | |
| Post condition | | – | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | | For all TPL: 1) Check "MTU in OPERATE" 2) Check "ArgBlock OD" 3) Check "PDInOut values" 4) Check "ArgBlock PDIn" | |
| Test passed | | "MTU in OPERATE" = TRUE, and On-request Data = [0xAA, 0xBF], and PDout length = pdoutlen, all "PDOut values" = "0x5A", and PDin.InputDataLength = pdinlen, all PDin.PDIx = "0x5A" | |
| Test not passed (examples) | | Any of the checks in Test passed failed or communication error | |
| Report | | All M-sequence TYPES (PD combinations): <ok nok> | |

2117

2118 **8.4.3 TYPE_2_V for different PD in/out and 8 octets OD**

2119 Table 202 defines the test conditions for this test case.

2120 **Table 202 – TYPE_2_V for different PD in/out and 8 octets OD**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0181 |
| Name | TCM_DLOD_CYCC_TYPE2VPDXOD8 |
| Purpose (short) | Master uses TYPE_2_V for different PD in/out and 8 octets OD |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 |
| Category / type | Master M-sequence test: test to pass |
| Specification (clause) | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.4, A.2.6, B.1.4, E.4, E.10, E.11, E.12, Table A.10 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Check whether Master uses TYPE_2_V for several different PD in/out combinations and 8 octets OD. The Master receives the information about the target M-sequence type via address 0x03 (M-sequenceCapability), 0x05 (ProcessDataIn), and 0x06 (ProcessDataOut) out of DPP1. Different PD lengths are tested within a test procedure loop (TPL). |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | <p>a) MTU_DPP1_Set(M-sequenceCapability) = 0x2D ;see B.1.4 in [7] b) MTU_ISDU_Add(64, 0, [0x00, ...,0x00]) ;ISDU with values 8 x "0" c) Assign first value to "pdinlen" and "pdoutlen" ;Test parameter d) MTU_DPP1_Set(PDIn length) = "pdinlen" × 8 ;in Bits e) MTU_DPP1_Set(PDOut length) = "pdoutlen" × 8 ;in Bits f) MTU_PD_Set = [0x5A,..., "pdinlen"-times] ;set "PDin" in MTU g) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;switch to OPERATE h) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE i) MTU_State_CheckOperate ;returns "MTU in OPERATE" j) Evaluation 1) k) SMI_PDOOut(ABPS_PDOOUT<"pdoutlen", PDO0=0x5A>) ;set "PDout" l) SMI_DeviceWrite(ABPS_DEVICEWRITE<Index=64, OD=[0xAA, 0xBF, 0x77, 0x40, 0x55, 0xCD, 0x33, 0xE4]>) m) SMI_DeviceRead(ABPS_DEVICEREAD<Index=64>);returns "ArgBlock OD" n) Evaluation 2) o) MTU_PD_Get ;returns "PDInOut values" p) Evaluation 3) q) SMI_PDid ;returns "ArgBlock PDin" r) Evaluation 4) s) SMI_PortConfiguration(ABPS_PORTINACTIVE) ;deactivate Port t) Repeat from d) with next values of "pdinlen", "pdoutlen" ;Test parameter </p> |
| Test parameter | pdinlen = {1, 32, 6, 0}, pdoutlen = {3, 32, 0, 20} ;variable PD lengths in octets |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | For all TPL: 1) Check "MTU in OPERATE" 2) Check "ArgBlock OD" 3) Check "PDInOut values" 4) Check "ArgBlock PDin" |
| Test passed | "MTU in OPERATE" = TRUE, and On-request Data = [0xAA, 0xBF, 0x77, 0x40, 0x55, 0xCD, 0x33, 0xE4], and PDout length = pdoutlen, all "PDOut values" = "0x5A", and PDid.InputDataLength = pdinlen, all PDid.PDIx = "0x5A" |
| Test not passed (examples) | Any of the checks in Test passed failed or communication error |
| Report | All M-sequence TYPES (PD combinations): <ok nok> |

2123 **8.4.4 TYPE_2_V for different PD in/out and 32 octets OD**

2124 Table 203 defines the test conditions for this test case.

2125 **Table 203 – TYPE_2_V for different PD in/out and 32 octets OD**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|---|--|
| Identification (ID) | SDCI_TC_0182 | |
| Name | TCM_DLOD_CYCC_TYPE2VPDXOD32 | |
| Purpose (short) | Master uses TYPE_2_V for different PD in/out and 32 octets OD | |
| Equipment under test (EUT) | Master + Port | |
| Test case version | 1.1 | |
| Category / type | Master M-sequence test: test to pass | |
| Specification (clause) | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.4, A.2.6, B.1.4, E.4, E.10, E.11, E.12, Table A.10 | |
| Configuration / setup | Master-Tester-System | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Check whether Master uses TYPE_2_V for several different PD in/out combinations and 32 octets OD. The Master receives the information about the target M-sequence type via address 0x03 (M-sequenceCapability), 0x05 (ProcessDataIn), and 0x06 (ProcessDataOut) out of DPP1. Different PD lengths are tested within a test procedure loop (TPL). | |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | |
| Procedure | a) MTU_DPP1_Set(M-sequenceCapability) = 0x2F ;see B.1.4 in [7] b) MTU_ISDU_Add(64, 0, [0x00, ..., 0x00]) ;ISDU with values 32 x "0" c) Assign first value to "pdinlen" and "pdoutlen" ;Test parameter d) MTU_DPP1_Set(PDIn length) = "pdinlen" × 8 ;in Bits e) MTU_DPP1_Set(PDOut length) = "pdoutlen" × 8 ;in Bits f) MTU_PD_Set = [0x5A,..., "pdinlen"-times] ;set "PDin" in MTU g) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;switch to OPERATE h) TM_AWAIT_PORT_STATUS(OPERATE) ;wait for OPERATE i) MTU_State_CheckOperate ;returns "MTU in OPERATE" j) Evaluation 1) k) SMI_PDOut(ABPS_PDOOUT<"pdoutlen", PDO0= 0x5A>) ;set "PDout" l) SMI_DeviceWrite(ABPS_DEVICEWRITE<Index=64, OD=[ODString]>) ;Test parameter m) SMI_DeviceRead(ABPS_DEVICEREAD<Index=64>);returns "ArgBlock OD" n) Evaluation 2) o) MTU_PD_Get ;returns "PDInOut values" p) Evaluation 3) q) SMI_PDid ;returns "ArgBlock PDin" r) Evaluation 4) s) SMI_PortConfiguration(ABPS_PORTINACTIVE) ;deactivate Port t) Repeat from d) with next values of "pdinlen", "pdoutlen" ;Test parameter | |
| Test parameter | pdinlen = {1, 32, 6, 0}, pdoutlen = {3, 32, 0, 20} ;variable PD lengths in octets ODstring = "Hello World, this is Master Test" | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | For all TPL: 1) Check "MTU in OPERATE" 2) Check "ArgBlock OD" 3) Check "PDInOut values" 4) Check "ArgBlock PDin" | |
| Test passed | "MTU in OPERATE" = TRUE, and On-request Data = ["Hello World, this is Master Test"], and PDout length = pdoutlen, all "PDOut values" = "0x5A", and PDid.InputDataLength = pdinlen, all PDid.PDIx = "0x5A" | |
| Test not passed (examples) | Any of the checks in Test passed failed or communication error | |
| Report | All M-sequence TYPES (PD combinations): <ok nok> | |

2129 **8.4.5 Master sends Idle after an accomplished ISDU service**

2130 Table 204 defines the test conditions for this test case.

2131 **Table 204 – Master sends Idle after an accomplished ISDU service**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|--|--|---|--|
| Identification (ID) | | SDCI_TC_0288 | |
| Name | | TCM_LGCY_MANY_IDLEAFTERISDU | |
| Purpose (short) | | Master sends ISDU request "IDLE 1" after an accomplished ISDU service | |
| Equipment under test (EUT) | | Master + Port | |
| Test case version | | 1.1 | |
| Category / type | | Master M-sequence test: test to pass | |
| Specification (clause) | | [7], 7.3.6.3, Figure 51 (Transition T8) | |
| Configuration / setup | | Master-Tester-System | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | | After completion of an ISDU service, the Master shall transmit at least one "IDLE 1" request to the Device as an acknowledgement of the ISDU service (I-Service). | |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | |
| Procedure | | a) MTU_DPP1_Set(MasterCycleTime) = 0xBF b) MTU_ISDU_Add(64, 0, [0xAA]) c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) d) TM_AWAIT_PORT_STATUS(OPERATE) e) MTU_ISDU_TrailingIdles f) SMI_DeviceRead(ABPS_DEVICEREAD <Index=64>) g) SMI_DeviceRead(ABPS_DEVICEREAD<Index=64>) h) MTU_ISDU_TrailingIdles i) Evaluation 1) | |
| ;cycle time = 132.8ms ;ISDU with length "1" ;switch to OPERATE ;wait for OPERATE ;reset "NumIdles" ;start second Read ;as soon as possible ;return "NumIdles" | | | |
| Test parameter | | – | |
| Post condition / next test | | – | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluation | | 1) Check value of "NumIdles" | |
| Test passed | | "NumIdles" > 0 | |
| Test not passed (examples) | | "NumIdles" = 0 | |
| Report | | IDLE 1 message: <yes/no> | |
| | | <ok nok> | |

2134

2135

2136 **8.5 STARTUP**2137 **8.5.1 Master reads communication parameters (Direct Parameter)**

2138 Table 205 defines the test conditions for this test case.

2139 **Table 205 – Master reads communication parameters (Direct Parameter)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0183 |
| Name | | TCM_DLST_CHCK_COMPARAM |
| Purpose (short) | | Check that Master starts communication and reads communication parameters |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.3 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 9.2.3.2, 9.3.3, Figures 71, 72, and 81 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Check correct start-up of Master comprising "V1.0" support. Master reads communication parameter address 0x02 to 0x06 (Direct Parameter page 1). |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) Assign first value to "com" b) MTU_Timing_SetCommunicationMode = "com" c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) d) TM_AWAIT_PORT_STATUS(OPERATE) e) MTU_Startup_GetLog ;returning MessageLog f) Evaluation 1) g) SMI_PortConfiguration(ABPS_PORTINACTIVE) h) Repeat from b) with next "com" |
| Test parameter | | com = {COM1, COM2, COM3} |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check MessageLog |
| Test passed | | For all COMx: MessageLog shall fulfil the following requirements: - No communication retries - Master read messages to parameters on address 0x02 to 0x06 in ascending order - One or two Master read messages to parameter on address 0x02 permitted - Only one Master read message to each parameter on addresses 0x03 to 0x06 |
| Test not passed (examples) | | Any of the requirements not fulfilled at any COMx |
| Report | | No communication retries: <ok nok> Master read messages in ascending order: <ok nok> Number of read accesses to address 0x02: <value> <ok nok> Number of read accesses to addresses 0x03 to 0x06 <ok nok> Communication modes COM1, COM2, COM3: <ok nok> NOTE In this test case, a Master read on address 0x02 only once is tolerated; however, the Master-Tester-System shall display and/or print out a warning. |

2142

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2144 **8.5.2 Master adjusts to protocol V1.1 (Direct Parameter)**

2145 Table 206 defines the test conditions for this test case.

2146 **Table 206 – Master adjusts to protocol V1.1 (Direct Parameter)**

2147 -CR096-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0184 |
| Name | TCM_DLST_CHCK_VIDDID |
| Purpose (short) | Check whether Master adjusts to protocol V1.1 and reads VendorID and DeviceID |
| Equipment under test (EUT) | Master |
| Test case version | 1.0 1 |
| Category / type | Master protocol test: test to pass |
| Specification (clause) | [7], 9.2.3.2, 9.2.3.3, Figures 71 to 75, and 81 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Check whether Master adjusts to protocol revision V1.0 V1.1 and reads VendorID and DeviceID. Check for the right decision with respect to the protocol revision. |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | a) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) b) TM_AWAIT_PORT_STATUS(OPERATE) c) MTU_Startup_GetLog <i>:returning MessageLog</i> d) Evaluation 1) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check MessageLog |
| Test passed | MessageLog shall contain after the sequence of reading parameter addresses 0x02 to 0x06 the following sequence of messages in this order: - Write MasterCommand 0x95 (Master_Ident) - Read VendorID - Read DeviceID |
| Test not passed (examples) | Master did not write MasterCommand 0x95 |
| Report | MasterCommand 0x95: <yes/no> <ok nok> Master reads VendorID: <value> <ok nok> Master reads DeviceID: <value> <ok nok> |

2150

2151

8.5.3 Master adjusts to protocol V1.0 (Direct Parameter)

2153 Table 207 defines the test conditions for this test case.

Table 207 – Master adjusts to protocol V1.0 (Direct Parameter)

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|----------------------------|--|
| Identification (ID) | SDCI_TC_0185 | | |
| Name | TCM_DLST_CHCK_V10VIDDID | | |
| Purpose (short) | Check whether Master adjusts to protocol V1.0 and reads VendorID and DeviceID | | |
| Equipment under test (EUT) | Master | | |
| Test case version | 1.2 | | |
| Category / type | Master protocol test: test to pass | | |
| Specification (clause) | [7], 9.2.3.2, 9.2.3.3, Figures 71 to 75, and 81 | | |
| Configuration / setup | Master-Tester-System | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | Check whether Master adjusts to protocol revision V1.0 and reads VendorID and DeviceID. Check for the right decision with respect to the protocol revision. | | |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE MTU_DPP1_Set(RevisionID) = 0x10 ;Set "Device" to revision V1.0 | | |
| Procedure | a) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) b) TM_AWAIT_PORT_STATUS(OPERATE) c) MTU_Startup_GetLog ;returning MessageLog d) Evaluation 1) | | |
| Test parameter | – | | |
| Post condition | – | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | 1) Check MessageLog | | |
| Test passed | MessageLog shall contain after the sequence of reading parameter addresses 0x02 to 0x06 the following sequence of messages in this order: - No Write MasterCommand 0x95 (Master_Ident) - Read VendorID - Read DeviceID | | |
| Test not passed (examples) | Master did not recognize the correct protocol version and wrote MasterCommand 0x95 and/or did not read the VendorID and DeviceID. | | |
| Report | No MasterCommand 0x95: <yes/no> Master reads VendorID: <value> Master reads DeviceID: <value> | | |
| | <ok nok> | | |

2159 **8.5.4 Master start-up with non configured VID and DID**

2160 Table 208 defines the test conditions for this test case.

2161 **Table 208 – Master start-up with non configured VID and DID**

2162 -CR044-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0186 |
| Name | TCM_DLST_CHCK_NONCONFVIDDID |
| Purpose (short) | Check whether Master performs start-up with non-configured VID and DID |
| Equipment under test (EUT) | Master |
| Test case version | 1.2 3 |
| Category / type | Master protocol test: test to pass |
| Specification (clause) | [7], 9.2.3.2, 9.2.3.3, Figures 71 to 75, and 81 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | <p>Check Master behavior. Master establishes communication with Device and turns it into OPERATE.</p> <p>Configured PortMode = IOL_AUTOSTART and Validation&Backup = No Device check.</p> |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | a) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) b) TM_AWAIT_PORT_STATUS(OPERATE) c) MTU_Startup_GetLog <i>;returning MessageLog</i> d) Evaluation 1 e) SMI_PortStatus <i>;returning PortStatusList</i> f) Evaluation 2 |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check MessageLog 2) Check PortStatusList |
| Test passed | <p>In 1) MessageLog shall contain after writing MasterCommand 0x95 (Master_Ident), the following sequence of messages in this order:</p> <ul style="list-style-type: none"> - Read VendorID - Read DeviceID - Read FunctionID - Write MasterCommand 0x9A <i>;Device Preoperate</i> <p>In 2) PortStatusList shall show the following values:</p> <ul style="list-style-type: none"> PortStatusList.PortStatusInfo = OPERATE PortStatusList.DeviceID = 0x002BD2 |
| Test not passed (examples) | Master does not write MasterCommand 0x9A |
| Report | Master reads VendorID: <value> <i><ok nok></i> Master reads DeviceID: <value> <i><ok nok></i> Master reads FunctionID: <value> <i><ok nok></i> MasterCommand 0x95: <yes/no> <i><ok nok></i> Correct values in PortStatusList: <yes/no> <i><ok nok></i> |

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2167 **8.5.5 Master start-up with configured VID and DID**

2168 Table 209 defines the test conditions for this test case.

2169 **Table 209 – Master start-up with configured VID and DID**

2170 -CR044-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0187 |
| Name | TCM_DLST_CHCK_CONFVIDDID |
| Purpose (short) | Check Master start-up behavior with configured VendorID and DeviceID |
| Equipment under test (EUT) | Master |
| Test case version | 1.3 4 |
| Category / type | Master protocol test: test to pass |
| Specification (clause) | [7], 9.2.3.2, 9.2.3.3, Figures 71 to 75, and 81 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Check Master start-up behavior. Master establishes communication with Device and turns it into OPERATE. Configured PortMode = IOL_MANUAL and Validation&Backup = Type compatible Device V1.1. |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | a) SMI_PortConfiguration(ABPS_TYPE_COMP) <i>:type compatibility</i> b) TM_AWAIT_PORT_STATUS(OPERATE) c) MTU_Startup_GetLog <i>:returning MessageLog</i> d) Evaluation 1) e) SMI_PortStatus <i>:returning PortStatusList</i> f) Evaluation 2) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check MessageLog 2) Check PortStatusList |
| Test passed | In 1) MessageLog shall contain after writing MasterCommand 0x95 (Master_Ident), the following sequence of messages in this order: - Read VendorID - Read DeviceID - Read FunctionID - Write MasterCommand 0x9A <i>:Device Preoperate</i> In 2) PortStatusList shall show the following values: PortStatusList.PortStatusInfo = OPERATE PortStatusList.DeviceID = 0x002BD2 |
| Test not passed (examples) | Master does not write MasterCommand 0x9A, or values in PortStatusList are not correct |
| Report | Master reads VendorID: <value> <i><ok nok></i> Master reads DeviceID: <value> <i><ok nok></i> Master reads FunctionID: <value> <i><ok nok></i> MasterCommand 0x95: <yes/no> <i><ok nok></i> Correct values in PortStatusList: <yes/no> <i><ok nok></i> |

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2175 **8.5.6 Master start-up with overwrite of the DID (compatible)**

2176 Table 210 defines the test conditions for this test case.

2177 **Table 210 – Master start-up with overwrite of the DID (compatible)**

2178 -CR044-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0188 |
| Name | TCM_DLST_CHCK_OVERDIDOK |
| Purpose (short) | Check Master start-up behavior with overwrite of DeviceID (compatible) |
| Equipment under test (EUT) | Master |
| Test case version | 1.5 6 |
| Category / type | Master protocol test: test to pass |
| Specification (clause) | [7], 9.2.3.2, 9.3.3, Figures 71 to 76, and 81 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | <p>Check Master start-up behavior with overwrite of DeviceID (compatible). Master establishes communication with the MTU, detects incorrect "Device", overwrites the DeviceID with requested DeviceID, reads communication parameters again, and turns MTU into OPERATE.</p> <p>Configured PortMode = IOL_MANUAL and Validation&Backup = Type compatible Device V1.1.</p> <p>NOTE MTU shall tolerate Masters reading communication parameter address 0x02 (Direct Parameter page 1) twice.</p> |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE MTU_DPP1_Set(DeviceID) = 0x00A439 |
| Procedure | <p>a) SMI_PortConfiguration(ABPS_TYPE_COMP) <i>:type compatibility</i> b) TM_AWAIT_PORT_STATUS(OPERATE) c) MTU_Startup_GetLog <i>:returning MessageLog</i> d) Evaluation 1) e) SMI_PortStatus <i>:returning PortStatusList</i> f) Evaluation 2)</p> |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check MessageLog 2) Check PortStatusList |
| Test passed | <p>MessageLog shall contain after writing MasterCommand 0x95 (Master_Ident) the following sequence of messages in this order: Read VendorID → Read DeviceID → Read FunctionID → Write Revision = "0x11" → Write configured DeviceID (0x002BD2) → Write MasterCommand 0x96 → Read communication parameter on address 0x02 to 0x06 → Read again VendorID → Read again DeviceID → Read again FunctionID → Write MasterCommand 0x9A, and</p> <p>PortStatusList: PortStatusInfo = OPERATE, DeviceID = 0x002BD2</p> |
| Test not passed (examples) | Master does not write MasterCommand 0x9A, or DeviceID of MTU ≠ 0x002BD2, or values in PortStatusList are not correct |
| Report | <p>Master writes Revision 0x11: <yes/no> <i><ok nok></i> MasterCommand 0x96: <yes/no> <i><ok nok></i> Master reads VendorID: <value> <i><ok nok></i> Master reads DeviceID: <value> <i><ok nok></i> Master reads FunctionID: <value> <i><ok nok></i> MasterCommand 0x9A: <yes/no> <i><ok nok></i> Correct values in PortStatusList: <yes/no> <i><ok nok></i></p> |

2183 **8.5.7 Master start-up with overwrite of the DID (incompatible)**

2184 Table 211 defines the test conditions for this test case.

2185 **Table 211 – Master start-up with overwrite of the DID (incompatible)**

2186 -CR049- -CR044-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0189 |
| Name | TCM_DLST_CHCK_OVERDIDNOK |
| Purpose (short) | Check Master start-up behavior with overwrite of the DeviceID (incompatible) |
| Equipment under test (EUT) | Master |
| Test case version | 1.4 5 |
| Category / type | Master protocol test: test to pass |
| Specification (clause) | [7], 9.2.3.2, 9.3.3, Figures 71 to 76, and 81 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Check Master start-up behavior with overwrite of the DeviceID. This test case supposes an incompatible DeviceID causing MTU to initiate a corresponding Event. Master starts communication with MTU, detects incorrect "Device", overwrites the DeviceID with the requested DeviceID, reads communication parameters again, and turns MTU into PREOPERATE. MTU shall tolerate Master reading communication parameter address 0x02 (Direct Parameter page 1) twice. |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE MTU_DPP1_Set(DeviceID) = 0x00AAAA ; <i>incompatible to any other DID</i> |
| Procedure | a) SMI_PortConfiguration(ABPS_TYPE_COMP) ; <i>type compatibility</i> b) TM_AWAIT_PORT_STATUS(OPERATE) (PORT_DIAG) c) MTU_Startup_GetLog ; <i>returning MessageLog</i> d) Evaluation 1) e) SMI_PortEvent ; <i>returning EventCode</i> f) Evaluation 2) g) SMI_PortStatus ; <i>returning PortStatusList</i> h) Evaluation 3) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check MessageLog 2) Check EventCode 3) Check PortStatusList |
| Test passed | MessageLog shall contain after writing MasterCommand 0x95 (Master_Ident), the following sequence of messages in this order: Read VendorID → Read DeviceID → Read FunctionID → Write Revision=0x11 → Write configured DeviceID → Write MasterCommand 0x96 → Read communication parameter on address 0x02 to 0x06 → Read again VendorID → Read again DeviceID → Read again FunctionID → Write MasterCommand 0x9A → No Write MasterCommand 0x99, and PortEvent: EventCode = 0x1803, and ; <i>"Incorrect DeviceID"</i> PortStatusList: PortStatusInfo = PORT_DIAG, DeviceID = 0x00AAAA, DiagEntry[any].EventCode = 0x1803 ; <i>"Incorrect DeviceID"</i> |
| Test not passed (examples) | No PORT_DIAG, or MasterCommand 0x9A and thereafter a MasterCommand 0x99 |
| Report | Master writes Revision 0x11: <yes/no> <ok nok> Master writes configured DeviceID: <yes/no> <ok nok> MasterCommand 0x96: <yes/no> <ok nok> Master reads VendorID: <value> <ok nok> Master reads DeviceID: <value> <ok nok> MasterCommand 0x9A: <yes/no> <ok nok> |

| TEST CASE RESULTS | CHECK / REACTION | |
|-------------------|--|------------|
| | Master reads FunctionID: <value> | <ok nok> |
| | No MasterCommand 0x99: <yes/no> | <ok nok> |
| | Master indicates Event: <EventCode> | <ok nok> |
| | Correct values in PortStatusList: <yes/no> | <ok nok> |

2189 **8.5.8 Master start-up with overwrite of the RID (incompatible)**

2190 Table 212 defines the test conditions for this test case.

2191 **Table 212 – Master start-up with overwrite of the RID (incompatible)**

2192 -CR050- -CR044- -CR060- -CR100-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0190 |
| Name | TCM_DLST_CHCK_OVERRIDNOK |
| Purpose (short) | Check Master start-up behavior with overwrite of the RevisionID (incompatible) |
| Equipment under test (EUT) | Master |
| Test case version | 1.5 6 |
| Category / type | Master protocol test: test to pass |
| Specification (clause) | [7], 9.2.3.2, 9.3.3, Figures 71 to 76, and 81 |
| Configuration / setup | Master-Tester-System |

| TEST CASE | CONDITIONS / PERFORMANCE |
|--------------------|--|
| Purpose (detailed) | Check Master start-up behavior with overwrite of RevisionID (RID). This test case supposes an incompatible RevisionID (>V1.1). Master starts communication with MTU, detects the "incorrect" RevisionID, and overwrites the RevisionID with the requested RevisionID. MTU in turn restores the original RID causing a corresponding Event. MTU shall tolerate Master reading communication parameter address 0x02 (Direct Parameter page 1) twice. |
| Precondition | EUT: PORT_INACTIVE (IOL_MANUAL, Type compatible Device V1.1) MTU: MTU_STANDARD_STATE with MTU_DPP1_Set(DeviceID) = 0x00A439, and MTU_DPP1_Set(RevisionID) = 0x12 ; <i>incorrect RevisionID (MTU does not accept any other protocol revision in this state)</i> |
| Procedure | a) SMI_PortConfiguration(ABPS_TYPE_COMP) ; <i>type compatibility</i> b) TM_AWAIT_PORT_STATUS(OPERATE PORT_DIAG) c) MTU_Startup_GetLog ; <i>returning MessageLog</i> d) Evaluation 1) e) SMI_PortEvent ; <i>returning EventCode</i> f) Evaluation 2) g) SMI_PortStatus ; <i>returning PortStatusList</i> h) Evaluation 3) |
| Test parameter | – |
| Post condition | – |

| TEST CASE RESULTS | CHECK / REACTION |
|-------------------|---|
| Evaluation | 1) Check MessageLog 2) Check EventCode 2) Check PortStatusList |
| Test passed | MessageLog shall contain after writing MasterCommand 0x95 (Master_Ident), the following sequence of messages in this order: Read VendorID → Read DeviceID → Read FunctionID → Write Revision = "0x11" → Write configured DeviceID → Write MasterCommand 0x96 → Read communication parameter on address 0x02 to 0x06 → Read again VendorID → Read again DeviceID → Read again FunctionID → Write MasterCommand 0x9A → No Write MasterCommand 0x99, and ; <i>Device Operate</i> PortEvent: EventCode = 0x1801, and ; <i>"Startup Parameterization-error"</i> PortStatusList: PortStatusInfo = PORT_DIAG, DeviceID = 0x00A439, RevisionID = 0x12, DiagEntry[any].EventCode = 0x1801 0x6001 ; <i>"Startup parametrization-error"</i> |

| TEST CASE RESULTS | CHECK / REACTION | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
|---|---|---------------------------------------|------------|---|------------|------------------------------|------------|--------------------------------|------------|--------------------------------|------------|---|------------|------------------------------|------------|---------------------------------|------------|-------------------------------------|------------|--|------------|--|--|---------------------------------------|------------|---|------------|------------------------------|------------|---|------------|--------------------------------|------------|---|------------|------------------------------|------------|---------------------------------|------------|-------------------------------------|------------|--|------------|
| | <p>MessageLog shall contain after writing MasterCommand 0x95 (Master_Ident), the following sequence of messages in this order:</p> <p>Read VendorID → Read DeviceID → Read FunctionID → Write Revision = "0x11" → Write configured DeviceID → Write MasterCommand 0x96 → Read communication parameter on address 0x02 to 0x06 → MasterCommand 0x95 (Master_Ident) Read again VendorID → Read again DeviceID → Read again FunctionID → Write MasterCommand 0x9A → No Write MasterCommand 0x99, and ;Device Operate PortEvent: EventCode = 0x1801, and ;"Startup Parameterization error"</p> <p>PortStatusList: PortStatusInfo = PORT_DIAG, DeviceID = 0x00A439, RevisionID = 0x12, DiagEntry[any].EventCode = 0x1801 0x6001 ;"Startup parametrization error"</p> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Test not passed (examples) | Master did not send MasterCommand 0x9A, or Master leaves PREOPERATE state. | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Report | <table> <tbody> <tr> <td>Master writes Revision 0x11: <yes/no></td> <td><ok nok></td> </tr> <tr> <td>Master writes configured DeviceID: <yes/no></td> <td><ok nok></td> </tr> <tr> <td>MasterCommand 0x96: <yes/no></td> <td><ok nok></td> </tr> <tr> <td>Master reads VendorID: <value></td> <td><ok nok></td> </tr> <tr> <td>Master reads DeviceID: <value></td> <td><ok nok></td> </tr> <tr> <td>Master reads FunctionID: <value></td> <td><ok nok></td> </tr> <tr> <td>MasterCommand 0x9A: <yes/no></td> <td><ok nok></td> </tr> <tr> <td>No MasterCommand 0x99: <yes/no></td> <td><ok nok></td> </tr> <tr> <td>Master indicates Event: <EventCode></td> <td><ok nok></td> </tr> <tr> <td>Correct values in PortStatusList: <yes/no></td> <td><ok nok></td> </tr> <tr> <td> </td> <td> </td> </tr> <tr> <td>Master writes Revision 0x11: <yes/no></td> <td><ok nok></td> </tr> <tr> <td>Master writes configured DeviceID: <yes/no></td> <td><ok nok></td> </tr> <tr> <td>MasterCommand 0x96: <yes/no></td> <td><ok nok></td> </tr> <tr> <td>Master reads VendorID: <value></td> <td><ok nok></td> </tr> <tr> <td>Master reads DeviceID: <value></td> <td><ok nok></td> </tr> <tr> <td>Master reads FunctionID: <value></td> <td><ok nok></td> </tr> <tr> <td>MasterCommand 0x9A: <yes/no></td> <td><ok nok></td> </tr> <tr> <td>No MasterCommand 0x99: <yes/no></td> <td><ok nok></td> </tr> <tr> <td>Master indicates Event: <EventCode></td> <td><ok nok></td> </tr> <tr> <td>Correct values in PortStatusList: <yes/no></td> <td><ok nok></td> </tr> </tbody> </table> | Master writes Revision 0x11: <yes/no> | <ok nok> | Master writes configured DeviceID: <yes/no> | <ok nok> | MasterCommand 0x96: <yes/no> | <ok nok> | Master reads VendorID: <value> | <ok nok> | Master reads DeviceID: <value> | <ok nok> | Master reads FunctionID: <value> | <ok nok> | MasterCommand 0x9A: <yes/no> | <ok nok> | No MasterCommand 0x99: <yes/no> | <ok nok> | Master indicates Event: <EventCode> | <ok nok> | Correct values in PortStatusList: <yes/no> | <ok nok> | | | Master writes Revision 0x11: <yes/no> | <ok nok> | Master writes configured DeviceID: <yes/no> | <ok nok> | MasterCommand 0x96: <yes/no> | <ok nok> | Master reads VendorID: <value> | <ok nok> | Master reads DeviceID: <value> | <ok nok> | Master reads FunctionID: <value> | <ok nok> | MasterCommand 0x9A: <yes/no> | <ok nok> | No MasterCommand 0x99: <yes/no> | <ok nok> | Master indicates Event: <EventCode> | <ok nok> | Correct values in PortStatusList: <yes/no> | <ok nok> |
| Master writes Revision 0x11: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Master writes configured DeviceID: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| MasterCommand 0x96: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Master reads VendorID: <value> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Master reads DeviceID: <value> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Master reads FunctionID: <value> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| MasterCommand 0x9A: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| No MasterCommand 0x99: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Master indicates Event: <EventCode> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Correct values in PortStatusList: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Master writes Revision 0x11: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Master writes configured DeviceID: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| MasterCommand 0x96: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Master reads VendorID: <value> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Master reads DeviceID: <value> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Master reads FunctionID: <value> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| MasterCommand 0x9A: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| No MasterCommand 0x99: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Master indicates Event: <EventCode> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Correct values in PortStatusList: <yes/no> | <ok nok> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |

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2196 **8.5.9 Master start-up with non configured VID and DID (V1.0)**

2197 Table 213 defines the test conditions for this test case.

2198 **Table 213 – Master start-up with non configured VID and DID (V1.0)**

2199 -CR044-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0192 |
| Name | | TCM_DLST_CHCK_VIDDIDNONCONFIG |
| Purpose (short) | | Check Master start-up behavior with non-configured VID and DID (V1.0) |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.4 5 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 9.2.3.2, 9.3.3, Figures 71 to 76, and 81 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Check Master start-up behavior with non-configured VID and DID for a legacy Device (V1.0). The Master establishes communication with the "Device" (MTU), writes the MasterCycleTime (address 0x01 in Direct Parameter page 1), and sends MasterCommand 0x99 (OPERATE) turning the "Device" from STARTUP to OPERATE. Configured PortMode = IOL_AUTOSTART and Validation&Backup = No Device check. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE MTU_DPP1_Set(RevisionID) = 0x10 <i>;Revision V1.0</i> |
| Procedure | | a) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) <i>;no type check</i> b) TM_AWAIT_PORT_STATUS(OPERATE) c) MTU_Startup_GetLog <i>;returning MessageLog</i> d) Evaluation 1) e) SMI_PortStatus <i>;returning PortStatusList</i> f) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check MessageLog 2) Check PortStatusList |
| Test passed | | MessageLog shall contain after read of parameter address 0x02 to 0x06 the following sequence of messages in this order: Read VendorID → Read DeviceID → Read FunctionID → Write MasterCycleTime → Write MasterCommand 0x99 PortStatusList: PortStatusInfo = OPERATE, DeviceID = 0x002BD2 |
| Test not passed (examples) | | Master does not write the MasterCycleTime (address 0x01) or does not send MasterCommand 0x99 |
| Report | | Master reads VendorID: <value> <i><ok nok></i> Master reads DeviceID: <value> <i><ok nok></i> Master reads FunctionID: <value> <i><ok nok></i> MasterCycleTime written: <yes/no> <i><ok nok></i> MasterCommand 0x99: <yes/no> <i><ok nok></i> |

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2204 **8.5.10 Master start-up with configured VID and DID (Device V1.0)**

2205 Table 214 defines the test conditions for this test case.

2206 **Table 214 – Master start-up with configured VID and DID (V1.0)**

2207 -CR044-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0193 |
| Name | | TCM_DLST_CHCK_VIDDIDCONFIG |
| Purpose (short) | | Check Master start-up behavior with configured VID and DID (Device V1.0) |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.4 5 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 9.2.3.2, 9.3.3, Figures 71 to 76, and 81 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Check Master start-up behavior with configured VID and DID for a legacy "Device" (V1.0). Master establishes communication with the "Device" (MTU) and writes the MasterCycleTime (address 0x01 in Direct Parameter page 1) only if the configured values match the values in the "Device". Then, the Master shall turn the "Device" from STARTUP into OPERATE via MasterCommand 0x99. Configured PortMode = IOL_MANUAL and Validation&Backup = Type compatible Device V1.0 |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE MTU_DPP1_Set(RevisionID) = 0x10 <i>;"Device" revision V1.0</i> |
| Procedure | | a) SMI_PortConfiguration(ABPS_TYPE_COMP< Validation&Backup= TYPE_compatible_Device_V1.0>) <i>;type compatibility</i> b) TM_AWAIT_PORT_STATUS(OPERATE) c) MTU_Startup_GetLog <i>;returning MessageLog</i> d) Evaluation 1) e) SMI_PortStatus <i>;returning PortStatusList</i> f) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check MessageLog 2) Check PortStatusList |
| Test passed | | MessageLog shall contain after read of parameter address 0x02 to 0x06 the following sequence of messages in this order: Read VendorID → Read DeviceID → Read FunctionID → Write MasterCycleTime → Write MasterCommand 0x99 PortStatusList: PortStatusInfo = OPERATE, DeviceID = 0x002BD2 |
| Test not passed (examples) | | Master does not write the MasterCycleTime (address 0x01) or does not send MasterCommand 0x99 |
| Report | | Master reads VendorID: <value> <i><ok nok></i> Master reads DeviceID: <value> <i><ok nok></i> Master reads FunctionID: <value> <i><ok nok></i> MasterCycleTime written: <yes/no> <i><ok nok></i> MasterCommand 0x99: <yes/no> <i><ok nok></i> |

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2212 **8.5.11 Master start-up with incorrect DID (Device V1.0)**

2213 Table 215 defines the test conditions for this test case.

2214 **Table 215 – Master start-up with incorrect DID (V1.0)**

2215 -CR101- -CR044-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0194 |
| Name | | TCM_DLST_CHCK_DIDWRONG |
| Purpose (short) | | Check Master start-up behavior with incorrect DID (Device V1.0) |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.4 5 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 9.2.3.2, 9.3.3, Figures 71 to 76, and 81 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Check Master start-up behavior with incorrect configured DID for a legacy "Device" (V1.0). Master establishes communication with MTU, recognizes a deviating DeviceID, and indicates a corresponding Event. Configured PortMode = IOL_MANUAL and Validation&Backup = Type compatible Device V1.0 |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE MTU_DPP1_Set(RevisionID) = 0x10 ; <i>Revision V1.0</i> MTU_DPP1_Set(DeviceID) = 0x00AAAA ; <i>incompatible to any other DID</i> |
| Procedure | | a) SMI_PortConfiguration(ABPS_TYPE_COMP<Validation&Backup=TYPE_compatible_Device_V1.0>) ; <i>type compatibility</i> b) TM_AWAIT_PORT_STATUS(PORT_DIAG) c) MTU_Startup_GetLog ; <i>returning MessageLog</i> d) Evaluation 1) e) SMI_PortEvent ; <i>returning EventCode</i> f) Evaluation 2) g) SMI_PortStatus ; <i>returning PortStatusList</i> h) Evaluation 3) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check MessageLog 2) Check EventCode 2) Check PortStatusList |
| Test passed | | MessageLog shall contain after read of parameter address 0x02 to 0x06, the following sequence of messages in this order: Read VendorID -> Read DeviceID -> Read FunctionID -> Write MasterCycleTime -> Write MasterCommand 0x99 -> No Write MasterCommand 0x98 PortEvent: EventCode = 0x1803 ; <i>"Incorrect DeviceID"</i> PortStatusList: PortStatusInfo = PORT_DIAG, DeviceID = 0x00AAAA, DiagEntry[any].EventCode = 0x1803 ; <i>"Incorrect DeviceID"</i> |
| Test not passed (examples) | | Master indicates no system specific fault information or sends MasterCommand 0x98. |
| Report | | Master reads VendorID: <value> <ok nok> Master reads DeviceID: <value> <ok nok> Master reads FunctionID: <value> <ok nok> No MasterCommand 0x98: <yes/no> <ok nok> Master indicates Event: <EventCode> <ok nok> Correct values in PortStatusList: <yes/no> <ok nok> |

2218

2220 **8.5.12 Master start-up with overwrite of the RID (compatible)**

2221 Table 216 defines the test conditions for this test case.

2222 **Table 216 – Master start-up with overwrite of the RID (compatible)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0307 |
| Name | | TCM_DLST_CHCK_OVERRIDOK |
| Purpose (short) | | Check Master start-up behavior with overwrite of the Device RID (compatible) |
| Equipment under test (EUT) | | Master |
| Test case version | | 1.2 [3] |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 9.2.3.2, 9.3.3, 10.6.3, Figures 71 to 76, and 81 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | <p>Check Master start-up behavior with overwrite of the RevisionID (compatible). This test supposes the active switching to protocol revision 1.0. Master overwrites the RID and the "Device" accepts the requested protocol revision.</p> <p>Configured PortMode = IOL_MANUAL and Validation&Backup = Type compatible Device V1.0</p> <p>NOTE MTU shall tolerate Master reading communication parameter address 0x02 (Direct Parameter page 1) twice.</p> |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE ; <i>MTU accepts protocol revision 1.0 in this state</i> |
| Procedure | | a) SMI_PortConfiguration(ABPS_TYPE_COMP, RevisionID = "CRID") (Test param.) b) TM_AWAIT_PORT_STATUS(OPERATE) c) MTU_Startup_GetLog ; <i>returning MessageLog</i> d) Evaluation 1) e) SMI_PortStatus ; <i>returning PortStatusList</i> f) Evaluation 2) |
| Test parameter | | CRID = 0x10 ; <i>configured RevisionID V1.0</i> |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check MessageLog 2) Check PortStatusList |
| Test passed | | MessageLog shall contain after writing MasterCommand 0x95 (Master_Ident) the following sequence of messages in this order: Write RevisionID = "0x10" → Write DeviceID → Write MasterCommand 0x96 → Read communication parameter on address 0x02 to 0x06 → Read again VendorID → Read again DeviceID → Read FunctionID Write MasterCommand 0x99 ; <i>DeviceOperate</i> PortStatusList: PortStatusInfo = OPERATE, DeviceID = 0x002BD2, RevisionID = "CRID" |
| Test not passed (examples) | | Master writes MasterCommand 0x9A or MTU does not show RevisionID 0x10 |

| TEST CASE RESULTS | CHECK / REACTION |
|-------------------|--|
| Report | Master writes RevisionID 0x11: <yes/no> <ok nok> MasterCommand 0x96: <yes/no> <ok nok> Master reads RevisionID: <value> <ok nok> No MasterCommand 0x9A: <yes/no> <ok nok> Correct values in PortStatusList: <yes/no> <ok nok> Master writes RevisionID 0x10: <yes/no> <ok nok> Master writes configured DeviceID: <yes/no> <ok nok> MasterCommand 0x96: <yes/no> <ok nok> Master reads DPP1 parameters 0x02 to 0x06: <yes/no> <ok nok> Master reads VendorID: <value> <ok nok> Master reads DeviceID: <value> <ok nok> Master reads FunctionID: <value> <ok nok> No MasterCommand 0x9A: <yes/no> <ok nok> Correct values in PortStatusList: <yes/no> <ok nok> |

2225

2226 **8.6 PREOPERATE**2227 **8.6.1 Master in PREOPERATE uses TYPE_0 to read Index 24 (1 OD)**

2228 Table 217 defines the test conditions for this test case.

2229 **Table 217 – Master in PREOPERATE uses TYPE_0 to read Index 24 (1 OD)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0202 |
| Name | | TCM_DLOD_PREP_TYPE0READOD1 |
| Purpose (short) | | Master uses TYPE_0 to read Index 24 in PREOPERATE (1 octet OD) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], A.2.2, A.5.2, B.2.1, Tables A.8, A.13 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master uses correct M_sequence type according to Device settings in DPP1 for PREOPERATE. TYPE_0 with 1 octet OD shall be used for Read access. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x01 ;see B.1.4 in [7] b) MTU_DPP1_Set(InputLength) = 0 c) MTU_DPP1_Set(OutputLength) = 0 d) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID e) MTU_ISDU_Add(Index = 24, Subindex = 0, Value = testdata) ;Test parameter f) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns "Reached" g) Evaluation 1) h) SMI_DeviceRead(ABPS_DEVICEREAD(Index = 24, Subindex = 0)) ;returns "OD" i) Evaluation 2) j) MTU_State_CheckOperate ;returns "MTU in OPERATE" k) Evaluation 3) |
| Test parameter | | testdata = "0x74, 0x65, 0x73, 0x74, 0x20, 0x6F, 0x66, 0x20, 0x74, 0x68, 0x65, 0x20, 0x6D, 0x61, 0x73, 0x74, 0x65, 0x72, 0x73, 0x20, 0x77, 0x69, 0x74, 0x68, 0x20, 0x33, 0x32, 0x20, 0x6F, 0x64, 0x64, 0x61" |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "Reached" 2) Check "OD" 3) Check "MTU in OPERATE" |
| Test passed | | "Reached" = TRUE, and "OD" = testdata, and "MTU in OPERATE" = FALSE |
| Test not passed (examples) | | Any evaluation failed or communication error |
| Report | | All evaluations <ok nok> |

2232

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2234 **8.6.2 Master in PREOPERATE uses TYPE_1_2 to read Index 24 (2OD)**

2235 Table 218 defines the test conditions for this test case.

2236 **Table 218 – Master in PREOPERATE uses TYPE_1_2 to read Index 24 (2OD)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0203 |
| Name | TCM_DLOD_PREP_TYPE12READOD2 |
| Purpose (short) | Master uses TYPE_1_2 to read Index 24 in PREOPERATE (2 octets OD) |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 |
| Category / type | Master protocol test: test to pass |
| Specification (clause) | [7], A.2.3, A.5.2, B.2.1, Tables A.8, A.13 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master uses correct M_sequence type according to Device settings in DPP1 for PREOPERATE. TYPE_1-2 with 2 octets OD shall be used for Read access. |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | a) MTU_DPP1_Set(M-sequenceCapability) = 0x11 ;see B.1.4 in [7] [7] b) MTU_DPP1_Set(InputLength) = 0 c) MTU_DPP1_Set(OutputLength) = 0 d) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID e) MTU_ISDU_Add(Index = 24, Subindex = 0, Value = testdata) ;Test parameter f) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns "Reached" g) Evaluation 1) h) SMI_DeviceRead(ABPS_DEVICEREAD(Index = 24, Subindex = 0)) ;returns "OD" i) Evaluation 2) j) MTU_State_CheckOperate ;returns "MTU in OPERATE" k) Evaluation 3) |
| Test parameter | testdata = "0x74, 0x65, 0x73, 0x74, 0x20, 0x6F, 0x66, 0x20, 0x74, 0x68, 0x65, 0x20, 0x6D, 0x61, 0x73, 0x74, 0x65, 0x72, 0x73, 0x20, 0x77, 0x69, 0x74, 0x68, 0x20, 0x33, 0x32, 0x20, 0x6F, 0x64, 0x61" |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluations | 1) Check "Reached" 2) Check "OD" 3) Check "MTU in OPERATE" |
| Test passed | "Reached" = TRUE, and "OD" = testdata, and "MTU in OPERATE" = FALSE |
| Test not passed (examples) | Any evaluation failed or communication error |
| Report | All evaluations <ok nok> |

2241 **8.6.3 Master in PREOPERATE uses TYPE_1_V to read Index 24 (8 OD)**

2242 Table 219 defines the test conditions for this test case.

2243 **Table 219 – Master in PREOPERATE uses TYPE_1_V to read Index 24 (8 OD)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0204 |
| Name | | TCM_DLOD_PREP_TYPE1VREADOD8 |
| Purpose (short) | | Master uses TYPE_1_V to read Index 24 in PREOPERATE (8 octets OD) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], A.2.3, A.5.2, B.2.1, Tables A.8, A.13 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master uses correct M_sequence type according to Device settings in DPP1 for PREOPERATE. TYPE_0_V with 8 octets OD shall be used for Read access. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x21 <i>;see B.1.4 in [7]</i> b) MTU_DPP1_Set(InputLength) = 0 c) MTU_DPP1_Set(OutputLength) = 0 d) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) <i>;invalid VendorID</i> e) MTU_ISDU_Add(Index = 24, Subindex = 0, Value = testdata) f) TM_AWAIT_PORT_STATUS(PORT_DIAG) <i>;returns "Reached"</i> g) Evaluation 1) h) SMI_DeviceRead(ABPS_DEVICEREAD(Index = 24, Subindex = 0)) <i>;returns "OD"</i> i) Evaluation 2) j) MTU_State_CheckOperate <i>;returns "MTU in OPERATE"</i> k) Evaluation 3) |
| Test parameter | | testdata = "0x74, 0x65, 0x73, 0x74, 0x20, 0x6F, 0x66, 0x20, 0x74, 0x68, 0x65, 0x20, 0x6D, 0x61, 0x73, 0x74, 0x65, 0x72, 0x73, 0x20, 0x77, 0x69, 0x74, 0x68, 0x20, 0x33, 0x32, 0x20, 0x6F, 0x64, 0x64, 0x61" |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "Reached" 2) Check "OD" 3) Check "MTU in OPERATE" |
| Test passed | | "Reached" = TRUE, and "OD" = testdata, and "MTU in OPERATE" = FALSE |
| Test not passed (examples) | | Any evaluation failed or communication error |
| Report | | All evaluations <i><ok nok></i> |

2246

2247

2248 **8.6.4 Master in PREOPERATE uses TYPE_1_V to read Index 24 (32 OD)**

2249 Table 220 defines the test conditions for this test case.

2250 **Table 220 – Master in PREOPERATE uses TYPE_1_V to read Index 24 (32 OD)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0205 |
| Name | | TCM_DLOD_PREP_TYPE1VREADOD32 |
| Purpose (short) | | Master uses TYPE_1_V to read Index 24 in PREOPERATE (32 octets OD) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], A.2.3, A.5.2, B.2.1, Tables A.8, A.13 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master uses correct M_sequence type according to Device settings in DPP1 for PREOPERATE. TYPE_1_V with 32 octets OD shall be used for Read access. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x31 ;see B.1.4 in [7] b) MTU_DPP1_Set(InputLength) = 0 c) MTU_DPP1_Set(OutputLength) = 0 d) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID e) MTU_ISDU_Add(Index = 24, Subindex = 0, Value = testdata) f) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns "Reached" g) Evaluation 1) h) SMI_DeviceRead(ABPS_DEVICEREAD(Index = 24, Subindex = 0)) ;returns "OD" i) Evaluation 2) j) MTU_State_CheckOperate ;returns "MTU in OPERATE" k) Evaluation 3) |
| Test parameter | | testdata = "0x74, 0x65, 0x73, 0x74, 0x20, 0x6F, 0x66, 0x20, 0x74, 0x68, 0x65, 0x20, 0x6D, 0x61, 0x73, 0x74, 0x65, 0x72, 0x73, 0x20, 0x77, 0x69, 0x74, 0x68, 0x20, 0x33, 0x32, 0x20, 0x6F, 0x64, 0x61" |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "Reached" 2) Check "OD" 2) Check "MTU in OPERATE" |
| Test passed | | "Reached" = TRUE, and "OD" = testdata, and "MTU in OPERATE" = FALSE |
| Test not passed (examples) | | Any evaluation failed or communication error |
| Report | | All evaluations <ok nok> |

2253

2254

2255 **8.6.5 Master in PREOPERATE uses TYPE_0 to write Index 24 (1 OD)**

2256 Table 221 defines the test conditions for this test case.

2257 **Table 221 – Master in PREOPERATE uses TYPE_0 to write Index 24 (1 OD)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0206 |
| Name | | TCM_DLOD_PREP_TYPE0WRITEOD1 |
| Purpose (short) | | Master uses TYPE_0 to write to Index 24 in PREOPERATE (1 octet OD) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], A.2.2, A.5.2, B.2.1, Tables A.8, A.13 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master uses correct M_sequence type according to Device settings in DPP1 for PREOPERATE. TYPE_0 with 1 octet OD shall be used for Write access. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x01 ;see B.1.4 in [7] b) MTU_DPP1_Set(InputLength) = 0 c) MTU_DPP1_Set(OutputLength) = 0 d) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID e) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns "Reached" f) Evaluation 1) g) MTU_ISDU_Add(Index = 24, Subindex = 0, OD = [0x74]) ;preset data h) SMI_DeviceWrite(ABPS_DEVICEWRITE <Index=24, Subindex = 0, Value = [0x54]>) ;writes test data i) MTU_ISDU_Read(Index = 24, Subindex = 0) ;returns "OD" j) Evaluation 2) k) MTU_State_CheckOperate ;returns "MTU in OPERATE" l) Evaluation 3) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "Reached" 2) Check OD 3) Check "MTU in OPERATE" |
| Test passed | | "Reached" = TRUE, and "OD" = [0x54], and "MTU in OPERATE" = FALSE |
| Test not passed (examples) | | Any evaluation failed or communication error |
| Report | | All evaluations <ok nok> |

2260

2261

2262 **8.6.6 Master in PREOPERATE uses TYPE_1_2 to write Index 24 (2 OD)**

2263 Table 222 defines the test conditions for this test case.

2264 **Table 222 – Master in PREOPERATE uses TYPE_1_2 to write Index 24 (2 OD)**

2265 -CR055-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0207 |
| Name | | TCM_DLOD_PREP_TYPE12WRITEOD2 |
| Purpose (short) | | Master uses TYPE_1_2 to write to Index 24 in PREOPERATE (2 octets OD) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 2 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], A.2.3, A.5.2, B.2.1, Tables A.8, A.13 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master uses correct M_sequence type according to Device settings in DPP1 for PREOPERATE. TYPE_1_2 with 2 octets OD shall be used for Write access. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x11 ;see B.1.4 in [7] b) MTU_DPP1_Set(InputLength) = 0 c) MTU_DPP1_Set(OutputLength) = 0 d) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID e) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns "Reached" f) Evaluation 1) g) MTU_ISDU_Add(Index = 24, Subindex = 0, OD = [0x74, 0x75]) ;preset data h) SMI_DeviceWrite(ABPS_DEVICEWRITE <Index=24, Subindex = 0, Value = [0x54, 0x65]>) ;writes test data i) MTU_ISDU_Read(Index = 24, Subindex = 0) ;returns "OD" j) Evaluation 2) k) MTU_State_CheckOperate ;returns "MTU in OPERATE" l) Evaluation 3) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "Reached" 2) Check OD 3) Check "MTU in OPERATE" |
| Test passed | | "Reached" = TRUE, and "OD" = [0x54, 0x65], and "MTU in OPERATE" = FALSE |
| Test not passed (examples) | | Any evaluation failed or communication error |
| Report | | All evaluations <ok nok> |

2268

2269

2270 **8.6.7 Master in PREOPERATE uses TYPE_1_V to write Index 24 (8 OD)**

2271 Table 223 defines the test conditions for this test case.

2272 **Table 223 – Master in PREOPERATE uses TYPE_1_V to write Index 24 (8 OD)**

2273 -CR055-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0208 |
| Name | | TCM_DLOD_PREP_TYPE1VWRITEOD8 |
| Purpose (short) | | Master uses TYPE_1_V to write to Index 24 in PREOPERATE (8 octets OD) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 2 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], A.2.3, A.5.2, B.2.1, Tables A.8, A.13 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master uses correct M_sequence type according to Device settings in DPP1 for PREOPERATE. TYPE_1_V with 8 octets OD shall be used for Write access. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x21 ;see B.1.4 in [7] b) MTU_DPP1_Set(InputLength) = 0 c) MTU_DPP1_Set(OutputLength) = 0 d) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID e) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns "Reached" f) Evaluation 1) g) MTU_ISDU_Add(Index = 24, Subindex = 0, OD = [0x74, 0x75, 0x76, 0x77, 0x78, 0x79, 0x7A, 0x7B]) ;preset data h) SMI_DeviceWrite(ABPS_DEVICEWRITE <Index=24, Subindex = 0, Value = [0x54, 0x65, 0x73, 0x74, 0x20, 0x38, 0x4F, 0x44]>) ;writes test data i) MTU_ISDU_Read(Index = 24, Subindex = 0) ;returns "OD" j) Evaluation 2) k) MTU_State_CheckOperate ;returns "MTU in OPERATE" l) Evaluation 3) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "Reached" 2) Check OD 3) Check "MTU in OPERATE" |
| Test passed | | "Reached" = TRUE, and "OD" = [0x54, 0x65, 0x73, 0x74, 0x20, 0x38, 0x4F, 0x44], and "MTU in OPERATE" = FALSE |
| Test not passed (examples) | | Any evaluation failed or communication error |
| Report | | All evaluations <ok nok> |

2276

2277

2278 **8.6.8 Master in PREOPERATE uses TYPE_1_V to write Index 24 (32 OD)**

2279 Table 224 defines the test conditions for this test case.

2280 **Table 224 – Master in PREOPERATE TYPE_1_V to write Index 24 (32 OD)**

2281 -CR055-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0209 |
| Name | TCM_DLOD_PREP_TYPE1VWRITED32 |
| Purpose (short) | Master uses TYPE_1_V to write to Index 24 in PREOPERATE (32 octets OD) |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 2 |
| Category / type | Master protocol test: test to pass |
| Specification (clause) | [7], A.2.3, A.5.2, B.2.1, Tables A.8, A.13 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master uses correct M_sequence type according to Device settings in DPP1 for PREOPERATE. TYPE_1_V with 32 octets OD shall be used for Write access. |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedureo | a) MTU_DPP1_Set(M-sequenceCapability) = 0x31 ;see B.1.4 in [7] b) MTU_DPP1_Set(InputLength) = 0 c) MTU_DPP1_Set(OutputLength) = 0 d) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID e) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns "Reached" f) Evaluation 1) g) MTU_ISDU_Add(Index = 24, Subindex = 0, OD = [0x74, 0x75, 0x76, 0x77, 0x78, 0x79, 0x7A, 0x7B, 0x7C, 0x7D, 0x7E, 0x7F, 0x80, 0x81, 0x82, 0x83, 0x84, 0x85, 0x86, 0x87, 0x88, 0x89, 0x8A, 0x8B, 0x8C, 0x8D, 0x8E, 0x8F, 0x90, 0x91, 0x92, 0x93]) ;preset data h) SMI_DeviceWrite(ABPS_DEVICEWRITE <Index=24, Subindex = 0, Value = [0x54, 0x65, 0x73, 0x74, 0x20, 0x6F, 0x66, 0x20, 0x74, 0x68, 0x65, 0x20, 0x4D, 0x61, 0x73, 0x74, 0x65, 0x72, 0x73, 0x20, 0x77, 0x69, 0x74, 0x68, 0x20, 0x33, 0x32, 0x20, 0x4F, 0x44, 0x44, 0x41]>) ;writes test data i) MTU_ISDU_Read(Index = 24, Subindex = 0) ;returns "OD" j) Evaluation 2) k) MTU_State_CheckOperate ;returns "MTU in OPERATE" l) Evaluation 3) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluations | 1) Check "Reached" 2) Check OD 2) Check "MTU in OPERATE" |
| Test passed | "Reached" = TRUE, and "OD" = [0x54, 0x65, 0x73, 0x74, 0x20, 0x6F, 0x66, 0x20, 0x74, 0x68, 0x65, 0x20, 0x4D, 0x61, 0x73, 0x74, 0x65, 0x72, 0x73, 0x20, 0x77, 0x69, 0x74, 0x68, 0x20, 0x33, 0x32, 0x20, 0x4F, 0x44, 0x44, 0x41], and "MTU in OPERATE" = FALSE |
| Test not passed (examples) | Any evaluation failed or communication error |
| Report | All evaluations <ok nok> |

2284

2285

2286 **8.7 OPERATE**2287 **8.7.1 Master in OPERATE uses TYPE_1_V for zero bit PD in/out (8 OD)**

2288 Table 225 defines the test conditions for this test case.

2289 **Table 225 – Master in OPERATE uses TYPE_1_V for zero bit PD in/out (8 OD)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0336 |
| Name | | TCM_DLPD_CYCC_TYPE1V_OD8BIT0INBIT0OUT |
| Purpose (short) | | Master uses M-sequence TYPE_1_V for zero bit PD in/out (8 octets OD) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.0 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (row 3) |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | The Master reads OD length and PD input/output length during STARTUP through DPP1 from Device. Due to these values, the Master shall select M-sequence TYPE_1_V in OPERATE and provide this information to SMI services. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x1D ;see B.1.4 in [7] [7] b) MTU_DPP1_Set(PDIn length) = 0x00 ;"0" Bit c) MTU_DPP1_Set(PDOut length) = 0x00 ;"0" Bit d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;switch to OPERATE e) TM_AWAIT_PORT_STATUS(OPERATE) f) MTU_State_CheckOperate ;returns "MTU in OPERATE" g) Evaluation 1) h) SMI_PDIn ;returns "InputDataLength" i) Evaluation 2) j) SMI_PDIOut ;returns "InputDataLength", "OutputDataLength" k) Evaluation 3) l) SMI_PortStatus ;returns "RevisionID", "InputDataLength", "OutputDataLength" m) Evaluation 4) n) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check value of PDIn.InputDataLength 3) Check value of PDIOut.InputDataLength and PDIOut.OutputDataLength 4) Check value of PortStatus.RevisionID, PortStatus.InputDataLength, and Portstatus.OutputDataLength 5) Check "vendorname" |
| Test passed | | "MTU in OPERATE" = TRUE, and PDIn: InputDataLength = "0", and PDIOut: InputDataLength = "0", OutputDataLength = "0", and PortStatus: RevisionID = 0x11, InputDataLength = "0", OutputDataLength = "0", and <vendorname> = "IO-Link Community" |
| Test not passed (examples) | | Any of the checks in Test passed failed or communication error |
| Report | | vendorname ok: <yes/no> <ok nok> |

2292

2293

2294 **8.7.2 Master in OPERATE uses TYPE_1_V for zero bit PD in/out (32 OD)**

2295 Table 226 defines the test conditions for this test case.

2296 **Table 226 – Master in OPERATE uses TYPE_1_V for zero bit PD in/out (32 OD)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0337 |
| Name | | TCM_DLPD_CYCC_TYPE1V_OD32BIT0INBIT0OUT |
| Purpose (short) | | Master uses M-sequence TYPE_1_V for zero bit PD in/out (32 octets OD) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.0 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], 9.2.3.5, 11.2.7, 11.2.17, 11.2.18, 11.2.19, A.2.6, E.4, E.10, E.11, E.12, Table A.10 (row 4) |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | The Master reads OD length and PD input/output length during STARTUP through DPP1 from Device. Due to these values, the Master shall select M-sequence TYPE_1_V in OPERATE and provide this information to SMI services. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x1F ;see B.1.4 in [7] b) MTU_DPP1_Set(PDIn length) = 0x00 ;"0" Bit c) MTU_DPP1_Set(PDOut length) = 0x00 ;"0" Bit d) SMI_PortConfiguration (ABPS_NOTYPE_CHECK) ;switch to OPERATE e) TM_AWAIT_PORT_STATUS(OPERATE) f) MTU_State_CheckOperate ;returns "MTU in OPERATE" g) Evaluation 1) h) SMI_PDIn ;returns "InputDataLength" i) Evaluation 1) j) SMI_PDIOut ;returns "InputDataLength", "OutputDataLength" k) Evaluation 2) l) SMI_PortStatus ;returns "RevisionID", "InputDataLength", "OutputDataLength" m) Evaluation 3) n) SMI_DeviceRead(ABPS_DEVICEREAD <vendorname>) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check value of PDIn.InputDataLength 3) Check value of PDIOut.InputDataLength and PDIOut.OutputDataLength 4) Check value of PortStatus.RevisionID, PortStatus.InputDataLength, and Portstatus.OutputDataLength 5) Check "vendorname" |
| Test passed | | "MTU in OPERATE" = TRUE, and PDIn: InputDataLength = "0", and PDIOut: InputDataLength = "0", OutputDataLength = "0", and PortStatus: RevisionID = 0x11, InputDataLength = "0", OutputDataLength = "0", and <vendorname> = "IO-Link Community" |
| Test not passed (examples) | | Any of the checks in Test passed failed or communication error |
| Report | | vendorname ok: <yes/no> <ok nok> |

2299

2300

2301 **8.7.3 Master in OPERATE uses TYPE_0 to read Index 24 (1 OD)**

2302 Table 227 defines the test conditions for this test case.

2303 **Table 227 – Master in OPERATE uses TYPE_0 to read Index 24 (1 OD)**

2304 -CR107-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|---|---|
| Identification (ID) | | SDCI_TC_0210 | |
| Name | | TCM_DLOD_OPER_TYPE0READOD1 | |
| Purpose (short) | | Master uses TYPE_0 to read Index 24 in OPERATE (1 octet OD) | |
| Equipment under test (EUT) | | Master + Port | |
| Test case version | | 1.1 | |
| Category / type | | Master protocol test: test to pass | |
| Specification (clause) | | [7], A.2.2, A.5.2, B.2.1, Tables A.10, A.13 | |
| Configuration / setup | | Master-Tester-System | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | | Master uses correct M_sequence type according to Device settings in DPP1 for OPERATE. TYPE_0 with 1 octet OD shall be used for Read access. | |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x01 b) MTU_DPP1_Set(InputLength = 0) c) MTU_DPP1_Set(OutputLength = 0) d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) e) MTU_ISDU_Add(Index = 24, Subindex = 0, OD = [0x74]) f) TM_AWAIT_PORT_STATUS(OPERATE) g) MTU_State_CheckOperate h) Evaluation 1) i) SMI_DeviceRead(ABPS_DEVICEREAD(Index = 24, Subindex = 0)) j) Evaluation 2) | <code>;see B.1.4 in [7]</code> <code>;test data</code> <code>;returns "MTU in OPERATE"</code> <code>;returns "OD"</code> |
| Test parameter | | - | |
| Post condition | | - | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluations | | 1) Check "MTU in OPERATE" 2) Check "OD" | |
| Test passed | | "MTU in OPERATE" = TRUE "OD" = [0x74] | |
| Test not passed (examples) | | Any evaluation failed or communication error | |
| Report | | All evaluations <code><ok nok></code> | |

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2308

2309 **8.7.4 Master in OPERATE uses TYPE_0 to write Index 24 (1 OD)**

2310 Table 228 defines the test conditions for this test case.

2311 **Table 228 – Master in OPERATE uses TYPE_0 to write Index 24 (1 OD)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0211 |
| Name | | TCM_DLOD_OPER_TYPE0WRITEOD1 |
| Purpose (short) | | Master uses TYPE_0 to write to Index 24 in OPERATE (1 octet OD) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master protocol test: test to pass |
| Specification (clause) | | [7], A.2.2, A.5.2, B.2.1, Tables A.10, A.13 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master uses correct M_sequence type according to Device settings in DPP1 for OPERATE. TYPE_0 with 1 octet OD shall be used for Write access. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x01 <i>;see B.1.4 in [7]</i> b) MTU_DPP1_Set(InputLength = 0) c) MTU_DPP1_Set(OutputLength = 0) d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) e) MTU_ISDU_Add(Index = 24, Subindex = 0, OD = [0x74]) <i>;preset test data</i> f) TM_AWAIT_PORT_STATUS(OPERATE) g) MTU_State_CheckOperate <i>;returns "MTU in OPERATE"</i> h) Evaluation 1) i) SMI_DeviceWrite(ABPS_DEVICEWRITE<Index=24, Subindex=0, Value=[0x54]>) <i>;write test data</i> j) MTU_ISDU_Read(Index = 24, Subindex = 0) <i>;returns "OD"</i> k) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "MTU in OPERATE" 2) Check "OD" |
| Test passed | | "MTU in OPERATE" = TRUE "OD" = [0x54] |
| Test not passed (examples) | | Any evaluation failed or communication error |
| Report | | All evaluations <i><ok nok></i> |

2314

2315

2316 **8.7.5 Master in OPERATE uses TYPE_1_2 to write Index 24 (2 OD)**

2317 Table 229 defines the test conditions for this test case.

2318 **Table 229 – Master in OPERATE uses TYPE_1_2 to write Index 24 (2 OD)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|--|
| Identification (ID) | | SDCI_TC_0212 | |
| Name | | TCM_DLOD_OPER_TYPE12WRITEOD2 | |
| Purpose (short) | | Master uses TYPE_1_2 to write to Index 24 in OPERATE (2 octets OD) | |
| Equipment under test (EUT) | | Master + Port | |
| Test case version | | 1.1 | |
| Category / type | | Master protocol test: test to pass | |
| Specification (clause) | | [7], A.2.3, A.5.2, B.2.1, Tables A.10, A.13 | |
| Configuration / setup | | Master-Tester-System | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | | Master uses correct M_sequence type according to Device settings in DPP1 for OPERATE. TYPE_1_2 with 2 octet OD shall be used for Write access. | |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE | |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x11 ;see B.1.4 in [7] b) MTU_DPP1_Set(InputLength = 0) c) MTU_DPP1_Set(OutputLength = 0) d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) e) MTU_ISDU_Add(Index = 24, Subindex = 0, OD = [0x74]) ;preset test data f) TM_AWAIT_PORT_STATUS(OPERATE) g) MTU_State_CheckOperate ;returns "MTU in OPERATE" h) Evaluation 1) i) SMI_DeviceWrite(ABPS_DEVICEWRITE <Index=24, Subindex=0, Value=[0x54, 0x65]>) ;write test data j) MTU_ISDU_Read(Index = 24, Subindex = 0) ;returns "OD" k) Evaluation 2) | |
| Test parameter | | – | |
| Post condition | | – | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluations | | 1) Check "MTU in OPERATE" 2) Check "OD" | |
| Test passed | | "MTU in OPERATE" = TRUE "OD" = [0x54, 0x65] | |
| Test not passed (examples) | | Any evaluation failed or communication error | |
| Report | | All evaluations <ok nok> | |

2321

2322

8.8 Fallback

8.8.1 Fallback from PREOPERATE

Table 230 defines the test conditions for this test case.

Table 230 – Fallback from PREOPERATE

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0213 |
| Name | TCM_DLFB_PROP_OK |
| Purpose (short) | Master Fallback from PREOPERATE |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 |
| Category / type | Master robustness test: test to pass |
| Specification (clause) | [7], 7.3.2.3, Figure 34, 11.3.2, Figure 101, 9.2.1, Figure 69, 9.2.2.2, 5.2.2.1, Table B.2 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | <p>Transition from PREOPERATE to SIO mode of Master Port via reconfiguration and check of its correct behavior afterwards. That means, Master communicates with Device and receives only a switching signal (DI) after reconfiguration.</p> <p>Hint: Master reconfiguration with a different VendorID than permitted for the Device causes Master to hold on in PREOPERATE.</p> |
| Precondition | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | a) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID=1>) ;invalid VendorID b) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns ArgBlock "PortStatusList" c) Evaluation 1) d) MTU_State_CheckPreoperate ;returns "MTU in PREOPERATE" e) Evaluation 2) f) SMI_PortConfiguration(ABPS_PORTTODI) ;switch to DI mode g) MTU_State_CheckFallback ;returns "Master sent Fallback" h) Evaluation 3) i) TM_AWAIT_DI_HIGH ;PDIIn.PDIO="1" within MTU_Timeout j) Evaluation 4) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluations | 1) Check ArgBlock "PortStatusList" 2) Check "MTU in PREOPERATE" 3) Check "Master sent Fallback" 4) Check MTU_Timeout |
| Test passed | "PortStatusList.PortStatusInfo" = PORT_DIAG, and "MTU in PREOPERATE" = TRUE, and "Master sent Fallback" = TRUE, and No MTU_Timeout |
| Test not passed (examples) | Any evaluation failed or MTU_Timeout |
| Report | All evaluations: <ok nok> |

2331 **8.8.2 Fallback from PREOPERATE fails**

2332 Table 231 defines the test conditions for this test case.

2333 **Table 231 – Fallback from PREOPERATE fails**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0214 |
| Name | | TCM_DLFB_PROP_FAILS |
| Purpose (short) | | Master Fallback from PREOPERATE fails |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master robustness test: test to pass |
| Specification (clause) | | [7], 7.3.2.3, 7.3.2.4, Figure 34, Table B.2 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Transition from PREOPERATE to SIO mode of Master Port via reconfiguration and check of its correct behavior afterwards. It is assumed that reconfiguration fails and Master initiates a Port restart or stops communicating. Hint: Master reconfiguration with a different VendorID than permitted for the Device causes Master to hold on in PREOPERATE. |
| Precondition | | EUT: PORT_INACTIVE MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DPP1_Set(M-sequenceCapability) = 0x21 ;see B.1.4 in [7] b) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID c) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns ArgBlock "PortStatusList" d) Evaluation 1) e) MTU_State_CheckPreoperate ;returns "MTU in PREOPERATE" f) Evaluation 2) g) MTU_State_BlockFallback(n=2) ;2 x refuse Fallback acknowledge h) SMI_PortConfiguration(ABPS_PORTTODI) ;switch to DI mode i) MTU_State_CheckFallback ;returns "Master sent Fallback" j) Evaluation 3) k) TM_AWAIT_DI_HIGH ;PDIn.PDI0="1" within Test_Timeout l) Evaluation 4) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check ArgBlock "PortStatusList" 2) Check "MTU in PREOPERATE" 3) Check "Master sent Fallback" 4) Check Test_Timeout |
| Test passed | | "PortStatusList.PortStatusInfo" = PORT_DIAG, and "MTU in PREOPERATE" = TRUE, and "Master sent Fallback" = TRUE, and No Test_Timeout |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations: <ok nok> |

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2338 **8.8.3 Fallback from OPERATE**

2339 Table 232 defines the test conditions for this test case.

2340 **Table 232 – Fallback from OPERATE**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0215 |
| Name | | TCM_DLFB_OPER_OK |
| Purpose (short) | | Master Fallback from OPERATE |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master robustness test: test to pass |
| Specification (clause) | | [7], 7.3.2.3, 7.3.2.4, Figure 34, Table B.2 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Transition from OPERATE to SIO mode of Master Port via reconfiguration and check of its correct behavior afterwards. That means, Master communicates with Device and receives only a switching signal (DI) after reconfiguration. |
| Precondition | | EUT: PORT_AUTOSTART MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_CheckOperate ;returns "MTU in OPERATE" b) Evaluation 1) c) SMI_PortConfiguration(ABPS_PORTTODI) d) MTU_State_CheckFallback ;switch to DI mode ;returns "Master sent Fallback" e) Evaluation 2) f) TM_AWAIT_DI_HIGH ;PDIn.PDIO = 1 within MTU_Timeout g) Evaluation 3) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "MTU in OPERATE" 2) Check "Master sent Fallback" 3) Check MTU_Timeout |
| Test passed | | "MTU in OPERATE" = TRUE, and "Master sent Fallback" = TRUE, and No MTU_Timeout |
| Test not passed (examples) | | Any evaluation failed or MTU_Timeout |
| Report | | All evaluations: <ok nok> |

2343

2344

2345 **8.8.4 Fallback from OPERATE fails**

2346 Table 233 defines the test conditions for this test case.

2347 **Table 233 – Fallback from OPERATE fails**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0216 |
| Name | | TCM_DLFB_OPER_FAILS |
| Purpose (short) | | Master Fallback from OPERATE fails |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master robustness test: test to pass |
| Specification (clause) | | [7], 7.3.2.3, 7.3.2.4, Figure 34, Table B.2 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Transition from OPERATE to SIO mode of Master Port via reconfiguration and check of its correct behavior afterwards. That means, Master shall send two times the Fallback command after the reception of a second invalid response. Upon receipt of the invalid response, Master initiates a Port restart or stops communicating. |
| Precondition | | EUT: PORT_AUTOSTART MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_CheckOperate ;returns "MTU in OPERATE" b) Evaluation 1) c) MTU_State_BlockFallback(<i>n</i> =2) ;2 x refuse Fallback acknowledge d) SMI_PortConfiguration(ABPS_PORTTODI) e) MTU_State_CheckFallback ;returns "Master sent Fallback" f) Evaluation 2) g) TM_AWAIT_DI_HIGH ;PDI0="1" within Test_Timeout h) Evaluation 3) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "MTU in OPERATE" 2) Check "Master sent Fallback" 3) Check Test_Timeout |
| Test passed | | "MTU in OPERATE" = TRUE, and "Master sent Fallback" = TRUE, and No Test_Timeout |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations: <ok nok> |

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2352 **8.9 Retry**

2353 **8.9.1 Retries after 2 reply messages with incorrect Checksum (STARTUP)**

2354 Table 234 defines the test conditions for this test case.

2355 **Table 234 – Retries after 2 reply messages with incorrect Checksum (STARTUP)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0338 |
| Name | | TCM_DLCC_RTRY_CKSINCORR2STRUP |
| Purpose (short) | | Retry behavior after 2 reply messages with incorrect checksum in STARTUP |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master robustness test: test to pass |
| Specification (clause) | | [7], 7.3.3.4, Figure 40, Table 46 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Retry behavior of Master after receiving reply message with incorrect checksum at STARTUP. Master repeats the request message and again reply with incorrect checksum. After a third trial, reply is correct. |
| Precondition | | EUT: PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_CountRestarts ;reset counter b) MTU_State_IncorrectChecksums(n=2) ;2 x reply with incorrect checksum c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;begin with start-up d) TM_AWAIT_PORT_STATUS(OPERATE) e) MTU_State_CountRestarts ;returns "Restarts" f) Evaluation 1) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "Restarts" |
| Test passed | | "Restarts" = 1 |
| Test not passed (examples) | | Any evaluation failed or communication error or Procedure does not terminate |
| Report | | All evaluations <ok nok> |

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2360 **8.9.2 Retries after 2 reply messages with incorrect Checksum (PREOP)**

2361 Table 235 defines the test conditions for this test case.

2362 **Table 235 – Retries after 2 reply messages with incorrect Checksum (PREOP)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0339 |
| Name | | TCM_DLCC_RTRY_CKSINCORR2PREOP |
| Purpose (short) | | Retry behavior after 2 reply messages with incorrect checksum in PREOPERATE |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master robustness test: test to pass |
| Specification (clause) | | [7], 7.3.3.4, Figure 40, Table 46 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Retry behavior of Master after receiving reply message with incorrect checksum at PREOPERATE. Master repeats the request message and again reply with incorrect checksum. After a third trial, reply is correct. |
| Precondition | | EUT: PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_CountRestarts b) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID c) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns ArgBlock "PortStatusList" d) Evaluation 1) ef) MTU_State_IncorrectChecksum(<i>n</i> =2) ;2 x reply with incorrect checksum f) SMI_DeviceRead(ABPS_DEVICEREAD [Index=0x10]) ;returns "VendorName" g) Evaluation 2) h) MTU_State_CheckPreoperate ;returns "Reached" i) Evaluation 3) j) MTU_State_CountRestarts ;returns "Restarts" k) Evaluation 4) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check ArgBlock "PortStatusList" 2) Check "VendorName" 3) Check "Reached" 4) Check "Restarts" |
| Test passed | | "PortStatusList.PortStatusInfo" = PORT_DIAG, and "VendorName" = IO-Link Community, and "Reached" = TRUE, and "Restarts" = 1 |
| Test not passed (examples) | | Any evaluation failed, or SMI_DeviceRead with negative response, or Procedure does not terminate |
| Report | | All evaluations <ok nok> |

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2366

2367 **8.9.3 Retries after 2 reply messages with incorrect Checksum (OPERATE)**

2368 Table 236 defines the test conditions for this test case.

2369 **Table 236 – Retries after 2 reply messages with incorrect Checksum (OPERATE)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0340 |
| Name | | TCM_DLCC_RTRY_CKSINCORR2OPERATE |
| Purpose (short) | | Retry behavior after 2 reply messages with incorrect checksum in OPERATE |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master robustness test: test to pass |
| Specification (clause) | | [7], 7.3.3.4, Figure 40, Table 46 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Retry behavior of Master after receiving reply message with incorrect checksum at OPERATE. Master repeats the request message and again reply with incorrect checksum. After a third trial, reply is correct. |
| Precondition | | EUT: PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_CountRestarts ;reset counter b) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;begin with start-up c) TM_AWAIT_PORT_STATUS(OPERATE) ;returns ArgBlock "PortStatusList" d) Evaluation 1) e) MTU_State_IncorrectChecksum(<i>n</i> =2) ;2 x reply with incorrect checksum f) SMI_DeviceRead(ABPS_DEVICEREAD [Index=0x10]) ;returns "VendorName" g) Evaluation 2) h) MTU_State_CountRestarts ;returns "Restarts" i) Evaluation 3) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check ArgBlock "PortStatusList" 2) Check "VendorName" 3) Check "Restarts" |
| Test passed | | "PortStatusList.PortStatusInfo" = PORT_DIAG, and "VendorName" = IO-Link Community, and "Restarts" = 1 |
| Test not passed (examples) | | Any evaluation failed, or SMI_DeviceRead with negative response, or Procedure does not terminate |
| Report | | All evaluations <ok nok> |

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2374 **8.9.4 Retries after 3 reply messages with incorrect Checksum (STARTUP)**

2375 Table 237 defines the test conditions for this test case.

2376 **Table 237 – Retries after 3 reply messages with incorrect Checksum (STARTUP)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0341 |
| Name | | TCM_DLCC_RTRY_CKSINCORR3STRUP&RESTOP |
| Purpose (short) | | Retry behavior after 3 reply messages with incorrect CKS at STARTUP (restart/stop) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master robustness test: test to fail |
| Specification (clause) | | [7], 7.3.3.4, Figure 40, Table 46 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Retry behavior of Master after receiving reply message with incorrect checksum at STARTUP. Master repeats the request message and again reply with incorrect checksum. After a third trial, reply is still incorrect. |
| Precondition | | EUT: PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_CountRestarts b) MTU_State_IncorrectChecksum($n=3$) c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) d) TM_AWAIT_PORT_STATUS (OPERATE) e) MTU_State_CountRestarts f) Evaluation 1 |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "Restarts" |
| Test passed | | "Restarts" = 2 |
| Test not passed (examples) | | Any evaluation failed, or Procedure does not terminate |
| Report | | All evaluations <ok nok> |

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2380

2381 **8.9.5 Retries after 3 reply messages with incorrect Checksum (PREOP)**

2382 Table 238 defines the test conditions for this test case.

2383 **Table 238 – Retries after 3 reply messages with incorrect Checksum (PREOP)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0342 |
| Name | | TCM_DLCC_RTRY_CKSINCORR3PREOP&RESTOP |
| Purpose (short) | | Retry behavior after 3 reply messages with incorrect CKS at PREOP (restart/stop) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master robustness test: test to fail |
| Specification (clause) | | [7], 7.3.3.4, Figure 40, Table 46 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Retry behavior of Master after receiving reply message with incorrect checksum at PREOPERATE. Master repeats the request message and again reply with incorrect checksum. After a third trial, reply is still incorrect. |
| Precondition | | EUT: PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_CountRestarts b) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID c) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns ArgBlock "PortStatusList" d) Evaluation 1) e) MTU_State_CheckPreoperate ;returns "reached" f) Evaluation 2) g) MTU_State_IncorrectChecksum(<i>n</i> =3) ;3 x reply with incorrect checksum h) SMI_DeviceRead(ABPS_DEVICEREAD [Index=0x10]) ;dummy read for delay i) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns ArgBlock "PortStatusList" j) Evaluation 3) k) MTU_State_CheckPreoperate ;returns "reached" l) Evaluation 4) m) MTU_State_CountRestarts ;returns "Restarts" n) Evaluation 5) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check ArgBlock "PortStatusList" 2) Check "reached" 3) Check ArgBlock "PortStatusList" 4) Check "reached" 5) Check "Restarts" |
| Test passed | | "PortStatusList.PortStatusInfo" = PORT_DIAG, and ;PREOPERATE reached "reached" = TRUE, and "PortStatusList.PortStatusInfo" = PORT_DIAG, and ;PREOPERATE reached "reached" = TRUE, and "RESTARTS" = 2 |
| Test not passed (examples) | | Any evaluation failed, or Procedure does not terminate |
| Report | | All evaluations <ok nok> |

2388 **8.9.6 Retries after 3 reply messages with incorrect Checksum (OPERATE)**

2389 Table 239 defines the test conditions for this test case.

2390 **Table 239 – Retries after 3 reply messages with incorrect Checksum (OPERATE)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0343 |
| Name | | TCM_DLCC_RTRY_CKSINCORR3OPER&RESTOP |
| Purpose (short) | | Retry behavior after 3 reply messages with incorrect CKS at OPERATE (restart/stop) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master robustness test: test to fail |
| Specification (clause) | | [7], 7.3.3.4, Figure 40, Table 46 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Retry behavior of Master after receiving reply message with incorrect checksum at OPERATE. Master repeats the request message and again reply with incorrect checksum. After a third trial, reply is still incorrect. |
| Precondition | | EUT: PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_CountRestarts ;reset counter b) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;begin with start-up c) TM_AWAIT_PORT_STATUS(OPERATE) ;returns ArgBlock "PortStatusList" d) Evaluation 1) e) MTU_State_CheckPreoperate ;returns "reached" f) Evaluation 2) g) MTU_State_IncorrectChecksum(<i>n</i> =3) ;3 x reply with incorrect checksum h) SMI_DeviceRead(ABPS_DEVICEREAD [Index=0x10]) ;dummy read for delay i) TM_AWAIT_PORT_STATUS(OPERATE) ;returns ArgBlock "PortStatusList" j) Evaluation 4) k) MTU_State_CheckPreoperate ;returns "reached" l) Evaluation 5) m) MTU_State_CountRestarts ;returns "Restarts" n) Evaluation 6) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check ArgBlock "PortStatusList" 2) Check "reached" 3) Check ArgBlock "PortStatusList" 4) Check "reached" 5) Check "Restarts" |
| Test passed | | "PortStatusList.PortStatusInfo" = OPERATE, and "reached" = TRUE, and "PortStatusList.PortStatusInfo" = OPERATE, and "reached" = TRUE, and "RESTARTS" = 2 |
| Test not passed (examples) | | Any evaluation failed, or Procedure does not terminate |
| Report | | All evaluations <ok nok> |

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2395 **8.9.7 Retries after 2 missing replies and finally correct Checksum (STARTUP)**

2396 Table 240 defines the test conditions for this test case.

2397 **Table 240 – Retries after 2 missing replies and finally correct Checksum (STARTUP)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|
| Identification (ID) | SDCI_TC_0344 | |
| Name | TCM_DLCC_RTRY_MISSREP2STRTUP | |
| Purpose (short) | Retry behavior after 2 missing replies and finally correct Checksum in STARTUP | |
| Equipment under test (EUT) | Master + Port | |
| Test case version | 1.1 | |
| Category / type | Master robustness test: test to pass | |
| Specification (clause) | [7], 7.3.3.4, Figure 40, Table 46 | |
| Configuration / setup | Master-Tester-System | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Retry behavior of Master after receiving no reply messages at STARTUP. Master sends request message, MTU does not send reply message. Master sends message again, MTU again does not send reply message. Master repeats the message once more and receives a valid reply message from MTU. | |
| Precondition | EUT: PORT_DI MTU: MTU_STANDARD_STATE | |
| Procedure | a) MTU_State_CountRestarts b) MTU_State_SkipResponse ($n=2$) c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) d) TM_AWAIT_PORT_STATUS (OPERATE) e) MTU_State_CountRestarts f) Evaluation 1) | <i>;reset counter</i> <i>;2 x no reply message</i> <i>;begin with start-up</i> <i>;returns "Restarts"</i> |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluations | 1) Check "Restarts" | |
| Test passed | "Restarts" = 1 | |
| Test not passed (examples) | Any evaluation failed, or Communication error, or Procedure does not terminate | |
| Report | All evaluations | <ok nok> |

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2402 **8.9.8 Retries after 2 missing replies and finally correct Checksum (PREOP)**

2403 Table 241 defines the test conditions for this test case.

2404 **Table 241 – Retries after 2 missing replies and finally correct Checksum (PREOP)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0345 |
| Name | | TCM_DLCC_RTRY_MISSREP2PREOP |
| Purpose (short) | | Retry behavior after 2 missing replies and finally correct Checksum in PREOP |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master robustness test: test to pass |
| Specification (clause) | | [7], 7.3.3.4, Figure 40, Table 46 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Retry behavior of Master after receiving no reply messages at PREOPERATE. Master sends request message, MTU does not send reply message. Master sends message again, MTU again does not send reply message. Master repeats the message once more and receives a valid reply message from MTU. |
| Precondition | | EUT: PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_CountRestarts ;reset counter b) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID c) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns ArgBlock "PortStatusList" d) Evaluation 1) e) MTU_State_CheckPreoperate ;returns "reached" f) Evaluation 2) g) MTU_State_SkipResponse (n=2) ;2 x no reply message h) SMI_DeviceRead(ABPS_DEVICEREAD [Index=0x10]) ; dummy read for delay i) MTU_State_CheckPreoperate" ;returns "reached" j) Evaluation 3) k) MTU_State_CountRestarts ;returns "Restarts" l) Evaluation 4) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check ArgBlock "PortStatusList" 2) Check "reached" 3) Check "reached" 4) Check "Restarts" |
| Test passed | | "PortStatusList.PortStatusInfo" = PORT_DIAG, and ;PREOPERATE reached "reached" = TRUE, and "reached" = TRUE, and "Restarts" = 1 |
| Test not passed (examples) | | Any evaluation failed, or SMI_DeviceRead with negative response, or Procedure does not terminate |
| Report | | All evaluations <ok nok> |

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2409 **8.9.9 Retries after 2 missing replies and finally correct Checksum (OPERATE)**

2410 Table 242 defines the test conditions for this test case.

2411 **Table 242 – Retries after 2 missing replies and finally correct Checksum (OPERATE)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0346 |
| Name | TCM_DLCC_RTRY_MISSREP2OPER |
| Purpose (short) | Retry behavior after 2 missing replies and finally correct Checksum in OPERATE |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 |
| Category / type | Master robustness test: test to pass |
| Specification (clause) | [7], 7.3.3.4, 9.3.3.2, Figure 40, Table 46 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Retry behavior of Master after receiving no reply messages at OPERATE. Master sends request message, MTU does not send reply message. Master sends message again, MTU again does not send reply message. Master repeats the message once more and receives a valid reply message from MTU. |
| Precondition | EUT: PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | a) MTU_State_CountRestarts ;reset counter b) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;begin with start-up c) TM_AWAIT_PORT_STATUS(OPERATE) ;returns ArgBlock "PortStatusList" d) Evaluation 1) e) MTU_State_CheckPreoperate ;returns "reached" f) Evaluation 2) g) MTU_State_SkipResponse (n=2) ;2 x no reply message h) SMI_DeviceRead(ABPS_DEVICEREAD [Index=0x10]) ;returns "VendorName" i) Evaluation 3) j) MTU_State_CountRestarts ;returns "Restarts" k) Evaluation 4) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluations | 1) Check ArgBlock "PortStatusList" 2) Check "reached" 3) Check "VendorName" 4) Check "Restarts" |
| Test passed | "PortStatusList.PortStatusInfo" = OPERATE, and "reached" = TRUE, and "VendorName" = IO-Link Community, and "Restarts" = 1 |
| Test not passed (examples) | Any evaluation failed or SMI_DeviceRead with negative response Procedure does not terminate |
| Report | All evaluations <ok nok> |

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2416 **8.9.10 Retries after 3 missing replies ending with restart/stop (STARTUP)**

2417 Table 243 defines the test conditions for this test case.

2418 **Table 243 – Retries after 3 missing replies ending with restart/stop (STARTUP)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0347 |
| Name | | TCM_DLCC_RTRY_REPMISS3STRTUP&RESTOP |
| Purpose (short) | | Retry behavior after 3 missing reply messages at STARTUP (restart/stop) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master robustness test: test to fail |
| Specification (clause) | | [7], 7.3.3.4, 9.3.3.2, Figure 40, Table 46 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Retry behavior of Master after receiving no reply messages at STARTUP. Master sends request message, MTU does not send reply message. Master sends message again, MTU again does not send reply message. After a third trial, reply is still missing. |
| Precondition | | EUT: PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_CountRestarts b) MTU_State_SkipResponse ($n=3$) c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) d) TM_AWAIT_PORT_STATUS (OPERATE) e) MTU_State_CountRestarts f) Evaluation 1) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "Restarts" |
| Test passed | | "Restarts" = 2 |
| Test not passed (examples) | | Any evaluation failed, or Procedure does not terminate |
| Report | | All evaluations <ok nok> |

2421

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2423 **8.9.11 Retries after 3 missing replies ending with restart/stop (PREOP)**

2424 Table 244 defines the test conditions for this test case.

2425 **Table 244 – Retries after 3 missing replies ending with restart/stop (PREOP)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0348 |
| Name | TCM_DLCC_RTRY_REPMISS3PREOP&RESTOP |
| Purpose (short) | Retry behavior after 3 missing reply messages at PREOP (restart/stop) |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 |
| Category / type | Master robustness test: test to fail |
| Specification (clause) | [7], 7.3.3.4, 9.3.3.2, Figure 40, Table 46 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Retry behavior of Master after receiving no reply messages at PREOPERATE. Master sends request message, MTU does not send reply message. Master sends message again, MTU again does not send reply message. After a third trial, reply is still missing. |
| Precondition | EUT: PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | a) MTU_State_CountRestarts ;reset counter b) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID c) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns ArgBlock "PortStatusList" d) Evaluation 1) e) MTU_State_CheckPreoperate ;returns "reached" f) Evaluation 2) g) MTU_State_SkipResponse (n=3) ;3 x no reply message h) SMI_DeviceRead(ABPS_DEVICEREAD [Index=0x10]) ;dummy read for delay i) TM_AWAIT_PORT_STATUS(PORT_DIAG) ;returns ArgBlock "PortStatusList" j) Evaluation 3) k) MTU_State_CheckPreoperate ;returns "reached" l) Evaluation 4) m) MTU_State_CountRestarts ;returns "Restarts" n) Evaluation 5) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluations | 1) Check ArgBlock "PortStatusList" 2) Check "reached" 3) Check ArgBlock "PortStatusList" 4) Check "reached" 5) Check "Restarts" |
| Test passed | "PortStatusList.PortStatusInfo" = PORT_DIAG, and "reached" = TRUE, and "PortStatusList.PortStatusInfo" = PORT_DIAG, and "reached" = TRUE, and "RESTARTS" = 2 ;PREOPERATE reached ;PREOPERATE reached |
| Test not passed (examples) | Any evaluation failed, or Procedure does not terminate |
| Report | All evaluations <ok nok> |

2428

2429

2430 **8.9.12 Retries after 3 missing replies ending with restart/stop (OPERATE)**

2431 Table 245 defines the test conditions for this test case.

2432 **Table 245 – Retries after 3 missing replies ending with restart/stop (OPERATE)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|--|---|--|
| Identification (ID) | | SDCI_TC_0349 | |
| Name | | TCM_DLCC_RTRY_REPMISS3OPER&RESTOP | |
| Purpose (short) | | Retry behavior after 3 missing reply messages at OPERATE (restart/stop) | |
| Equipment under test (EUT) | | Master + Port | |
| Test case version | | 1.1 | |
| Category / type | | Master robustness test: test to fail | |
| Specification (clause) | | [7], 7.3.3.4, 9.3.3.2, Figure 40, Table 46 | |
| Configuration / setup | | Master-Tester-System | |
| TEST CASE | | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | | Retry behavior of Master after receiving no reply messages at OPERATE. Master sends request message, MTU does not send reply message. Master sends message again, MTU again does not send reply message. After a third trial, reply is still missing. | |
| Precondition | | EUT: PORT_DI MTU: MTU_STANDARD_STATE | |
| Procedure | | a) MTU_State_CountRestarts ;reset counter b) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ;begin with start-up c) TM_AWAIT_PORT_STATUS(OPERATE) ;returns ArgBlock "PortStatusList" d) Evaluation 1) e) MTU_State_CheckPreoperate ;returns "reached" f) Evaluation 2) g) MTU_State_SkipResponse (n=3) ;3 x no reply message h) SMI_DeviceRead(ABPS_DEVICEREAD [Index=0x10]) ;dummy read for delay i) TM_AWAIT_PORT_STATUS(OPERATE) ;returns ArgBlock "PortStatusList" j) Evaluation 3) k) MTU_State_CheckPreoperate ;returns "reached" l) Evaluation 4) m) MTU_State_CountRestarts ;returns "Restarts" n) Evaluation 5) | |
| Test parameter | | – | |
| Post condition | | – | |
| TEST CASE RESULTS | | CHECK / REACTION | |
| Evaluations | | 1) Check ArgBlock "PortStatusList" 2) Check "reached" 3) Check ArgBlock "PortStatusList" 4) Check "reached" 5) Check "Restarts" | |
| Test passed | | "PortStatusList.PortStatusInfo" = OPERATE, and "reached" = TRUE, and "PortStatusList.PortStatusInfo" = OPERATE, and "reached" = TRUE, and "RESTARTS" = 2 | |
| Test not passed (examples) | | Any evaluation failed, or Procedure does not terminate | |
| Report | | All evaluations <ok nok> | |

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2436

8.9.13 Maximum WURQs and final success

-CR047- -CR092-

Table 246 defines the test conditions for this test case.

Table 246 – Maximum WURQs and final success ???

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0224 |
| Name | TCM_DLCC_RTRY_MAXWURQSUCCESS |
| Purpose (short) | Behavior at maximum WURQ sequences and final success |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 2 |
| Category / type | Master robustness test: test to pass |
| Specification (clause) | [7], 7.3.2.2, 7.3.2.4, Figures 31, 32, and 33 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master behavior at maximum WURQ sequences and final success. Master is in non-communicative mode. Master sends a wakeup pulse (WURQ) for the first time with subsequent communication requests. MTU does not respond to the 3 subsequent communication requests (COM3 to COM1). Master sends a wakeup pulse (WURQ) again with subsequent communication requests. MTU again does not respond. Master repeats the wakeup pulse (WURQ) a third time with subsequent communication requests. Finally, MTU responds to the communication requests. |
| Precondition | EUT: PORT_D1 MTU: MTU_STANDARD_STATE |
| Procedure | a) MTU_State_CountRestarts ; <i>reset counter</i> b) MTU_State_SkipResponse ($n=3$ 2 , WURQ=TRUE) ; <i>6.3.2 x no reply message</i> c) SMI_PortConfiguration (ABPS_NOTYPE_CHECK) ; <i>begin with start-up</i> d) TM_AWAIT_PORT_STATUS(OPERATE) e) MTU_State_CheckOperate ; <i>returns "reached"</i> f) Evaluations 1) g) MTU_State_CountRestarts ; <i>counts Restarts</i> h) Evaluation 2) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluations | 1) Check "reached" 2) Check "Restarts" |
| Test passed | "reached" = TRUE, and "Restarts" = 3 |
| Test not passed (examples) | Any evaluation failed, or Communication error |
| Report | All evaluations <ok nok> |

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2444

2445 **8.9.14 Maximum WURQs and no final success**

2446 Table 247 defines the test conditions for this test case.

2447 **Table 247 – Maximum WURQs and no final success**

2448 -CR046- -CR92-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0222 |
| Name | | TCM_DLCC_RTRY_MAXWURQNOSUCCESS |
| Purpose (short) | | Behavior at maximum WURQ sequences and no final success |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.4 2 |
| Category / type | | Master robustness test: test to fail |
| Specification (clause) | | [7], 7.3.2.2, 7.3.2.4, Figures 31, 32, and 33 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master behavior with maximum WURQ sequences and no final success. Master is in STARTUP mode. Master sends at first a Wakeup pulse (WURQ) with subsequent communication requests. MTU does not respond to the subsequent communication requests. Master resends the Wakeup pulse (WURQ) with subsequent communication requests and again there is no response from MTU. Master repeats again the Wakeup pulse (WURQ) with subsequent communication requests and again there is no response from MTU. After a break, Master restarts the Wake-up requests and this time MTU responds in a correct manner. |
| Precondition | | EUT: PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_State_CountRestarts ;reset counter b) MTU_State_SkipResponse ($n=9$ 3 , WURQ=TRUE) ; 3 x no reply message) ; 9 x no reply message c) SMI_PortConfiguration (ABPS_NOTYPE_CHECK) ;begin with start-up d) TM_AWAIT_PORT_STATUS(OPERATE) e) MTU_State_CheckOperate ;returns "reached" f) Evaluations 1) g) MTU_State_CountRestarts ;returns "Restarts" h) Evaluation 2) |
| Test parameter | | - |
| Post condition | | - |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluations | | 1) Check "reached" 2) Check "Restarts" |
| Test passed | | "reached" = TRUE, and "Restarts" = 4 ; 4 restarts counted, last with 1 s delay |
| Test not passed (examples) | | Any evaluation failed, or Communication error |
| Report | | All evaluations <ok nok> |

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2453 **8.10 ISDU (Indexed Service Data Unit) – Application ErrorTypes**

2454 **8.10.1 ISDU Write rejected with ErrorType**

2455 Table 248 defines the test conditions for this test case.

2456 **Table 248 – ISDU Write rejected with ErrorType**

2457 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0223 |
| Name | | TCM_ALIC_AERR_WRITEREJECT |
| Purpose (short) | | ISDU Write service rejected with defined ErrorType, no details |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write service rejected with ErrorType, no details. Access to a supported Index of the MTU is rejected with an application error without details. The response reports an ErrorCode "0x8000" (APP_DEV). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16383,Subindex=0,Value=[0x00],ErrorType_W=0x8000) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16383,Subindex=0,OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8000 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

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2461

2462 **8.10.2 ISDU Write to unsupported Index rejected with ErrorType**

2463 Table 249 defines the test conditions for this test case.

2464 **Table 249 – ISDU Write to unsupported Index rejected with ErrorType**

2465 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0224 |
| Name | | TCM_ALIC_AERR_WRITEINDEXUNSUPPORTED |
| Purpose (short) | | ISDU Write to unsupported Index rejected with ErrorType |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write to unsupported Index rejected with ErrorType. Access to a non-supported Index in the MTU is rejected with an application error. The response reports an ErrorCode "0x8011" (IDX_NOTAVAIL). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=254, Subindex=0, Value=[0x00], ErrorType_W=0x8011) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=254, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8011 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2468

2469

2470 **8.10.3 ISDU Write to unsupported Subindex rejected with ErrorType**

2471 Table 250 defines the test conditions for this test case.

2472 **Table 250 – ISDU Write to unsupported Subindex rejected with ErrorType**

2473 -CR099-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0225 |
| Name | TCM_ALIC_AERR_WRITESUBINDEXNOTSUPPORTED |
| Purpose (short) | ISDU Write to unsupported Subindex (>0) rejected with ErrorType |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 |
| Category / type | Master ISDU test: test to pass |
| Specification (clause) | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | ISDU Write to unsupported Subindex (>0) rejected with ErrorType. Access to a non-supported Subindex in the MTU is rejected with an application error. The response reports an ErrorCode "0x8012" (SUBIDX_NOTAVAIL). |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=253, Subindex=0, Value=[0x00], ErrorType_W=0x8012) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=253, Subindex=1, OD=[0x00])) e) Evaluation 2) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8012 |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <i><ok nok></i> |

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2478 **8.10.4 ISDU Write to temporarily unavailable Index rejected with ErrorType**

2479 Table 251 defines the test conditions for this test case.

2480 **Table 251 – ISDU Write to temporarily unavailable Index rejected with ErrorType**

2481 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0226 |
| Name | | TCM_ALIC_AERR_WRITETEMPUNAV |
| Purpose (short) | | ISDU Write to temporarily unavailable Index rejected with ErrorType |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write to temporarily unavailable Index rejected with ErrorType. Access to a temporarily unavailable Index in the MTU is rejected with an application error. The response reports an ErrorCode "0x8020" (SERV_NOTAVAIL). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=252, Subindex=0, Value=[0x00], ErrorType_W=0x8020) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=252, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8020 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <i><ok nok></i> |

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2486 **8.10.5 ISDU Write to temporarily unavailable Index due to local control**

2487 Table 252 defines the test conditions for this test case.

2488 **Table 252 – ISDU Write to temporarily unavailable Index due to local control**

2489 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0227 |
| Name | | TCM_ALIC_AERR_WRITEINDEXTEMPANAVLC |
| Purpose (short) | | ISDU Write to temporarily unavailable Index due to local control |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to a temporarily unavailable Index due to local control in the MTU is rejected with an application error. The response reports an ErrorCode "0x8021" (SERV_NOTAVAIL_LOCCRTL). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=251, Subindex=0, Value=[0x00], ErrorType_W=0x8021) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=251, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8021 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

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2494 **8.10.6 ISDU Write to temporarily unavailable Index due to Device control**

2495 Table 253 defines the test conditions for this test case.

2496 **Table 253 – ISDU Write to temporarily unavailable Index due to Device control**

2497 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0228 |
| Name | | TCM_ALIC_AERR_WRITEINDEXTEMPANAVDC |
| Purpose (short) | | ISDU Write to temporarily unavailable Index due to Device control |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to temporarily unavailable Index due to Device control in the MTU is rejected with an application error. The response reports an ErrorCode "0x8022" (SERV_NOTAVAIL_DEVCTRL). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=250, Subindex=0, Value=[0x00], ErrorType_W=0x8022) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=250, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8022 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

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2502 **8.10.7 ISDU Write to read-only Index denied**

2503 Table 254 defines the test conditions for this test case.

2504 **Table 254 – ISDU Write to read-only Index denied**

2505 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0229 |
| Name | | TCM_ALIC_AERR_WRITEINDEXRO |
| Purpose (short) | | ISDU Write to read-only Index denied |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to read-only Index in the MTU is denied with an application error. The response reports an ErrorCode "0x8023" (IDX_NOT_ACCESSIBLE). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=249, Subindex=0, Value=[0x00], ErrorType_W=0x8023) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=249, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8023 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2508

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2510 **8.10.8 ISDU Write with invalid Length**

2511 Table 255 defines the test conditions for this test case.

2512 **Table 255 – ISDU Write with invalid Length**

2513 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0230 |
| Name | | TCM_ALIC_AERR_WRITEINVALIDLEN |
| Purpose (short) | | ISDU Write with invalid Length |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access with too short data length to an Index in the MTU is rejected with an application error. The response reports an ErrorCode "0x8034" (VAL_LE-NUNDRUN). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=248, Subindex=0, Value=[0x00], ErrorType_W=0x8034) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=248, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8034 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

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2518 **8.10.9 ISDU Write with parameter value out of range**

2519 Table 256 defines the test conditions for this test case.

2520 **Table 256 – ISDU Write with parameter value out of range**

2521 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0231 |
| Name | | TCM_ALIC_AERR_WRITEPARAMOUTOFRNG |
| Purpose (short) | | ISDU Write with parameter value out of range |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access with parameter values out of range to an Index in the MTU is rejected with an application error. The response reports an ErrorCode "0x8030" (PAR_VALOUTOFRNG). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16382, Subindex=0, Value=[0x00], ErrorType_W=0x8030) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16382, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8030 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

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2526 **8.10.10 ISDU Write with parameter value above limit**

2527 Table 257 defines the test conditions for this test case.

2528 **Table 257 – ISDU Write with parameter value above limit**

2529 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0232 |
| Name | | TCM_ALIC_AERR_WRITEPARAMABOVELIMIT |
| Purpose (short) | | ISDU Write with parameter value above limit |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access with parameter values above limit to an Index in the MTU is rejected with an application error. The response reports an ErrorCode "0x8031" (PAR_VALGTLIM). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16381, Subindex=0, Value=[0x00], ErrorType_W=0x8031) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16381, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8031 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <i><ok nok></i> |

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2534 **8.10.11 ISDU Write with parameter value below limit**

2535 Table 258 defines the test conditions for this test case.

2536 **Table 258 – ISDU Write with parameter value below limit**

2537 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0233 |
| Name | | TCM_ALIC_AERR_WRITEPARAMBELOWLIMIT |
| Purpose (short) | | ISDU Write with parameter value below limit |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access with parameter values below limit to an Index in the MTU is rejected with an application error. The response reports an ErrorCode "0x8032" (PAR_VALLTLM). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16380, Subindex=0, Value=[0x00], ErrorType_W=0x8032) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16380, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8032 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

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2542 **8.10.12 ISDU Write with invalid parameter set**

2543 Table 259 defines the test conditions for this test case.

2544 **Table 259 – ISDU Write with invalid parameter set**

2545 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0234 |
| Name | | TCM_ALIC_AERR_WRITEPARAMINVALID |
| Purpose (short) | | ISDU Write with invalid parameter set |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access with invalid parameter values to an Index in the MTU is rejected with an application error. For example, lower threshold value is above upper threshold value. The response reports an ErrorCode "0x8040" (PAR_SETINVALID). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16379, Subindex=0, Value=[0x00], ErrorType_W=0x8040) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16379, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8040 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

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2550 **8.10.13 ISDU Write while Device application fault**

2551 Table 260 defines the test conditions for this test case.

2552 **Table 260 – ISDU Write while Device application fault**

2553 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0235 |
| Name | | TCM_ALIC_AERR_WRITEDeviceAPPFAULT |
| Purpose (short) | | ISDU Write while Device application fault |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to an Index in the MTU, whose technology specific application is not performing, is rejected with an application error. The response reports an Error-Code "0x8082" (APP_DEVNOTRDY). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16378, Subindex=0, Value=[0x00], ErrorType_W=0x8082) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16378, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8082 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

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2559 **8.10.14 ISDU Write to reserved Indices**

2560 Table 261 defines the test conditions for this test case.

2561 **Table 261 – ISDU Write to reserved Indices**

2562 -CR099- -CR106-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0237 |
| Name | TCM_ALIC_AERR_WRITERESERVEDINDEX |
| Purpose (short) | ISDU Write to reserved Indices |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.2 |
| Category / type | Master ISDU test: test to pass |
| Specification (clause) | [5], 8.2.4.1.2; [7], A.5.2, Table B.7, Annex C |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | ISDU Write access to a reserved Index in the MTU is rejected with an application error. The response reports an ErrorCode "0x8011" (IDX_NOTAVAIL). |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=65025, Subindex=0, Value=[0x00], ErrorType_W=0x8011) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=65025, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8011 |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2565

2566

2567 **8.10.15 ISDU Write to reserved Indices and no ISDU**

2568 Table 262 defines the test conditions for this test case.

2569 **Table 262 – ISDU Write to reserved Indices and no ISDU**

2570 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0238 |
| Name | | TCM_ALIC_AERR_WRITERESERVEDINDEXNOISDU |
| Purpose (short) | | ISDU Write to reserved Indices and unavailable ISDU is rejected with ErrorType. |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.2 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to a reserved Index and ISDU not available in MTU is rejected by an application error. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_DI |
| Procedure | | a) MTU_DPP1_Set(RevisionID=1.0) b) MTU_DPP1_Set(M-sequenceCapability=0x10) c) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) d) TM_AWAIT_PORT_STATUS(O PERATE) e) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16, Subindex=0, OD=[0x00])) f) Evaluation 1) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check returned ArgBlock |
| Test passed | | ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x8011 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2573

2574

2575 8.11 ISDU (Indexed Service Data Unit) – Derived ErrorTypes

2576 8.11.1 ISDU Write response without busy indication

Table 263 defines the test conditions for this test case. MTU specialty "NO_DEVICE_BUSY" causes an immediate Device response without busy indication (see A.4.8.3).

Table 263 – ISDU Write response without busy indication

2580 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|---|----------------------------|
| Identification (ID) | SDCI_TC_0239 | |
| Name | TCM_ALIC_DERR_WRITENOBUSY | |
| Purpose (short) | ISDU Write response "No service" (without busy) reports Derived ErrorType. | |
| Equipment under test (EUT) | Master + Port | |
| Test case version | 1.1 | |
| Category / type | Master ISDU test: test to pass | |
| Specification (clause) | [5], 8.2.4.1.2; [7], A.5.2, Annex C | |
| Configuration / setup | Master-Tester-System with MTU | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | ISDU Write access to an Index in the MTU. The MTU directly (without any busy response) responds with "No service" (I-Service/Length = 0x00). The response provides the Derived ErrorCode "0x1000" (COM_ERR). | |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART | |
| Procedure | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16376, Subindex=0, Value=[0x00], Specialty=NO_SERVICE) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16376, Subindex=0, OD=[0x00])) e) Evaluation 2) | |
| Test parameter | – | |
| Post condition | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check "OPERATE-reached" 2) Check returned ArgBlock | |
| Test passed | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x1000 | |
| Test not passed (examples) | Any evaluation failed | |
| Report | All evaluations | <ok nok> |

2583

2584

2585 **8.11.2 ISDU Write response with timeout after busy indication**

2586 Table 264 defines the test conditions for this test case. MTU specialty "TIMEOUT" causes an
 2587 inappropriate delay of Device's response (see A.4.8.3).

2588 **Table 264 – ISDU Write response with timeout after busy indication**

2589 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0240 |
| Name | | TCM_ALIC_DERR_WRITEAFTERBUSYTIMEOUT |
| Purpose (short) | | ISDU Write response with timeout after busy indication reports Derived ErrorType |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], 8.3.2.3, 10.8.7, A.5.2, Annex C, Tables B.7, C.2 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to an Index in the MTU, which does not generate a response after an adequate time for the ISDU acknowledgement and despite indicating the "Device busy" bit in the ISDU Service/Length octet, is responded with an application error. The response reports a derived ErrorCode "0x1000" (COM_ERR) or "0x1100" (I-SERVICE_TIMEOUT). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate b) Evaluation 1) c) MTU_ISDU_Add(Index=16376, Subindex=0, Value=[0x00], Specialty=TIMEOUT) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16376, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x1000 or 0x1100 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2592

2593

2594 **8.11.3 ISDU Write response with illegal service code**
 2595 Table 265 defines the test conditions for this test case. MTU specialty "INCORRECT_SERVICE_CODE" causes an incorrect service code in Device's response (see A.4.8.3).

2597 **Table 265 – ISDU Write response with illegal service code**

2598 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0241 |
| Name | | TCM_ALIC_DERR_ILLSERVICECODE |
| Purpose (short) | | ISDU Write response with illegal service code reports Derived ErrorType |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C, Table C.2, Figure A.19 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to an Index in the MTU generating a response with incorrect service code, is responded with an application error. The response reports a derived ErrorCode "0x5700" (M_ISDU_ILLEGAL). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16374, Subindex=0, Value=[0x00], Specialty=INCORRECT_SERVICE_CODE) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16374, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x5700 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2601
2602

2603 **8.11.4 ISDU Write response with wrong checksum (CHKPDU)**

2604 Table 266 defines the test conditions for this test case. MTU specialty "INCORRECT_CHKPDU"
 2605 causes a checksum error in Device's response (see A.4.8.3).

2606 **Table 266 – ISDU Write response with wrong checksum (CHKPDU)**

2607 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0242 |
| Name | | TCM_ALIC_DERR_WRONGCHECKSUM |
| Purpose (short) | | ISDU Write response with incorrect checksum (CHKPDU) reports Derived ErrorType. |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C, Table C.2, Figure A.19 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to an Index in the MTU generating a response with wrong CHKPDU, is responded with an application error. The response reports a derived Er- rorCode "0x5600" (M_ISDU_CHECKSUM). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16374, Subindex=0, Value=[0x00], Specialty=INCORRECT_CHKPDU) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16374, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x5600 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2610

2611

2612 **8.11.5 ISDU Write response with reserved data length**
 2613 Table 267 defines the test conditions for this test case. MTU specialty "RESERVED_DATA-
 2614 _LENGTH" causes reserved combinations of iService and length in Device's response (see
 2615 A.4.8.3).

2616 **Table 267 – ISDU Write response with reserved data length**

2617 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0244 |
| Name | | TCM_ALIC_DERR_WRITERESERVEDDL |
| Purpose (short) | | ISDU Write response with reserved data length reports Derived ErrorType |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, Annex C, Table C.2, Figure A.19 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to an Index in the MTU is responded with "reserved data length" and results in an application error. The response reports a Derived ErrorCode "0x1000" (COM_ERR) or 0x5700 (M_ISDU_ILLEGAL). |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16372, Subindex=0, Value=[0x00], Specialty=RESERVED_DATA_LENGTH) d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16372, Subindex=0, OD=[0x00])) e) Evaluation 2) |
| Test parameter | | - |
| Post condition | | - |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "Job Error" received, and JobError.ErrorCode/AdditionalCode = 0x1000 or 0x5700 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <i><ok nok></i> |

2620
 2621

2622 **8.12 ISDU (Indexed Service Data Unit) – Limit checks**

2623 **8.12.1 ISDU Read response without data**

2624 Table 268 defines the test conditions for this test case.

2625 **Table 268 – ISDU Read response without data**

2626 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0243 |
| Name | | TCM_ALIC_DERR_READNODATA |
| Purpose (short) | | ISDU Read response without data reports no Derived ErrorType |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, A.5.7, Annex C, Figure A.19 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Read access to an Index in the MTU generating a positive response without data is responded without error. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16372, Subindex=0, Value=[]) <i>:prepare MTU</i> d) SMI_DeviceRead(ABPS_DEVICEREAD(Index=16372, Subindex=0)) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "On-request_Data" received, and OD = [] |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <i><ok nok></i> |

2629

2630

2631 **8.12.2 ISDU Write with minimum data length (zero octets)**

2632 Table 269 defines the test conditions for this test case.

2633 **Table 269 – ISDU Write with minimum data length (zero octets)**

2634 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0245 |
| Name | | TCM_ALIC_LIMIT_WRITEMINLENGTH |
| Purpose (short) | | ISDU Write with minimum data length (zero octets) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, A.5.4, A.5.7, Annex C, Table A.15, Figure A.18 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to an Index in the MTU using the minimum data of zero octets. The response shall be positive. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16000, Subindex=0, Value=[]) ; <i>prepare MTU</i> d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16000, Subindex=0, OD=[])) e) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "VoidBlock" received |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2637

2638

2639 **8.12.3 ISDU Write with maximum service length (238 octets)**

2640 Table 270 defines the test conditions for this test case.

2641 **Table 270 – ISDU Write with maximum service length (238 octets)**

2642 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0246 |
| Name | | TCM_ALIC_LIMIT_WRITELENGTH |
| Purpose (short) | | ISDU Write with maximum service length (238 octets) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, A.5.4, A.5.7, Annex C, Table A.15, Figure A.18 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to an Index in the MTU using the maximum service length of 238 octets. The response shall be positive. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16001, Subindex=0, Value=<data>) ; <i>prepare MTU</i> d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16001, Subindex=0, OD=<data>)) e) Evaluation 2) f) MTU_ISDU_Read(Index=16001,Subindex=0) ; <i>returns <value> (octet string)</i> g) Evaluation 3) |
| Test parameter | | data = [0x00, 0x01 to 0xE7] (232 octets user data) |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock 3) Check returned <value> |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "VoidBlock" received Returned <value> = data |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2645

2646

2647 **8.12.4 ISDU Read with maximum service length (238 octets)**

2648 Table 271 defines the test conditions for this test case.

2649 **Table 271 – ISDU Read with maximum service length (238 octets)**

2650 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0248 |
| Name | | TCM_ALIC_LIMIT_READMAXDATALENGTH |
| Purpose (short) | | ISDU Read with maximum service length (238 octets) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, A.5.4, A.5.7, Annex C, Table A.15, Figure A.18 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Read access to an Index in the MTU using the maximum service length of 238 octets. The response shall be positive. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16003, Subindex=0, Value=<data>) ; <i>prepare MTU</i> d) SMI_DeviceRead(ABPS_DEVICEREAD(Index=16003, Subindex=0)) e) Evaluation 2) |
| Test parameter | | data = [0x01, 0x02 to 0xE8] (232 octets user data) |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "On-request_Data" received, and OD = data |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2653

2654

2655 **8.12.5 ISDU Write to 8-bit Index and no Subindex**

2656 Table 272 defines the test conditions for this test case.

2657 **Table 272 – ISDU Write to 8-bit Index and no Subindex**

2658 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0249 |
| Name | | TCM_ALIC_LIMIT_WRITEINDEX8NOSUBINDEX |
| Purpose (short) | | ISDU Write to 8-bit Index and no Subindex |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, A.5.4, A.5.7, Annex C, Table A.15, Figure A.18 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to an 8-bit Index in the MTU. The response shall be positive. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=255, Subindex=0, Value=[0xAB]) ; <i>prepare MTU</i> d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=255, Subindex=0, OD=[0x00])) e) Evaluation 2) f) MTU_ISDU_Read(Index=255, Subindex=0) ; <i>returns <value> (octet string)</i> g) Evaluation 3) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock 3) Check returned <value> |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "VoidBlock" received Returned <value> = 0x00 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

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2663 **8.12.6 ISDU Write to 8-bit Index and 8-bit Subindex**

2664 Table 273 defines the test conditions for this test case.

2665 **Table 273 – ISDU Write to 8-bit Index and 8-bit Subindex**

2666 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0250 |
| Name | | TCM_ALIC_LIMIT_WRITEINDEX8SUBINDEX8 |
| Purpose (short) | | ISDU Write to 8-bit Index and 8-bit Subindex |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, A.5.4, A.5.7, Annex C, Table A.15, Figure A.18 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to an 8-bit Index and 8-bit Subindex in the MTU. The response shall be positive. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=255, Subindex=255, Value=[0xAB]) ; <i>prepare MTU</i> d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=255, Subindex=255, OD=[0x00])) e) Evaluation 2) f) MTU_ISDU_Read(Index=255, Subindex=255) ; <i>returns <value> (octet string)</i> g) Evaluation 3) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock 3) Check returned <value> |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "VoidBlock" received Returned <value> = 0x00 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

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2671 **8.12.7 ISDU Write to 16-bit Index and 8-bit Subindex**

2672 Table 274 defines the test conditions for this test case.

2673 **Table 274 – ISDU Write to 16-bit Index and 8-bit Subindex**

2674 -CR099-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0251 |
| Name | TCM_ALIC_LIMIT_WRITEINDEX16SUBINDEX8 |
| Purpose (short) | ISDU Write to 16-bit Index and 8-bit Subindex |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 |
| Category / type | Master ISDU test: test to pass |
| Specification (clause) | [5], 8.2.4.1.2; [7], A.5.2, A.5.4, A.5.7, Annex C, Table A.15, Figure A.18 |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | ISDU Write access to a 16-bit Index and 8-bit Subindex in the MTU. The response shall be positive. |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | a) MTU_State_CheckOperate <i>:returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=16004, Subindex=1, Value=[0xAB]) <i>:prepare MTU</i> d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=16004, Subindex=1, OD=[0x00])) e) Evaluation 2) f) MTU_ISDU_Read(Index=16004, Subindex=1) <i>:returns <value> (octet string)</i> g) Evaluation 3) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "OPERATE-reached" 2) Check returned ArgBlock 3) Check returned <value> |
| Test passed | "OPERATE-reached" = TRUE ArgBlock "VoidBlock" received Returned <value> = 0x00 |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <i><ok nok></i> |

2677

2678

2679 **8.12.8 ISDU Write response without busy bit**

2680 Table 275 defines the test conditions for this test case.

2681 **Table 275 – ISDU Write response without busy bit**

2682 -CR099-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0252 |
| Name | TCM_ALIC_LIMIT_IMMEDIATERESPNOBUSY |
| Purpose (short) | ISDU Write immediate response (without busy) |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 |
| Category / type | Master ISDU test: test to pass |
| Specification (clause) | [5], 8.2.4.1.2; [7], A.5.2, A.5.4, A.5.7, Figure A.19, Annex C |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | ISDU Write access to an 8-bit Index and 8-bit Subindex in the MTU. MTU generates an immediate response to the request without any busy responses (no I-Service/Length = 0x01 responses, see Table A.14). |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | a) MTU_State_CheckOperate ;returns "OPERATE-reached" b) Evaluation 1) c) MTU_ISDU_Add(Index=255, Subindex=1, Value=[0xAB], Specialty=NO_DEVICE_BUSY) ;prepare MTU d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=255, Subindex=1, OD=[0x00])) e) Evaluation 2) f) MTU_ISDU_Read(Index=255, Subindex=1) ;returns <value> (octet string) g) Evaluation 3) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "OPERATE-reached" 2) Check returned ArgBlock 3) Check returned <value> |
| Test passed | "OPERATE-reached" = TRUE ArgBlock "VoidBlock" received Returned <value> = 0x00 |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2685

2686

2687 **8.12.9 ISDU Write response with busy bit**

2688 Table 276 defines the test conditions for this test case.

2689 **Table 276 – ISDU Write response with busy bit**

2690 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0253 |
| Name | | TCM_ALIC_LIMIT_IMMEDIATERESPWITHBUSY |
| Purpose (short) | | ISDU Write response with at least one busy response |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, A.5.4, A.5.7, Figure A.19, Annex C |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to an 8-bit Index and 8-bit Subindex in the MTU. MTU generates an ISDU response to the request with at least one busy response (I-Service/Length = 0x01, see Table A.14) |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) MTU_ISDU_Add(Index=255, Subindex=2, Value=[0xAB], Specialty=DEVICE_BUSY) ; <i>prepare MTU</i> d) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=255, Subindex=2, OD=[0x00])) e) Evaluation 2) f) MTU_ISDU_Read(Index=255, Subindex=2) ; <i>returns <value> (octet string)</i> g) Evaluation 3) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" 2) Check returned ArgBlock 3) Check returned <value> |
| Test passed | | "OPERATE-reached" = TRUE ArgBlock "VoidBlock" received Returned <value> = 0x00 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2693

2694

2695 **8.12.10 ISDU Write with maximum service Length (15 octets)**

2696 Table 277 defines the test conditions for this test case.

2697 **Table 277 – ISDU Write with maximum service Length (15 octets)**

2698 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0254 |
| Name | | TCM_ALIC_LIMIT_WRITEMAXSERVICELEN15 |
| Purpose (short) | | ISDU service (with maximum service length 15) is carried out. |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.2 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, A.5.4, A.5.7, Annex C, Table A.15, Figure A.18 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to several Index and Subindex combinations in the MTU. MTU with maximum service length 15. The response shall be positive. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate :returns "OPERATE-reached" b) Evaluation 1) c) Assign first values to "index", "subindex", "init", "data" d) MTU_ISDU_Add(Index=<index>, Subindex=<subindex>, Value=<init>) ;prep MTU e) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=<index>, Subindex=<subindex>, OD=<data>)) f) Evaluation 2) g) MTU_ISDU_Read(Index=<index>, Subindex=<subindex>) :returns <value> h) Evaluation 3) i) Repeat from c) with next "index", "subindex", "init", "data" |
| Test parameter | | index = {100, 101, 16005} subindex = {0, 1, 1} init = { [0x00, 0x00, 0x00], [0x00, 0x00, 0x00], [0x00, 0x00, 0x00]} data = { [0x01, 0x02, 0x03, 0x04, 0x05, 0x06, 0x07, 0x08, 0x09, 0x0A, 0x0B, 0x0C], [0x01, 0x02, 0x03, 0x04, 0x05, 0x06, 0x07, 0x08, 0x09, 0x0A, 0x0B], [0x01, 0x02, 0x03, 0x04, 0x05, 0x06, 0x07, 0x08, 0x09, 0x0A]} |
| Post condition | | - |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" For all loops: 2) Check returned ArgBlock 3) Check returned <value> |
| Test passed | | "OPERATE-reached" = TRUE For all loops: ArgBlock "VoidBlock" received Returned <value> = data |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2701

2702

2703 **8.12.11 ISDU Write with minimum service Extended Length (17)**

2704 Table 278 defines the test conditions for this test case.

2705 **Table 278 – ISDU Write with minimum service Extended Length (17)**

2706 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0255 |
| Name | | TCM_ALIC_LIMIT_WRITEMINSERVICEEXTLEN17 |
| Purpose (short) | | ISDU service (with minimum Extended Length 17) is carried out. |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.2 |
| Category / type | | Master ISDU test: test to pass |
| Specification (clause) | | [5], 8.2.4.1.2; [7], A.5.2, A.5.4, A.5.7, Annex C, Table A.15, Figure A.18 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | ISDU Write access to several Index and Subindex combinations in the MTU. MTU with minimum Extended Length 17. The response shall be positive. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ; <i>returns "OPERATE-reached"</i> b) Evaluation 1) c) Assign first values to "index", "subindex", "init", "data" d) MTU_ISDU_Add(Index=<index>, Subindex=<subindex>, Value=<init>) ; <i>prep MTU</i> e) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=<index>, Subindex=<subindex>, OD=<data>)) f) Evaluation 2) g) MTU_ISDU_Read(Index=<index>, Subindex=<subindex>) ; <i>returns <value></i> h) Evaluation 3) i) Repeat from c) with next "index", "subindex", "init", "data" |
| Test parameter | | index = {100, 101, 16005} subindex = {0, 1, 1} init = { [0x00, 0x00, 0x00] [0x00, 0x00, 0x00] [0x00, 0x00, 0x00]} data = { [0x01, 0x02, 0x03, 0x04, 0x05, 0x06, 0x07, 0x08, 0x09, 0x0A, 0x0B, 0x0C, 0x0D] [0x01, 0x02, 0x03, 0x04, 0x05, 0x06, 0x07, 0x08, 0x09, 0x0A, 0x0B, 0x0C] [0x01, 0x02, 0x03, 0x04, 0x05, 0x06, 0x07, 0x08, 0x09, 0x0A, 0x0B]} |
| Post condition | | - |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "OPERATE-reached" For all loops: 2) Check returned ArgBlock 3) Check returned <value> |
| Test passed | | "OPERATE-reached" = TRUE For all loops: ArgBlock "VoidBlock" received Returned <value> = data |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2709

2710

2711 **8.13 Events**
 2712 **8.13.1 General**
 2713 The Event propagation to the upper-level system, for example a fieldbus, is not subject matter
 2714 of this document. This behavior shall be defined in the corresponding "upper-level systems
 2715 integration" specification. Thus, there is no immediate Event acknowledgement of the Master
 2716 as with the Legacy-Master. Therefore, the timeout for waiting on the acknowledgement shall be
 2717 adjustable in the MTU.

2718 **8.13.2 Master receives Events without details (notification)**

2719 Table 279 defines the test conditions for this test case.

2720 **Table 279 – Master receives Events without details (notification)**

2721 -CR083-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|----------------------------|
| Identification (ID) | SDCI_TC_0256 | |
| Name | TCM_ALIC_EVNT_NODETAILSNOTIFY | |
| Purpose (short) | Master receives Event (notification) without details (notification) | |
| Equipment under test (EUT) | Master + Port | |
| Test case version | 1.4 2 | |
| Category / type | Master Event test: test to pass | |
| Specification (clause) | [5], 7.2.4.4.2.1; [7], 7.3.8.3, 8.3.3.1, 11.6, Annex A.6, Annex D | |
| Configuration / setup | Master-Tester-System | |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master receives Event without details (StatusCode type 1, notification). Master extracts the EventCode (type 1), converts it accordingly into StatusCode (type 2) and transfers it to the upper level system. Master acknowledges the Event. MTU resets the Event flag. Five different combinations are tested in TPLs. | |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_INACTIVE | |
| Procedure | a) MTU_DPP1_Set(RevisionID = 0x10) b) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) c) TM_AWAIT_PORT_STATUS(OPERATE) d) Assign first values to "status_code" <i>;see Test parameter</i> e) DLL_ClearAllEvents <i>;clears buffer in test interface</i> f) MTU_Event_Clear <i>;removes Events in memory</i> g) MTU_Event_SetStatusCode(<status_code>) <i>;enters StatusCode in memory</i> h) MTU_Event_TriggerAndWaitForAck <i>;returns "EventAck"</i> i) Evaluation 2 j) DLL_GetDeviceEvents(1) <i>;minED = 1, returns "EventList" with converted Event</i> k) Evaluation 3 l) Repeat from e) with next "status_code" | |
| Test parameter | status_code = {0x01, 0x02, 0x04, 0x08, 0x10} event_code = {0xFF80, 0xFF80, 0x6320, 0xFF80, 0xFF10} | |
| Post condition | – | |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | 1) Check "MTU in OPERATE" 2) 1) Check "EventAck" 3) 2) Check "EventList" | |
| Test passed | For all TPLs: "MTU in OPERATE" = TRUE, and EventAck.StatusCodeRead = TRUE, EventAck.Acknowledge = TRUE, and EventList.Entry1 (EventQualifier = 0x54, EventCode = <event_code>) <i>;type1 to type2</i> | |
| Test not passed (examples) | Any evaluation failed | |

| TEST CASE RESULTS | CHECK / REACTION |
|-------------------|-------------------------------|
| Report | All evaluations <ok nok> |

2724

2725 **8.13.3 Master receives event with details (single event)**

2726 Table 280 defines the test conditions for this test case.

2727 **Table 280 – Master receives event with details (single event)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0261 |
| Name | TCM_ALIC_EVNT_WITHDETAILSSINGLEVENT |
| Purpose (short) | Master receives Event with details (single Event) |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 |
| Category / type | Master Event test: test to pass |
| Specification (clause) | [7], 7.3.8.3, 8.3.3.1, 11.5, Annex A.6, Annex D |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master receives Event with details (StatusCode type 2). Master transfers the EventCode and EventQualifier to the upper-level system. Master acknowledges the Event. MTU resets the Event flag. |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | a) MTU_State_CheckOperate :returns "MTU in OPERATE" b) Evaluation 1) c) MTU_Event_SetStatusCode(0x81) :enters StatusCode in memory d) MTU_Event_SetSlot(1, 0xF4, 0x1000) :enters in slot 1 Event Q and Code e) MTU_Event_TriggerAndWaitForAck :returns "EventAck" f) Evaluation 2 g) DLL_GetDeviceEvents(1) :minED = 1, returns "EventList" h) Evaluation 3) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "MTU in OPERATE" 2) Check "EventAck" 3) Check "EventList" |
| Test passed | "MTU in OPERATE" = TRUE, and EventAck.StatusCodeRead = TRUE, EventAck.AllSlotsRead = TRUE, EventAck.Acknowledge = TRUE, and EventList.Entry1 (EventQualifier = 0xF4, EventCode = 0x1000) |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2730

2731

2732 **8.13.4 Master receives event with details (double event)**

2733 Table 281 defines the test conditions for this test case.

2734 **Table 281 – Master receives event with details (double event)**

2735 -CR074-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0262 |
| Name | TCM_ALIC_EVNT_WITHDETAILSDOUBLEEVENT |
| Purpose (short) | Master receives Event with details (double Event) |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.4 2 |
| Category / type | Master Event test: test to pass |
| Specification (clause) | [7], 7.3.8.3, 8.3.3.1, 11.5, Annex A.6, Annex D |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master receives Event with details (StatusCode type 2). Master transfers it to the upper level system. Master acknowledges the Event. The MTU resets the Event flag. This procedure can be carried out in loops for different Events in the Event buffer (TPL). |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | a) MTU_State_CheckOperate ;returns "MTU in OPERATE" b) Evaluation 1) c) Assign first values to "status_code", "slot_a", "slot_b", "qual_a", "qual_b" ;clears buffer in test interface d) DLL_ClearAllEvents ;removes Events in memory e) MTU_Event_Clear ;enters StatusCode in memory f) MTU_Event_SetStatusCode(<status_code>) ;enters Event 1 in memory g) MTU_Event_SetSlot(<slot_a>, <qual_a>, 0x1000) ;enters Event 2 in memory h) MTU_Event_SetSlot(<slot_b>, <qual_b>, 0x4210) ;returns "EventAck" i) MTU_Event_TriggerAndWaitForAck ;minED = 2, returns "EventList" j) Evaluation 2 k) DLL_GetDeviceEvents(2) ;Evaluation 3) l) Evaluation 3) m) wait for 1 second ; to ensure that the event rules are respected m) Repeat from d) with next "status_code", "slot_a", "slot_b", "qual_a", "qual_b" |
| Test parameter | status_code = {0xA1, 0x92, 0x8C, 0x8C, 0x92, 0xA1} slot_a = {1, 2, 3, 4, 5, 6} slot_b = {6, 5, 4, 3, 2, 1} qual_a = {0xF4, 0xB4, 0xE4, 0xA4, 0xF4, 0xB4} qual_b = {0xE4, 0xA4, 0xF4, 0xB4, 0xE4, 0xA4} |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "MTU in OPERATE" 2) Check "EventAck" 3) Check "EventList" |
| Test passed | For all TPLs: "MTU in OPERATE" = TRUE, and EventAck: StatusCodeRead = TRUE, AllSlotsRead = TRUE, Acknowledge = TRUE, and EventList: 2 elements EventList: Entry1 (EventQualifier = "qual_a", EventCode = 0x1000), Entry2 (EventQualifier = "qual_b", EventCode = 0x4210) |
| Test not passed (examples) | Any evaluation failed |

| TEST CASE RESULTS | CHECK / REACTION | |
|-------------------|------------------|------------|
| Report | All evaluations | <ok nok> |

2738

2739

2740 **8.13.5 Events of type notification**

2741 Table 282 defines the test conditions for this test case.

2742 **Table 282 – Events of type notification**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|
| Identification (ID) | SDCI_TC_0308 | |
| Name | TCD_DLIC_EVNTOPER_SINGLENOTIFICATION | |
| Purpose (short) | Master receives Event with details (single Event, notification) | |
| Equipment under test (EUT) | Master + Port | |
| Test case version | 1.1 | |
| Category / type | Master Event test: test to pass | |
| Specification (clause) | [7], 7.3.8.3, 8.3.3.1, 11.5, Annex A.6, Annex D | |
| Configuration / setup | Master-Tester-System | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | Master receives Event with details (StatusCode type 2, notification). Master transfers the EventCode and EventQualifier to the upper-level system (optional). Master acknowledges the Event. MTU resets the Event flag. | |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART | |
| Procedure | a) MTU_State_CheckOperate b) Evaluation 1) c) MTU_Event_SetStatusCode(0x81) d) MTU_Event_SetSlot(1, 0x54, 0x1800) e) MTU_Event_TriggerAndWaitForAck f) Evaluation 2 g) DLL_GetDeviceEvents(1) h) Evaluation 3) i) SMI_PortStatus j) Evaluation 4) | :returns "MTU in OPERATE" ;enters StatusCode in memory ;enters Event in memory ;returns "EventAck" ;minED = 1, returns "EventList" ;returns "ArgBlock PortStatusList" |
| Test parameter | – | |
| Post condition / next test | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check "MTU in OPERATE" 2) Check "EventAck" 3) Check "EventList" 4) Check "ArgBlock PortStatusList" | |
| Test passed | "MTU in OPERATE" = TRUE, and EventAck.StatusCodeRead = TRUE, EventAck.AllSlotsRead = TRUE, EventAck.Acknowledge = TRUE, and EventList.Entry1 (EventQualifier = 0x54, EventCode = 0x1800), and ;"No Device" PortStatusList.NumberOfDiags = 0 | |
| Test not passed | Any evaluation failed | |
| Report | All evaluations <ok nok> | |

2745

2746 **8.13.6 Master receives Event with details (six Events)**

2747 Table 283 defines the test conditions for this test case.

2748 **Table 283 – Master receives Event with details (six Events)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0263 |
| Name | | TCM_ALIC_EVNT_WITHDETAILSSIXEVENTS |
| Purpose (short) | | Master receives event with details (six Events) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.2 |
| Category / type | | Master Event test: test to pass |
| Specification (clause) | | [5], 7.2.4.4.2.1; [7], 7.3.8.3, 8.3.3.1, 11.5, Annex A.6 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master receives six Events with details (StatusCode type 2). Master transfers it to the upper-level system. Master acknowledges the Event. MTU resets the Event flag. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ;returns "MTU in OPERATE" b) Evaluation 1 c) MTU_Event_SetStatusCode(0xBF) ;enters StatusCode in memory d) MTU_Event_SetSlot(1, 0xF4, 0x1800) ;enter Event appears, Error e) MTU_Event_SetSlot(2, 0xE4, 0x1801) ;enter Event appears, Warning f) MTU_Event_SetSlot(3, 0x54, 0x1802) ;enter Event single shot, Notification g) MTU_Event_SetSlot(4, 0xB4, 0x1803) ;enter Event disappears, Error h) MTU_Event_SetSlot(5, 0xA4, 0x1804) ;enter Event disappears, Warning i) MTU_Event_SetSlot(6, 0x54, 0x1805) ;enter Event single shot, Notification j) MTU_Event_TriggerAndWaitForAck ;returns "EventAck" k) Evaluation 2 l) DLL_GetDeviceEvents(6) ;minED = 6, returns "EventList" m) Evaluation 3 n) SMI_PortStatus ;returns "ArgBlock PortStatusList" o) Evaluation 4 |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check "EventAck" 3) Check "EventList" 4) Check "ArgBlock PortStatusList" |
| Test passed | | "MTU in OPERATE" = TRUE, and EventAck.StatusCodeRead = TRUE, EventAck.AllSlotsRead = TRUE, EventAck.Acknowledge = TRUE, and EventList.Entry1 (EventQualifier = 0xF4, EventCode = 0x1800), EventList.Entry2 (EventQualifier = 0xE4, EventCode = 0x1801), EventList.Entry3 (EventQualifier = 0x54, EventCode = 0x1802), EventList.Entry4 (EventQualifier = 0xB4, EventCode = 0x1803), EventList.Entry5 (EventQualifier = 0xA4, EventCode = 0x1804), EventList.Entry6 (EventQualifier = 0x54, EventCode = 0x1805), and PortStatusList.NumberOfDiags = 2, PortStatusList.DiagEntry0: Qualifier = 0xF4, Code = 0x1800 PortStatusList.DiagEntry1: Qualifier = 0xE4, Code = 0x1801 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2751

2752

2753 **8.13.7 Master receives Event while in ISDU Write transfer (stopover)**

2754 Table 284 defines the test conditions for this test case.

2755 **Table 284 – Master receives Event while in ISDU Write transfer (stopover)**

2756 -CR084- -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0264 |
| Name | | TCM_ALIC_EVNT_WRITEISDUWITH EVENT |
| Purpose (short) | | Master receives one Event while in ISDU transfer (stopover; with no details) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.2 3 |
| Category / type | | Master Event test: test to pass |
| Specification (clause) | | [7], 7.3.8.3, 8.3.3.1, 11.5, Annex A.6, Annex I |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master receives one Event while in ISDU Write transfer (stopover; with no details). The Event flag shall be set during transfer of an ISDU. The Master interrupts the ISDU and retrieves the Event content. After Event handling, the ISDU transfer shall be continued. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ;returns "MTU in OPERATE" b) Evaluation 1) c) MTU_ISDU_Add(Index=0x18,Subindex=0, Value=[0xAB,0xCD,0x12,0x34],Specialty=EVENT) ;test data d) MTU_Event_SetStatusCode(0x81 0x01) ;enters StatusCode in memory e) MTU_Event_SetSlot(1, 0xF4, 0x1000) ;enters in slot 1 Event Q and Code f) e) SMI_DeviceWrite(ABPS_DEVICEWRITE(Index=0x18,Subindex=0, Value=[0x00,0x00,0x00,0x00])) ;returns "ArgBlock" g) f) Evaluation 2) h) DLL_GetDeviceEvents(1) ;minED = 1, returns "EventList" i) h) Evaluation 3) j) i) MTU_Event_ISDUIinterrupted ;returns "Interrupted" k) j) Evaluation 4) l) k) MTU_ISDU_Read(Index=0x18, Subindex=0) ;returns "Value" m) l) Evaluation 5) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check "Argblock" 3) Check "EventList" 4) Check "Interrupted" 5) Check "Value" |
| Test passed | | "MTU in OPERATE" = TRUE, and "Argblock" = VoidBlock, and EventList.Entry1 (EventQualifier = 0xF4 0x54, EventCode = 0x1000 0xFF80), and "Interrupted" = TRUE, and "Value" = [0x00, 0x00, 0x00, 0x00] |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2759

2760

2761 **8.13.8 Master receives Event while in ISDU Read transfer (stopover)**

2762 Table 285 defines the test conditions for this test case.

2763 **Table 285 – Master receives Event while in ISDU Read transfer (stopover)**

2764 -CR084- -CR099-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0265 |
| Name | TCM_ALIC_EVNT_READISDUWITH EVENT |
| Purpose (short) | Master receives Event while in ISDU Read transfer (stopover; with no details) |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.2 [3] |
| Category / type | Master Event test: test to pass |
| Specification (clause) | [7], 7.3.8.3, 8.3.3.1, 11.5, Annex A.6 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master receives one Event while in ISDU Read transfer (stopover; with no details). The Event flag shall be set during transfer of an ISDU. The Master interrupts the ISDU and retrieves the Event content. After Event handling, the ISDU transfer shall be continued. |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | a) MTU_State_CheckOperate ;returns "MTU in OPERATE" b) Evaluation 1) c) MTU_ISDU_Add(Index=0x18, Subindex=0, Value=[0xAB,0xCD,0x12,0x34], Specialty=EVENT) ;test data d) MTU_Event_SetStatusCode(0x81 0x01) ;enters StatusCode in memory e) MTU_Event_SetSlot(1,0xF4, 0x1000) ;enters in slot 1 Event-Q and Code f) e) SMI_DeviceRead(ABPS_DEVICEREAD (Index=0x18, Subindex=0)) ;returns "ArgBlock" g) f) Evaluation 2) h) DLL_GetDeviceEvents(1) ;minED = 1, returns "EventList" i) h) Evaluation 3) j) i) MTU_Event_ISDUnterrupted ;returns "Interrupted" k) j) Evaluation 4) |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "MTU in OPERATE" 2) Check "Argblock" 3) Check "EventList" 4) Check "Interrupted" |
| Test passed | "MTU in OPERATE" = TRUE, and ArgBlock.OD = [0xAB, 0xCD, 0x12, 0x34], and EventList.Entry1 (EventQualifier = 0xF4 0x54, EventCode = 0x1000 0xFF80), and "Interrupted" = TRUE |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2767

2768

2769 **8.13.9 Master receives Event details while in ISDU Write transfer (stopover)**

2770 Table 286 defines the test conditions for this test case.

2771 **Table 286 – Master receives Event details while in ISDU Write transfer (stopover)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0266 |
| Name | TCM_ALIC_EVNT_WRITEISDUWITH EVENTDETAILS |
| Purpose (short) | Master receives Event while in ISDU Write transfer (stopover; with details) |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.1 |
| Category / type | Master Event test: test to pass |
| Specification (clause) | [7], 7.3.8.3, 8.3.3.1, 11.5, Annex A.6 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master receives Event while in ISDU Write transfer (stopover; with details). The Event flag shall be set during transfer of an ISDU. The Master interrupts the ISDU and retrieves the Event content. After Event handling, the ISDU transfer shall be continued. |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | a) MTU_State_CheckOperate ;returns "MTU in OPERATE" b) Evaluation 1) c) MTU_ISDU_Add(Index=0x18,Subindex=0, Value=[0xAB,0xCD,0x12,0x34],Specialty=EVENT) ;test data d) MTU_Event_SetStatusCode(0x81) ;enters StatusCode in memory e) MTU_Event_SetSlot(1, 0xF4, 0x1000) ;enter Event appears, unknown Error f) SMI_DeviceWrite(ABPS_DEVICE_WITE(Index=0x18,Subindex=0, Value=[0x00,0x00,0x00,0x00])) ;returns "ArgBlock" g) Evaluation 2) h) DLL_GetDeviceEvents(1) ;minED = 1, returns "EventList" i) Evaluation 3) j) MTU_Event_ISDUninterrupted ;returns "Interrupted" k) Evaluation 4) |
| Test parameter | – |
| Post condition | - |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "MTU in OPERATE" 2) Check "Argblock" 3) Check "EventList" 4) Check "Interrupted" |
| Test passed | "MTU in OPERATE" = TRUE, and "Argblock" = VoidBlock, and EventList.Entry1 (EventQualifier = 0xF4, EventCode = 0x1000), and "Interrupted" = TRUE |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2774

2775

2776 **8.13.10 Master receives Event details while in ISDU Read transfer (stopover)**

2777 Table 287 defines the test conditions for this test case.

2778 **Table 287 – Master receives Event details while in ISDU Read transfer (stopover)**

2779 -CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0267 |
| Name | | TCM_ALIC_EVNT_READISDUWITH EVENTDETAILS |
| Purpose (short) | | Master receives event while in ISDU Read transfer (stopover; with details) |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.1 |
| Category / type | | Master Event test: test to pass |
| Specification (clause) | | [7], 7.3.8.3, 8.3.3.1, 11.5, Annex A.6 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master receives one Event while in ISDU Read transfer (stopover; with details). The Event flag shall be set during transfer of an ISDU. The Master interrupts the ISDU and retrieves the Event content. After Event handling, the ISDU transfer shall be continued. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ;returns "MTU in OPERATE" b) Evaluation 1) c) MTU_ISDU_Add(Index=0x18,Subindex=0, Value=[0xAB,0xCD,0x12,0x34], Specialty=EVENT) ;test data d) MTU_Event_SetStatusCode(0x81) ;enters StatusCode in memory e) MTU_Event_SetSlot(1, 0xF4, 0x1000) ;enter Event appears, unknown Error f) SMI_DeviceRead(ABPS_DEVICEREAD (Index=0x18,Subindex=0)) ;returns "ArgBlock" g) Evaluation 2) h) DLL_GetDeviceEvents(1) ;minED = 1, returns "EventList" i) Evaluation 3) j) MTU_Event_ISDUnterrupted ;returns "Interrupted" k) Evaluation 4) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check "Argblock" 3) Check "EventList" 4) Check "Interrupted" |
| Test passed | | "MTU in OPERATE" = TRUE, and ArgBlock.OD = [0xAB, 0xCD, 0x12, 0x34], and EventList.Entry1 (EventQualifier = 0xF4, EventCode = 0x1000), and "Interrupted" = TRUE |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2782

2783

2784 **8.13.11 Behavior and Port Event at Device lost (COMLOST)**

2785 Table 288 defines the test conditions for this test case.

2786 **Table 288 – Behavior and Port Event at Device lost (COMLOST)**

2787 -CR065-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0350 |
| Name | | TCM_ALIC_EVNT_NODEV |
| Purpose (short) | | Master sends Port Event "No Device" at COMLOST |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.0 |
| Category / type | | Master Event test: test to pass |
| Specification (clause) | | [7], Annex D.3 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master is expected to send Port Event "No Device" (0x1800) and to clear Device Events in DiagEntries of ArgBlock "PortStatusList" whenever Device gets COMLOST |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_AUTOSTART |
| Procedure | | a) MTU_State_CheckOperate ;returns "MTU in OPERATE" b) Evaluation 1) c) DLL_GetPortEvents DLL_ClearAllEvents ;clear Event entries d) MTU_Event_SetStatusCode(0x81) ;enters StatusCode in memory e) MTU_Event_SetSlot(1, 0xF4, 0x1800) ;enters in slot 1 Event Q and Code f) MTU_Event_TriggerAndWaitForAck ;returns "EventAck" (0x1800) g) Evaluation 2) h) DLL_GetDeviceEvents(1) ;minED=1, returns "DeviceEventList1" i) Evaluation 3) j) SMI_PortStatus ;returns "ArgBlock PortStatusList1" k) Evaluation 4) l) MTU_State_Deactivate ;disable MTU response m) TM_AWAIT_PORT_STATUS(NO_DEVICE) n) DLL_GetPortEvents(1) ;minEP=1, returns "PortEventList1" o) Evaluation 5) p) SMI_PortStatus ;returns "ArgBlock PortStatusList2" q) Evaluation 6) r) MTU_State_Activate ;enable MTU response s) TM_AWAIT_PORT_STATUS(OPERATE) t) DLL_GetPortEvents(1) ;minEP=1, returns "PortEventList2" u) Evaluation 7) v) SMI_PortStatus ;returns "ArgBlock PortStatusList3" w) Evaluation 8) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "MTU in OPERATE" 2) Check "EventAck" 3) Check "DeviceEventList1" 4) Check "ArgBlock PortStatusList1" 5) Check "PortEventList1" 6) Check "ArgBlock PortStatusList2" 7) Check "PortEventList2" 8) Check "ArgBlock PortStatusList3" |
| Test passed | | "MTU in OPERATE" = TRUE, and EventAck: StatusCodeRead = TRUE, AllSlotsRead = TRUE, Acknowledge = TRUE, and DeviceEventList1.Entry1 (EventQualifier = 0xF4, EventCode = 0x1800), and |

| | |
|----------------------------|--|
| | PortStatusList1: NumberOfDiags = 1, DiagEntry0 (EventQualifier = 0xF4, EventCode = 0x1800), and PortEventList1: Entry1 (EventQualifier = 0xFC, EventCode = 0x1800), and PortStatusList2: NumberOfDiags = 1, DiagEntry0 (EventQualifier = 0xFC, EventCode = 0x1800), and PortEventList2: Entry1 (EventQualifier = 0x5C, EventCode = 0xFF26), or Entry1 (EventQualifier = 0xBC, EventCode = 0x1800), and PortStatusList3: NumberOfDiags = 0 |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2790

2791

2792 **8.13.12 Event in PREOPERATE**

2793 Table 289 defines the test conditions for this test case.

2794

Table 289 – Event in PREOPERATE

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0351 |
| Name | TCM_ALIC_EVNT_PREOPERATE |
| Purpose (short) | MTU sends Event in PREOPERATE |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.0 |
| Category / type | Master Event test: test to pass |
| Specification (clause) | [7], Annex D.3 |
| Configuration / setup | Master-Tester-System |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Master receives Event with details (StatusCode type 2) in PREOPERATE. Master transfers the EventCode and EventQuaifier to the upper-level system. Master acknowledges the Event. MTU resets the Event flag. |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_DI |
| Procedure | a) MTU_Event_SetStatusCode(0x81) ;enters StatusCode in memory b) MTU_Event_SetSlot(1, 0xF4, 0x1000) ;enters in slot 1 Event Q and Code c) MTU_Event_SetFlag ;set Event flag in M-sequence CKS d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) e) TM_AWAIT_PORT_STATUS(OPERATE) f) DLL_GetDeviceEvents(1) ;minED=1, returns "EventList" g) Evaluation 1 h) SMI_PortStatus ;returns "ArgBlock PortStatusList" i) Evaluation 2 |
| Test parameter | – |
| Post condition | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "EventList" 2) Check "ArgBlock PortStatusList" |
| Test passed | EventList.Entry1 (EventQualifier = 0xF4, EventCode = 0x1000), and PortStatusList.NumberOfDiags = 1, PortStatusList.DiagEntry0 (EventQualifier = 0xF4, EventCode = 0x1000) |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2797

2798

2799 **8.13.13 Event in PORT_DIAG**

2800 Table 290 defines the test conditions for this test case.

2801 **Table 290 – Event in PORT_DIAG**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0352 |
| Name | | TCM_ALIC_EVNT_PORT_DIAG |
| Purpose (short) | | MTU sends Event in PORT_DIAG |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.0 |
| Category / type | | Master Event test: test to pass |
| Specification (clause) | | [7], Annex D.3 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master receives Event with details (StatusCode type 2) in PORT_DIAG. Master transfers the EventCode and EventQuaifier to the upper level system. Master acknowledges the Event. MTU resets the Event flag. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_DI |
| Procedure | | a) MTU_Event_SetStatusCode(0x81) ;enters StatusCode in memory b) MTU_Event_SetSlot(1, 0xF4, 0x1800) ;enters in slot 1 Event Q and Code c) MTU_Event_SetFlag ;set Event flag in M-sequence CKS d) SMI_PortConfiguration(ABPS_TYPE_COMP <VendorID = 1>) ;invalid VendorID e) TM_AWAIT_PORT_STATUS(PORT_DIAG) f) DLL_GetDeviceEvents(1) ;minED=1, returns "DeviceEventList" g) Evaluation 1 h) DLL_GetPortEvents(1) ;minEP=1, returns "PortEventList" i) Evaluation 2) j) SMI_PortStatus ;returns "ArgBlock PortStatusList" k) Evaluation 3) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "DeviceEventList" 2) Check "PortEventList" 3) Check "ArgBlock PortStatusList" |
| Test passed | | DeviceEventList.Entry1 (EventQualifier = 0xF4, EventCode = 0x1800), and PortEventList.Entry1 (EventQualifier = 0xFC, EventCode = 0x1802), and PortStatusList.NumberOfDiags = 2, PortStatusList.DiagEntry0 (EventQualifier = 0xF4, EventCode = 0x1800), PortStatusList.DiagEntry1 (EventQualifier = 0xFC, EventCode = 0x1802) |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2804

2805

2806 **8.13.14 Invalid cycle time requested**

2807 Table 291 defines the test conditions for this test case.

2808 **Table 291 – Invalid cycle time requested**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0353 |
| Name | | TCM_ALIC_EVNT_INVALID_CYCLE_TIME |
| Purpose (short) | | Master sends Port Event 0x6000 due to a requested invalid cycle time |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.0 |
| Category / type | | Master Event test: test to pass |
| Specification (clause) | | [7], Annex D.3 |
| Configuration / setup | | Master-Tester-System |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | MTU is configured to a minimal cycle time of 10 ms. Master port is configured to a cycle time of 4 ms. Since the requested cycle time cannot be achieved, the Master enters PORT_DIAG and sends the Port Event 0x6000 "Invalid cycle time". |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_DI |
| Procedure | | a) MTU_DPP1_Set(MinCycleTime = 10 ms) b) SMI_PortConfiguration(ABPS_TYPE_COMP <PortCycleTime = 4 ms>) c) TM_AWAIT_PORT_STATUS(PORT_DIAG) d) DLL_GetPortEvents(1) <i>;minEP=1, returns "PortEventList"</i> e) Evaluation 1) f) SMI_PortStatus <i>;returns "ArgBlock PortStatusList"</i> g) Evaluation 2) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "PortEventList" 2) Check "ArgBlock PortStatusList" |
| Test passed | | EventList.Entry1 (EventQualifier = 0xFC, EventCode = 0x6000), and PortStatusList.NumberOfDiags = 1 PortStatusList.DiagEntry0 (EventQualifier = 0xFC, EventCode = 0x6000) |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <i><ok nok></i> |

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| 2813 | 8.14 Data Storage (DS) | | | | | | | | | | | | | | | | |
|--|--|--------------------------|----------------------------|---|--|---|---|---|--|--|----------------------------|-------------------|--------------|-----------------|------------------------------|------------------------|--|
| 2814 | 8.14.1 General | | | | | | | | | | | | | | | | |
| 2815 | Some test cases need cleared Data Storage as a precondition to perform the test. One possibility is the re-configuration of the Master Port. | | | | | | | | | | | | | | | | |
| 2816 | | | | | | | | | | | | | | | | | |
| 2817 | 8.14.2 Delete stored DS object after reconfiguration | | | | | | | | | | | | | | | | |
| 2818 | Table 292 defines the test conditions for this test case. | | | | | | | | | | | | | | | | |
| 2819 | Table 292 – Delete stored DS object after reconfiguration | | | | | | | | | | | | | | | | |
| 2820 | -CR059- | | | | | | | | | | | | | | | | |
| 2821 | <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th style="text-align: left; padding: 2px;">TEST CASE ATTRIBUTES</th><th style="text-align: left; padding: 2px;">IDENTIFICATION / REFERENCE</th></tr> </thead> <tbody> <tr> <td style="padding: 2px;">Identification (ID)</td><td style="padding: 2px;">SDCI_TC_0354</td></tr> <tr> <td style="padding: 2px;">Name</td><td style="padding: 2px;">TCM_ALIC_STOR_DELETEDSAFTERRECONF</td></tr> <tr> <td style="padding: 2px;">Purpose (short)</td><td style="padding: 2px;">Delete DS data object after Port reconfiguration</td></tr> <tr> <td style="padding: 2px;">Equipment under test (EUT)</td><td style="padding: 2px;">Master and Master Port</td></tr> <tr> <td style="padding: 2px;">Test case version</td><td style="padding: 2px;">1.0 1</td></tr> <tr> <td style="padding: 2px;">Category / type</td><td style="padding: 2px;">Master DS test: test to pass</td></tr> <tr> <td style="padding: 2px;">Specification (clause)</td><td style="padding: 2px;">[7], 11.3, Figure 101, Table E.3, Annex G, Table G.2</td></tr> </tbody> </table> | TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | Identification (ID) | SDCI_TC_0354 | Name | TCM_ALIC_STOR_DELETEDSAFTERRECONF | Purpose (short) | Delete DS data object after Port reconfiguration | Equipment under test (EUT) | Master and Master Port | Test case version | 1.0 1 | Category / type | Master DS test: test to pass | Specification (clause) | [7], 11.3, Figure 101, Table E.3, Annex G, Table G.2 |
| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | | | | | | | | | | | | | | | | |
| Identification (ID) | SDCI_TC_0354 | | | | | | | | | | | | | | | | |
| Name | TCM_ALIC_STOR_DELETEDSAFTERRECONF | | | | | | | | | | | | | | | | |
| Purpose (short) | Delete DS data object after Port reconfiguration | | | | | | | | | | | | | | | | |
| Equipment under test (EUT) | Master and Master Port | | | | | | | | | | | | | | | | |
| Test case version | 1.0 1 | | | | | | | | | | | | | | | | |
| Category / type | Master DS test: test to pass | | | | | | | | | | | | | | | | |
| Specification (clause) | [7], 11.3, Figure 101, Table E.3, Annex G, Table G.2 | | | | | | | | | | | | | | | | |
| <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th style="text-align: left; padding: 2px;">TEST CASE</th><th style="text-align: left; padding: 2px;">CONDITIONS / PERFORMANCE</th></tr> </thead> <tbody> <tr> <td style="padding: 2px;">Purpose (detailed)</td><td style="padding: 2px;"> <p>Any change of Port configuration ("PortConfigList") via SMI service causes the stored DataStorageObject to be cleared. Six Five Port reconfigurations to different PortModes are tested during 6 5 test procedure loops (TPL):</p> <p>TPL1: Change to PortMode = DI_C/Q ;see [7], Table E.3 TPL2: Change to PortMode = DO_C/Q TPL3: Change to PortMode = IOL_AUTOSTART TPL4: Change to PortMode = IOL_MANUAL and DeviceID = 0x002BD4, Validation&Backup = "4" ;Restore TPL5: Change to PortMode = DEACTIVATED TPL6: Change to PortMode = IOL_MANUAL and Validation&Backup = "4" ;Restore</p> </td></tr> <tr> <td style="padding: 2px;">Precondition</td><td style="padding: 2px;">EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE</td></tr> <tr> <td style="padding: 2px;">Procedure</td><td style="padding: 2px;"> <ul style="list-style-type: none"> a) Assign first value to "ConfigList" b) TM_MASTER_UPLOAD (PARSET1) ;prepare EUT and MTU for identical DS data ;returns "DS_Data" (uploaded) c) SMI_DSToParServ d) Evaluation 1) e) SMI_PortConfiguration(<ConfigList>) ;change Port configuration f) SMI_DSToParServ ;returns "DS_Data" (cleared) g) Evaluation 2) h) Repeat from b) with next "ConfigList" </td></tr> <tr> <td style="padding: 2px;">Test parameter</td><td style="padding: 2px;">ConfigList = {APBS_PORTTODI, APBS_PORTTODO, APBS_NOTYPE_CHECK, APBS_TYPE_COMP(<DeviceID = 0x002BD4>, <Validation&Backup = "4">), APBS_PORTINACTIVE, APBS_TYPE_COMP(<Validation&Backup = "4">)}</td></tr> <tr> <td style="padding: 2px;">Post condition / next test</td><td style="padding: 2px;">–</td></tr> </tbody> </table> | TEST CASE | CONDITIONS / PERFORMANCE | Purpose (detailed) | <p>Any change of Port configuration ("PortConfigList") via SMI service causes the stored DataStorageObject to be cleared. Six Five Port reconfigurations to different PortModes are tested during 6 5 test procedure loops (TPL):</p> <p>TPL1: Change to PortMode = DI_C/Q ;see [7], Table E.3 TPL2: Change to PortMode = DO_C/Q TPL3: Change to PortMode = IOL_AUTOSTART TPL4: Change to PortMode = IOL_MANUAL and DeviceID = 0x002BD4, Validation&Backup = "4" ;Restore TPL5: Change to PortMode = DEACTIVATED TPL6: Change to PortMode = IOL_MANUAL and Validation&Backup = "4" ;Restore</p> | Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE | Procedure | <ul style="list-style-type: none"> a) Assign first value to "ConfigList" b) TM_MASTER_UPLOAD (PARSET1) ;prepare EUT and MTU for identical DS data ;returns "DS_Data" (uploaded) c) SMI_DSToParServ d) Evaluation 1) e) SMI_PortConfiguration(<ConfigList>) ;change Port configuration f) SMI_DSToParServ ;returns "DS_Data" (cleared) g) Evaluation 2) h) Repeat from b) with next "ConfigList" | Test parameter | ConfigList = {APBS_PORTTODI, APBS_PORTTODO, APBS_NOTYPE_CHECK, APBS_TYPE_COMP(<DeviceID = 0x002BD4>, <Validation&Backup = "4">), APBS_PORTINACTIVE, APBS_TYPE_COMP(<Validation&Backup = "4">)} | Post condition / next test | – | | | | | |
| TEST CASE | CONDITIONS / PERFORMANCE | | | | | | | | | | | | | | | | |
| Purpose (detailed) | <p>Any change of Port configuration ("PortConfigList") via SMI service causes the stored DataStorageObject to be cleared. Six Five Port reconfigurations to different PortModes are tested during 6 5 test procedure loops (TPL):</p> <p>TPL1: Change to PortMode = DI_C/Q ;see [7], Table E.3 TPL2: Change to PortMode = DO_C/Q TPL3: Change to PortMode = IOL_AUTOSTART TPL4: Change to PortMode = IOL_MANUAL and DeviceID = 0x002BD4, Validation&Backup = "4" ;Restore TPL5: Change to PortMode = DEACTIVATED TPL6: Change to PortMode = IOL_MANUAL and Validation&Backup = "4" ;Restore</p> | | | | | | | | | | | | | | | | |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE | | | | | | | | | | | | | | | | |
| Procedure | <ul style="list-style-type: none"> a) Assign first value to "ConfigList" b) TM_MASTER_UPLOAD (PARSET1) ;prepare EUT and MTU for identical DS data ;returns "DS_Data" (uploaded) c) SMI_DSToParServ d) Evaluation 1) e) SMI_PortConfiguration(<ConfigList>) ;change Port configuration f) SMI_DSToParServ ;returns "DS_Data" (cleared) g) Evaluation 2) h) Repeat from b) with next "ConfigList" | | | | | | | | | | | | | | | | |
| Test parameter | ConfigList = {APBS_PORTTODI, APBS_PORTTODO, APBS_NOTYPE_CHECK, APBS_TYPE_COMP(<DeviceID = 0x002BD4>, <Validation&Backup = "4">), APBS_PORTINACTIVE, APBS_TYPE_COMP(<Validation&Backup = "4">)} | | | | | | | | | | | | | | | | |
| Post condition / next test | – | | | | | | | | | | | | | | | | |
| 2822 | <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th style="text-align: left; padding: 2px;">TEST CASE RESULTS</th><th style="text-align: left; padding: 2px;">CHECK / REACTION</th></tr> </thead> <tbody> <tr> <td style="padding: 2px;">Evaluation</td><td style="padding: 2px;">For all TPL: 1) Check ArgBlock "DS_Data" 2) Check ArgBlock "DS_Data"</td></tr> <tr> <td style="padding: 2px;">Test passed</td><td style="padding: 2px;">For all TPL: DataStorageObject = PARSET1 in 1), and DataStorageObject = no data/invalid (Header = "0") and length = 12 octets in 2)</td></tr> <tr> <td style="padding: 2px;">Test not passed (examples)</td><td style="padding: 2px;">Any evaluation failed or communication error</td></tr> <tr> <td style="padding: 2px;">Report</td><td style="padding: 2px;">All evaluations <ok nok></td></tr> </tbody> </table> | TEST CASE RESULTS | CHECK / REACTION | Evaluation | For all TPL: 1) Check ArgBlock "DS_Data" 2) Check ArgBlock "DS_Data" | Test passed | For all TPL: DataStorageObject = PARSET1 in 1), and DataStorageObject = no data/invalid (Header = "0") and length = 12 octets in 2) | Test not passed (examples) | Any evaluation failed or communication error | Report | All evaluations <ok nok> | | | | | | |
| TEST CASE RESULTS | CHECK / REACTION | | | | | | | | | | | | | | | | |
| Evaluation | For all TPL: 1) Check ArgBlock "DS_Data" 2) Check ArgBlock "DS_Data" | | | | | | | | | | | | | | | | |
| Test passed | For all TPL: DataStorageObject = PARSET1 in 1), and DataStorageObject = no data/invalid (Header = "0") and length = 12 octets in 2) | | | | | | | | | | | | | | | | |
| Test not passed (examples) | Any evaluation failed or communication error | | | | | | | | | | | | | | | | |
| Report | All evaluations <ok nok> | | | | | | | | | | | | | | | | |

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2825 **8.14.3 Data Storage size limits (quantities)**

2826 Table 293 defines the test conditions for this test case.

2827 **Table 293 – Data Storage size limits (quantities)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0355 |
| Name | | TCM_ALIC_STOR_MAXSIZELIMITS |
| Purpose (short) | | Check the maximum size limits of DS upload/download |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.0 |
| Category / type | | Master DS test: test to pass |
| Specification (clause) | | [7], 11.2, 11.3, B.2.3, B.2.4 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | <p>Checks the maximum conditions of DS behavior with respect to Index_List and DS memory size. Using the two data sets in "Test parameter", DS works correctly during the 2 test procedure loops (TPL):</p> <p>TPL1: Maximum permitted size of the DS data object and maximum length of Index_List (MAXINDEXLIST) TPL2: Maximum length of data objects (MAXDATA)</p> |
| Precondition | | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | <ul style="list-style-type: none"> a) Assign first value to "config" b) MTU_DS_SetMaxDataStorage(<config>) <i>;provide MTU with max DS data</i> c) SMI_PortConfiguration(ABPS_TYPE_COMP <Validation&Backup = "3">) d) TM_AWAIT_PORT_STATUS(OPERATE) e) MTU_DS_CheckUpload <i>;returns "upload sequence performed"</i> f) Evaluation 1 g) SMI_DSToParServ <i>;returns "DS_Data" (uploaded)</i> h) Evaluation 2 i) Repeat from b) with next "config" |
| Test parameter | | config = {MAXINDEXLIST, MAXDATA} See A.4.8 |
| Post condition / next test | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | <p>For all TPL:</p> <ol style="list-style-type: none"> 1) Check "upload sequence performed" 2) Check ArgBlock "DS_Data" |
| Test passed | | <p>TPL1: "upload sequence performed" = TRUE, and DataStorageObject = MAXINDEXLIST</p> <p>TPL2: "upload sequence performed" = TRUE, and DataStorageObject = MAXDATA</p> |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <i><ok nok></i> |

2830

2831

2832 **8.14.4 Write consistent DS data object from parameter server**

2833 Table 294 defines the test conditions for this test case.

2834 **Table 294 – Write consistent DS data object from parameter server**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0356 |
| Name | TCM_ALIC_STOR_DSFROMPARAMSERV |
| Purpose (short) | Write consistent DS data object from upper level system |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.0 |
| Category / type | Master DS test: test to pass |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4, Annex G |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Upper level system writes DS data object with header information via service SMI_ParServToDS. There is no difference between current stored DS data object and written DS data object (match of checksum). Master does not perform any upload or download activities at identical DS data. |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | a) TM_MASTER_UPLOAD(PARSET1) ;prepare EUT and MTU for identical DS data b) SMI_ParServToDS (PARSET1) ;write identical DS data (checksum match) c) MTU_DS_CheckDownload ;returns "download sequence performed" d) Evaluation 1) |
| Test parameter | – |
| Post condition / next test | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "download sequence performed" |
| Test passed | "download sequence performed" = FALSE |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

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2839 **8.14.5 Write inconsistent DS data object from parameter server**

2840 Table 295 defines the test conditions for this test case.

2841 **Table 295 – Write inconsistent DS data object from parameter server**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0357 |
| Name | TCM_ALIC_STOR_INCONSDSFROMPARSERV |
| Purpose (short) | Write inconsistent DS data object from upper-level system (checksum mismatch) |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.0 |
| Category / type | Master DS test: test to pass |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4 |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Upper-level system writes DS data object with header information via service SMI_ParServToDS. There is a difference between current stored DS data object and written DS data object (mismatch of checksum). This causes the Master to restart the Port and to download DS data. |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | a) TM_MASTER_UPLOAD(PARSET1) ; <i>prepare EUT and MTU for identical DS data</i> b) SMI_ParServToDS(PARSET2) ; <i>write different DS data (checksum mismatch)</i> c) TM_AWAIT_PORT_STATUS(OPERATE) ; <i>wait until OPERATE</i> d) MTU_State_CheckPreoperate ; <i>returns "PREOPERATE"</i> e) Evaluation 1) f) MTU_DS_CheckDownload ; <i>returns "download sequence performed"</i> g) Evaluation 2) h) MTU_DS_CheckParameterSet(PARSET2) ; <i>returns "PARSET2 active"</i> i) Evaluation 3) |
| Test parameter | – |
| Post condition / next test | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "PREOPERATE" 2) Check "download sequence performed" 3) Check "PARSET2 active" |
| Test passed | "PREOPERATE" = PASSED, and "download sequence performed" = TRUE, and "PARSET2 active" = TRUE |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2844

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2846 **8.14.6 Write DS data object to improper Port configuration**

2847 Table 296 defines the test conditions for this test case.

2848 **Table 296 – Write DS data object to improper Port configuration**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0358 |
| Name | | TCM_ALIC_STOR_DSTOIMPROPORTCONF |
| Purpose (short) | | Write DS data object from upper-level system to improper Port configuration |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.0 |
| Category / type | | Master DS test: test to pass |
| Specification (clause) | | [7], 11.2, 11.3, B.2.3, B.2.4, Table E.3, Annex G |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Write DS data from upper-level system via SMI_ParServToDS. In case of improper Port configuration (PortMode = DI_C/Q, DO_C/Q, IOL_AUTOSTART, or VendorID and/or DevicelD ≠ values in DS data header), the service returns a negative response, and no download activity occurs. |
| Precondition | | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) ; <i>improper configuration for DS</i> b) TM_AWAIT_PORT_STATUS(OPERATE) ; <i>wait until OPERATE</i> c) SMI_ParServToDS(PARSET2) ; <i>PortMode prevents from performance</i> d) Evaluation 1) e) MTU_DS_CheckDownload ; <i>returns "download sequence performed"</i> f) Evaluation 2) |
| Test parameter | | — |
| Post condition / next test | | — |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check returned ArgBlock 2) Check "download sequence performed" |
| Test passed | | ArgBlock "Job Error" received, JobError.ErrorCode/AdditionalCode = 0x4039 (INCONSISTENT_DS_DATA), and "download sequence performed" = FALSE |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

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2853 **8.14.7 Upload request Event in OPERATE (Backup + Restore)**

2854 Table 297 defines the test conditions for this test case.

2855 **Table 297 – Upload request Event in OPERATE (Backup + Restore)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0359 |
| Name | | TCM_ALIC_STOR_UPLOADREQEVENTOPERBACKREST |
| Purpose (short) | | Detection of upload request Event in OPERATE and Backup + Restore |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.0 |
| Category / type | | Master DS test: test to pass |
| Specification (clause) | | [7], 11.2, 11.3, B.2.3, B.2.4, Table E.3 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | MTU generates a hidden "DS_UPLOAD_REQ" Event while in OPERATE. Master Port configuration is proper for DS (PortMode and Validation&Backup = "3"). Master uploads parameter values from Device. |
| Precondition | | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) TM_MASTER_UPLOAD(PARSET1) <i>;prepare EUT and MTU for identical DS data</i> b) MTU_Set_ParameterSet(PARSET2) <i>;MTU activates PARSET2</i> c) MTU_DS_SetUpload(Event) <i>;MTU generates DS_UPLOAD_REQ Event</i> d) TM_AWAIT(2000) <i>;wait 2 sec</i> e) MTU_DS_CheckUpload <i>;returns "upload sequence performed"</i> f) Evaluation 1) g) SMI_DSToParServ <i>;returns "DS_Data" (uploaded)</i> h) Evaluation 2) |
| Test parameter | | — |
| Post condition / next test | | — |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "upload sequence performed" 2) Check ArgBlock "DS_Data" |
| Test passed | | "upload sequence performed" = TRUE, and DataStorageObject = PARSET2 |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <i><ok nok></i> |

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2860 **8.14.8 Upload request Event in OPERATE (Restore)**

2861 Table 298 defines the test conditions for this test case.

2862 **Table 298 – Upload request Event in OPERATE (Restore)**

2863 -CR086-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0360 |
| Name | TCM_ALIC_STOR_UPLOADREQEVENTOPERREST |
| Purpose (short) | Detection of upload request Event in OPERATE and Restore |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.0 1 |
| Category / type | Master DS test: test to pass |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4, Table E.3 |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | MTU generates a hidden "DS_UPLOAD_REQ" Event while in OPERATE. Master Port configuration is proper for DS (PortMode and Validation&Backup = "4"). Master downloads parameter values to Device. |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | a) TM_MASTER_UPLOAD(PARSET1) ;prepare EUT and MTU for identical DS data b) SMI_PortConfiguration(ABPS_TYPE_COMP,< Validation&Backup = "4">) c) TM_GET_PORT_STATUS TM_AWAIT_PORT_STATUS (OPERATE) d) MTU_DS_Set_Parameter(PARSET2) ;MTU activates PARSET2 e) MTU_DS_SetUpload(Event) ;MTU generates DS_UPLOAD_REQ Event f) TM_AWAIT(2000) ;wait 2 sec g) MTU_DS_CheckDownload ;returns "download sequence performed" h) Evaluation 1) i) SMI_DSToParServ ;returns "PARSET1 active" j) Evaluation 3) |
| Test parameter | – |
| Post condition / next test | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "download sequence performed" 2) Check "PARSET1 active" 2) Check ArgBlock "DS_Data" |
| Test passed | "download sequence performed" = TRUE, and "PARSET1 active" = TRUE, and DataStorageObject = PARSET1 |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

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2868 **8.14.9 Upload request Event in OPERATE (Backup + Restore inactive)**

2869 Table 299 defines the test conditions for this test case.

2870 **Table 299 – Upload request Event in OPERATE (Backup + Restore inactive)**

2871 -CR056- -CR086-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0361 |
| Name | TCM_ALIC_STOR_UPLOADREQEVENTOPERBACKRESTINACT |
| Purpose (short) | Detection of upload request Event in OPERATE and Backup + Restore inactive |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.0 [1] |
| Category / type | Master DS test: test to pass |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4, Table E.3 |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | MTU generates a hidden "DS_UPLOAD_REQ" Event while in OPERATE. Master Port configuration is improper for DS (PortMode = DEACTIVATED, DI_C/Q, DO_C/Q, IOL_AUTOSTART and PortMode = IOL_MANUAL) and Validation&Backup = "0" or "2"). Master does not show upload or download activities. |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | a) TM_MASTER_UPLOAD(PARSET1) ; <i>prepare EUT and MTU for identical DS data</i> b) SMI_PortConfiguration (ABPS_NOTYPE_CHECK <ConfigList>) ; <i>improper configuration for DS</i> c) TM_GET_PORT_STATUS TM_AWAIT_PORT_STATUS (OPERATE) d) MTU_Set_ParameterSet(PARSET2) ; <i>MTU activates PARSET2</i> e) MTU_DS_SetUpload(Event) ; <i>MTU generates DS_UPLOAD_REQ Event</i> f) TM_WAIT(2000) ; <i>wait 2 sec</i> g) MTU_DS_CheckUpload ; <i>returns "upload sequence performed"</i> h) Evaluation 1) ; <i>returns "download sequence performed"</i> i) MTU_DS_CheckDownload ; <i>returns "DS_Data" (uploaded)</i> j) Evaluation 3) |
| Test parameter | ConfigList = {ABPS_NOTYPE_CHECK, ABPS_TYPE_COMP(<Validation&Backup = "0">), ABPS_TYPE_COMP(<VendorID = 0x02A4>, <DeviceID = 0x002BD2>, <Validation&Backup = "2">)} |
| Post condition / next test | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "upload sequence performed" 2) Check "download sequence performed" 3) Check ArgBlock "DS_Data" |
| Test passed | "upload sequence performed" = FALSE, and "download sequence performed" = FALSE, and DataStorageObject = no data/invalid (Header = "0") and length = 12 octets |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2874

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2876 **8.14.10 Start-up with empty DS (DS deactivated)**

2877 Table 300 defines the test conditions for this test case.

2878 **Table 300 – Start-up with empty DS (DS deactivated)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0362 |
| Name | | TCM_ALIC_STOR_STARTUPEMPTDSDEACTIV |
| Purpose (short) | | Start-up with empty/invalid DS data object and deactivated Data Storage |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.0 |
| Category / type | | Master DS test: test to pass |
| Specification (clause) | | [7], 11.2, 11.3, B.2.3, B.2.4, Table E.3 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | For Port start-up an empty or invalid DS data object in Master is assumed as well as two different improper Port configurations. No upload takes place in both Test Procedure Loops: TPL1: PortMode = IOL_AUTOSTART (no type compatibility check) TPL2: PortMode = IOL_MANUAL (no Backup, no Restore) |
| Precondition | | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) Assign first value to "config" b) MTU_DS_SetParameter(PARSET2) ; <i>MTU activates PARSET2</i> c) MTU_DS_SetUpload(Flag_ON) ; <i>set DS_UPLOAD_FLAG</i> d) SMI_PortConfiguration(<config>) e) TM_AWAIT_PORT_STATUS(OPERATE) f) MTU_DS_CheckDSCommands ; <i>returns "DS_Commands performed"</i> g) Evaluation 1) h) SMI_DSToParServ ; <i>returns "DS_Data"</i> i) Evaluation 2) j) Repeat from b) with next "config" |
| Test parameter | | config = {APBS_NOTYPE_CHECK, ABPS_TYPE_COMP(< Backup&Restore = "2">)} |
| Post condition / next test | | — |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | For all TPL: 1) Check "DS_Commands performed" 2) Check ArgBlock "DS_Data" |
| Test passed | | For all TPL: "DS_Commands performed" = FALSE, and DataStorageObject = no data/invalid (Header = "0") and length = 12 octets |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2881

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2883 **8.14.11 Start-up with empty DS (DS activated – DS Upload)**

2884 Table 301 defines the test conditions for this test case.

2885 **Table 301 – Start-up with empty DS (DS activated – DS Upload)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0363 |
| Name | TCM_ALIC_STOR_STRTUPEMPTYDSDSACTIV |
| Purpose (short) | Start-up with empty/invalid DS data object and activated Data Storage |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.0 |
| Category / type | Master DS test: test to pass |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4, Table E.3 |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | For Port start-up an empty or invalid DS data object in Master is assumed as well as four different proper Port configurations. Upload takes place in all four Test Procedure Loops, where PortMode = IOL_MANUAL: TPL1: Validation&Backup = "3", DS_UPLOAD_FLAG = "0" ;Backup+Restore TPL2: Validation&Backup = "3", DS_UPLOAD_FLAG = "1" ;Backup+Restore TPL3: Validation&Backup = "4", DS_UPLOAD_FLAG = "0" ;Restore TPL4: Validation&Backup = "4", DS_UPLOAD_FLAG = "1" ;Restore |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | a) Assign first value to "config", "flag" b) MTU_DS_SetParameter(PARSET2) ;MTU activates PARSET2 c) MTU_DS_SetUpload(<flag>) ;Test parameter d) SMI_PortConfiguration(ABPS_TYPE_COMP, <Validation&Backup = "config">) ;Test parameter e) TM_AWAIT_PORT_STATUS(OPERATE) f) MTU_DS_CheckUpload ;returns "upload sequence performed" g) Evaluation 1) h) SMI_DSToParServ ;returns "DS_Data" i) Evaluation 2) j) Repeat from b) with next "config", "flag" |
| Test parameter | config = {3, 3, 4, 4} ;Type compatible Device V1.1 (Backup+Restore or Restore) flag = {Flag_off, Flag_on, Flag_off, Flag_on} ;DS_UPLOAD_FLAG |
| Post condition / next test | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | For all TPL: 1) Check "upload sequence performed" 2) Check ArgBlock "DS_Data" |
| Test passed | For all TPL: "upload sequence performed" = TRUE, and DataStorageObject = PARSET2 |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

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2890 **8.14.12 Start-up with stored DS (Device replacement – DS Download)**

2891 Table 302 defines the test conditions for this test case.

2892 **Table 302 – Start-up with stored DS (Device replacement – DS Download)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0364 |
| Name | TCM_ALIC_STOR_STRTUPDEVREPLACEDSDOWN |
| Purpose (short) | Start-up after Device replacement with DS Download (checksum mismatch) |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.0 |
| Category / type | Master DS test: test to pass |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4, Table E.3 |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | For Port start-up a stored or valid DS data object in Master is assumed as well as three different proper Port configurations. Download takes place in all three Test Procedure Loops, where PortMode = IOL_MANUAL, DS = activated, and DS checksum = mismatch: TPL1: Validation&Backup = "3", DS_UPLOAD_FLAG = "0" ;Backup+Restore TPL2: Validation&Backup = "4", DS_UPLOAD_FLAG = "0" ;Restore TPL3: Validation&Backup = "4", DS_UPLOAD_FLAG = "1" ;Restore |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | a) Assign first value to "config", "flag" b) MTU_Set_Parameter(PARSET1) ;MTU activates PARSET1 c) SMI_PortConfiguration(ABPS_TYPE_COMP, <Validation&Backup = "config">) ;Test parameter d) TM_AWAIT_PORT_STATUS(OPERATE) e) SMI_DSToParServ ;returns DataStorageObject f) MTU_State_Deactivate ;disable response to Master request g) MTU_DS_SetParameter(PARSET2) ;MTU activates PARSET2 h) MTU_DS_SetUpload(<flag>) ;Test parameter i) MTU_State_Activate ;enable response to Master request j) TM_AWAIT_PORT_STATUS(OPERATE) k) MTU_DS_CheckDownload ;returns "download sequence performed" l) Evaluation 1 m) MTU_DS_CheckParameter(PARSET1) ;returns "PARSET1 active" n) Evaluation 2 o) Repeat from b) with next "config", "flag" |
| Test parameter | config = {3, 4, 4} ;Type compatible Device V1.1 (Backup+Restore or Restore) flag = {Flag_off, Flag_off, Flag_on} ;DS_UPLOAD_FLAG |
| Post condition / next test | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | For all TPL 1) Check "download sequence performed" 2) Check "PARSET1 active" |
| Test passed | For all TPL "download sequence performed" = TRUE, and "PARSET1 active" = TRUE |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

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2896

2897 **8.14.13 Start-up with stored DS (Device replacement – no DS Download)**

2898 Table 303 defines the test conditions for this test case.

2899 **Table 303 – Start-up with stored DS (Device replacement – no DS Download)**

2900 -CR079-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE | |
|----------------------------|---|---|--|
| Identification (ID) | | SDCI_TC_0365 | |
| Name | | TCM_ALIC_STOR_STRTUPDEVREPLACENODSDOWN | |
| Purpose (short) | | Start-up after Device replacement without DS Download (checksum match) | |
| Equipment under test (EUT) | | Master + Port | |
| Test case version | | 1.0-1 | |
| Category / type | | Master DS test: test to pass | |
| Specification (clause) | | [7], 11.2, 11.3, B.2.3, B.2.4, Table E.3 | |
| Configuration / setup | | Master-Tester-System with MTU | |
| TEST CASE | CONDITIONS / PERFORMANCE | | |
| Purpose (detailed) | For Port start-up a stored or valid DS data object in Master is assumed and the Device is replaced by a type compatible one. No Download takes place in all four Test Procedure Loops: TPL1: PortMode = IOL_MANUAL, Validation&Backup = "3" ;Backup+Restore TPL2: PortMode = IOL_MANUAL, Validation&Backup = "4" ;Restore TPL3: PortMode = IOL_AUTOSTART ;no type compatibility check TPL2 4: PortMode = IOL_MANUAL, Validation&Backup = "2" ;no Backup, no Restore | | |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE | | |
| Procedure | a) Assign first value to "config" b) MTU_Set_Parameter(PARSET1) c) SMI_PortConfiguration(<config>) d) TM_AWAIT_PORT_STATUS(OPERATE) e) MTU_State_Deactivate f) MTU_State_Activate g) TM_AWAIT_PORT_STATUS(OPERATE) h) MTU_DS_CheckDSCommands i) Evaluation 1 j) MTU_DS_CheckParameter(PARSET1) k) Evaluation 2 l) Repeat from b) with next "config" | ;MTU activates PARSET1 ;Test parameter ;disable response to Master request ;enable response to Master request ;returns "DS_Commands performed" ;returns "PARSET1 active" | |
| Test parameter | config= {ABPS_TYPE_COMP, <Validation&Backup = "3">, ABPS_TYPE_COMP, <Validation&Backup = "4">, APBS_NO_TYPE_CHECK, ABPS_TYPE_COMP, <Validation&Backup = "2">} | | |
| Post condition / next test | – | | |
| TEST CASE RESULTS | CHECK / REACTION | | |
| Evaluation | For all TPL: 1) Check "DS_Commands <i>performed</i> " 2) Check "PARSET1 active" | | |
| Test passed | "DS_Commands <i>performed</i> " = FALSE, and "PARSET1 active" = TRUE | | |
| Test not passed (examples) | Any evaluation failed | | |
| Report | All evaluations <ok nok> | | |

2903

2904

2905 **8.14.14 Start-up with stored DS (Device replacement – DS Upload)**

2906 Table 304 defines the test conditions for this test case.

2907 **Table 304 – Start-up with stored DS (Device replacement – DS Upload)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0366 |
| Name | TCM_ALIC_STOR_STRTUPDEVREPLACEDSUPFLAG |
| Purpose (short) | Start-up after Device replacement with raised DS upload flag |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.0 |
| Category / type | Master DS test: test to pass |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4 |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | For Port start-up a stored or valid DS data object in Master is assumed and the Device is replaced by a type compatible one setting DS_UPLOAD_FLAG. Upload takes place at proper PortConfiguration (PortMode = IOL_MANUAL, Validation&Backup = "3") |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | a) MTU_DS_SetParameter(PARSET1) ; <i>MTU activates PARSET1</i> b) SMI_PortConfiguration(ABPS_TYPE_COMP, Validation&Backup = "3") c) TM_AWAIT_PORT_STATUS(OPERATE) d) MTU_State_Deactivate ; <i>disable response to Master request</i> e) MTU_DS_SetParameter(PARSET2) ; <i>MTU activates PARSET2</i> f) MTU_DS_SetUpload(<Flag_on>) ; <i>set DS_UPLOAD_FLAG</i> g) f) MTU_State_Activate ; <i>enable response to Master request</i> h) TM_AWAIT_PORT_STATUS(OPERATE) i) MTU_DS_CheckUpload ; <i>returns "upload sequence performed"</i> j) Evaluation 1) k) SMI_DSToParServ ; <i>returns "DS_Data"</i> l) Evaluation 2) |
| Test parameter | – |
| Post condition / next test | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check "upload sequence performed" 2) Check ArgBlock "DS_Data" |
| Test passed | "upload sequence performed" = TRUE, and DataStorageObject = PARSET2 |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2910

2911

2912 **8.14.15 Start-up with stored DS (Device replacement – no DS Upload)**

2913 Table 305 defines the test conditions for this test case.

2914 **Table 305 – Start-up with stored DS (Device replacement – no DS Upload)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0367 |
| Name | | TCM_ALIC_STOR_STRTUPDEVREPLACEDSFLAGNOUPLOAD |
| Purpose (short) | | Start-up after Device replacement with raised DS upload flag – DS upload blocked |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.0 |
| Category / type | | Master DS test: test to pass |
| Specification (clause) | | [7], 11.2, 11.3, B.2.3, B.2.4 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | <p>For Port start-up a stored or valid DS data object in Master is assumed and the Device is replaced by a type compatible one setting DS_UPLOAD_FLAG. No Upload takes place in all three Test Procedure Loops:</p> <p>TPL1: PortMode = IOL_MANUAL, Validation&Backup = "4" ;Restore TPL2: PortMode = IOL_MANUAL, Validation&Backup = "2" ;no Backup, no Restore TPL3: PortMode = IOL_AUTOSTART ;no type compatibility check</p> |
| Precondition | | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | <ul style="list-style-type: none"> a) Assign first value to "config" b) MTU_DS_SetParameter(PARSET1) ;MTU activates PARSET1 ;Test parameter c) SMI_PortConfiguration(<config>) d) TM_AWAIT_PORT_STATUS(OPERATE) e) MTU_State_Deactivate ;disable response to Master request f) MTU_DS_SetParameter(PARSET2) ;MTU activates PARSET2 g) MTU_DS_SetUpload(<Flag_on>) ;set DS_UPLOAD_FLAG h) f) MTU_State_Activate ;enable response to Master request i) TM_AWAIT_PORT_STATUS(OPERATE) j) MTU_DS_CheckUpload ;returns "upload sequence performed" k) Evaluation 1) l) SMI_DSToParServ ;returns "DS_Data" m) Evaluation 2) n) Repeat from b) with next "config" |
| Test parameter | | config = {ABPS_TYPE_COMP, <Validation&Backup = "4">, ABPS_TYPE_COMP, <Validation&Backup = "2">, APBS_NO_TYPE_CHECK} |
| Post condition / next test | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | <p>For all TPL:</p> <ol style="list-style-type: none"> 1) Check "upload sequence performed" 2) Check ArgBlock "DS_Data" |
| Test passed | | <p>For all TPL:</p> <p>"upload sequence performed" = FALSE, and DataStorageObject ≠ PARSET2</p> |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2917

2918

2919 **8.14.16 Corrupted DS Index_List**

2920 Table 306 defines the test conditions for this test case.

2921 **Table 306 – Corrupted DS Index_List**

2922 -CR062--CR075-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0368 |
| Name | TCM_ALIC_STOR_DSINDLISTCORRUPT |
| Purpose (short) | DS error in case of read Index_List fault during Port start-up |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.0 1 |
| Category / type | Master DS test: test to pass |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4, Annex E.16 |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | An error occurs while reading an Index_List during Port start-up. This leads to the following consequences: - No Upload/Download occurs (user view) - MTU is on hold in PREOPERATE - PortEvent is generated |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | a) TM_MASTER_UPLOAD(PARSET1) ;PARSET1 uploaded to Master DS b) DLL_GetPortEvents ;clear Event entries b c) MTU_State_Deactivate ;disable response to Master request e-d) MTU_DS_SetParameter(PARSET2) ;MTU activates PARSET2 d e) MTU_DS_SetUpload(<Flag_on>) ;set DS_UPLOAD_FLAG e f) MTU_DS_SetError(IndexList_err) ;MTU falsifies Index_List f g) MTU_State_Activate ;enable response to Master request h) DLL_GetPortEvents(3) ;minED=3, returns "PortEventList" g) TM_AWAIT_PORT_EVENT ;returns EventQualifier+EventCode h i) Evaluation 1) i j) MTU_DS_CheckUpload ;returns "upload sequence performed" j k) Evaluation 2) k l) MTU_State_CheckPreoperate ;returns "PREOPERATE" l m) Evaluation 3) m n) SMI_PortStatus ;returns "PortStatusList" n o) Evaluation 4) o p) SMI_PortConfiguration(ABPS_PORTTODI) ;switch Port to DI mode q) DLL_GetPortEvents(1) ;minED=1, returns "PortEventList" p) TM_AWAIT_PORT_EVENT ;returns EventQualifier+EventCode q r) Evaluation 5) r s) SMI_PortStatus ;returns "PortStatusList" s t) Evaluation 6) |
| Test parameter | – |
| Post condition / next test | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check ArgBlock "PortEventList" 2) Check "upload sequence performed" 3) Check "PREOPERATE" 4) Check ArgBlock "PortStatusList" 5) Check ArgBlock "PortEventList" 6) Check ArgBlock "PortStatusList" |

| TEST CASE RESULTS | CHECK / REACTION |
|----------------------------|--|
| Test passed | <p>PortEventList.Entry1 (EventQualifier: Master/Port, Error, Event appears, EventCode = 0x180B 0x180C), and</p> <p>"upload sequence performed" = FALSE, and</p> <p>"PREOPERATE" = REACHED, and</p> <p>PortStatusList: PortStatusInfo = PORT_DIAG, DiagEntryx = result of 1), and</p> <p>PortEventList.Entry1 (EventQualifier: Master/Port, Error , ..., MODE = Event disappears, ..., EventCode = 0x180B), and</p> <p>PortStatusList: PortStatusInfo = DI, DiagEntryx = empty</p> |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2925

2926

2927 **8.14.17 DS Download fault**

2928 Table 307 defines the test conditions for this test case.

2929 **Table 307 – DS Download fault**

2930 -CR062-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|
| Identification (ID) | SDCI_TC_0369 | |
| Name | TCM_ALIC_STOR_DSDOWNLOADFAULT | |
| Purpose (short) | DS error during DS download at Port start-up | |
| Equipment under test (EUT) | Master + Port | |
| Test case version | 1.0 [1] | |
| Category / type | Master DS test: test to pass | |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4, Annex E.16 | |
| Configuration / setup | Master-Tester-System with MTU | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | An error occurs while downloading DS data object during Port start-up, for example a read Index returns negative response. This leads to Download aborted, MTU on hold in PREOPERATE, PortEvent generated, rollback of DS data object. | |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE | |
| Procedure | a) TM_MASTER_UPLOAD(PARSET1) ;PARSET1 uploaded to Master DS b) DLL_GetPortEvents ;clear Event entries b c) MTU_State_Deactivate ;disable response to Master request e d) MTU_DS_SetParameter(PARSET2) ;MTU activates PARSET2 d e) MTU_DS_SetError(W_Index19_err) ;MTU to return negative response e f) MTU_State_Activate ;enable response to Master request f g) MTU_DS_WAIT(DS_BREAK) ;wait until Download aborted g h) Evaluation 1) h) TM_AWAIT_PORT_EVENT ;returns EventQualifier+EventCode i) DLL_GetPortEvents(3) ;minED=3, returns "PortEventList" l j) Evaluation 2) j k) MTU_DS_CheckParameter(PARSET1) ;returns "PARSET1 active" k l) Evaluation 3) l m) MTU_State_CheckPreoperate ;returns "PREOPERATE" m n) Evaluation 4) n o) SMI_PortStatus ;returns "PortStatusList" o p) Evaluation 5) p q) SMI_PortConfiguration(ABPS_PORTTODI) ;switch Port to DI mode q) TM_AWAIT_PORT_EVENT ;returns EventQualifier+EventCode r) DLL_GetPortEvents(1) ;minED=1, returns "PortEventList" r s) Evaluation 6) s t) SMI_PortStatus ;returns "PortStatusList" t u) Evaluation 7) | |
| Test parameter | – | |
| Post condition / next test | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check DS_BREAK 2) Check ArgBlock "PortEventList" 3) Check "PARSET1 active" 4) Check "PREOPERATE" 5) Check ArgBlock "PortStatusList" 6) Check ArgBlock "PortEventList" 7) Check ArgBlock "PortStatusList" | |
| Test passed | DS_BREAK detected, and PortEventList.Entry1 (EventQualifier: Master/Port, Error, Event appears, EventCode = 0x180D, and "PARSET1 active" = TRUE, and "PREOPERATE" = REACHED, and | |

| TEST CASE RESULTS | CHECK / REACTION |
|----------------------------|---|
| | PortStatusList: PortStatusInfo = PORT_DIAG, DiagEntryx = result of 1), and PortEventList.Entry1 (EventQualifier: Master/Port, Error, Event disappears, EventCode = 0x180D), and PortStatusList: PortStatusInfo = DI, DiagEntryx = empty |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2933

2934 **8.14.18 DS Upload fault**

2935 Table 308 defines the test conditions for this test case.

2936 **Table 308 – DS Upload fault**

2937 -CR062-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|---|--|
| Identification (ID) | SDCI_TC_0370 | |
| Name | TCM_ALIC_STOR_DSUPLOADFAULT | |
| Purpose (short) | DS error during DS Upload at Port start-up | |
| Equipment under test (EUT) | Master + Port | |
| Test case version | 1.0 [1] | |
| Category / type | Master DS test: test to pass | |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4 | |
| Configuration / setup | Master-Tester-System with MTU | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | An error occurs while uploading DS data object during Port start-up, for example a read Index returns negative response. This leads to Upload aborted, MTU on hold in PREOPERATE, PortEvent generated, rollback of DS data object. | |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE | |
| Procedure | a) TM_MASTER_UPLOAD(PARSET1) ;PARSET1 uploaded to Master DS b) DLL_GetPortEvents ;clear Event entries b c) MTU_State_Deactivate ;disable response to Master request c d) MTU_DS_SetParameter(PARSET2) ;MTU activates PARSET2 d e) MTU_DS_SetUpload(<Flag_on>) ;set DS_UPLOAD_FLAG e f) MTU_DS_SetError(R_Index19_err) ;MTU to return negative response f g) MTU_State_Activate ;enable response to Master request g h) MTU_DS_WAIT(DS_BREAK) ;wait until Download aborted h i) Evaluation 1) i) TM_AWAIT_PORT_EVENT ;returns EventQualifier+EventCode I j) DLL_GetPortEvents(3) ;minED=3, returns "PortEventList" J k) Evaluation 2) k l) SMI_DSToParServ ;returns "DS_Data" l m) Evaluation 3) m n) MTU_State_CheckPreoperate ;returns "PREOPERATE" n o) Evaluation 4) o p) SMI_PortStatus ;returns "PortStatusList" p q) Evaluation 5) q r) SMI_PortConfiguration(ABPS_PORTTODI) ;switch Port to DI mode r) TM_AWAIT_PORT_EVENT ;returns EventQualifier+EventCode s) DLL_GetPortEvents(1) ;minED=1 , returns "PortEventList" s t) Evaluation 6) t u) SMI_PortStatus ;returns "PortStatusList" u v) Evaluation 7) | |
| Test parameter | – | |
| Post condition / next test | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check DS_BREAK 2) Check ArgBlock "PortEventList" 3) Check ArgBlock "DS_Data" 4) Check "PREOPERATE" 5) Check ArgBlock "PortStatusList" 6) Check ArgBlock "PortEventList" 7) Check ArgBlock "PortStatusList" | |

| TEST CASE RESULTS | CHECK / REACTION |
|----------------------------|---|
| Test passed | DS_BREAK detected, and PortEventList.Entry1 (EventQualifier: Master/Port, Error, Event appears, EventCode = 0x180C), and DataStorageObject = PARSET1, and "PREOPERATE" = REACHED, and PortStatusList: PortStatusInfo = PORT_DIAG, DiagEntryx = result of 1), and PortEventList.Entry1 (EventQualifier: Master/Port, Error,..., MODE = Event disappears, ..., EventCode = 0x180C), and PortStatusList: PortStatusInfo = DI, DiagEntryx = empty |
| Test not passed (examples) | Any evaluation failed |
| Report | All evaluations <ok nok> |

2940

2941 **8.14.19 Incompatible Device and DS**

2942 Table 309 defines the test conditions for this test case.

2943 **Table 309 – Incompatible Device and DS**

2944 -CR062--CR091--CR080-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|--|
| Identification (ID) | SDCI_TC_0371 |
| Name | TCM_ALIC_STOR_INCOMPDEVICE&DS |
| Purpose (short) | DS in case of identification fault (incompatible Device) |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.0-1 |
| Category / type | Master DS test: test to pass |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4 |
| Configuration / setup | Master-Tester-System with MTU |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | At start-up, the Master detects a Device, not type compatible with configured data. This leads to PortEvent generated, no DS Upload/Download, MTU is on hold in PREOPERATE and shows diagnosis information. |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | <p>a) TM_MASTER_UPLOAD(PARSET1) ;PARSET1 uploaded to Master DS</p> <p>b) DLL_GetPortEvents ;clear Event entries</p> <p>b) c) MTU_State_Deactivate ;disable response to Master request</p> <p>c) d) MTU_DPP1_Set(DeviceID = 0x102BD2);MTU gets different DeviceID</p> <p>d) e) MTU_DS_SetParameter(PARSET2) ;MTU activates PARSET2</p> <p>e) f) MTU_DS_SetUpload(<Flag_on>) ;set DS_UPLOAD_FLAG</p> <p>f) g) MTU_State_Activate ;enable response to Master request</p> <p>g) TM_AWAIT_PORT_EVENT ;returns EventQualifier+EventCode</p> <p>h) DLL_GetPortEvents(3) ;minED=3, returns "PortEventList"</p> <p>i) Evaluation 1)</p> <p>i) j) MTU_DS_CheckDSCommands; ;returns "DS_Command performed"</p> <p>j) k) Evaluation 2)</p> <p>k) l) SMI_PortStatus ;returns "PortStatusList"</p> <p>l) m) Evaluation 3)</p> <p>m) n) SMI_DSToParServ ;returns "DS_Data"</p> <p>n) o) Evaluation 4)</p> <p>o) p) SMI_PortConfiguration(ABPS_PORTTODI) ;switch Port to DI mode</p> <p>p) q) TM_AWAIT_PORT_EVENT ;returns EventQualifier+EventCode</p> <p>s) q) DLL_GetPortEvents(1) ;minED=1 , returns "PortEventList"</p> <p>r) Evaluation 5)</p> <p>s) SMI_PortStatus TM_AWAIT_PORT_STATUS(DI) ;returns "PortStatusList"</p> <p>t) Evaluation 6)</p> |
| Test parameter | – |
| Post condition / next test | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | <p>1) Check ArgBlock "PortEventList"</p> <p>2) Check "DS_Command"</p> <p>3) Check ArgBlock "PortStatusList"</p> <p>4) Check ArgBlock "DS_Data"</p> <p>5) Check ArgBlock "PortEventList"</p> <p>6) Check ArgBlock "PortStatusList"</p> |

| TEST CASE RESULTS | CHECK / REACTION |
|----------------------------|---|
| Test passed | <p>PortEventList.Entry1 EventQualifier: Master/Port, Error, Event appears, EventCode = 0x1803), and "DS_Commands performed" = FALSE, and PortStatusList: PortStatusInfo = PORT_DIAG, DiagEntryx = result of 1), and DataStorageObject = PARSET1, and PortEventList.Entry1 (EventQualifier: : Master/Port, Error, Event disappears,EventCode = 0x180C 0x1803, and PortStatusList: PortStatusInfo = DI, DiagEntryx = empty</p> |
| Test not passed (examples) | Evaluation 1,2,3,4,5,6 failed |
| Report | All evaluations <ok nok> |

2947

2948 **8.14.20 Master power OFF/ON (non-volatile DS data)**

2949 Table 310 defines the test conditions for this test case.

2950 **Table 310 – Master power OFF/ON (non-volatile DS data)**

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE | |
|----------------------------|--|--|
| Identification (ID) | SDCI_TC_0372 | |
| Name | TCM_ALIC_STOR_POWEROFFNONVOLATILEDS | |
| Purpose (short) | Non-volatile storage of Port configuration and DS data | |
| Equipment under test (EUT) | Master + Port | |
| Test case version | 1.0 | |
| Category / type | Master DS test: test to pass | |
| Specification (clause) | [7], 11.2, 11.3, B.2.3, B.2.4 | |
| Configuration / setup | Master-Tester-System with MTU | |
| TEST CASE | CONDITIONS / PERFORMANCE | |
| Purpose (detailed) | After power off/on, the Master starts with the same configuration data and DS data as before the power cycle. These data are saved in non-volatile memory. | |
| Precondition | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE | |
| Procedure | a) TM_MASTER_UPLOAD (PARSE1) b) Switch off EUT power supply c) Switch on EUT power supply d) TM_AWAIT_PORT_STATUS (OPERATE) e) SMI_DSToParServ f) Evaluation 1) | ;PARSE1 uploaded to Master DS ;Depending on Tester implementation ;returns "DS_Data" |
| Test parameter | – | |
| Post condition / next test | – | |
| TEST CASE RESULTS | CHECK / REACTION | |
| Evaluation | 1) Check ArgBlock "DS_Data" | |
| Test passed | DataStorageObject = PARSET1 | |
| Test not passed (examples) | Any evaluation failed | |
| Report | All evaluations | <ok nok> |

2953

2954 **8.14.21 DS Upload trial with locked Device Data Storage**

2955 Table 311 defines the test conditions for this test case.

2956 **Table 311 – DS Upload trial with locked Device Data Storage**

2957 -CR057--CR062-

2958

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0280 |
| Name | TCM_ALIC_STOR_DSLOCKED |
| Purpose (short) | DS Upload trial with locked Device Data Storage |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.4 2 |
| Category / type | Master DS test: test to pass |

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|---|
| Specification (clause) | | [7], 11.2, 11.4, B.2.3, B.2.4 |
| Configuration / setup | | Master-Tester-System with MTU |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | <p>Master shall detect the locked Data Storage of a Device. In this case the Master shall deny access for all data storage actions from its own data storage handler.</p> <p>NOTE Even it is highly recommended for Devices not to implement locking for DS, Devices in the field can show this feature and Master shall be able to handle it.</p> |
| Precondition | | EUT: EUT_PORT_DI MTU: MTU_STANDARD_STATE |
| Procedure | | a) MTU_DS_Locked ;Parameter_DeviceAccessLocks_Data_Storage = "1" b) DLL_GetPortEvents ;clear Event entries c) SMI_PortConfiguration(ABPS_TYPE_COMP <Validation&Backup = "3">) d) TM_AWAIT_PORT_STATUS (PORT_DIAG) e) MTU_DS_CheckDSCommands ;returns "DS_Command performed" f) Evaluation 1) g) DLL_GetPortEvents(1) ;minED=1, returns "PortEventList" h) TM_AWAIT_PORT_EVENT i) Evaluation 2) j) SMI_DSToParServ ;returns "DS_Data" k) Evaluation 3) |
| Test parameter | | - |
| Post condition / next test | | - |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check "DS_Command performed" 2) Check ArgBlock "PortEvent" 3) Check "DS_Data" |
| Test passed | | "DS_Command performed" = FALSE, and PortEventList.Entry1 (EventQualifier: INSTANCE = SYS, SOURCE = Master/Port, TYPE = Error, Mode = Single-shot Event appears, EventCode = 0xFF25 0x180B), and "DS_Data" = no data/invalid (Header = "0") and length = 12 octets |
| Test not passed (examples) | | Any evaluation failed |
| Report | | All evaluations <ok nok> |

2961

2962

2963

2964 **8.15 Legacy Device ("V1.0")**2965 **8.15.1 General**

2966 Since a Master designed according to [7] shall support legacy Devices designed according to
 2967 [5], it shall pass the following test cases.

2968 **8.15.2 Master detects legacy Device and establishes connection**

2969 Table 312 defines the test conditions for this test case.

2970 **Table 312 – Master detects legacy Device and establishes connection**

2971 -CR077-

| TEST CASE ATTRIBUTES | IDENTIFICATION / REFERENCE |
|----------------------------|---|
| Identification (ID) | SDCI_TC_0285 |
| Name | TCM_LGCY_MANY_DETECTANDCONNECT |
| Purpose (short) | Master detects legacy Device and establishes connection |
| Equipment under test (EUT) | Master + Port |
| Test case version | 1.2 3 |
| Category / type | Master legacy Device test: test to pass |
| Specification (clause) | [5], 7.2.2.1, 9.3.3; [7], 9.2.3.2, A.2.6, Figures 71, 72 |
| Configuration / setup | Master-Tester-Unit |
| TEST CASE | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | Compatibility of the startup phase of V1.1 Master and a V1.0 Device. Master shall detect connection to a V1.0 Device and shall adjust its startup behavior. |
| Precondition | MTU: MTU_STANDARD_STATE EUT: PORT_INACTIVE |
| Procedure | a) MTU_DPP1_Set(RevisionID = 0x10) b) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) c) TM_AWAIT_PORT_STATUS(OPERATE) <i>:returns "PortStatusList"</i> d) Evaluation 1) e) MTU_Startup_Check10 <i>:returns "Startup1.0"</i> f) Evaluation 2) |
| Test parameter | – |
| Post condition /next test | – |
| TEST CASE RESULTS | CHECK / REACTION |
| Evaluation | 1) Check ArgBlock "PortStatusList" 2) Check "Startup1.0" |
| Test passed | PortStatusList: PortStatusInfo = OPERATE, TransmissionRate = COM2, MasterCycleTime (decoded) \geq 4 ms, InputDataLength = 1, OutputDataLength = 1, VendorID = 0x02A4 0xFDE8 , DeviceID = 0x002BD2, RevisionID = 0x10, and Startup1.0 = TRUE |
| Test not passed (examples) | Any evaluation failed, or Test_Timeout |
| Report | Start-up according to [5]: <yes/no> <i><ok nok></i> |

2974

2975

2976 **8.15.3 Master detects legacy Device and establishes interleave mode**

2977 Table 313 defines the test conditions for this test case.

2978 **Table 313 – Master detects legacy Device and establishes interleave mode**

2979 -CR077-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0286 |
| Name | | TCM_LGCY_MANY_DETECTANDINTERLEAVE |
| Purpose (short) | | Master detects legacy Device and establishes interleave mode |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.2 3 |
| Category / type | | Master legacy Device test: test to pass |
| Specification (clause) | | [5], 9.3.3; [7], 9.2.3.5, A.2.6, Figures 71, 72 |
| Configuration / setup | | Master-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Compatibility of the startup phase of V1.1 Master and a V1.0 Device using M-sequence TYPE_1 in interleave mode. Master shall detect connection to a V1.0 Device and shall adjust its startup behavior. |
| Precondition | | MTU: MTU_STANDARD_STATE EUT: PORT_INACTIVE |
| Procedure | | a) MTU_DPP1_Set(RevisionID = 0x10) b) MTU_DPP1_Set(InputLength = 3) c) MTU_DPP1_Set(OutputLength = 3) d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) e) TM_AWAIT_PORT_STATUS(OPERATE) <i>:returns "PortStatusList"</i> f) Evaluation 1) g) MTU_Startup_Check10 <i>:returns "Startup1.0"</i> h) Evaluation 2) |
| Test parameter | | – |
| Post condition / next test | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check ArgBlock "PortStatusList" 2) Check "Startup1.0" |
| Test passed | | PortStatusList: PortStatusInfo = OPERATE, TransmissionRate = COM2, MasterCycleTime (decoded) \geq 4 ms, InputDataLength = 3, OutputDataLength = 3, VendorID = 0x02A4 0xFDE8 , DeviceID = 0x002BD2, RevisionID = 0x10, and Startup1.0 = TRUE |
| Test not passed (examples) | | Any evaluation failed, or Test_Timeout |
| Report | | Start-up according to [5]: <yes/no> <i><ok nok></i> M-sequence TYPE_1 used: <yes/no> <i><ok nok></i> |

2982

2983

2984 **8.15.4 Master receives an Event without details (Warning)**

2985 Table 314 defines the test conditions for this test case.

2986 **Table 314 – Master receives an Event without details (Warning)**

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0287 |
| Name | | TCM_ALIC_EVNT_NODETAILSWARNING |
| Purpose (short) | | Master receives an Event without details |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.2 |
| Category / type | | Master legacy Device test: test to pass |
| Specification (clause) | | [5], 7.2.4.4.1 [7], 7.3.8.3, 8.3.3.1, 11.5, Annex A.6, Annex D |
| Configuration / setup | | Master-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master receives Event without details (StatusCode type 1, notification). Master extracts the EventCode (type 1), maps it accordingly into StatusCode (type 2) and transfers it to the upper-level system. Similarly, the StatusCode indicates with 1 bit the validity of the Process Data. The Master shall read this information as soon as possible to indicate the actual state of the Process Data to the upper system. The Master acknowledges the Event; the Master-Tester-Unit resets the Event flag. |
| Precondition | | MTU: MTU_STANDARD_STATE, No Event in process EUT: PORT_INACTIVE |
| Procedure | | a) MTU_DPP1_Set(RevisionID = 0x10) b) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) c) TM_AWAIT_PORT_STATUS(OPERATE) ; <i>returns "PortStatusList"</i> d) Evaluation 1) e) MTU_Event_SetStatusCode(0x01) f) MTU_Event_TriggerAndWaitForAck ; <i>returns "EventAck"</i> j) Evaluation 2) g) DLL_GetDeviceEvents(1) :minED = 1, <i>returns "EventList"</i> h) Evaluation 3) k) TM_AWAIT_PORT_STATUS(OPERATE) ; <i>returns "PortStatusList"</i> l) Evaluation 4) |
| Test parameter | | – |
| Post condition / next test | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check ArgBlock "PortStatusList" 2) Check "EventAck" 3) Check "EventList" 4) Check ArgBlock "PortStatusList" |
| Test passed | | PortStatusList: PortStatusInfo = OPERATE, RevisionID = 0x10, NumberOfDiags = 0, and EventAck: StatusCodeRead = TRUE, AllSlotsRead = TRUE, Ack. = TRUE, and EventList.Entry1 = 0xFF80, Application, notification, and PortStatusList: PortStatusInfo = OPERATE, RevisionID = 0x10, NumberOfDiags = 0 ; <i>since notifications will not be placed into list</i> |
| Test not passed (examples) | | Any evaluation failed, or Test-Timeout |
| Report | | Propagated information to the upper-level system: <code> <ok nok> Master acknowledgement: <code> <ok nok> Event flag: <0/1> <ok nok> |

2989

2990 **8.15.5 ISDU Write interrupted by an Event leads to a Write error**

2991 Table 315 defines the test conditions for this test case.

2992 **Table 315 – ISDU Write interrupted by an Event leads to a Write error**

2993 -CR081--CR099-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|----------------------------|--|--|
| Identification (ID) | | SDCI_TC_0289 |
| Name | | TCM_LGCY_MANY_EVENTINTERRUPTSISDU |
| Purpose (short) | | ISDU Write interrupted by an Event leads to write error |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.2 3 |
| Category / type | | Master legacy Device test: test to pass |
| Specification (clause) | | [5], 7.3.6.3, Figure 47; [7], Table C.2, Annex C.3.8 |
| Configuration / setup | | Master-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | According to [5], the legacy Device can cancel an ongoing ISDU transfer via an Event. This Event shall lead to a Read error or Write error on the Master side. |
| Precondition | | MTU: MTU_STANDARD_STATE, no Event pending EUT: EUT_INACTIVE PORT_INACTIVE |
| Procedure | | a) MTU_DPP1_Set(RevisionID = 0x10) b) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) c) TM_AWAIT_PORT_STATUS(OPERATE) <i>;returns "PortStatusList"</i> d) Evaluation 1) e) MTU_Add_ISDU(Index = <Index>, Subindex = 0, Specialty = ISSUE_EVENT) f) SMI_DeviceWrite(ABPS_DEVICEWRITE(<Index>)) <i>;returns "JobError"</i> <i>;the Master initiates an ISDU Write with too large length of data. The legacy Device sends an Event (DL, Error, Event single shot, ErrorCode = 0x5200) during the ISDU service to abort it.</i> g) Evaluation 2) h) TM_AWAIT_PORT_STATUS(OPERATE) <i>;returns "PortStatusList"</i> i) Evaluation 3) |
| Test parameter | | <Index> = 251, data = all "0", data length = 33 |
| Post condition / next test | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check ArgBlock "PortStatusList" 2) Check ArgBlock "JobError" 3) Check ArgBlock "PortStatusList" |
| Test passed | | PortStatusList: PortStatusInfo = OPERATE, RevisionID = 0x10, NumberOfDiags = 0, and JobError: ErrorCode = 0x80, AdditionalCode = 0x23, and PortStatusList: PortStatusInfo = OPERATE, RevisionID = 0x10, NumberOfDiags = 0 |
| Test not passed (examples) | | Any evaluation failed, or Test_Timeout, or Receive "JobError" does not terminate within 10 s, or Received positive result |
| Report | | Event received by the upper-level system: <yes/no> ISDU service aborted: <yes/no> |
| | | <i><ok nok></i> |

2996

2997

2998 **8.15.6 Master transforms PD_invalid Event into appropriate propagation**

2999 Table 316 defines the test conditions for this test case.

3000 **Table 316 – Master transforms PD_invalid Event into appropriate propagation**

3001 -CR081-

| TEST CASE ATTRIBUTES | | IDENTIFICATION / REFERENCE |
|-----------------------------|--|---|
| Identification (ID) | | SDCI_TC_0290 |
| Name | | TCM_LGCY_MANY_PDINVALIDEVENT |
| Purpose (short) | | Master transforms PD_invalid and PD_valid Event into appropriate propagation |
| Equipment under test (EUT) | | Master + Port |
| Test case version | | 1.4 2 |
| Category / type | | Master legacy Device test: test to pass |
| Specification (clause) | | [5], 7.2.4.4; [7], A.6.2, A.6.3 |
| Configuration / setup | | Master-Tester-Unit |
| TEST CASE | | CONDITIONS / PERFORMANCE |
| Purpose (detailed) | | Master transforms a "PD invalid" and a "PD_valid" Event from a legacy Device into an appropriate propagation form and passes Process Data correctly. |
| Precondition | | MTU: MTU_STANDARD_STATE, No Event in process EUT: EUT_INACTIVE PORT_INACTIVE |
| Procedure | | a) MTU_DPP1_Set(RevisionID = 0x10) b) MTU_DPP1_Set(PDIn length) = 0x83 ;"32" Bit c) MTU_DPP1_Set(PDOut length) = 0x83 ;"32" Bit d) SMI_PortConfiguration(ABPS_NOTYPE_CHECK) e) TM_AWAIT_PORT_STATUS(OPERATE) ;returns "PortStatusList" f) Evaluation 1) g) MTU_State_MirrorPD ;perform PD mirroring h) MTU_State_SetPDValidity(VALID) i) TM_AWAIT_PD_VALIDITY(VALID) ;return "PDIn" j) Evaluation 2) k) SMI_PDOut(ABPS_PDOOUT<OutputDataLength=4, PDO = [0x12,0x34,0x56,0x78]>) l) SMI_PDIn ;returns "PDIn" m) Evaluation 3) n) MTU_State_SetPDValidity(INVALID) ;Device issues Event with PD Invalid o) TM_AWAIT_PD_VALIDITY(INVALID) ;return "PDIn" p) Evaluation 4) q) MTU_State_SetPDValidity(VALID) ;Device issues Event with PD Valid r) TM_AWAIT_PD_VALIDITY(VALID) ;return "PDIn" s) Evaluation 5) |
| Test parameter | | – |
| Post condition | | – |
| TEST CASE RESULTS | | CHECK / REACTION |
| Evaluation | | 1) Check ArgBlock "PortStatusList" 2) Check ArgBlock "PDIn" 3) Check ArgBlock "PDIn" |
| Test passed | | 4) Check ArgBlock "PDIn" 5) Check ArgBlock "PDIn" |
| Test passed | | PortStatusList: PortStatusInfo = OPERATE, RevisionID = 0x10, and PDIn: PQI.PQ = VALID, and PDIn: PDI = [0x12,0x34,0x56,0x78], and PDIn: PQI.PQ = INVALID, and PDIn: PQI.PQ = VALID |
| Test not passed (examples) | | Any evaluation failed, or Test_Timeout |
| Report | | Correct propagation of PD_INVALID: <yes/no> Correct propagation of PD_VALID: <yes/no> Event acknowledged: <yes/no> |
| | | <ok nok> <ok nok> <ok nok> |

3005

3006 **8.16 Test report template**

3007 The template is defined by the Master-Tester. The test report shall present at least the reports
3008 of the test cases.

3009

3010 9 Environmental tests**3011 9.1 General**

3012 Annex G in [7] defines the environmental tests (EMC) for the SDCI communication part of a
3013 Master/Device system. A passed EMC test is a precondition for a Manufacturer Declaration. It
3014 depends on the particular technology of a Device and the countries of deployment, whether
3015 additional environmental tests are necessary to achieve for example a CE mark for Europe.

3016 9.2 Product specific standards

3017 Usually, the product standard for a Master is the IEC 61131-2. For Devices, the major product
3018 standard is the IEC 60947-1.

3019 9.3 EMC tests

3020 EMC tests in respect to a particular phenomenon are defined in the IEC 61000-4-x series. De-
3021 tails for the execution are described in Annex G.2 in [7] and in 4.4 or 4.5 respectively.

3022 Hint: Length "L" in Figures G.4 and G.8 in [7] shall be as short as possible.

3023 9.4 Test report templates**3024 9.4.1 Overview**

3025 Tests are required for the following phenomena:

- 3026 • Electrostatic discharge (ESD: IEC 61000-4-2)
- 3027 • Electromagnetic field (HF: IEC 61000-4-3)
- 3028 • Fast transients (Burst: IEC 61000-4-4)
- 3029 • Conducted radio frequency (CRF: IEC 61000-4-6)

3030 The SDCI manufacturer declaration of conformity comprises EMC tests according to Annex
3031 G.2.4 in [7]. The following forms or any other document may be used as long as it contains the
3032 same information.

3033

3034 **9.4.2 ESD**

3035 Figure 14 shows a proposed template for ESD tests.

| | |
|-----------------------------|--|
| Project: | |
| Test Item: | |
| Responsible Party: | |
| Tester: | |
| Applied Standard/Guideline: | |
| Type of Device: | |
| Test Location: | |
| Time Range: | |

3036

| Test Requirements/Results: | | | | |
|----------------------------|------------------------|----|------------------------------|-----------------------|
| Type of discharge | Requirement fulfilled? | | Achieved Immunity Voltage kV | Performance Criterion |
| | yes | no | | |
| Contact discharge | | | | |
| Air discharge | | | | |
| HCP | | | | |
| VCP | | | | |

3037

| | |
|---------------------------------------|--|
| Result: | |
| Test requirements are | <input type="checkbox"/> <input checked="" type="checkbox"/> fulfilled <input type="checkbox"/> not fulfilled |
| Every single requirement must be met. | |

3038

3039 **Remarks:**

3040 _____
3041 _____
3042 _____
3043 _____
3044 _____

3045

3046 **Enclosures:**

3047 _____
3048 _____
3049 _____
3050 _____
3051 _____

3052

Date

Tester's Signature

3053

3054 **Figure 14 – Proposed template for ESD tests**

3055

9.4.3 HF

3056 **9.4.3 HF**
 3057 Figure 15 shows a proposed template for HF tests.

| | |
|-----------------------------|--|
| Project: | |
| Test Item: | |
| Responsible Party: | |
| Tester: | |
| Applied Standard/Guideline: | |
| Type of Device: | |
| Test Location: | |
| Time Range: | |

3058

| Test Requirements/Results: | | | | |
|----------------------------|------------------------|----|----------------------------------|-----------------------|
| Type of HF Field | Requirement fulfilled? | | Achieved Immunity Test Field V/m | Performance Criterion |
| | yes | no | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |

3059

| | | | |
|---------------------------------------|--------------------------|---------------|--|
| Result: | | | |
| Test requirements are | <input type="checkbox"/> | fulfilled | |
| | <input type="checkbox"/> | not fulfilled | |
| Every single requirement must be met. | | | |

3060

Remarks:

3061 _____
 3062 _____
 3063 _____
 3064 _____
 3065 _____
 3066 _____
 3067 _____

Enclosures:

3068 _____
 3069 _____
 3070 _____
 3071 _____
 3072 _____
 3073 _____

3074

Date

Tester's Signature

3075

Figure 15 – Proposed template for HF tests

3076

3077

3078 **9.4.4 Burst**

3079 Figure 16 shows a proposed template for Burst tests.

| | |
|-----------------------------|--|
| Project: | |
| Test Item: | |
| Responsible Party: | |
| Tester: | |
| Applied Standard/Guideline: | |
| Type of Device: | |
| Test Location: | |
| Time Range: | |

3080

| Test Requirements/Results: | | | | |
|----------------------------|-------------------------|----|-----------------------------------|-----------------------|
| Type of burst | Requirement ful-filled? | | Achieved Immunity Test Voltage kV | Performance Criterion |
| | yes | no | | |
| power supply lines | | | | |
| data lines | | | | |
| | | | | |
| | | | | |

3081

| | |
|---------------------------------------|--|
| Result: | |
| Test requirements are | <input type="checkbox"/> fulfilled <input type="checkbox"/> not fulfilled |
| Every single requirement must be met. | |

3082

3083 **Remarks:**

3084 _____
3085 _____
3086 _____
3087 _____
3088 _____
3089 _____

3090

Enclosures:

3091 _____
3092 _____
3093 _____
3094 _____
3095 _____

3096

Date

Tester's Signature

3097

Figure 16 – Proposed template for Burst tests

3098

3099

9.4.5 Conducted RF

Figure 17 shows a proposed template for conducted RF tests.

| | |
|-----------------------------|--|
| Project: | |
| Test Item: | |
| Responsible Party: | |
| Tester: | |
| Applied Standard/Guideline: | |
| Type of Device: | |
| Test Location: | |
| Time Range: | |

3102

| Test Requirements/Results: | | | | |
|----------------------------|-----------------------------|--------------------------|-------------------------------------|--------------------------|
| Type of Frequency MHz | Requirement ful- filled? | | Achieved Immunity Test Voltage V | Performance Criterion |
| | yes | no | | |
| 0,15 to 80 | <input type="checkbox"/> | <input type="checkbox"/> | <input type="checkbox"/> | <input type="checkbox"/> |

3103

| | | |
|---------------------------------------|--|---------------|
| Result: | | |
| Test requirements are | <input type="checkbox"/> <input type="checkbox"/> | fulfilled |
| | | not fulfilled |
| Every single requirement must be met. | | |

3104

Remarks:

3105

Enclosures:

3106

Date

Tester's Signature

3107

Figure 17 – Proposed template for conducted RF tests

3108

3121 **9.4.6 Explanation of template terms**

3122 The terms in the templates are defined as follows:

- 3123 • "Project" means for example the name of an SDCI Device.
- 3124 • "Test Item" means the name and order number of the particular Device under test.
- 3125 • "Responsible Party" means the manufacturer or a third-party company who takes responsi-
3126 bility for the Device.
- 3127 • "Tester" means the full name of the test person in charge.
- 3128 • "Applied standards or guidelines" shall comprise at least [7] and a product standard such
3129 as IEC 60947-1
- 3130 • "Type of Device" identifies the type of the device thus indicating the appropriate level of
3131 EMC test. Possible types are "open type", "cabinet" or "enclosed type".
- 3132 • "Test Location" indicates the name and address of the EMC test laboratory.
- 3133 • "Time Range" indicates the date and the duration of the test.

Annex A
(normative)
Test configurations and test tools

A.1 Test configurations

A.1.1 Overview

The test cases for the physical layer tests and data link layer tests can be performed with the help of

- A variable power supply between 20 V and 30 V
- Discrete components such as capacitors and resistors according to the test case
- A voltmeter (accuracy of 2 %) and a current meter (accuracy of 10 %)
- An oscilloscope for Wake-up pulses and eye-diagrams
- A logic analyzer for message timings
- A line-monitor to record protocol sequences
- A Reference-Master and a Reference-Device

A.1.2 Measurement circuits for electrical isolation

A.1.2.1 Measurement of Master Port class B isolation

Figure A.1 shows the measurement circuit for electrical isolation of Master Port class B.

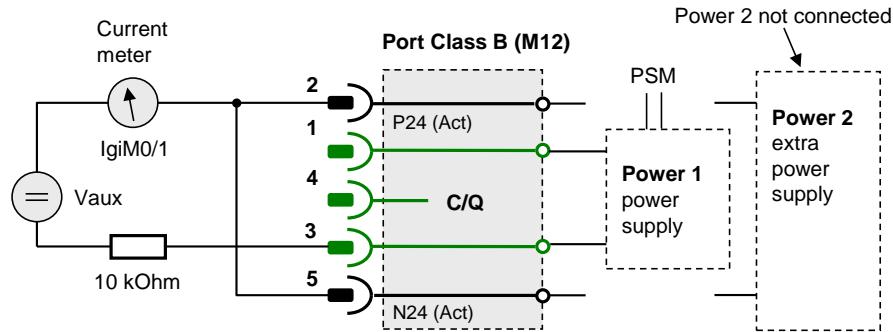


Figure A.1 – Measurement of Master Port class B isolation

A.1.2.2 Measurement of Device isolation

Figure A.2 shows the measurement circuit for electrical isolation of Device power supplies.

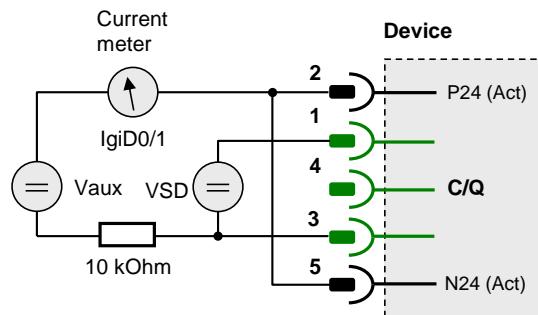


Figure A.2 – Measurement of Device isolation

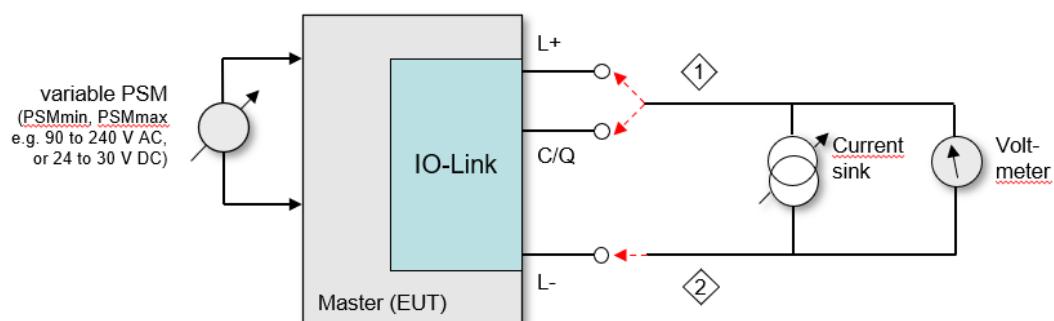
3160 **A.1.3 Measurement circuits for the physical layer tests**

3161 **A.1.3.1 Measurement of static parameters**

3162

3163 **-CR041-**

3164 Figure A.3 shows the measurement circuit diagram for static parameters with the help of a
3165 voltmeter.



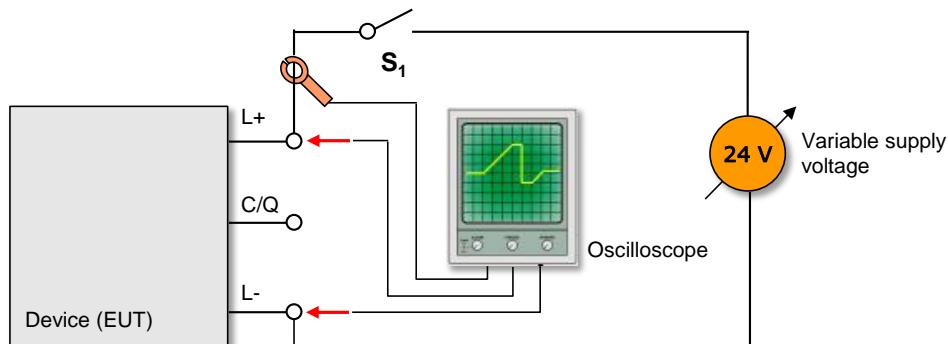
3166

3167 **Figure A.3 – Measurement circuit diagram for static parameters**

3168

3169 **A.1.3.2 Measurement of power supply behavior**

3170 Figure A.4 shows the circuit diagram for the measurement of the power-on behavior of Devices.



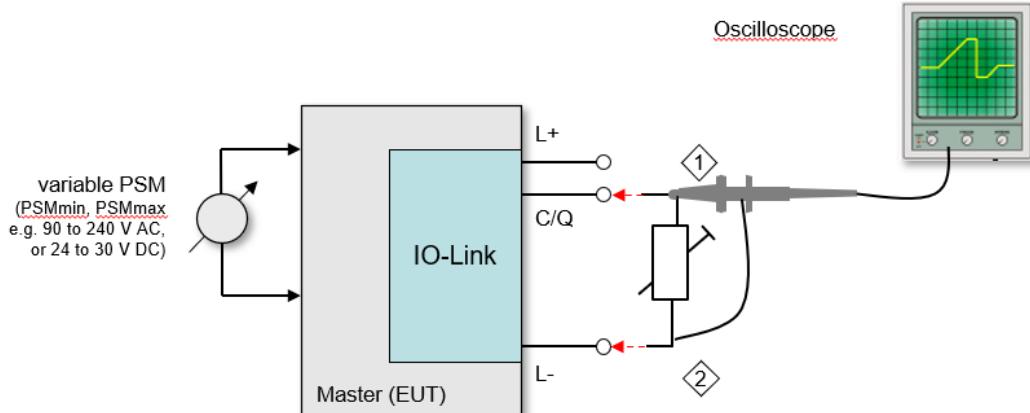
3171

3172 **Figure A.4 – Measurement circuit diagram for power supply behavior**

3173

3174 **A.1.3.3 Measurement of dynamic parameters**

3175 Figure A.5 shows the measurement circuit diagram for dynamic parameters with the help of an
 3176 oscilloscope.



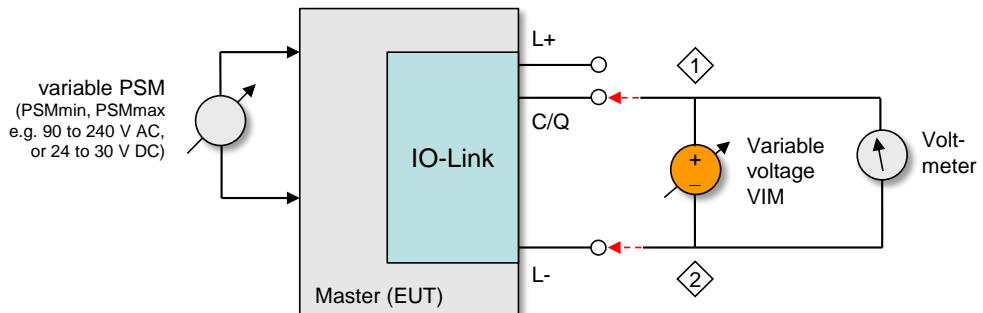
3177

3178 **Figure A.5 – Measurement circuit diagram for dynamic parameters**

3179

3180 **A.1.3.4 Measurement of Master input thresholds**

3181 Figure A.6 shows the measurement circuit diagram for Master input thresholds with the help of
 3182 an auxiliary variable voltage and a voltmeter.



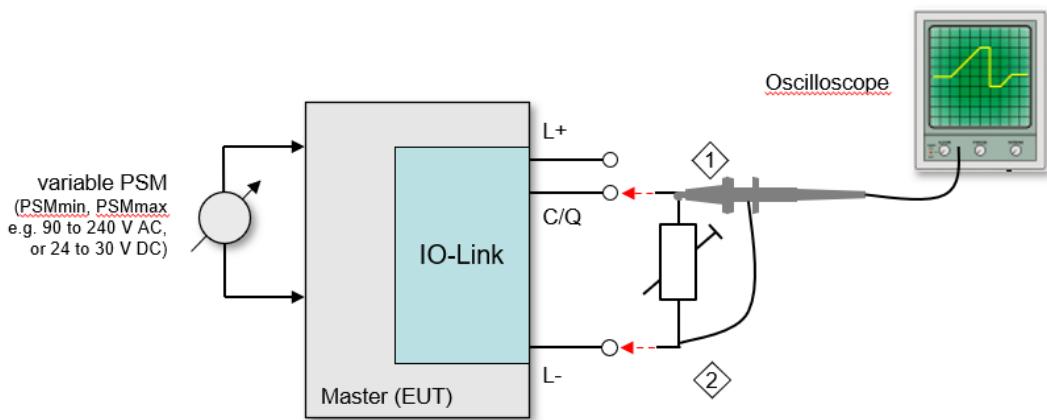
3183

3184 **Figure A.6 – Measurement circuit diagram for input thresholds**

3185

3186 **A.1.3.5 Measurement of Wake-up requests (high)**

3187 Figure A.7 shows the measurement circuit diagram for Wake-up requests with the help of an
 3188 oscilloscope if the steady state level (of a Device) is high.



3189

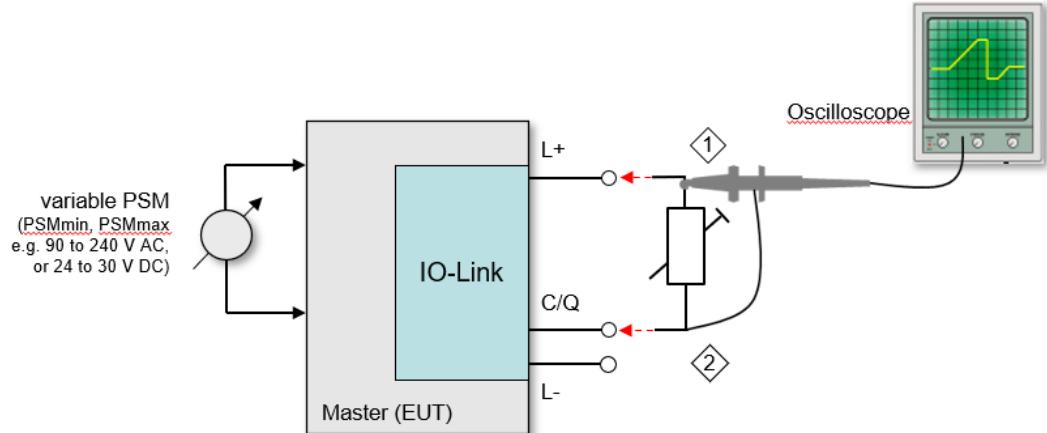
3190 -CR041-

3191 **Figure A.7 – Measurement circuit diagram for Wake-up requests (high)**

3192

3193 **A.1.3.6 Measurement of Wake-up requests (low)**

3194 Figure A.8 shows the measurement circuit diagram for Wake-up requests with the help of an
3195 oscilloscope if the steady state level (of a Device) is low.



3196

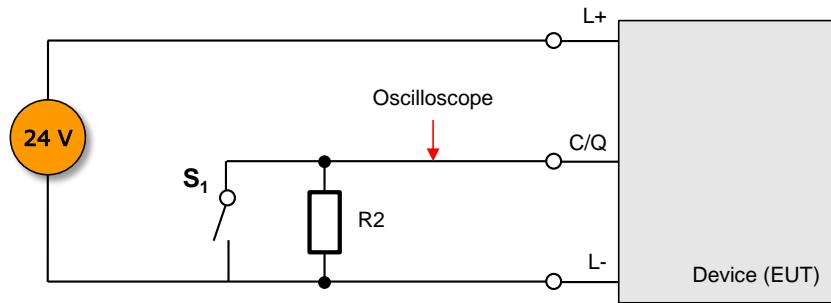
3197 -CR041-

3198 **Figure A.8 – Measurement circuit diagram for Wake-up requests (low)**

3199

3200 **A.1.3.7 Measurement of return time delay to SIO mode**

3201 Figure A.9 shows the circuit diagram for measurements of the delay time of a Device to return
3202 to SIO-mode with the help of an oscilloscope.



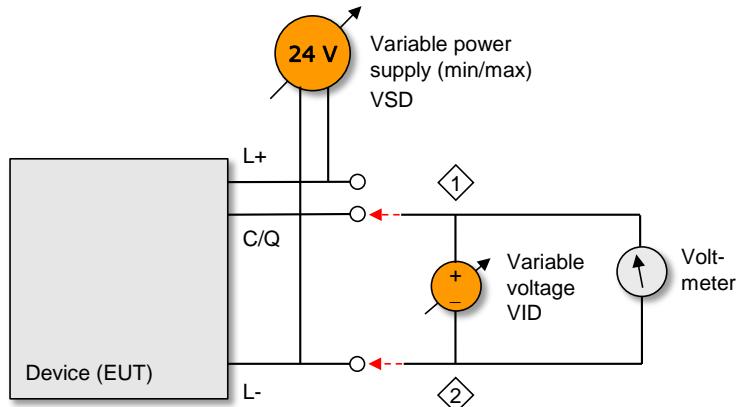
3203

Figure A.9 – Measurement of return time delay to SIO mode

3205

A.1.3.8 Measurement of dynamic parameters (Device input threshold)

3207 Figure A.10 shows the measurement circuit diagram for Device input thresholds with the help
3208 of an auxiliary variable voltage and a voltmeter.



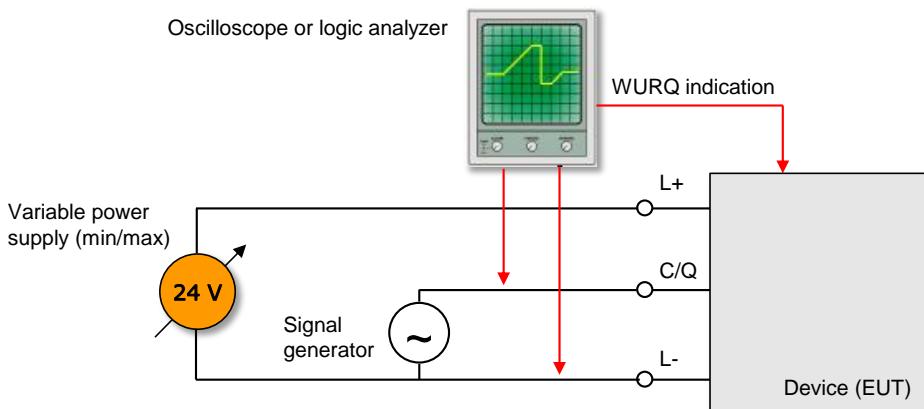
3209

Figure A.10 – Measurement circuit diagram for input thresholds

3211

A.1.3.9 Measurement of Wake-up requests (timing)

3213 Figure A.11 shows the measurement circuit diagram for the timing of Wake-up requests with
3214 the help of an oscilloscope.



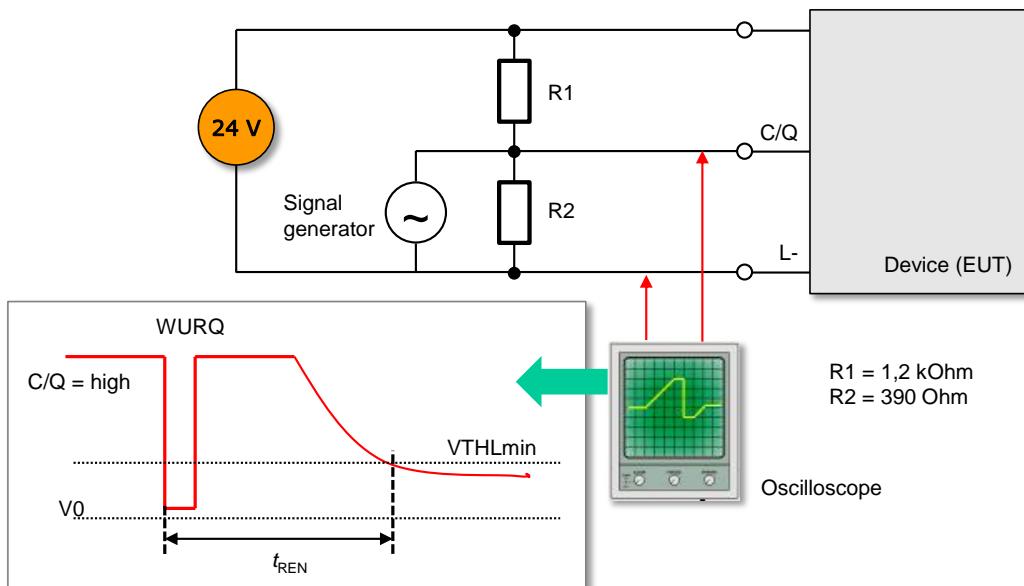
3215

Figure A.11 – Measurement circuit diagram for Wake-up request timings

3217

3218 **A.1.3.10 Measurement of Receive Enable after Wake-up (C/Q high)**

3219 Figure A.12 shows the circuit diagram for the measurement timing of t_{REN} (receive enable de-
3220 lay) with the help of an oscilloscope in case of C/Q = high.



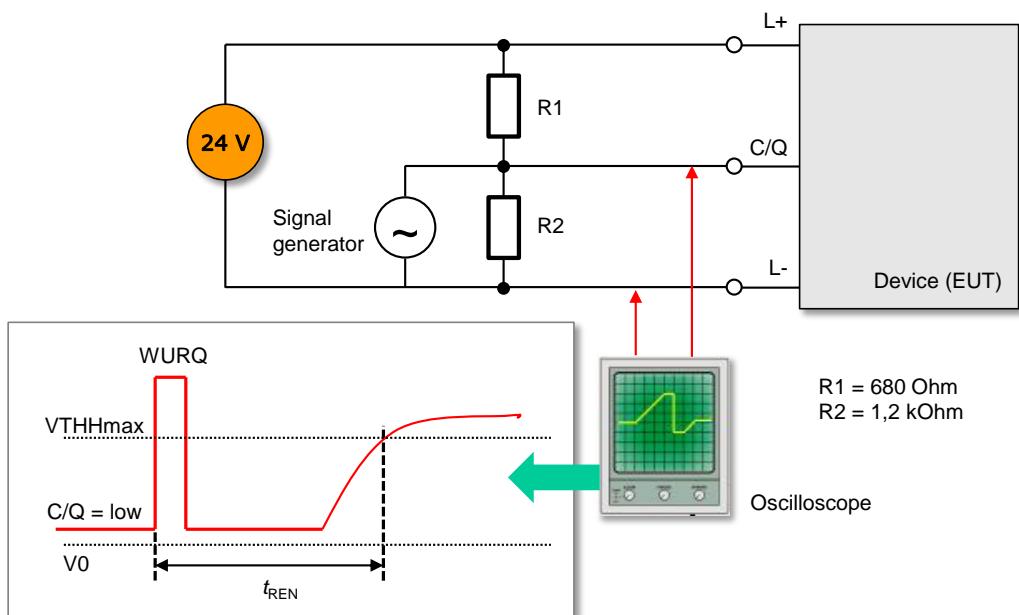
3221

3222 **Figure A.12 – Measurement circuit diagram for timing t_{REN} (C/Q high)**

3223

3224 **A.1.3.11 Measurement of Receive Enable after Wake-up (C/Q low)**

3225 Figure A.13 shows the circuit diagram for the timing measurement of t_{REN} (receive enable de-
3226 lay) with the help of an oscilloscope in case of C/Q = low.



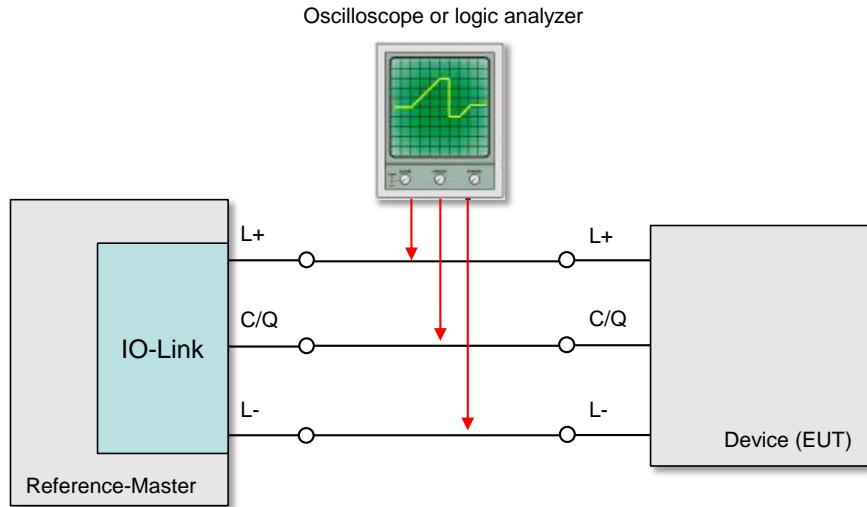
3227

3228 **Figure A.13 – Measurement circuit diagram for timing t_{REN} (C/Q low)**

3229

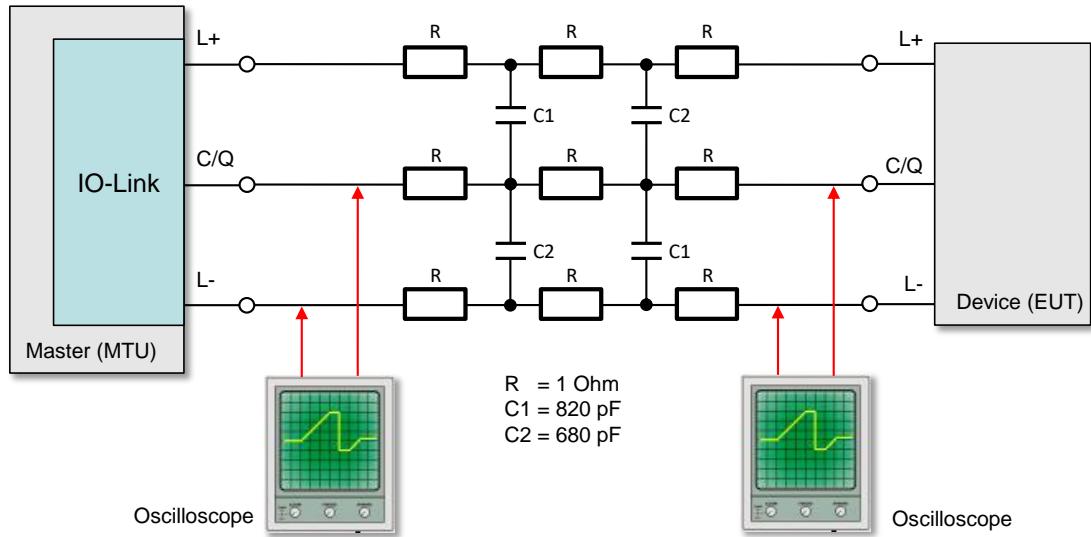
3230 **A.1.3.12 Measurement of start-up and readiness timings**

3231 Figure A.14 shows the measurement circuit diagram for start-up and readiness timings with the
3232 help of an oscilloscope or a logic analyzer.



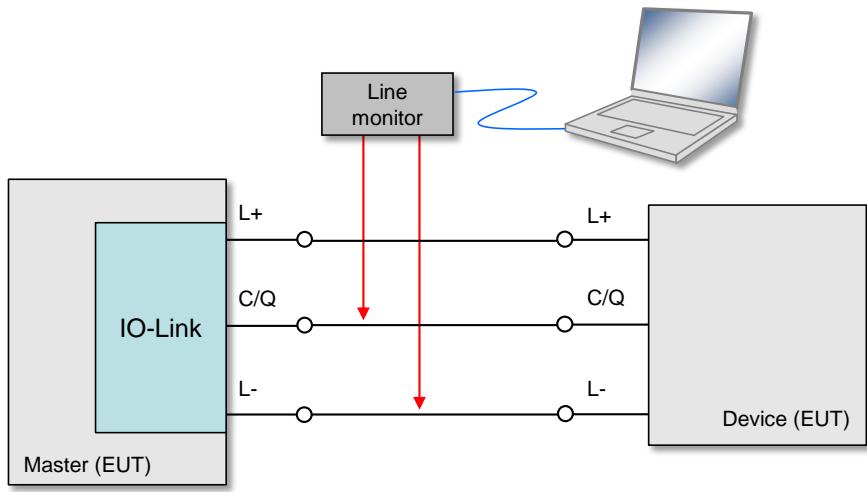
A.1.3.13 Eye diagram measurement using a line simulation

3236 Figure A.15 shows the circuit diagram for the eye diagram measurements using a line simulation
 3237 as required load.



A.1.4 Protocol recording via a Line-Monitor

3242 Usually, the test cases assume that a test passed if data are written or read in the expected
 3243 manner. Sometimes it is easier to observe the protocol steps with the help of a Line-Monitor
 3244 that lists the Master request messages and the Device response messages in a convenient
 3245 manner on the screen of a laptop. Figure A.16 shows the principle.



3247

3248

Figure A.16 – Message recording via Line-Monitor

3249

A.1.5 Requirements for a Reference-Master and a Reference-Device

3250 The features in Table A.1 are mandatory for a Reference-Master as referred to in the physical
 3251 layer tests of Devices.

3253

Table A.1 – Mandatory features of a Reference-Master

| Number | Feature | Reference |
|--------|---|--|
| FRM1 | Full compliance with respect to the signal on C/Q | [7] |
| FRM2 | VSM voltage adjustable in the range from 20V to 30V | Master with nominal 24 V |
| FRM3 | CQM selectable between 500 pF and 1 nF | [7], Table 6 |
| FRM4 | Functionality of the following SMI services: a) SMI_PortPowerOffOn(ABPS_PORTPOWERON), b) SMI_PortConfiguration(ABPS_NO_TYPE_CHECK), c) SMI_PortConfiguratoin(ABPS_PORT_INACTIVE) d) SMI_PortConfiguration(ABPS_TYPE_COMP) | [7], 11.2 and Annex E For parameter sets see Table A.10 |

3254

3255 The features in Table A.2 are mandatory for a Reference-Device as referred to in the physical
 3256 layer tests of Masters.

3257

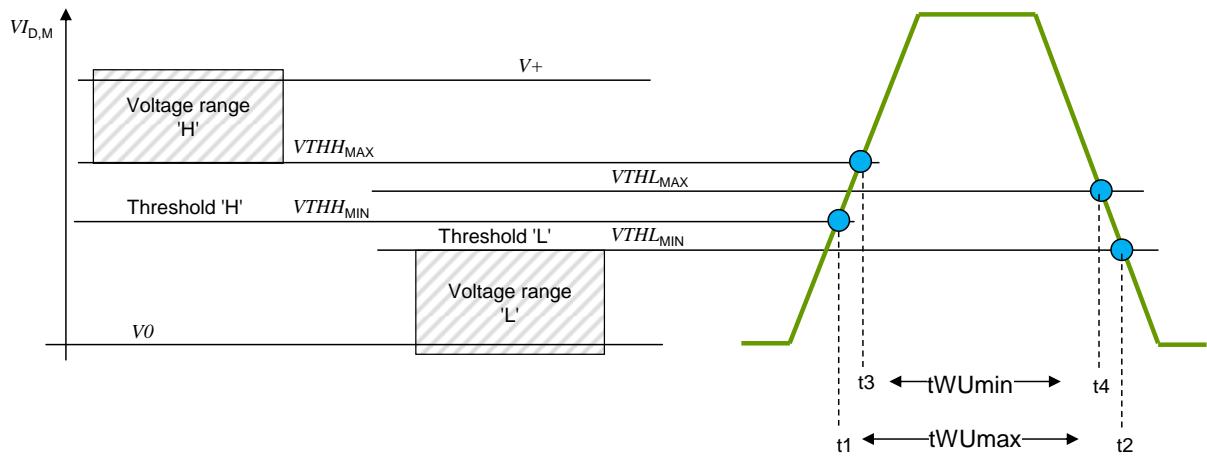
Table A.2 – Mandatory features of a Reference-Device

| Number | Feature | Reference |
|--------|---|--------------|
| FRD1 | Full compliance with respect to the signal on C/Q | [7] |
| FRD2 | Transmission rates selectable between COM2 and COM3 | [7], Table 9 |
| FRD3 | CQD selectable between 500 pF, 1 nF, and 10 nF | [7], Table 7 |

3258

A.1.6 Diagrams for evaluations

3259 Figure A.17 demonstrates how to determine maximum and minimum durations of Wake-up
 3260 pulse high.

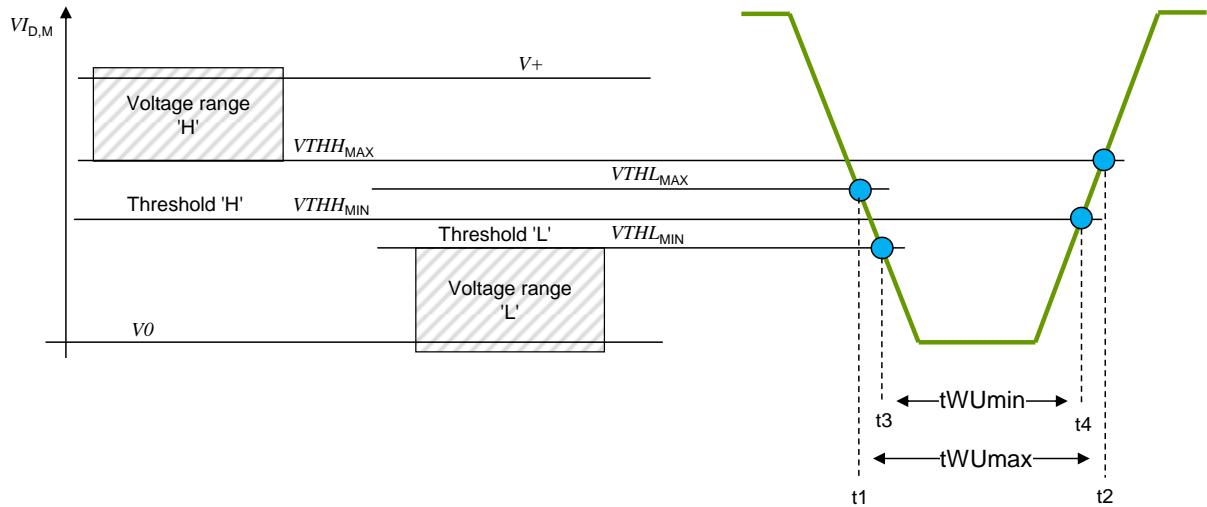


3262

3263

Figure A.17 – Evaluation of Wake-up pulse duration high

3264 Figure A.18 demonstrates how to determine maximum and minimum durations of Wake-up
3265 pulse low.



3266

3267

Figure A.18 – Evaluation of Wake-up pulse duration low

3268

3269 **A.2 Device-Tester-System**

3270 **A.2.1 Overview**

3271 To facilitate the tests of Devices and to ensure highest levels of conformity, several tools and
3272 the associated requirements (see Table A.3) are defined. These tools shall be type-approved
3273 by the organization mentioned in Annex D prior to any conformity testing for a manufacturer
3274 declaration.

3275 **A.2.2 Test principle and requirements**

3276 Figure A.19 shows the principle of a Device-Tester-System comprising

- 3277 • A Device-Tester-Unit hardware with at least one SDCI port, which can be a modified stand-
3278 ard Master with an adequate communication interface to a personal computer,
- 3279 • A personal computer supporting the communication interface of the Device-Tester-Unit
3280 hardware,
- 3281 • A Device-Tester-Program running on that personal computer serving as a control and mon-
3282 itoring program for the Device-Tester-Unit hardware,

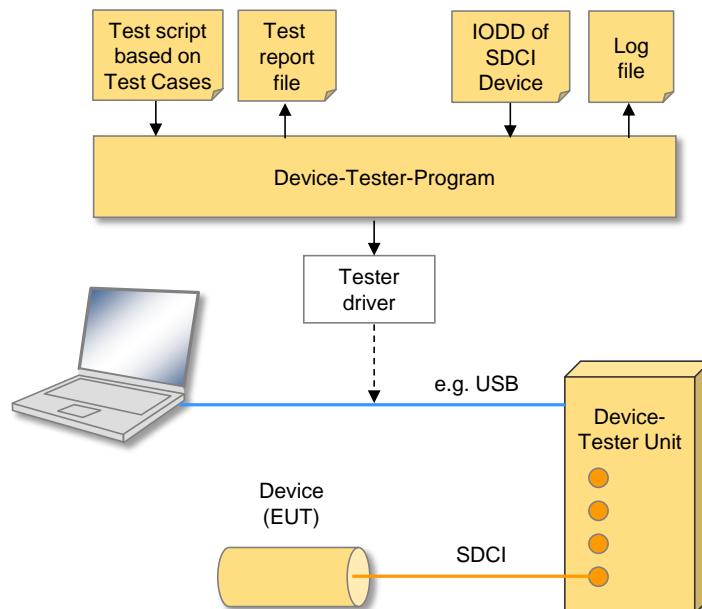
- 3283 • A Device – the EUT – that shall be tested for conformity.

3284

3285 **Table A.3 – Requirements for the Device-Tester-System**

| Requirement | Description |
|-------------|--|
| SR1 | The Device-Tester system shall execute and evaluate the test cases defined in this specification. This can include some functions or behavior not defined in the SDCI specification but is necessary to run the EUT into a specific state, e.g. generation of checksum errors. |
| SR2 | The result of each test case and additional information about the test execution shall be reported to the user (test report, log file). The user shall be able to store and print this information. |
| SR3 | The conformity test cases shall be secured against manipulation. |
| SR4 | Optional requirement: The Device-Tester can interpret a valid IODD and generate different settings which are required for the conformity test. In case of absence of the IODD file there shall be a possibility to edit the settings manually. |

3286



3287

3288 **Figure A.19 – Principle of a Device-Tester-System**

3289

3290 **A.3 Master-Tester-System and approach to Master testing**

3291 **A.3.1 Master-Tester using common communication interfaces**

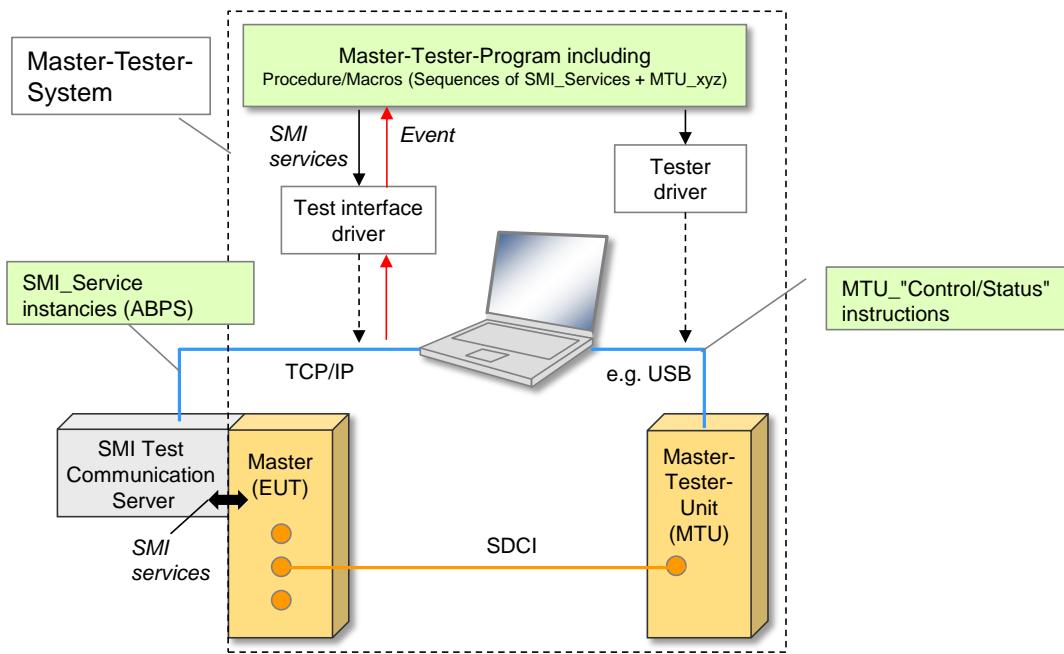
3292 Figure A.20 shows the principle of a Master-Tester-System comprising

- 3293 • A Master-Tester-Unit (MTU), which is a configurable and observable Device emulator with
3294 an IO-Link Port and with any communication interface to a personal computer, e.g. USB
3295 (Universal Serial Bus),
- 3296 • A personal computer supporting the communication interface of the MTU and a communica-
3297 tion interface to the SMI services (SMI Test Communication Server) of the Master to be
3298 tested (EUT = Equipment Under Test),
- 3299 • A Master-Tester-Program running on that personal computer serving as a control and mon-
3300 itoring program for the MTU as well as for the EUT,
- 3301 • A Master – the EUT – that shall be tested for conformity and that provides at least one Port
3302 and usually a communication interface based on Ethernet to an upper level system or in
3303 this case to the personal computer.

3304 To perform a test case, the Master-Tester-Program uses SMI service instances with appropriate
 3305 ArgBlock parameters (ABPS) to establish preconditions for the EUT (Master) and to step
 3306 through the procedure.

3307 In addition, the Master-Tester-Program also communicates with the Master-Tester-Unit using
 3308 "Control/Status" instructions via a common interface, e.g. USB. These MTU-Instructions are
 3309 identified by a characteristic and intuitive name.

3310



3311

3312 **Figure A.20 – Principle of a Master-Tester-System using SMI**

3313 **A.3.2 System requirements for Master-Tester**

3314 The tools of a Master-Test-System shall be type-approved by the organization mentioned in
 3315 Annex D prior to any conformity testing for a manufacturer declaration.

3316 Table A.4 lists the system requirements for the approval of a Master-Tester-System.

3317 **Table A.4 – System requirements for the Master-Tester**

3318 -CR0111- -CR112-

| Requirement | Description |
|-------------|---|
| SR1 | The test system shall execute and evaluate the test cases defined in this specification |
| SR2 | It should be possible to define, execute and evaluate additional customer specific test cases. |
| SR3 | The result of every test case and also additional information about test execution shall be reported to the user (test report, log file). The user shall be able to store and print this information. |
| SR4 | The conformity test cases defined in this specification and the user defined test cases should be coded in a script file (XML or TCL). |
| SR5 | The conformity test script file shall be provided by test system supplier. |
| SR6 | The conformity test script file shall be secured against manipulation. |
| SR7 | For the sake of an approval of the test system, it shall have a TCP/IP communication path between EUT (SDCI Master) and the personal computer. |
| | |
| | |

| Requirement | Description |
|-------------|---|
| SR10 | The test system manual shall be provided as PDF document. The user shall be able to read this document via freely available Adobe Reader software. |
| SR11 | The Master-Tester software can be used to download new firmware updates to the Master-Tester. The download process can not be interrupted by the user. The software can not verify the content of the downloaded file. The user is responsible to use a valid and correct Master-Tester firmware update file. |
| | |
| SR13 | The timeout for the time between entering the PREOPERATE state and leaving this state shall be adjustable in the Master tester |

3319

3320 Table A.5 lists the functional requirements for the approval of a Master-Tester-System.

3321

Table A.5 – Functional requirements for the performance of test cases

| Requirement | Description |
|-------------|---|
| FR1 | Usecase 1: Simulation of an SDCI Device |
| FR2 | Usecase 2: Error behavior (stack-Errors like checksum errors, invalid timing and application errors such as creation of ErrorCode) |
| FR3 | Usecase 3: Creation of status information (number of transmitted messages by the master, number erroneous messages) |
| FR4 | Usecase 4: Stand-alone device for EMC tests |
| FR5 | Hardware EMC Requirements: - IEC61000-4-4 (Burst) +/- 2 kV Crit. A; +/- 4 kV Crit. B - IEC61000-4-6 (RF) 13 V Crit. A |
| FR6 | Hardware Requirements: - SDCI interface - Slew Rate > 200 ns - Signaling LED or display: error counter (with active reset) - Power LED - SDCI communication LED - USB interface V2.0 (API) - Power supply via SDCI (optional USB or battery or external supply) - Non-volatile storage of configuration (maximum 1024 octets) - Monitoring (optional as independent tool) - Trigger output (24 V/10 mA) |
| FR7 | Configuration areas: - Device configuration (MinCycleTime, M-sequence Capability, RevisionID, ProcessDataIn, ProcessDataOut, VendorID, DeviceID, FunctionID, transmission rate) - IO data configuration (Input data adjustable, mirror output data onto input data, increment input data) - Event configuration (maximum 6 events, unique, cyclic, depending on output) - ISDU configuration (all Indices) - Stack configuration |
| FR8 | SDCI functionality: - all transmission rates (4,8; 38,4; 230,4 kbit/s) - SIO-Mode - All valid M-sequence types (TYPE_0, TYPE_1_1, TYPE_1_2, TYPE_1_V, TYPE_2_1, TYPE_2_2, TYPE_2_3, TYPE_2_4, TYPE_2_5, TYPE_2_6, TYPE_2_V) - All specified IO configurations - All specified ISDU Indices - Direct Parameter page (Index 0 and 1) |
| FR9 | Trigger incidences: - Begin of start-up sequence (Wake-up is detected) - New Process Data cycle started - New SDCI M-sequence detected - Start of a new ISDU request detected - New ISDU response is generated - An Event is generated - Errors (checksum, parity, frame, protocol) |

3322

A.3.3 SMI Test Communication Server (STCS)

In order to perform an automated type testing, it is recommended for a Master manufacturer to provide an SMI Test Communication Server allowing the Master-Tester-Program to send and receive SMI service messages that carry the corresponding ArgBlocks. Send and receive is performed using the Transmission Control Protocol (TCP/IP) on Ethernet communication to the TCP/IP client of the Master-Tester-Program (see Figure A.20).

TCP/IP eliminates possible transmission errors and ensures that the transferred packages remain in the correct order. The Master-Tester-Program sends and receives the SMI service messages as described in [7] in serialized form and with Big-Endian encoding for multiple octet elements. The SMI service messages are self-contained as the receiving side can extract all the information necessary for decoding (length, Port, ClientID, etc.) from the octet stream. Thus, there is no need to add any overhead.

The STCS consists of a socket listener and a mapping logic converting SMI service messages into a form that can be understood by the Master (EUT). To establish a TCP/IP connection between Master-Tester-Program and STCS, the following sequence of steps is performed:

- a) STCS listens on a local port (preferred: 49850) to connection requests issued by the Master-Tester-Program,
- b) The Master-Tester-Program requests a connection from the STCS, which it shall accept,
- c) A port is created by the Master-Tester-Program and is connected to the corresponding STCS port,
- d) A socket is created on both ends of the connection, and the details of the connection are encapsulated by the socket,
- e) The Master-Tester-Program sends SMI request messages and receives SMI response messages or event messages,
- f) The STCS continues to listen for further connection requests.

The port number 49850 shall be used as default port number. If this port is not available or already in use, the next available port shall be used. Means for port number reassignment shall be provided both on the STCS and the Master-Tester-Program client. The following rules apply to the described TCP/IP connection:

- One STCS shall only correspond with one Master (EUT) instance,
- The STCS shall not store any status information including event queues. The Master-Tester-Program shall be responsible for queuing and processing events,
- The selected TCP/IP port number shall be within the dynamic, private port range (49152 to 65535). This range is used for private or customized services, for temporary purposes, and for automatic allocation of ephemeral ports.

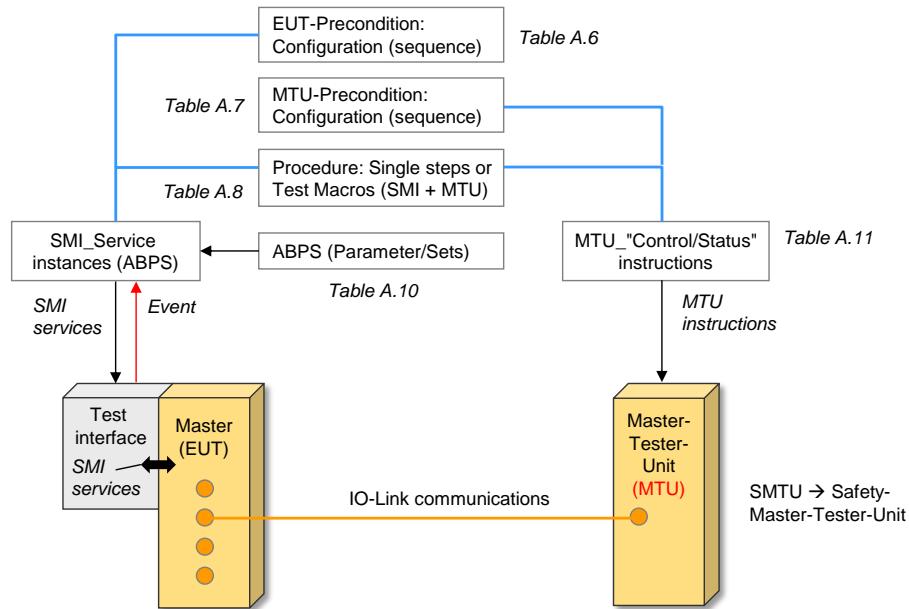
The following hints should be considered for the implementation of the STCS and the Master-Tester-Program client:

- It is not guaranteed over TCP/IP that the sent SMI service messages are transmitted within one TCP/IP package. Therefore, means for splitting and merging SMI service messages shall be part of the implementation of the STCS and the Master-Tester-Program.
- The communication interface is full duplex.
- This concept allows for parallel testing of several Master Ports using different STCS connection ports (> 49850).

3369 **A.4 Components of Master test cases**

3370 **A.4.1 Overview**

3371 SMI service instances and MTU-Instructions can be directly used to define test cases. In certain
 3372 cases, it is advantageous to use macros combining basic SMI service instances and/or MTU-
 3373 Instructions. Flow control expressions such as "wait until", "repeat from", etc. can supplement
 3374 these macros. Macros shall be named intuitively and shall be preceded by the prefix "TM_" for
 3375 test macro. Figure A.21 shows the components of Master test cases.



3376

3377 **Figure A.21 – Components of Master test cases**

3378 **A.4.2 EUT preconditions (Master Port)**

3379 Table A.6 shows preconditions of the EUT. They can represent a description of a state or a sequence of activities to reach a certain state of the EUT.

3381 **Table A.6 – Preconditions of the EUT**

3382 -CR090-

| Identifier | Description of state or activities to reach state |
|---|--|
| PORT_DI | Port is in DI Mode ; SMI_PortConfiguration |
| PORT_DO | Port is in DO Mode |
| PORT_INACTIVE | Port is in Inactive Mode |
| PORT_AUTOSTART | Port is in Autostart Mode |
| NOTE EUT that supports PortPowerOffOn (SMI_Masteridentification; Features_1, Bit 2 = 1), the port power shall be switched on (SMI_PortPowerOffOn; PortPower-mode = 2) before the SMI_Portconfiguration command is sent. | |

3383

3384 **A.4.3 MTU preconditions**

3385 Table A.7 shows macros of preconditions of the MTU playing the role of a controllable and
 3386 observable Device. They describe values (instances) of parameters of a state or a sequence of
 3387 activities to reach a certain state of the MTU.

3388 **Table A.7 – Preconditions of the MTU**

3389 -CR077-

| Identifier | Description of state or activities to reach state |
|--|--|
| MTU_STANDARD_STATE | <p>Transmission rate = 38,4 kbit/s DS_UPLOAD_FLAG = "0" DPP1(MinCycleTime) = 0x28 DPP1(M-sequenceCapability) = 0x11</p> <p>DPP1(RevisionID) = 0x11 (NOTE) DPP1(ProcessDataIn) = 0x08 DPP1(ProcessDataOut) = 0x08 DPP1(VendorID) = 0x02A4 0xFDE8 DPP1(DeviceID) = 002BD2 (NOTE) DPP1(FunctionID) = 0x0000 Device is activated Event flag = 0 PD status flag = 1 Mandatory Indices: Index 0x0010 (VendorName) = "IO-Link Community" ;UTF8 coding Index 0x0012 (ProductName) = "MTU" ;UTF8 coding Index 0x0003 (DataStorageIndex) = PARSET1 ;see Table A.13 All states and counters reset</p> |
| NOTE Only these IDs can be overwritten by Master for compatibility tests (see 8.5) | |
| Permitted values for RevisionID are: 0x11 and 0x10. | |

3390

3391 **A.4.4 TestMacros (TM) of the Master-Tester-Program**

3392 Table A.8 shows TestMacros of the Master-Tester-Program for both EUT (Master) and MTU.
 3393 All TestMacros shall return after ≤ 30 s (default Test_Timeout).

3394 **Table A.8 – TestMacros of the Master-Tester-Program**

3395 -CR055--CR053-

3396

| TestMacro identifier | Variable | Test Service Action to enter mode | Comment |
|----------------------|--|--|---|
| TM_AWAIT | Time | Pause "Time" (e.g. 2000) before next step | Milliseconds |
| TM_AWAIT_PORT_STATUS | NO_DEVICE, PORT_DIAG, OPERATE, PREOPERATE | a) TM_AWAIT_PORT_EVENT b) Check_EventCode = 0xFF26 c) a) Repeat SMI_PortStatus service until PortStatusList.PortStatusInfo = NO_DEVICE, or PORT_DIAG, or PREOPERATE, or OPERATE | Monitored by Test_Timeout |
| TM_AWAIT_DI_HIGH | – | Repeat SMI_PDI until PDI.PDI0 = 1 and PDI.PQI = 0x00 | Monitored by Test_Timeout |
| TM_AWAIT_PD_VALIDITY | VALID/ INVA-LID | Repeat SMI_PDI until PDI.PQI.PQ = "1" (VALID) or "0" (INVALID) | – |
| TM_MASTER_UPLOAD | PARSET1, PARSET2 (see Table A.13) | a) MTU_DS_SetParameter(<variable> b) SMI_PortConfiguration(ABPS_TYPE_ COMP, <Validation&Backup = 3>) c) TM_AWAIT_PORT_STATUS(OPERATE) d) SMI_DSToParServ e) MTU_DS_CheckUpload ;delete moni- ring states | Provides EUT and MTU with DS data ob- ject |

3397

3398 **A.4.5 SMI Event Handling**

3399 Since the SMI services SMI_DeviceEvent and SMI_PortEvent are initiated by the EUT, the "Test
 3400 interface driver" implementation shall provide a synchronous API to the Master-Tester-Program
 3401 (see Figure A.18). Events sent by the EUT shall be enqueued into a separate internal queue
 3402 data structure (one queue for Device Events, one queue for Port Events). The Master-Tester-
 3403 Program can access these queues by means of the functions in Table A.9.

Table A.9 – Event functions for Event tester handling

| Event function name | Parameter | Return value | Description |
|---------------------|-----------|--|---|
| DLL_ClearAllEvents | – | – | Clear both queues |
| DLL_GetPortEvents | minEP | List of PortEvents (Qualifier, Code) | Buffer up to minEP Port Events in queue or until timeout before returning the list. Ignores optional 0xFF26, 0xFF27, or vendor-specific Events. |
| DLL_GetDeviceEvents | minED | List of DeviceEvents (Qualifier, Code) | Buffer up to minED Device Events in queue or until timeout before returning the list |

A.4.6 SMI ArgBlock parameter sets (ABPS)

Table A.10 contains a list of ArgBlock parameter sets (ABPS). They contain predefined values for ArgBlock elements. The data types of the elements are specified in [7]. ABPS shall use the prefix "ABPS_".

ABPS names can be used in the description of SMI service instances. Predefined elements of an ABPS can be overwritten via the following syntax:

ABPS_xxxx<element1 = value, element2 = value, ...>

For example, ABPS_PORTTODI<VendorID = 286> uses all element definitions of the ABPS_- PORTTODI but replaces the default value "0" the element "VendorID" by the value "286".

Table A.10 – ArgBlock Parameter Sets (ABPS)

-CR108- -CR077- CR054- -CR057- -CR092- -CR045-

| ABPS | ArgBlock | Element | Type | Value |
|-------------------|----------------|-------------------|---------------|------------------|
| ABPS_VOIDBLOCK | VoidBlock | ArgBlockID | | 0xFFFF0 |
| ABPS_PORTTODI | PortConfigList | ArgBlockID | Unsigned16 | 0x8000 |
| | | PortMode | PortMode | PM_DI_CQ |
| | | Validation&Backup | DSType | No_Device_Check |
| | | I/Q behavior | IQ_Behavior | IQ_not_supported |
| | | PortCycleTime | Unsigned8 | 0 |
| | | VendorID | Unsigned8 | 0 |
| | | DeviceID | Unsigned8 | 0 |
| ABPS_PORTTODO | PortConfigList | ArgBlockID | Unsigned16 | 0x8000 |
| | | PortMode | PortMode | PM_DO_CQ |
| | | Validation&Backup | DSType | No_Device_Check |
| | | I/Q behavior | IQ_Behavior | IQ_not_supported |
| | | PortCycleTime | Unsigned8 | 0 |
| | | VendorID | Unsigned8 | 0 |
| | | DeviceID | Unsigned8 | 0 |
| ABPS_PORTINACTIVE | PortConfigList | ArgBlockID | Unsigned16 | 0x8000 |
| | | PortMode | PortMode | PM_DEACTIVATED |
| | | Validation&Backup | DSType | No_Device_Check |
| | | I/Q behavior | IQ_Behavior | IQ_not_supported |
| | | PortCycleTime | Unsigned8 | 0 |
| | | VendorID | Unsigned8 | 0 |
| | | DeviceID | Unsigned8 | 0 |
| ABPS_PORTPOWERON | PortPowerOffOn | ArgBlockID | Unsigned16 | 0x7003 |
| | | PortPowerMode | PortPowerMode | PP_Port_Power_On |

| ABPS | ArgBlock | Element | Type | Value |
|-------------------|-----------------|-------------------|-------------------|-----------------------------|
| | | PortPowerOffTime | Unsigned16 | 0 |
| ABPS_PORTPOWEROFF | PortPowerOffOn | ArgBlockID | Unsigned16 | 0x7003 |
| | | PortPowerMode | PortPowerMode | PP_Port_Power_Off |
| | | PortPowerOffTime | Unsigned16 | 0 |
| ABPS_DO_HIGH | PDOOut | ArgBlockID | Unsigned16 | 0x1002 |
| | | OE | PDOOutQualityInfo | PQ_PDOUTVALID |
| | | DO | Q_Value | Q_High |
| ABPS_DO_LOW | PDOOut | ArgBlockID | Unsigned16 | 0x1002 |
| | | OE | PDOOutQualityInfo | PQ_PDOUTVALID |
| | | DO | Q_Value | Q_Low |
| ABPS_TYPE_COMP | PortCycleTime | ArgBlockID | Unsigned16 | 0x8000 |
| | | PortMode | PortMode | PM_IOL_MANUAL |
| | | Validation&Backup | DSType | TYPE_compatible_Device_V1.1 |
| | | I/Q behavior | IQ_Behavior | IQ_not_supported |
| | | PortCycleTime | Unsigned8 | 0x28 |
| | | VendorID | Unsigned16 | 0x02A4 0xFDE8 |
| | | DeviceID | Unsigned8 | 0x002BD2 |
| ABPS_NOTYPE_CHECK | PortCycleTime | ArgBlockID | Unsigned16 | 0x8000 |
| | | PortMode | PortMode | PM_IOL_AUTO-START |
| | | Validation&Backup | DSType | No_Device_Check |
| | | I/Q behavior | IQ_Behavior | IQ_not_supported |
| | | PortCycleTime | Unsigned8 | 0x28 |
| | | VendorID | Unsigned16 | 0x02A4 0xFDE8 |
| | | DeviceID | Unsigned8 | 0x002BD2 |
| ABPS_DEVICEWRITE | On-request_Data | ArgBlockID | Unsigned16 | 0x3000 |
| | | Index | Unsigned16 | 0 |
| | | SubIndex | Unsigned8 | 0 |
| | | On-request-Data | Octet string | 0 |
| ABPS_DEVICEREAD | On-request_Data | ArgBlockID | Unsigned16 | 0x3001 |
| | | Index | Unsigned16 | 0 |
| | | SubIndex | Unsigned8 | 0 |
| ABPS_PDOUT | PDOOut | ArgBlockID | Unsigned16 | 0x1002 |
| | | OE | Unsigned8 | 1 |
| | | OutputDataLength | Unsigned8 | 1 |
| | | PDO0 | Unsigned8 | 0x00 |

3416

3417 **A.4.7 MTU instructions**3418 Table A.11 shows (fixed) instructions of the Master-Tester-Program for the MTU. Every MTU-
3419 instruction returns the specified parameters defined in "Return value".

Table A.11 – MTU instructions

| Name | Parameter | Return value | Definition |
|--------------------------|---|--------------|---|
| MTU_Startup_Check10 | – | TRUE/FALSE | Monitor whether Master connects to Device via standard start-up: a) Initiate wake-up b) Read DPP1 (Address 0x02 to 0x06) c) Write MasterCycleTime d) Write MasterCommand OPERATE e) Change to the appropriate M-sequence type (see TestCase) Reset monitoring states after invocation |
| MTU_Startup_GetLog | – | MessageLog | Returns a log of all Master messages at STARTUP |
| MTU_DPP1_Get | ParameterName | Value | Get parameter in full length from DPP1 (Direct Parameter Page 1) |
| MTU_DPP1_Set | ParameterName, Value | – | Set parameter in DPP1, e.g. MTU_DPP1_Set(VendorID = 0x02A4 0xFDE8) Values for PDIn and PDOOut lengths presented in bits |
| MTU_DS_CheckDownload | – | TRUE/FALSE | Monitoring Device activity a) Read Index 3 b) Master sends DS_DownloadStart c) Master writes Parameter d) Master sends DS_DownloadEnd Returns TRUE if sequence above was performed at least once since start-up Reset monitoring states after invocation and start-up |
| MTU_DS_CheckDSCommands | – | TRUE/FALSE | Monitoring Device activity whether DS_Download commands or DS_Upload commands have been performed. Reset monitoring states after invocation and start-up |
| MTU_DS_CheckParameter | PARSET1, or PARSET2 | TRUE/FALSE | Returns TRUE if requested PARSET is active |
| MTU_DS_CheckUpload | – | TRUE/FALSE | Checks Device activity a) Read Index 3 b) Master sends DS_UploadStart c) Master reads Parameter d) Master sends DS_UploadEnd Returns TRUE if sequence above was performed at least once since start-up Reset monitoring states after invocation and start-up |
| MTU_DS_Locked | – | – | Parameter DeviceAccessLocks.DataStorage = locked Parameter DSIndex.StateProperty = "Data Storage locked" |
| MTU_DS_SetMaxDataStorage | MAXDATA, or MAXINDEXLIST | – | Activates Index_List MAXINDEXLIST or MAXDATA as shown in Table A.11 |
| MTU_DS_SetParameter | PARSET1, or PARSET2 | – | MTU activates PARSET1 or PARSET2 (see Table A.13) |
| MTU_DS_SetUpload | Flag_off, or Flag_on, or Event | TRUE/FALSE | Set upload behavior on MTU side: Sets/resets DS_UPLOAD_FLAG or raises a DS_UPLOAD_REQ Event and sets DS_UPLOAD_FLAG. |
| MTU_DS_SetError | IndexList_err, or R_Index19_err, or W_Index19_err | – | MTU to generate ErrorType = 0x8023 "Access denied". Either via - IndexList_err: Read on Index 3, Subindex 05 - R_Index19_err: Read on Index 19 - W_Index19_err: Write on Index 19 |

| Name | Parameter | Return value | Definition |
|-------------------------------------|--|--|--|
| MTU_DS_Wait | DS_BREAK, or DS_DOWN- LOADEND, or DS_UPLOAD END | – | MTU delays processing until it detects the chosen parameter. Monitored by Test_Timeout. |
| MTU_Event_CheckNoDetail | – | TRUE/FALSE | Check if Master reads Event without details and acknowledges within Test_Timeout a) Read Event StatusCode (address "0") in next cycle b) Write Event StatusCode (address "0") within Test_Timeout c) Master does not read other Event memory addresses |
| MTU_Event_Clear | – | – | Clear all values in Event memory |
| MTU_Event_SetStatusCode | code | – | Set StatusCode of the Event memory (address "0") to "code" |
| MTU_Event_SetSlot | Slot number, Qualifier, Code | – | Set Event Qualifier and Code of slot number in the Event memory |
| MTU_Event_Trigger- AndWaitForAck | – | Statuscode- Read, AllSlotsRead, Acknowledge | a) Set Event flag in Msequence.CKS b) Wait until Master Write to StatusCode (address "0" in Event memory, acknowledge) or until Test-Timeout. c) Return StatusCodeRead = TRUE if Master read the StatusCode d) Return AllSlotsRead = TRUE if Master read all Qualifier and Code values of the activated Events (indicated by StatusCode, always TRUE for StatusCode type 1) e) Return Acknowledge = TRUE if Master wrote to StatusCode and = FALSE upon Test-Timeout |
| MTU_Event_ISDUIinterrupted | – | TRUE/FALSE | Return TRUE if the master switched to communication channel Diagnosis while last ISDU transfer was running |
| MTU_Event_SetFlag | – | – | In PREOPERATE, OPERATE: Set Event flag in MSequence.CKS immediately. Else: Set Event flag when PREOPERATE is reached. |
| MTU_ISDU_Add | Index, Subindex, Value (Octet- String), ErrorType_W, ErrorType_R, Specialty | – | Adds virtual ISDU to parameter-space. Length of OctetString reflects size ([0x01, 0x02...]). Master Read or Write instruction returns ErrorType_R/W as defined in Table C.1. [7] respectively, for example 0x8033. Specialties see Table A.14. |
| MTU_ISDU_Read | Index, Subindex, | Value (Octet- String) | Returns ISDU Parameter content as OctetString value |
| MTU_ISDU_TrailingIdles | – | NumIdles | Return minimum number of "IDLE 1" requests between ISDU services. Reset monitoring states after invocation. |
| MTU_ISDU_Write | Index, Subindex, Value (Octet- String) | – | Writes Value defined as OctetString to virtual or real ISDU. |
| MTU_PD_Get | – | OctetString | Return PDout values |
| MTU_PD_Set | OctetString | – | Set PDin values |
| MTU_State_Activate | – | – | Enable response to Master request |
| MTU_State_Deactivate | – | – | Disable response to Master request |
| MTU_State_BlockFallback | n | – | MTU does not respond to the next n Fallback commands |

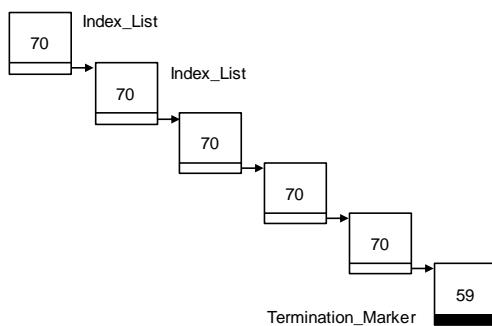
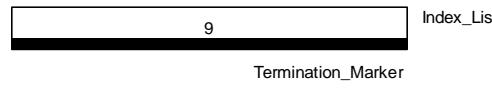
| Name | Parameter | Return value | Definition |
|---|-------------------|--|---|
| MTU_State_CheckFallback | – | TRUE/FALSE | Observe whether MasterCommand "Fallback" has been sent |
| MTU_State_CheckOperate | – | TRUE/FALSE | TRUE if MTU is in OPERATE |
| MTU_State_CheckPreoperate | – | NONE/REACHED/PASSED | MTU returns information on occurrence of state PREOPERATE. Reset after invocation. Reset when the communication is restarted (STARTUP state is entered) |
| MTU_State_GetMasterRetryCTviolCount | – | RETRIES, CTVIOLS | Provides Retries and CycleTime violations. Values shall be cleared after performance. |
| MTU_State_CountRestarts | – | Restarts | MTU counts number of MTU restarts. Reset after invocation. |
| MTU_State_IncorrectChecksums | n | – | n reply messages to Master with incorrect checksums |
| MTU_State_MirrorPD | – | – | Applies only for PDInLength = PDOutLength. Mirrors PDOut to PDIn within the same M-sequence. |
| MTU_State_SkipReplyMessages MTU_State_SkipResponse | n WURQ | – | Skip n reply messages to Master (at the expected COM speed). If WURQ = TRUE responses are skipped at wake up sequence, default WURQ = FALSE |
| MTU_State_SetPDValidity | VALID, or INVALID | – | Set PD validity to a given value. The MTU decides if it will propagate the information via flag (V1.1) or via Event (V1.0) whenever validity changed |
| MTU_Timing_Startup | – | TDWU12 TDWU23 WURQ WURQ101-500 TSD TDMT(COM1) TDMT(COM2) TDMT(COM3) | Returns timing measurement values in ms during start-up |
| MTU_Timing_GetTinicyc-InStartup | – | Min | Measure cycle times in STARTUP (minimum recovery time) |
| MTU_Timing_GetTinitcyc-InPreoperate | – | Min | Measure cycle times in PREOPERATE |
| MTU_Timing_GetTcyc-InOperate | – | Min | Measure cycle times in OPERATE during 20 Master cycles |
| MTU_Timing_SetReplyMessageDelay | TA, or T2 | – | in TBIT; default values: TA = 5 TBIT, T2 = 0 TBIT |
| MTU_Timing_SetCommunicationMode | COM1, COM2, COM3 | – | Transmission rates: COM1 = 4,8 kbit/s COM2 = 38,4 kbit/s COM3 = 230,4 kbit/s |
| MTU_Timing_GetT1 | – | Max | Measure the delays between the end of the stop bit and the beginning of the start bit of the next octet |

3421

3422 **A.4.8 MTU data sets**3423 **A.4.8.1 MTU Index lists for Data Storage tests**3424 Table A.12 shows the two data sets used for Data Storage testing of Masters (see Table B.10
3425 and G.1 in [7]).

3426

Table A.12 – MTU Index lists for Data Storage tests

| Item | MAXINDEXLIST (Concatenated) | MAXDATA per object |
|-------------------|--|---|
| DataStorage Index | Index 3, Subindex 03 (Data_Storage_Size) = maximum size (2048 octets) | Index 3, Subindex 03 (Data_Storage_Size) = size (2048 octets) |
| Index_List | Six concatenated Index_Lists. Five of them with 70 entries, the sixth with 59 entries plus Termination_Marker  | Single Index_List contains 9 entries (X1 to X9) plus Termination_Marker.  |
| Entries | 408 Objects (2 octets Index, 1 octet Subindex, 1 octet length) with 1 octet data length > 2040 octets. | 8 objects with 232 octets data length plus 1 object with 156 octets data length. This leads to a total size of 8 x (4+232) + 1 x (4+156) = 2048 octets for the structure defined in Annex G.1 in [7]. |

3427

A.4.8.2 MTU parameter sets

3428 Table A.13 shows the parameter sets used for MTU instructions "MTU_DS_SetParameter" and "MTU_DS_CheckParameter" (see Table A.11).

Table A.13 – MTU parameter sets

3432 -CR098-

| Name | Content 1 | Content 2 |
|---------|---|--|
| PARSET1 | Index: 49 64 Subindex 1: [0x12, 0x34] Subindex 2: [0x35, 0x69] | Index: 20 256 Subindex1: [0x79, 0x85] Subindex2: [0x92, 0x23] |
| PARSET2 | Index: 49 64 Subindex 1: [0x47, 0x11] Subindex 2: [0x98, 0x76] | Index: 20 256 Subindex 1: [0x97, 0x85] Subindex 2: [0x40, 0x40] |

3433

A.4.8.3 MTU specialties

3435 -CR052-

3436 Table A.14 shows specialties used for MTU instructions "MTU_ISDU_Add" and "MTU_ISDU_Write" (see Table A.11).

Table A.14 – MTU specialties

| Name | Definition |
|----------------|---|
| NO_DEVICE_BUSY | MTU generates an immediate response to the ISDU request without indicating "Device busy" (no I-Service/Length = 0x01 responses, see Table A.14 in [7]). |
| DEVICE_BUSY | MTU responds to the ISDU request indicating "Device busy" (at least one I-Service/Length = 0x01 response, see Table A.14 in [7]) |
| ISSUE_EVENT | Event (DL, Error, Event single shot, EventCode = "0x5200") |
| TIMEOUT | Device does not respond (protocol error) |

| Name | Definition |
|------------------------|--|
| INCORRECT_SERVICE_CODE | Device responds with incorrect service code (I-Service/Length = 0x02, see Table A.14 in [7]) (sequence) (protocol error) |
| INCORRECT_CHKPDU | Device creates incorrect CRC signature within response (protocol error) |
| RESERVED_DATA_LENGTH | Device uses reserved combinations of iService and length (I-Service/Length = 0x10, see Table A.14 in [7]) |
| EVENT | Set the Event flag bit in M-sequence.CKS on the next M-sequence after flowCTRL = 2 for the ISDU request/response on ISDU Write/Read access |
| NO_SERVICE | MTU responds directly (no busy responses) with “No service” (I-Service/Length = 0x00 response, see Table A.14 in [7]) |

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Annex B
(normative)

Supplement to the legacy specification V1.0

3443

B.1 General

3444 The definitions in [7] are more comprehensive than the definitions in the predecessor [5]. In
3445 order to establish a reliable interoperation of legacy Master and Devices with their SDCI coun-
3446 terparts it is necessary to supplement the predecessor specification [5] by a few clarifications.

3447

B.2 Legacy-Master power-on driver capability

3448 If the actual power-on driver capability does not meet the requirements defined in [7], the meas-
3449 ured value(s) of TC_0002 (5.2.2) shall be documented in the user manual of the Legacy-Master.

3450

B.3 Legacy-Device power-on current consumption

3451 If the actual power-on current consumption does not meet the requirements defined in [7], the
3452 measured value(s) of TC_0012 (5.3.2) shall be documented in the user manual of the Legacy-
3453 Device.

3454

B.4 ISDU request and response abort

3455 The "abort" feature is not specifically defined in [5]. All Legacy-Devices shall have implemented
3456 this behavior, which is tested in TC_0067 (6.5.17) and TC_0068 (6.5.18).

3457

B.5 "Device 1.1" connected to a "Master 1.0"

3458 A manufacturer or vendor of a Device without backward compatibility (V1.0 not supported) shall
3459 document in product sheet or user manual that the Device supports IO-Link V1.1 only (6.8.2.2).

3460

B.6 Maximum MasterCycleTime

3461 The maximum MasterCycleTime for both Master and Legacy-Master is 134 ms. This limit is
3462 checked in TC_0089 (6.9.1).

3463

B.7 Maximum MinCycleTime

3464 The maximum MinCycleTime for both Device and Legacy-Device is 134 ms. This limit is
3465 checked in TC_0090 (6.9.2).

3466

B.8 Write access to reserved system commands

3467 The following System commands shall not be tested in Legacy-Devices: 0x5A; 0x8D to 0x8F;
3468 0x97 to 0x99.

3469 A Write access to reserved system commands within a Legacy-Device returns a negative re-
3470 sponse: PAR_VALOUTOFRNG (0x8030). TC_0104 (6.10.2) is affected.

3471

B.9 Time-out for Write access to system commands

3472 Legacy-Devices shall respond within 5 s.

3473

B.10 Text string length for Application Specific Tag

3474 Existing Legacy-Devices are permitted to have text string length <16 octets. In this case, the
3475 manufacturer or vendor shall document the text string length in the user manual. It is highly
3476 recommended to provide a minimum of 16 octets. TC_0122 (6.10.19) and TC_0123 (6.10.20)
3477 are affected.

3478 **B.11 Write access with invalid length**

3479 A Write access to reserved system commands within a Legacy-Device returns a negative re-
3480 sponse: PAR_VALOUTOFRNG (0x8030). TC_0141 (6.10.32) and TC_0142 (6.10.33) are af-
3481 fected.

3482 **B.12 IODD "reset to factory settings" verification**

3483 It is highly recommended for Legacy-Devices to show the behavior defined in [7]. Deviations
3484 shall be documented in the user manual. TC_0155 (0) is affected.

3485 **B.13 Fallback in PREOPERATE**

3486 If the Master does not support the Fallback through a command from the upper-level system
3487 such as a fieldbus, the manufacturer or vendor of the Device or Legacy-Device respectively
3488 shall document the restriction or behavior in the user manual. TC_0213 (8.8.1) and TC_0214
3489 (8.8.2) are affected.

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Annex C
(normative)
Listing of test cases

3494

C.1 Listing of test cases sorted by IDs

3495 Table C.1 shows the Test cases and its references.

3496 **Table C.1 – Test cases sorted by IDs**

| SDCI TC ID | TC Name | Reference |
|------------|------------------------------|-----------|
| TC_0001 | TCM_PHYL_INTF_ISM | Table 7 |
| TC_0002 | TCM_PHYL_INTF_ISIRM | Table 8 |
| TC_0003 | TCM_PHYL_INTF_ILLM | Table 9 |
| TC_0004 | TCM_PHYL_INTF_VRESHIGH | Table 10 |
| TC_0005 | TCM_PHYL_INTF_VRESLOW | Table 11 |
| TC_0006 | TCM_PHYL_INTF_VTHHM | Table 12 |
| TC_0007 | TCM_PHYL_INTF_VTHLM | Table 13 |
| TC_0008 | TCM_PHYL_INTF_VHYSM | Table 14 |
| TC_0011 | TCD_PHYL_INTF_ISD | Table 17 |
| TC_0012 | TCD_PHYL_INTF_ISIRD | Table 18 |
| TC_0013 | TCD_PHYL_INTF_VRESHIGH | Table 20 |
| TC_0014 | TCD_PHYL_INTF_VRESLOW | Table 21 |
| TC_0015 | TCD_PHYL_INTF_IQDD | Table 22 |
| TC_0016 | TCD_PHYL_INTF_VTHHD | Table 23 |
| TC_0017 | TCD_PHYL_INTF_VTHLD | Table 24 |
| TC_0018 | TCD_PHYL_INTF_VHYS | Table 25 |
| TC_0021 | TCM_PHYL_INTF_IQWUH | Table 28 |
| TC_0022 | TCM_PHYL_INTF_TWUH | Table 29 |
| TC_0023 | TCM_PHYL_INTF_IQWUL | Table 30 |
| TC_0024 | TCM_PHYL_INTF_TWUL | Table 31 |
| TC_0025 | TCD_PHYL_INTF_TWUH | Table 32 |
| TC_0026 | TCD_PHYL_INTF_TWUL | Table 33 |
| TC_0027 | TCD_PHYL_INTF_TRENHIGH | Table 34 |
| TC_0028 | TCD_PHYL_INTF_TRENLOW | Table 35 |
| TC_0029 | TCD_PHYL_INTF_TRDL | Table 36 |
| TC_0030 | TCM_PHYL_INTF_BITEYEMAXLOAD | Table 39 |
| TC_0031 | TCM_PHYL_INTF_BITEYEMINLOAD | Table 41 |
| TC_0032 | TCM_PHYL_INTF_UARTEYEMAXLOAD | Table 43 |
| TC_0033 | TCM_PHYL_INTF_UARTEYEMINLOAD | Table 45 |
| TC_0034 | TCD_DLPC_STUP_CYCTIME | Table 52 |
| TC_0035 | TCD_DLPC_STUP_STUPOPER1 | Table 53 |
| TC_0036 | TCD_DLPC_STUP_STUPOPER2 | Table 55 |
| TC_0037 | TCD_DLPC_OPER_OPERSTUP1 | Table 56 |
| TC_0038 | TCD_DLPC_OPER_OPERSTAR2 | Table 57 |
| TC_0039 | TCD_DLPC_PROP_READDPP1 | Table 58 |
| TC_0040 | TCD_DLPC_PROP_WRITEDPP1 | Table 59 |

| | | |
|---------|---------------------------------------|-----------|
| TC_0041 | TCD_DLPC_PROP_SHORTMESSAGE | Table 60 |
| TC_0043 | TCD_DLPC_PROP_SIMRESET | Table 61 |
| TC_0044 | TCD_DLPC_PROP_MSEQFAULT | Table 62 |
| TC_0045 | TCD_DLPC_OPER_READ | Table 63 |
| TC_0046 | TCD_DLPC_OPER_WRITE | Table 64 |
| TC_0047 | TCD_DLPC_OPER_NEGWRITE | Table 65 |
| TC_0049 | TCD_DLPC_OPER_SIMRESET | Table 66 |
| TC_0052 | TCD_DLPC_ISDU_AVAILMSEQCAP | Table 69 |
| TC_0053 | TCD_DLIC_ISDU_IDLEBUSYCHECK | Table 70 |
| TC_0054 | TCD_DLIC_ISDU_READINDEX8 | Table 71 |
| TC_0055 | TCD_DLIC_ISDU_READ8EXTLENGTH | Table 72 |
| TC_0056 | TCD_DLIC_ISDU_WRITE8 | Table 73 |
| TC_0057 | TCD_DLIC_ISDU_READ8RESERVED | Table 74 |
| TC_0058 | TCD_DLIC_ISDU_READ8NOSUBINDEX | Table 75 |
| TC_0059 | TCD_DLIC_ISDU_READ16 | Table 76 |
| TC_0060 | TCD_DLIC_ISDU_WRITE16 | Table 77 |
| TC_0061 | TCD_DLIC_ISDU_READ16RESERVED | Table 78 |
| TC_0062 | TCD_DLIC_ISDU_READ16NOSUBINDEX | Table 79 |
| TC_0063 | TCD_DLIC_ISDU_WRITE8LENVERRUN | Table 80 |
| TC_0064 | TCD_DLIC_ISDU_WRITE8WRONGLEN | Table 81 |
| TC_0065 | TCD_DLIC_ISDU_WRITE8WRONGCHECKSUM | Table 82 |
| TC_0066 | TCD_DLIC_ISDU_WRITE8ROIINDEX | Table 83 |
| TC_0067 | TCD_DLIC_ISDU_ABORTREADREQ | Table 84 |
| TC_0068 | TCD_DLIC_ISDU_ABORTREADRESP | Table 85 |
| TC_0069 | TCD_DLIC_EVNT_OPERSINGLEEVENT | Table 87 |
| TC_0070 | TCD_DLIC_EVNT_PROPSINGLEEVENT | Table 88 |
| TC_0071 | TCD_DLIC_EVNT_OPEREVENTCLEAR | Table 89 |
| TC_0072 | TCD_DLIC_EVNT_OPERCOMMINTERRUPT | Table 90 |
| TC_0073 | TCD_DLIC_EVNT_OPERPOWERINTERRUPT | Table 91 |
| TC_0074 | TCD_DLIC_EVNT_OPERAPPEARDISAPPEAR | Table 92 |
| TC_0075 | TCD_DLIC_EVNT_OPERMULTEVENT | Table 93 |
| TC_0076 | TCD_DLIC_EVNT_OPERSHORTEVENT | Table 94 |
| TC_0077 | TCD_APPS_DSUP_NOFLAG | Table 95 |
| TC_0078 | TCD_APPS_DSUP_VIADOWNLOADSTORE | Table 96 |
| TC_0079 | TCD_APPS_DSUP_VIADOWNLOADSTORENOWRITE | Table 97 |
| TC_0080 | TCD_APPS_DSUP_VIALOCALCHANGE | Table 98 |
| TC_0081 | TCD_APPS_DSUP_PARABREAKABORT | Table 99 |
| TC_0082 | TCD_APPS_DSDN_PARAMODIFICATION | Table 100 |
| TC_0083 | TCD_APPS_DSDN_FACTORYRESET | Table 101 |
| TC_0084 | TCD_APPS_DSDN_PARABREAKABORT | Table 102 |
| TC_0085 | TCD_DLIC_COMP_STARTUP | Table 105 |
| TC_0086 | TCD_DLIC_COMP_TYPE1INTERLEAVE | Table 106 |
| TC_0087 | TCD_DLIC_COMP_PDINVALIDEVENT | Table 107 |
| TC_0089 | TCD_DLPC_STDP_MASTERCYCLETIME | Table 108 |
| TC_0090 | TCD_DLPC_STDP_MINCYCLETIME | Table 109 |

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|---------|-------------------------------------|-----------|
| TC_0091 | TCD_DLPC_STDP_MSEQCAPABILITY | Table 110 |
| TC_0092 | TCD_DLPC_STDP_REVISIONID | Table 111 |
| TC_0093 | TCD_DLPC_STDP_PDIN | Table 112 |
| TC_0094 | TCD_DLPC_STDP_PDOUT | Table 113 |
| TC_0095 | TCD_DLPC_STDP_VENDORID | Table 114 |
| TC_0096 | TCD_DLPC_STDP_DEVICEID | Table 115 |
| TC_0097 | TCD_DLPC_STDP_FUNCTIONID | Table 116 |
| TC_0101 | TCD_DLPC_STDP_WRITERESPAR | Table 117 |
| TC_0104 | TCD_DLIC_DEFP_SYSCMDRES | Table 118 |
| TC_0107 | TCD_DLIC_DEFP_DSINDEX | Table 119 |
| TC_0108 | TCD_DLIC_DEFP_DSRECORD | Table 120 |
| TC_0109 | TCD_DLIC_DEFP_ACCESSLOCKSVAL | Table 122 |
| TC_0110 | TCD_DLIC_DEFP_ACCESSLOCKSINVAL | Table 123 |
| TC_0111 | TCD_DLIC_DEFP_PROFILCHARAC | Table 124 |
| TC_0112 | TCD_DLIC_DEFP_PDINDESC | Table 125 |
| TC_0113 | TCD_DLIC_DEFP_PDOUTDESC | Table 126 |
| TC_0114 | TCD_DLIC_DEFP_VENDORNAM | Table 127 |
| TC_0115 | TCD_DLIC_DEFP_VENDORTEXT | Table 128 |
| TC_0116 | TCD_DLIC_DEFP_PRODUCTNAM | Table 129 |
| TC_0117 | TCD_DLIC_DEFP_PRODUCTID | Table 130 |
| TC_0118 | TCD_DLIC_DEFP_PRODUCTTEXT | Table 131 |
| TC_0119 | TCD_DLIC_DEFP_SERNUM | Table 132 |
| TC_0120 | TCD_DLIC_DEFP_HARDREV | Table 133 |
| TC_0121 | TCD_DLIC_DEFP_FIRMREV | Table 134 |
| TC_0122 | TCD_DLIC_DEFP_TAGVALID | Table 135 |
| TC_0123 | TCD_DLIC_DEFP_TAGINVALID | Table 136 |
| TC_0124 | TCD_DLIC_DEFP_ERRCOUNT | Table 137 |
| TC_0128 | TCD_DLIC_DEFP_DEVSTAT | Table 138 |
| TC_0129 | TCD_DLIC_DEFP_DETAILDEVSTAT | Table 139 |
| TC_0130 | TCD_DLIC_DEFP_DETAILDEVSTATINACTIVE | Table 140 |
| TC_0131 | TCD_DLIC_DEFP_DETAILDEVSTATACTIVE | Table 141 |
| TC_0132 | TCD_DLIC_DEFP_PDIN | Table 142 |
| TC_0133 | TCD_DLIC_DEFP_PDOUT | Table 143 |
| TC_0134 | TCD_DLIC_DEFP_OFFSETTIMEVALID | Table 144 |
| TC_0136 | TCD_DLIC_DEFP_PROFILEPARREAD | Table 145 |
| TC_0137 | TCD_DLIC_DEFP_PROFILEPARWRITE | Table 146 |
| TC_0140 | TCD_DLIC_DEFP_WRISETOREADONLY | Table 147 |
| TC_0141 | TCD_DLIC_DEFP_WRISETOOSHORT | Table 148 |
| TC_0142 | TCD_DLIC_DEFP_WRISETOOLONG | Table 149 |
| TC_0143 | TCD_DSBP_APPL_BPDOWNLOAD | Table 150 |
| TC_0144 | TCD_DSBP_APPL_BPBREAKCMD | Table 151 |
| TC_0145 | TCD_DSBP_APPL_BPBREAKRESET | Table 152 |
| TC_0146 | TCD_DSBP_APPL_BPBREAKILLPARAM | Table 153 |
| TC_0147 | TCD_DSBP_APPL_BPBREAK2DOWNLOADS | Table 154 |
| TC_0148 | TCD_DSBP_APPL_BPBREAKLOCALLOCK | Table 155 |

| | | |
|---------|-----------------------------------|-----------|
| TC_0149 | TCD_IODD_PARV_IDENT | Table 163 |
| TC_0150 | TCD_IODD_PARV_COMPROFILE | Table 164 |
| TC_0151 | TCD_IODD_PARV_READVERIFY | Table 165 |
| TC_0152 | TCD_IODD_PARV_WRITEVERIFY | Table 166 |
| TC_0155 | TCD_IODD_PARV_FACTORYSETTINGS | Table 171 |
| TC_0156 | TCD_IODD_PARV_ACCESSLOCK | Table 168 |
| TC_0157 | TCD_IODD_PARV_INDEXCONSISTENT | Table 167 |
| TC_0158 | TCM_PHYL_TIME_TDMT | Table 175 |
| TC_0159 | TCM_PHYL_TIME_TDWF | Table 176 |
| TC_0160 | TCM_PHYL_TIME_NUMOFWURQS | Table 177 |
| TC_0161 | TCM_PHYL_TIME_TSD | Table 178 |
| TC_0162 | TCM_PHYL_TIME_TINITCYC | Table 179 |
| TC_0163 | TCM_PHYL_TIME_MASTERCYCLETIME | Table 183 |
| TC_0164 | TCM_PHYL_TIME_MASTERCYCLETIMEREAL | Table 184 |
| TC_0165 | TCM_PHYL_TIME_DEVRESPTIMES | Table 185 |
| TC_0166 | TCM_PHYL_TIME_UARTT2 | Table 186 |
| TC_0167 | TCM_PHYL_TIME_UARTT1 | Table 187 |
| TC_0168 | TCM_DLDP_CYCC_TYPE21BIT8IN | Table 188 |
| TC_0169 | TCM_DLDP_CYCC_TYPE22BIT16IN | Table 189 |
| TC_0170 | TCM_DLDP_CYCC_TYPE23BIT8OUT | Table 190 |
| TC_0171 | TCM_DLDP_CYCC_TYPE24BIT16OUT | Table 191 |
| TC_0172 | TCM_DLDP_CYCC_TYPE25BIT8INBIT8OUT | Table 192 |
| TC_0173 | TCM_DLDP_CYCC_TYPE1OCTET32IN | Table 194 |
| TC_0176 | TCM_DLDP_CYCC_MIRRORREPD | Table 197 |
| TC_0177 | TCM_DLDP_CYCC_PDINVALID | Table 198 |
| TC_0178 | TCM_DLDP_CYCC_PDVALID | Table 199 |
| TC_0179 | TCM_DLOD_CYCC_TYPE2VPDXOD1 | Table 200 |
| TC_0180 | TCM_DLOD_CYCC_TYPE2VPDXOD2 | Table 201 |
| TC_0181 | TCM_DLOD_CYCC_TYPE2VPDXOD8 | Table 202 |
| TC_0182 | TCM_DLOD_CYCC_TYPE2VPDXOD32 | Table 203 |
| TC_0183 | TCM_DLST_CHCK_COMPAREAM | Table 205 |
| TC_0184 | TCM_DLST_CHCK_VIDDID | Table 206 |
| TC_0185 | TCM_DLST_CHCK_V10VIDDID | Table 207 |
| TC_0186 | TCM_DLST_CHCK_NONCONFVIDDID | Table 208 |
| TC_0187 | TCM_DLST_CHCK_CONFVIDDID | Table 209 |
| TC_0188 | TCM_DLST_CHCK_OVERDIDOK | Table 210 |
| TC_0189 | TCM_DLST_CHCK_OVERDIDNOK | Table 211 |
| TC_0190 | TCM_DLST_CHCK_OVERRIDNOK | Table 212 |
| TC_0192 | TCM_DLST_CHCK_VIDDIDNONCONFIG | Table 213 |
| TC_0193 | TCM_DLST_CHCK_VIDDIDCONFIG | Table 214 |
| TC_0194 | TCM_DLST_CHCK_DIDWRONG | Table 215 |
| TC_0202 | TCM_DLOD_PREP_TYPE0READOD1 | Table 217 |
| TC_0203 | TCM_DLOD_PREP_TYPE12READOD2 | Table 218 |
| TC_0204 | TCM_DLOD_PREP_TYPE1VREADOD8 | Table 219 |
| TC_0205 | TCM_DLOD_PREP_TYPE1VREADOD32 | Table 220 |

| | | |
|---------|---|-----------|
| TC_0206 | TCM_DLOD_PREP_TYPE0WRITEOD1 | Table 221 |
| TC_0207 | TCM_DLOD_PREP_TYPE12WRITEOD2 | Table 222 |
| TC_0208 | TCM_DLOD_PREP_TYPE1VWRITEOD8 | Table 223 |
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Annex D
(informative)
Information on conformity testing of SDCI

3502 Information about testing Masters and Devices for conformity with [6] and [7] can be obtained
3503 from the following organization:

3504 **IO-Link Community**
3505 Haid-und-Neu-Str. 7
3506 76131 Karlsruhe
3507 Germany
3508 Phone: +49 (0) 721 / 96 58 590
3509 Fax: +49 (0) 721 / 96 58 589
3510 E-mail: info@io-link.com
3511 Web site: <http://www.io-link.com>
3512

3513 Usually, type testing of Master or Device is completed by a manufacturer declaration, which
3514 can be downloaded from the IO-Link website www.io-link.com.

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IO-Link Community
Ohiostrasse 8
76149 Karlsruhe
Germany
Phone: +49 (0) 721 / 98 61 97 0
Fax: +49 (0) 721 / 98 61 97 11
e-mail: info@io-link.com
<http://www.io-link.com/>



IO-Link